CR-128921

Final Report

NASA-MSC CONTRACT NO. NAS 9-12452 DRL NO. T-728, LINE ITEM NO. 4 DRD NO. MA-183T

ENVIRONMENTAL CONTROL SYSTEM TRANSDUCER DEVELOPMENT STUDY

72-8537-1

February 10, 1973

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Prepared for

NASA Manned Spacecraft Center Houston, Texas 77058



AIRESEARCH MANUFACTURING COMPANY
Los Angeles, California

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ABSTRACT

A failure evaluation of the transducers used in the environmental control systems of the Apollo command service module, lunar module, and portable life support system is presented in matrix form for several generic categories of transducers to enable identification of chronic failure modes. Transducer vendors were contacted and asked to supply detailed information. The evaluation data generated for each category of transducer were compiled and published in failure design evaluation reports which are contained in the Appendix of this report. The evaluation reports also present a review of the failure and design data for the transducers and suggest both design criteria to improve reliability of the transducers and, where necessary, design concepts for required redesign of the transducers. Remedial designs were implemented on a family of pressure transducers and on the oxygen flow transducer. The design concepts were subjected to analysis, breadboard fabrication, and verification testing. The results of this work are included in this report.

CONTENTS

Section		Page
1	INTRODUCTION AND SUMMARY	1-1
	Study Objectives	1-1
	Background	1 - 1
	Program Scope	1-1
	Summary of Program Activities	1-3
	Accomplishments and Conclusions	1-3
	Report Organization	1-5
2	STUDY METHODOLOGY	2-1
	General Methods and Approach	2-1
	Transducer Evaluation	2-3
	Design Concept	2-9
	Verification Testing	2-14
	Design Criteria	2-14
3	PRESSURE TRANSDUCERS	3-1
	Transducer Evaluation	3-1
	Design Concept	3-1
	Verification Testing	3-8
	Design Criteria	3-8
	Unresolved Problems	3-8
4	TEMPERATURE TRANSDUCERS	4-1
	Transducer Evaluation	4-1
	Resistance - Temperature Characteristics	4-1
	Purpose	4-3
	Description	4-3
	Temperature Signal Amplifier	4-4
	Purpose	4 – 4
	Parformance and Design Data	1 1.

CONTENTS (Continued)

Section		Page
	Design Concept	4-6
	Verification Testing	4-6
	Design Criteria	4-6
	Unresolved Problem	4-6
5	FLOW TRANSDUCERS	5-1
	Transducer Evaluation	5-1
	Design Concept	5-5
	Sensor Development	5-7
	Results of Sensor Tests	5-9
	Electronic Circuit Design Considerations	5-11
	Electronic Circuit Analysis and Test	5-12
	Transducer Mechanical Features	5-14
	Flow Transducer Package Outline	5-16
	Verification Testing	5-16
	Design Criteria	5-18
	Conclusions	5-18
	Recommendations for Future Work	5-18
	EXHIBIT 5A: OXYGEN FLOWMETER MODIFICATION STUDY STATEMENT OF WORK	5A-1
	EXHIBIT 5B: SENSOR TEST DATA SHEETS	5B-1
	EXHIBIT 5C: VIBRATION TEST REPORT	5C-1
6	SPEED SENSORS	6-1
7	PRESSURE SWITCHES	7-1
8	VALVE POSITION INDICATING SWITCHES	8-1
	Transducer Evaluation	8-1
	Design Concept	8-1
	Verification Testing	8-1
	Design Criteria	8-1
Appendix	FAILURE AND DESIGN EVALUATION OF APOLLO ECS	A-1



SECTION 1

INTRODUCTION AND SUMMARY

STUDY OBJECTIVES

The objective of this study was the evaluation of spacecraft environmental control system (ECS) transducer failures, and the origination and development of techniques for the correction of chronic transducer failure mechanisms. During the study the existing space-flight-qualified Apollo transducers were compared to those required by future spacecraft, and in certain cases superseding hardware or formulated design concept fixes for existing hardware were recommended. The study also formulated criteria for design, manufacturing, test, and system application for ECS transducers.

The design criteria were directed toward providing the rules by which transducer deficiencies may be avoided before they reach manufacturing or are incorporated in a project.

BACKGROUND

Many of the transducers used in existing spacecraft ECS applications have exhibited only marginal reliability during both flight and test. This is demonstrated in failure data compiled on conventional transducers, which show that in many cases the transducers and signal conditioners are more prone to failure than most other components in the system.

Generally, a transducer is used in one of two ways in an ECS: (1) as a monitor for system health, or (2) as a sensing element for system control. Thus, transducer failures can result in a false indication of system failure or can produce an erroneous control signal, which changes the normal operation of the system. These factors coupled with the increasing use of automated checkout systems have led to requirements for transducers that exhibit significantly greater reliability than is exhibited by the systems in which they are installed.

PROGRAM SCOPE

The tasks required of this program, as stated in the contract statement of work, include the following:

• Transducer Evaluation--Evaluate the operational characteristics of transducers and precision switches that are used for ECS application in the Apollo spacecraft to determine the area(s) that are sensitive or subject to malfunction. The evaluation shall include, but not be limited to, a comprehensive review of the Apollo ECS instrumentation failure reports. A complete file of ECS transducer failure reports will be supplied GFE.

- Design Concept--Using the results from the transducer evaluation, conceptual designs shall be developed for rugged, reliable ECS transducers and precision switches.
- Verification Testing--Demonstrate by bench test the conceptual designs formulated to generate the required data for proof of concept.
- Design Criteria--Formulate design criteria for rugged, reliable ECS transducers, precision switches and the associated signal conditioning equipment for ECS space flight application. The criteria shall include, but not be limited to, the types of transducers evaluated in the transducer evaluation task.
- Final Report--Submit a comprehensive final report at the completion of the contract. The report shall contain, but not be limited to:
 - (a) A discussion of the technical parameters affecting the design of rugged, reliable ECS transducers and precision switches.
 - (b) Results of the verification testing.
 - (c) Design criteria for rugged, reliable ECS transducers and precision switches.
 - (d) Recommendations.

This program was initiated after the receipt of approximately 800 Apollo trouble reports. These trouble reports were evaluated, and the data summarized on failure evaluation forms. The data were then sorted into generic categories of transducers and summarized in a matrix format that provided insight into the chronic failure modes and mechanisms for each type of transducer.

To review the status of each of the transducers adequately, it was necessary to obtain design details of the units. A program of vendor contact was undertaken to solicit vendor cooperation in obtaining design details.

The evaluation data generated for each generic category of transducer were compiled and published in failure and design evaluation reports. The evaluation reports also presented a review of the failure data and design data for the transducers and suggested both design criteria to improve reliability of the transducers and, where necessary, design concepts for required redesign of the transducers.

For two of the transducers for which redesign was indicated as necessary to meet future reliability goals, the potential design concepts were evaluated and the most promising were subjected to analysis, breadboard fabrication and verification testing.

SUMMARY OF PROGRAM ACTIVITIES

The task activities accomplished during the course of this program are summarized in Figure 1-1. These tasks included performing the following:

- (a) Evaluating approximately 800 GFE trouble reports
- (b) Performing data search for transducer performance and design data
- (c) Analyzing design and failure data and preparing evaluation reports
- (d) Identifying transducer problem areas
- (e) Developing a new design concept for gas flow sensors to solve basic problems found during the failure investigations
- (f) Developing an electronic circuit design modification for Bourdontube, variable reluctance pressure sensors that would allow power reversal to the unit without damage, thus eliminating a large class of failures that have occurred in the past
- (g) Performing verification testing of the new gas flow sensor design concept
- (h) Preparation of monthly progress reports and a final report

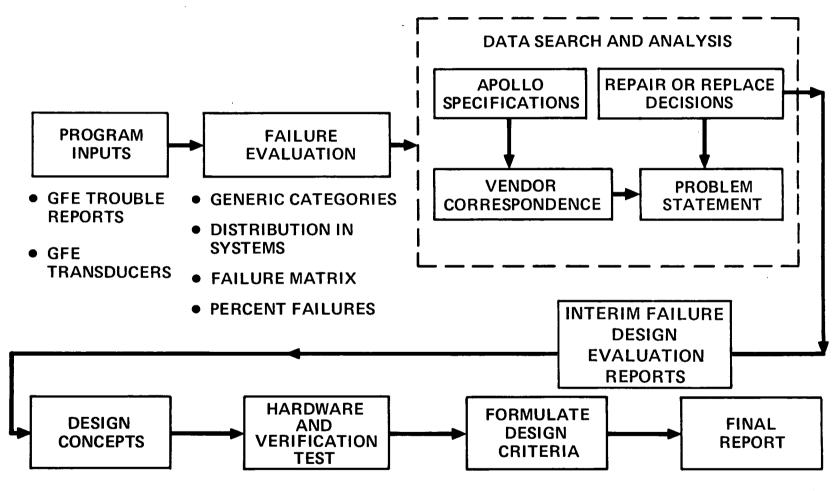
ACCOMPLISHMENTS AND CONCLUSIONS

During the study, approximately 800 trouble reports relating to failures of Apollo ECS transducers were reviewed, tabulated, and statistically analyzed. Design data were gathered for each of the transducers that were studied and design and failure analysis reports for several generic types of transducers were prepared. From a review of the design and failure data, transducer design criteria were generated that were aimed at correcting the design, manufacturing, or test problems that have occurred.

For two types of transducers, the Bourdon tube pressure sensors and the oxygen flowmeter, design concepts were developed to eliminate the most prevalent causes of failure.

Approximately 17 percent of the reported failures of Bourdon tube pressure sensors with variable reluctance transduction elements was due to the test technician errors in which the 28-vdc supply was connected to the transducer output terminals. Thus, a recommended design improvement was to build output circuit protection for this type of test error. A program was initiated to investigate the required circuitry changes to guard against this type of error and its results are presented in detail in Section 3 of this report.





3-5.30

Figure 1-1. Task Activities

The oxygen flowmeter used on Apollo had resistive coils mounted in the gas stream to heat the gas and measure the temperatures of the heated and unheated coils thus determining the flow rate. Discussion with the sensor manufacturer revealed that a newer design exists which appears to be a better choice for future environmental control systems.

In the newer design, the resistive coils are wrapped around a bypass tube rather than installed in the gas stream, which results in several immediately apparent advantages over the old design. Since the sensing elements are external to the plumbing, it is easier to support the elements more rigidly with the advantages of occupying less of the flow path with sensors and having potentially less complex installation. A disadvantage of the new approach, however, is that the theoretically obtainable response to flow changes is slower, because the sensor is external to the flow line.

A program was initiated to develop a prototype sensor of the newer type, which would conform to the environmental and performance requirements for future spacecraft ECS applications of this type of transducer. This program successfully produced a sensor that appears to satisfy the desired requirements. The details of this program are presented in Section 5 of this report.

REPORT ORGANIZATION

This report is organized into a general section of study methodology (Section 2) followed by specific sections for each major category of ECS transducers: pressure (Section 3), temperature (Section 4), flow (Section 5), speed sensor (Section 6), pressure switches (Section 7) and position switches (Section 8). Each section is organized in accordance with the contract work statement by title, work breakdown structure (WBS) number and statement of work (SOW) paragraph number.

The major WBS tasks are summarized below:

- I. Transducer evaluation (WBS 1.0, SOW 3.2.1).
- 2. Design concept (WBS 2.0, SOW 3.2.2).
- 3. Verification testing (WBS 3.0, SOW 3.2.3).
- 4. Design criteria (WBS 4.0, SOW 3.2.4).

Interim reports were prepared and submitted to NASA-MSC during the program. These reports were assigned a dash number of the final report number and were published as separate volumes. All of these interim reports are included in the appendix. The final report is identified as a dash one (-I) of the same basic report No. 72-8537 to differentiate it from the interim reports. The interim reports contained in the appendix are listed on the following page by document number, title, and transducer generic type.

Document Number	Document Title	Transducer Generic Type
72-8537-2, Rev. 1	Report on Failure and Design Evaluation of Apollo ECS Pressure Transducers, Variable- Reluctance Twisted Bourdon Tube Type	Pressure
72-8537-3, Rev. 2	Report on Failure and Design Evaluation of Apollo ECS Pressure Transducers, Variable- Reluctance Diaphragm with Electronics Type	Pressure
72-8537-12, Rev.1	Report on Failure and Design Evaluation of Apollo ECS Temperature Sensors, Thermistor Type	Temperature
72-8537-13, Rev.1	Report on Failure and Design Evaluation of Apollo ECS Temperature Sensor, Thermistor Bead and Coil Type	Temperature
72-8537-14, Rev. 1	Report on Failure and Design Evaluation of Apollo ECS Cabin Temperature Sensor, Thermistor with Electronics Type	Temperature
72-8537-15, Rev. 1	Report on Failure and Design Evaluation of Apollo ECS Temperature Sensors, Coil with Electronics Type	Temperature
72-8537 - 22, Rev.1	Report on Failure and Design Evaluation of Apollo ECS Oxygen Flow Transducer Temperature Sensor with Electronics Type	Flow
72-8537-51, Rev. 1	Report on Failure and Design Evaluation of Apollo ECS Valve Position Indicator Switches	Position Switch

SECTION 2

STUDY METHODOLOGY

This section presents the general study methodology employed to accomplish the study objectives. The general methods are discussed followed by more detailed discussion of each study task.

GENERAL METHODS AND APPROACH

The study program approach that was used during this study is presented in the methodology flow diagram of Figure 2-1. This methodology was implemented by the tasks outlined below.

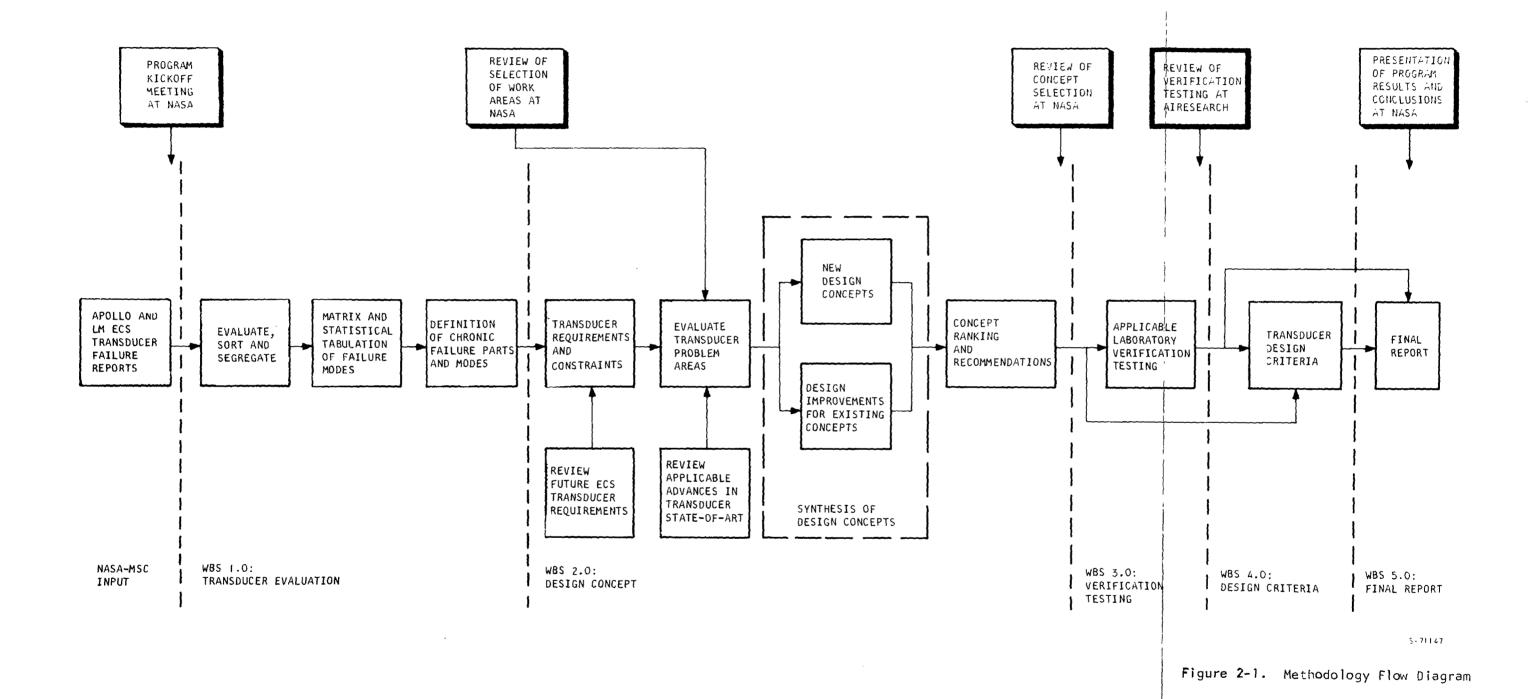
The study was initiated by a review of the NASA-supplied failure reports for Apollo instrumentation. The first phase of the program was transducer evaluation based upon the failure reports. Specific tasks during this phase included the following:

- Evaluation of the NASA-supplied failure reports
- Sorting the failure data into basic categories
- Statistical evaluation of the failure data to determine chronic failure modes

The second phase of the program, the design concept phase, included the following specific tasks:

- Review of future spacecraft ECS transducer requirements
- Soliciting of transducer design data from the various transducer manufacturers
- Evaluation of transducers to determine where a significant redesign appears necessary
- Preparation of a failure and design evaluation report for generic types of transducers
- Review of the current state of the art for two types of transducers requiring redesign
- Exploration of possible design fixes for these two transducers with the transducer manufacturers
- Evaluation to determine the most favorable design fix concepts





FOLDOUT FRAME

FOLDOUT FRAME 2

72-8537-1 Page 2-2 During the third program phase, verification testing was conducted to validate certain design concepts. The necessary verification testing and development was performed by the transducer vendor under subcontract to AiResearch. The specific tasks required during this phase included the following.

- Preparation of verification test plan and test procedures for testing a new design concept for a gas flow transducer
- Fabrication of required laboratory test equipment
- Testing of the concept to establish performance characteristics
- Evaluation and documentation of the test results

In the fourth program phase, the transducer design criteria that were established from the evaluation phase and from verification testing were developed.

The final study phase involved preparation of this final report to document the study. This report includes the final design criteria generated during the fourth phase and the results of the verification testing performed during the third phase.

TRANSDUCER EVALUATION (WBS 1.0, SOW 3.2.1)

Various methods of evaluating and sorting the GFE trouble reports were considered during the study. The objective was to ensure an evaluation method that would allow maximum visibility of the failure reports, include all of the data that might prove significant, and yet be efficiently prepared and used.

A decision was made to tabulate the trouble reports for each of the transducer part numbers on an evaluation form. These failure report summaries were then evaluated for commonality of malfunction on the following bases:

- (a) Problem areas common to transducers of a given type or operating principle
- (b) Problem areas associated with a given transducer part number

Insight into these problem areas came from preparation of failure matrixes for these classes that drew attention to a recurring failure mode, failure mechanisms, or failure causes.

The format that was selected for the failure evaluation task is presented in Figure 2-2. This form was completed for each transducer basic part number.

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Figure 2-2. Failure Evaluation Form

The selected format is relatively self-explanatory, although, for clarification, the definitions of certain terms are presented below:

- Failure Type--This refers to the general type of failure, usually either mechanical, electrical or human.
- Failure Mode--This refers to the failure symptom which the transducer exhibits. Examples would be drift, no output, high output, or setpoint shift.
- Failure Mechanism—This refers to what has failed, and in what manner that resulted in the given failure mode. Examples would be bellows leakage, broken leadwire, failed transistor, or cracked sensing bead.
- Failure Cause--This refers to the action that resulted in the occurrence of the failure mechanism. Examples would be overpressure applied to the unit, poor weld quality, inadequate circuit design or test procedure not followed.
- Problem Area--This refers to the general area responsible for the failure cause. This would generally be either design, manufacturing, testing, installation, handling, human, or random.
- Corrective Action--This refers to the corrective action taken that is referred to on the trouble report.

Figure 2-3 presents a sample of the matrix configuration used in presentation of failure categories and their analytical qualities. This figure is a superimposed composition of three different matrixes, three summation columns, and four percentage columns.

Rows in all three of the matrixes list the problem areas. Columns are related to the failure information. Matrix A in Figure 2-3 is concerned with the failure mode, matrix B is concerned with the failure type, and matrix C is concerned with the failure mechanism. Because the row designations of the matrixes are identical, the matrixes have been placed side by side so one listing of row nomenclature, D, will apply to all three matrixes.

Nomenclature of rows have been categorized to distinguish the problem responsibility sources. The major problem sources are engineering, manufacturing, test equipment, cleaning, handling, final installation, random failures, and error on the part of failure reporter where the failure can not be duplicated. Various activities within the engineering, manufacturing, and final installation areas are designated as subheadings of the respective rows.

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Figure 2-3. Sample Failure Matrix Configuration

Under the general column heading, FAILURE, there are three subheadings, MECHANISM, TYPE, and MODE, each representing a distinct matrix.

Matrix A, MODE, presents the failure indicators. Basically, besides the visual inspection that locates the physically damaged parts, the out-of-specification-limits performance of the components is the failure indication. Therefore, the column headings of this matrix are directly related to the performance parameters and their measurement criteria.

Matrix B, TYPE, shown in Figure 2-4, provides distinction between induced and unpreventable types of failures. Unpreventable failures are either mechanical or electrical failures, and are generally of random type. On the other hand, induced failures are those that result from errors in design, manufacturing, testing, handling, cleaning and final installation. Categorically, all of the induced failures are the result of human error and, therefore, are both preventable and correctable.

Matrix C, MECHANISM, presents the failed part or mechanism. Because this matrix is designed for transducers only, matrix columns have been grouped under two categories: those related to the sensing mechanism, and those related to the signal conditioning and transmission mechanism. The subheadings within these two groups, which indicate the failure cause, are listed in the lower end of the columns for convenience.

The row designated TOTALS presents the totals of each column in all three matrixes. The row designated PERCENT presents the percent of the number in each column with respect to the total failures listed in each matrix. The column designated PERCENT presents the percent of the problem area incidents with respect to the total number of failures.

Any failure report that is to be registered in this matrix first will have its failure responsibility area established. Then the failure mechanism as determined by the failure analyst will be registered in the corresponding column and in the row representing the responsibility area. Next, the type of failure will be established and registered in the corresponding failure type column, and in the same row of responsibility area. Last, the failure indication mode as listed in the failure report will be registered in the corresponding failure mode column. Thus, after registering all the failure reports of a part number in a composite matrix, summations are made for each column and percentage values calculated for each summation.

Such a composite failure matrix of any specific design enables the observer to evaluate the reliability of that design at a glance. By studying the failure types and various percentages, the observer can pinpoint the problem areas that can be eliminated and failures that can be prevented

The failure matrix was prepared for each generic category of ECS transducers shown in Figure 2-5.

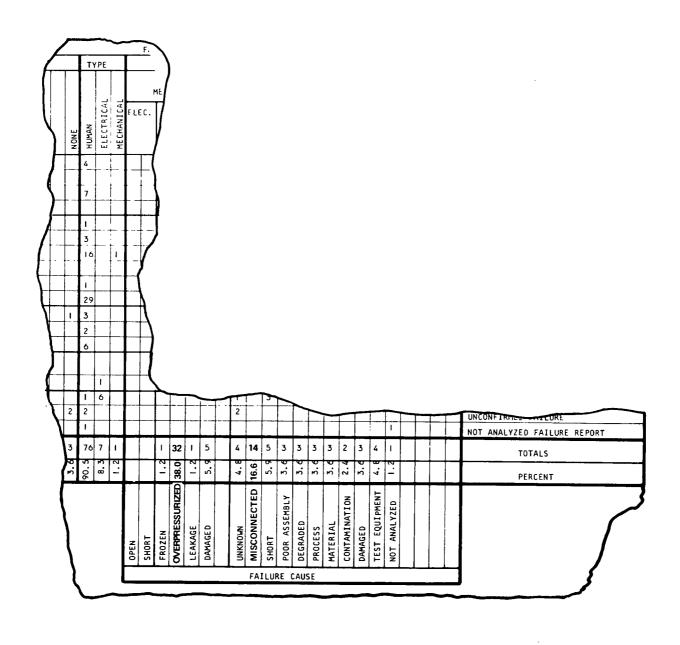


Figure 2-4. Failure Type Matrix

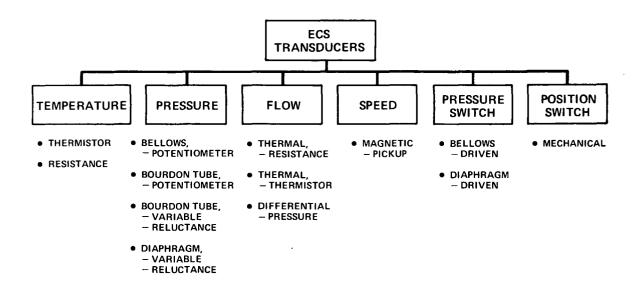


Figure 2-5. Generic Categories of ECS Transducers

To obtain maximum value from the information obtained during the evaluation phase, it became apparent that detailed information on the various transducer designs was required. A literature search was initiated to gather as much information as possible. NASA was requested to supply as much data, in the form of component specifications, outline drawings, principle of operation and performance and design data, as possible. In addition, AiResearch attempted to gather the data by correspondance with each of the vendors that produced Apollo ECS transducers. A copy of one of these letters, addressed to the Whittaker Corporation, is presented as Figure 2-6.

DESIGN CONCEPT (WBS 2.0, SOW 3.2.2)

A review of the failure and design data generated during the program led to the definition of problem areas associated with the various transducers. Certain of these problem areas could be cured by a relatively obvious design change which directly resulted in a recommended design criteria. Other changes were more complex, with a variety of alternate solutions available.

In Reply Refer To: RMG2074

19 May 1972

Whittaker Corporation Pace-Wiencko Division 9601 Canoga Avenue Chatsworth, California BCC: M. Brudnicki H. Kay Chrono File

Attention: Sales Manager

Subject: Request for Quotation No. 1372-2

Contlemen:

In the interest of economy, space shuttle contractors are being urged to select instrumentation including transducers, switches, etc., from existing qualified sources. As a result, NASA, MSC contracted Garrett-AiResearch to study and analyze instrumentation failures recorded on the Environmental Control System (ECS) for the Apollo program. This includes the Apollo Command Service Module (CSM), the Lunar Excursion Module (LEM) and the Portable Life Support System (PLSS).

The purpose of the study is to categorize transducer failures with the objective of defining the chronic failure causes so that solutions for eliminating or reducing them can be determined. It is recognized that improvements were incorporated during the course of the Apolio program as noted by transducer part number changes and/or changes to the dash number of the basic part. It is also conceivable that design improvements and fabrication techniques were developed and not incorporated because of the design configuration freeze that occurred on the Apolio program. Further, it is possible that completely new transducers have been designed and developed which supersede the units used on the Apolio program. The above information is much needed to greatly enhance the selection of the appropriate transducer for the ECS on the Space Shuttle.

Your ecoperation is solicited in obtaining the following informatic. in order to avoid an inadvertent misrepresentation of your hardware. It is understood that the information you supply will not contain any proprietary data such as detail drawings, stc.

- Total number of P/N 600255-2 transducers supplied AiResearch In accordance with AiResearch SCD 836130 and the total of P/N 600255-2 transducers supplied to other contractors for the Apollo program.
- 2. Any design improvement changes or improved fabrication techniques incorporated during the course of the Apollo program.
- 3. Any changes to P/N 600255-2 you recommend for future use.

Figure 2-6. Vendor Correspondence



- 4. Any newly developed and qualified transducer you recommend to supersede P/N 600255-2.
- 5. Outline drawing, brochure information, operational descriptions and any other information to provide the potential user with sufficient details to enable the selection of the appropriate transducer for the application considered.
- 6. Cost and delivery information on 1 to 5 pieces of transducer P/N 600255-2.
- 7. Any special precautions relative to handling, testing and using this particular transducer.

AlResearch Intends to reduce the NASA furnished failure reports on this part number transducer to a matrix showing the cause of failure and the mechanism within the transducer affected by the cause. The failure causes and or mechanisms representing the largest percentage of the failures will be followed up by a data search including actual testing if necessary so that precautionary criteria can be specified for this transducer. For example, if a pressure spike during system testing is the greatest cause for permanent distortion of the twisted bourdon tube then the design criteria will caution the system engineer to be sure pressure spikes of a given magnitude are dampened to prevent damage to the transducer.

Please include similar information for the following additional transducers supplied by your company for the Apollo ECS.

AlResearch Source Control Drawing	Whittaker-Pace-Wiancko Part Number
837044-4-1	600245-1
837044-5-1	630027-5
836132-2-1	600265-1
836132-3-1	60026 5-3 *
837016-1-1 -	54628-1
837016-2	600225
837016-3	600225

Figure 2-6 (Continued)



Whittaker Corporation RFQ 1372-2

RM02074 19 May 1972 Page 3

Technical problems may be resolved by Supplier's direct contact with AlResearch's cognizent engineer, Mike Brudnicki, phone: (213) 323-9500, extension 1773, or the undersigned.

Please address ail replies and requests for further information to AiResearch Manufacturing Company, a Division of The Garrett Corporation, 2525 West 190th Street, Torrance, California 90509, attention R. M. Grotz.

Very truly yours,

AIRESEARCH MANUFACTURING COMPANY

R. M. Grotz
Administrator
Major Subcontracts

RMG:daw

CC: Mr. Frank Collier Contract Technical Monitor NASA Contract NAS 9-12452 NASA, MSC Houston, Texas 77058

Figure 2-6 (Continued)

The order of tasks that were followed in developing the design concepts was:

- (a) Determine applicable design requirements and constraints
- (b) Synthesize types of concept fixes possible
- (c) Evaluate and select a fix based on weighing of benefit versus cost, practicality, and similar considerations.

These tasks are discussed below.

To determine the design requirements and constraints for the next generation of spacecraft ECS transducers, a review of the transducer requirements for future spacecraft programs was performed. This review permitted a decision to be made as to the basic suitability of the transducers being studied for future use. The review was based on an analysis of the transducer requirements for the ECS systems proposed by the different space shuttle vendors, the requirements that have been generated in the past for various other spacecraft, such as MOL, Skylab, etc., and the transducer requirements for fault detection and failure isolation as developed under other contracts.

The required ECS instrumentation was classified according to the following basic types of transducers:

Pressure transducers

Temperature transducers

Flow transducers

For each of these categories, the required transducers were tabulated on the basis of the following:

Measurement media

Measurement range

Signal type

Accuracy requirements

Response time

The completed tabulations for future ECS transducer requirements are presented in the appropriate sections of this report.

With the transducer design and failure data generated during the transducer evaluation phase of the study, the transducer requirements generated for future



ECS systems, such as the space shuttle, and the design data obtained from vendor correspondence, a repair or replace decision could be made and a transducer problem statement subsequently generated. A diagram that enumerates the various factors that were considered is presented in Figure 2-7.

During the review of future ECS transducer requirements, it was seen that longer mission times and rapid vehicle turnaround are two factors that will influence transducer selection. Thus, even in the case of temperature sensors that have a good history, it must be expected that they will fail at some time and it must be realized that the Apollo requirements for purging and backfilling liquid loops to replace liquid temperature sensors represent a very undesirable requirement from the point of view of attaining rapid turnaround. Consequently, part of the review of transducer advances is the investigation of sensing techniques that do not require internally installed sensing elements. Specifically, the use of temperature sensors that can be attached to the outside of the fluid lines and removed and replaced easily was investigated. The most promising sensors of this type are resistive temperature sensors made of platinum (as were most of the Apollo resistive temperature sensors) or nickel. Surface temperature sensors of this type have been used in aircraft applications for liquid measurements such as engine oil temperature.

For the two types of transducers that were selected for incorporation of a design fix (twisted Bourdon tube type pressure transducers, and oxygen flow transducers) the state of the art of the transducer designs was reviewed to arrive at a number of possible fixes, which were evaluated to arrive at a recommended design fix.

VERIFICATION TESTING (WBS 3.0, SOW 3.2.3)

The transducer design concepts selected for verification testing were fabricated in a breadboard configuration and tested as required to verify that the performance and design requirements were met. The role of verification testing in the repair or replace decision is presented in Figure 2-7.

DESIGN CRITERIA (WBS 4.0, SOW 3.2.4)

Based on the design and failure analysis data generated for all transducers and the verification testing performed on two types of transducers, design criteria were developed. The design criteria are instructions and recommendations aimed at the correction and prevention of transducer failures. They include the following categories:

Transducer component design

Materials and processes

Manufacturing techniques

Testing



APOLLO SPECIFICATIONS

VENDOR CORRESPONDENCE

- TRANSDUCER DESCRIPTIONS (DWGS, ETC)
- NO. SUPPLIED, COST AND AVAILABILITY
- DESIGN IMPROVEMENTS
- SUPERSEDED DESIGNS
- PRECAUTIONARY CRITERIA

REPAIR OR REPLACE DECISION

- APPLICATION TO SSV
- PERCENT FAILURES
- AVAILABILITY
- COST
- STATE-OF-THE-ART IMPROVEMENTS
- COMMONALITY

PROBLEM STATEMENT
SSV SERVICE LIFE; SERVICEABILITY ENVIRONMENT

Figure 2-7. Data Search and Analysis

SECTION 3

PRESSURE TRANSDUCERS

TRANSDUCER EVALUATION (WBS 1.0, SOW 3.2.1)

Table 3-I summarizes all of the pressure transducers that were used on the Apollo ECS programs. A failure evaluation was made for those units shown in Table 3-I for which failure reports were available. Each of the transducer suppliers was contacted and requested to supply technical data relative to operating principle, cross-sectional and outline drawings, performance characteristics, number of parts delivered, and current cost information for I to 5 articles.

The percent of pressure transducers rejected was determined from the number of parts delivered versus the number of recorded failure reports for each particular part number. The average rejection rate of several part numbered units was approximately 27% for a total of 320 pressure transducers. The rejection rate for specific part numbered units varied considerably. These data, including failure matrixes that show the cause of the failures, are contained in AiResearch Reports 72-8537-2 and 72-8537-3 in the Appendix.

DESIGN CONCEPT (WBS 2.0, SOW 3.2.2)

Twenty of the 24 part numbers shown in Table 3-1 are supplied by Celesco Industries. These transducers represent the Pace-Wiancko pressure transducer product line that Celesco recently purchased from The Whittaker Corporation. A failure evaluation was made on the Celesco transducers that were used in the ECS of the Apollo command service module. This evaluation shows (see Figure 2-6 of AiResearch Report 72-8537-2) that most of the transducer failures were caused by overpressurizing the transducer in the form of a pressure spike (38%) causing the sensing mechanism to take a permanent set and misapplication of input 28 vdc electrical power to the 0-5 vdc output pins (16.6%). This latter condition caused an open failure of the electrical circuitry in the transducer. Recommendations in the form of design concepts were made and described in Report 72-8537-2 for modifying the units so that they would be less prone to failure when subjected to the above conditions. These recommendations were discussed with the NASA Technical Monitor and it was agreed, due to the funding limitations, to concentrate on the development of design concepts to make the units withstand an electrical power reversal. As a result, making the units capable of withstanding a reasonable overpressure spike was deferred for possible follow-on work.

Several meetings were held between AiResearch and Celesco personnel and correspondence in the form of letters and telephone calls made between the months of May and December 1972. During the early part of the program, AiResearch submitted Report 72-8537-2 to Celesco and reviewed it with Celesco engineers. The report describes the failures and recommendations for the Celesco transducers used in the Apollo command service module. During the discussions it was determined that provisions for withstanding an inadvertent



TABLE 3-1

PRESSURE TRANSDUCERS USED IN THE APOLLO CSM, LM, AND PLSS ENVIRONMENTAL CONTROL SYSTEMS

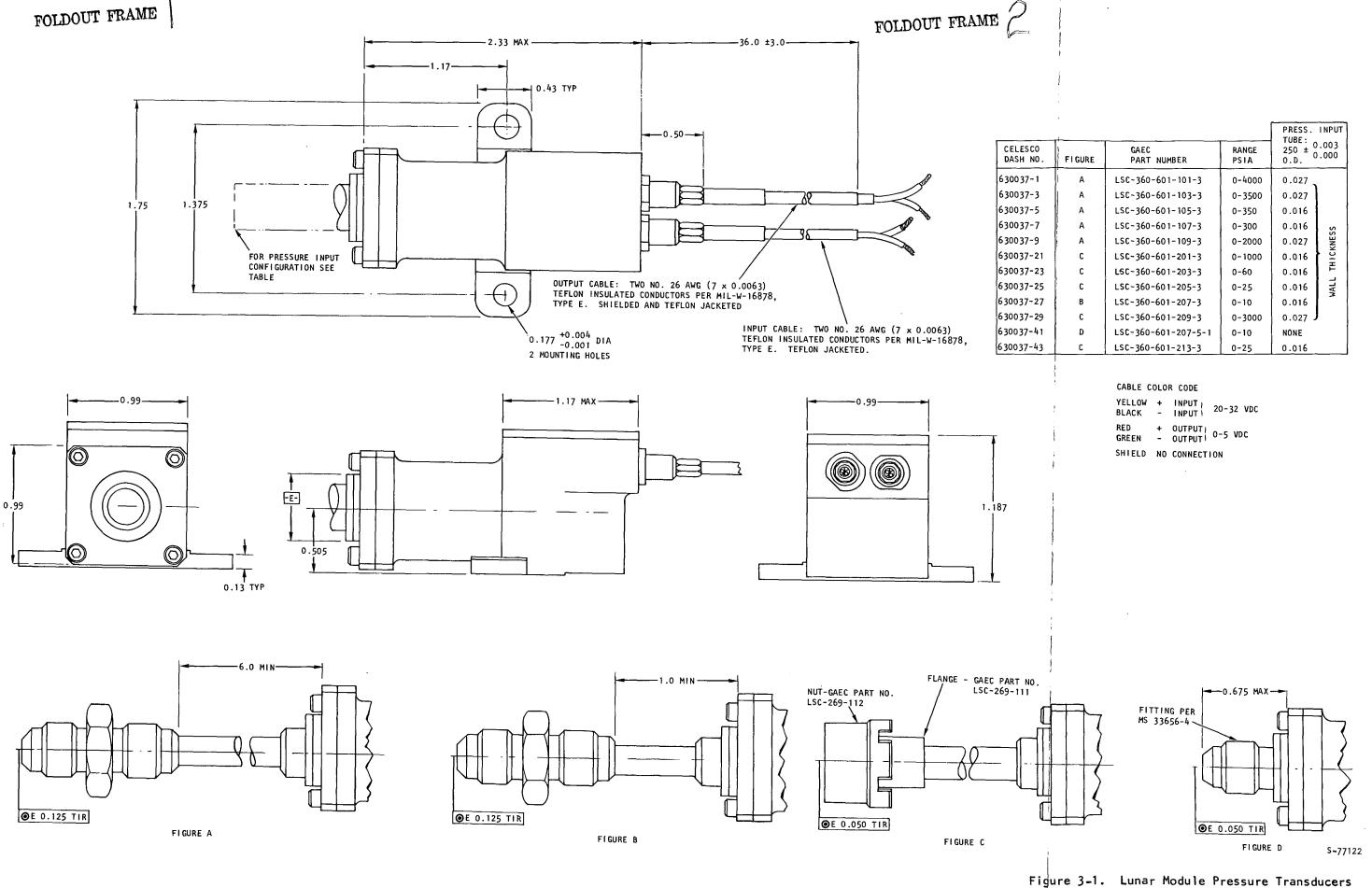
Pre	ssure Range			Transducer		Specification A/R, H.S., GAEC	Ven	dor	Output			Unit
Operating	Proof	Burst	Media	Title - Application	Item No.	& NR (Dash No.)	Name	Part No.	Signal	Accuracy	Remarks	Max. Wt.
0-25 in. H ₂ 0	7.5 psig*	12.5 psig*	0xygen	Suit Compressor AP	7.12 CSM	A/R 837054-3	Consol. Controls	R41PD34-15	0-5 vdc	±0.625 in. H ₂ 0	*Applied simultaneously to both ports. Proof and burst of 1.35 and 2.25 psid when	15 oz
.0525 psia	22.5 psia	37.5 psia	Steam	Steam duct pressure	8.17 CSM	A/R 837036-2	Celesco	601555	0-5 vdc	±0.005 psi	applied to high pressure port only.	22 oz
0-2 psid	-15 psid +50 psid	-30 psid +100 psid	0xygen & water	Suit loop to water system ΔP	126 LEM	SV HS 4098 (SV728378)	Celesco	630021-5	0-5 vdc	+.04 psi	Input polarity 32 vdc may be reversed.	9 oz
0-5 psia			Water	Feedwater press. Xducer & switch	239 PLSS	SV HS 3867 (SV718788)	Bourns	2004419301	0-5 vdc	±.25 psi	Switch actuates at 1.2 to 1.7 psia.	6 oz
2.5-5.0 psid			0xygen	Press garment (PGA) ΔP Xducer	203 PLSS	SV HS 3380 4311 (SV714171)	Bourns	2004414601	0-5 vdc	±0.15 psi		2.5 oz
0-17 psia	22.5	43	0xygen	Cabin pressure	10.5 CSM	A/R 836132-3	Celesco	600265-3	0-5 vdc	±.425 psia		9 oz
0-17 psia	25.5	43	0xygen	Suit & cabin pressure	7.6 CSM	A/R 837044-7	Celesco	630027-7	0-5 vdc	±0.34 psia		9 oz
0-25 psi	-15 psig +90 psig	150 psig	Water Glycol	Accumulator quantity	8.16 CSM	A/R 837026-4	Celesco	600235-1	0-5 vdc	±0.625 psi		10 oz
0-50 psid	±100 psid	±200 psid	0xygen & glycol- water	Glycol-water pump ΔP	202 LEM	SV HS 4098 (SV728380)	Celesco		0-5 vdc	±0,75 psi	Input polarity 32 vdc may be reversed.	9 oz
0-60 psi	II5 psia	190 psia	Water glycol	W-G pump press rise	8.1 CSM	A/R 836130-2	Celesco	600255-2	0-5 vdc	±1.5 psi		9 oz
0-150 psig	225	375	0xygen	0xygen-supply pressure	9.8 CSM	A/R 837016-2	Celesco	600225	0-5 vdc	±3.0 psig		9 oz
0-1500 psia			0xygen ਦ	Pri. O ₂ press Xducer	232.1 PLSS	SV HS 3226 (SV714168) SV HS 4901 (SV723032	Gulton Servonic	2191- 0201 2191- 0301	0-5 vdc	±41.3 psi		6.4 oz
0-4000 psi	6000	4	vater. 5- 5tille	Xducer, pressure absolute		LSC360-601- 101-3	Celesco	630037-1 (A)	0-5 vdc	±32 psi		6 oz
0-3500 psi	5250		o pa			103-3	4	-3	🛊	±28 psi		l †
0-350 psi	700		ine (6)			105-3		-5	1 1	±2.8 psi	•	
0-300 psi	600	ge	eiol raz H) I2)			107-3		-7		±2.4 psi		
0-2000 psi	3000	range	р-р р ф ф ф ф ф ф ф			109-3		-9		±16 psi	These units are capable of	
0-1000 psi	1500	ting	tille , 5) -50% iodin	Press ascent 0 ₂ tanks & 2	GF3582P GF3583P	201-3		-21		±8 psi	withstanding an input 32 vdc power polarity reversal and	
0-60 psi	120	operating) dis N204) N2H4 PPm	Pri. pump dis- charge press	GF2741P	203-3		-23		±.48 psi	an application of input power to the signal output leads.	
0-25 psi	50	t i mes	1) Telium, 2) oxygen, 3) distilled-deionized water, and a hitrogen tetroxide (No4,), 5) Nydrazine-uns-dimethyl-hydrazine (50% N244-50% UDMH), 6) distilled deionized water with 13 ppm iodine (12).	Press safety valve No. I & 2 servo	GF3591P GF3592P	205-3		-25		±0.2 psi		
0-10 psi	20.5	5.0 t	oxyg etrox azine er wi	Cabin pressure Xducer	GF3571P	207-3		-27		±0.1 psi		
0-3000 psi	4500		im, 2) igen t -hydr id wat	Press descent O ₂ tank	GF3584P	209-3		-29		±24 psi		
0-10 psi		↓	neliu nitro methyl	Xducer, pressure absolute		207-51		-41	(A)	±0.08 psi		
0-25 psi			de di di	Xducer, pressure absolute		213-3	Celesco	630037-43 (B)	0-5 vdc	±0.2 psi		6 oz

reversal of input 28 vdc power on the 0-5 vdc output pins had been incorporated in Celesco transducers that were supplied to Grumman Aircraft and Engineering Co. (GAEC) for use in the lunar module. These transducers are tabulated in Table 3-1 and are identified by Celesco part numbers 630037-1 through -43. A study was made to determine if the electronics package contained in Celesco pressure transducer PN 630037 could be incorporated in the pressure transducers made for the Apollo command service module. The objective of the proposed transfer of electronics would: (1) provide the capability of withstanding an input 32-vdc power polarity reversal and misapplication of input power to the signal output leads for all the Celesco-supplied Apollo pressure transducers; (2) retain the status of being highly qualified Apollo equipment; (3) provide transducers covering many pressure ranges; and (4) retain the external shape of the Apollo CSM transducers so that next assembly interfaces would not be affected.

An AiResearch statement of work for a design analysis including verification testing was negotiated with Celesco for the purpose of determining the best approach for modifying six different part numbered Celesco transducers that were used in the Apollo command service module. The study tasks for eliminating failures caused by inadvertent reversal of 28-vdc power on the 0-5 vdc output pins included the following options:

- 1. Modify the electronics by adding diodes.
- 2. Supersede the CSM style transducers with an LM style transducer that currently contains provisions to withstand inadvertent power reversals. The outline dimensions of these units are much different from the CSM style transducers. The shape and size of the Celesco transducers made for the CSM are described in AiResearch Report 72-8537-2. The configuration of the Celesco transducers designed for the LM are shown in Figure 3-1 which also contains appropriate reference to the GAEC part numbers.
- 3. Transfer the electronics from the LM transducer to each of the CSM units. The electronic package for the LM unit is much smaller and will fit within the CSM units with room to spare.
- 4. Redesign a new electronics package that utilizes the latest state-of-the-art electronics including power reversal protection that will fit within all of the Celesco transducers.

A detailed design analysis including laboratory verification tests was made by Celesco to assure protection of proprietary design details. The analysis was reviewed in detail with AiResearch personnel and the results are summarized in Celesco letter LP-L586, reproduced as Figure 3-2.



72-8537-1 Page 3-4



environmental and industrial products division

7800 Deering Avenue Canoga Park, Calif. 91304 (213) 884-6860

In reply refer to: LP-L586

December 13, 1972

Airesearch Manufacturing Company 2525 West 190th Street Torrance, California 90509

Attention:

R. M. Grotz

Administrator

Major Subcontracts

Reference:

(a) Airesearch Manufacturing Company Report 82-8537-2

dated July 1972

(b) Airesearch RFQ 1372

(c) Celesco Q-7054

Gentlemen:

The subject report points out that 17% of the failures of the pressure transducers supplied to Airesearch on the Apollo Program was attributed to application of 28 VDc to the 5 VDc output terminal of the transducer electronics. We have investigated the possibility of modifying the electronics and adding circuit protection of 28v. We have also considered modifying the transducer by substituting an amplifier design which does provide for mis-circuit protection. The transducer which contains this amplifier was supplied to Grumman and qualified for the Apollo Program.

The feasibility of providing protection to the E-package used in Airesearch pressure transducer against misapplication of 28 VDc to the output terminals of the E-package was evaluated and due to major design work involved, it is recommended by Celesco that this solution shall not be considered.

The second possible solution was interfacing the present sensor to the present Grumman E-package. This solution was considered since the Grumman E-package design does provide the circuit protection. The differences between

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Figure 3-2. Summary of Results of Design Analysis





Airesearch Manufacturing Company December 13, 1972 Page 2

the present Airesearch E-package and Grumman E-package was studied by Celesco. A summary of these differences and their effects follow:

Differences Between Two E-packages:

Two E-packages are completely different from each other in their design approach. Following are the main differences which are of main concern.

- 1. The Airesearch pressure transducer uses a sensor whose coil inductance is approximately 3.2 mh. The transducer used in conjuction with Grumman E-pak has coil inductance of approximately 22 mh. Hence, there is approximately 1:7 ratio in sensor inductances.
- 2. The oscillator frequency in the Airesearch E-pak is 22 KHz $^{+}$ 1 KHz. The oscillator frequency in the Grumman E-pak is 17.5 KHz.
- 3. The amplitude between the secondary windings of the transformer used for sensor excitation in the Airesearch E-pak is approximately 75v p-p. The amplitude between secondary windings of the transformer used for sensor excitation in the Grumman E-pak is $33v^{\frac{1}{2}}v$ p-p.

Effects of the above Differences on Performances:

- I. Since the oscillator frequency and the coils inductance determine the impedance of the sensor. As noted above, the Airesearch sensor used low inductance coil and Grumman E-pak has low oscillator frequency. Both of these factors tend to give low impedance to the sensor because $X_L = 2\pi f L$; where X_L is the impedance of the sensor at frequency f and with coil inductance L. If this sensor was used in conjuction with Grumman E-pak, the secondary winding of the transformer will be loaded down and the amplitude of excitation to the sensor will drop. Also, due to heavy inductive loading on the transformer secondary, the oscillator circuit will possibly produce a ringing effect and excessive noise in the circuit.
- 2. The frequency difference between the oscillators of E-pak has no significant effect in the performance of the transducer except that it does lower the sensor impedance as discussed above.
- 3. The low amplitude between the transformer secondary windings in the Grumman E-pak reduces the sensor excitation. This will reduce the sensor

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Figure 3-2 (Continued)





Airesearch Manufacturing Company December 13, 1972 Page 3

excitation. This will reduce the sensor output proportionally. Hence, to get 5 VDc output at the final output at full-scale pressure, the gain of the amplifier in the Grumman E-pak will have to be increased.

Comments and Recommendations:

The following recommendations are offered as a solution to the problem:

- 1. Redesign the sensor coils in the present sensor so that the coil inductance is <30 mh. This will enable Celesco interface this new sensor with Grumman E-package with minimum or no changes in the E-package. Redesign of the sensor will be such that it will not change the mechanical configuration of the sensor. The change in the coil inductance will be accomplished by changing the wire size and the number of turns.
- 2. Redesign the complete new E-package which will interface with the present Airesearch sensor directly. The present Airesearch E-package uses transformers and discrete components in its design. The new E-package will be designed with the state-of-the-art components using integrated circuits. Hence, the new E-package will be updated using the present day technological advancements in the semiconductor industry.

After we have had an opportunity to discuss the solution to the problem, we will be happy to supply you with cost estimates. If we can be of further assistance, please do not hesitate to contact me.

Sincerely,

CELESCO INDUSTRIES INC.

Larry Penssiero

Manager, Marketing

Environmental & Industrial Products Division

fet/

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Figure 3-2 (Continued)



VERIFICATION TESTING (WBS 3.0, SOW 3.2.3)

Laboratory tests were performed by Celesco Industries to verify the design details of the analysis. The results of these tests are reflected in the summary data contained in the Celesco letter of Figure 3-2.

DESIGN CRITERIA (WBS 4.0, SOW 3.2.4)

Design criteria appropriate to the Celesco pressure transducers are described on page 2-13 in AiResearch Report 72-8537-2. The design criteria specific to the design analysis made by Celesco Industries consist of recommendations for a complete redeisgn of the electronics package using state-of-the-art components and integrated circuits. Redesign is recommended because many of the component electronic parts used in the Celesco transducer for the Apollo Program are obsolete (1965 circuit design), startup costs are required, part prices are high and high-rel parts are not available except by special test.

As a result of this analysis, Celesco has defined all circuit changes that will be required for future application of the Celesco-supplied pressure transducers contained in Table 3-1. In the event the Celesco transducers find application on future aerospace programs, it is recommended that the changes defined in the Celesco analysis be incorporated and qualification-tested in accordance with the requirements of the particular program.

A review of the pressure transducer requirements for the Shuttle ECS was made by the AiResearch Manufacturing Company. These requirements are tabulated in Table 3-2.

UNRESOLVED PROBLEMS

The data contained in this section of the report, including the referenced appendixes, were gathered to identify internal portions of the transducers that were responsible for chronic failures determined from an analysis of the GFE failure reports. It is suggested that failure reports be obtained from NASA files on the transducers procured to LSC 360-601 (refer to Table 3-1) and that additional data be gathered from the transducer suppliers. The data needed specifically include cross-sectional drawings, operational descriptions, performance and design data. These data are also needed for the Bourns and Gulton (Servonic) transducers. These data had been requested; however, the information received is not sufficiently complete to permit a thorough analysis to be made.

More information also is needed concerning the total number or parts delivered for each of the specific part numbers. Only partial data was made available by the suppliers because records were not kept for longer than five years and, in all cases, the major portion of the hardware was procured and delivered over a seven-year period. The total number of parts delivered is needed so that a rejection rate can be determined for each of the failure modes identified from a review of the NASA-furnished failure reports.



TABLE 3-2

PRESSURE TRANSDUCER REQUIREMENTS FOR SHUTTLE ECS

	Transducer Identification			}	1		_	Fligh	t Environment		I
ltem Number	Part Description	Qty Per System	Operating Range	Proof	Burst	Fluid Media	Normal Temperature, OF	Temperature,	Pressure	Accuracy Required	Response Required
1.100	N2 Source Tank Pressure	1	0-3500 psig	5250 psig	8750 psig	N2	-20 to 165	0 to 160	Vacuum	±3% F.S.	50 MS
1.101	N2 Source Tank Pressure	1	0-3500 psig	5250 psig	8750 psig	N2	-20 to 165	0 to 160	Vacuum	±3% F.S.	50 MS
1.102	N2 Source Tank Pressure	1 1	0-3500 psig	5250 psig	8750 psig	N2	-20 to 165	0 to 160	Vacuum	±3% F.S.	50 MS
1.103	N2 Source Tank Pressure	1 1	0-3500 psig	5250 psig	8750 psig	N2	-20 to 165	0 to 160	Vacuum	±3% F.S.	50 MS
1.104	N2 Source Tank Pressure	1	0-3500 psig	5250 psig	8750 psig	N2	-20 to 165	0 to 160	Vacuum	±3% F.S.	50 MS
1.105	N2 Source Tank Pressure	1	0-3500 psig	5250 psig	8750 psig	N2	-20 to 165	0 to 160	Vacuum	±3% F.S.	50 MS
1.106	N2 Source Tank Pressure	1 1	0-3500 psig	5250 psig	8750 psig	N2	-20 to 165	0 to 160	Vacuum	±3% F.S.	50 MS
1.107	N2 Source Tank Pressure	1	0-3500 psig	5250 psig	8750 psig	N2	-20 to 165	0 to 160	Vacuum	±3% F.S.	50 MS
1.108	02 Source Tank Pressure	1	0-3500 psig	5250 psig	8750 psig	02	-20 to 165	0 to 160	Vacuum	±3% F.S.	50 MS
1.109	02 Source Tank Pressure	1	0-3500 psig	5250 psig	8750 psig	02	-20 to 165	0 to 160	Vacuum	±3% F.S.	50 MS
1.110	N2 Manifold Pressure	1	0-200 psig	300 psig	500 psig	N2	-20 to 165	-40 to 120	14.7 psi, 2 psi min	±3% F.S.	50 MS
1.111	N2 Manifold Pressure	1	0-200 psig	300 psig	500 psig	N2	-20 to 165	-40 to 120	14.7 psi, 2 psi min	±3% F.S.	50 MS
1.112	02 Manifold Pressure	1 1	0-1000 psig	1500 psig	2500 psig	02	-20 to 165	-40 to 120	14.7 psi, 2 psi min	±3% F.S.	50 MS
1.113	02 Manifold Pressure	1 1	0-1000 psig	1500 psig	2500 psig	02	-20 to 165	-40 to 120	14.7 psi, 2 psi min	±3% F.S.	50 MS
1.114	N2 Water Tank Pressure	1	0-50 psig	37.5 psig	62.5 psig	N2	-20 to 165	60 to 120	14.7 psi, 2 psi min	±3% F.S.	50 MS
1.115	N2 Water Tank Pressure	1 1	0-50 psig	37.5 psig	62.5 psig	N2	-20 to 165	60 to 120	14.7 psi, 2 psi min	±3% F.S.	50 MS
1.126	Avionic Bay Delta P	1	-2 to 2 psid	22.5 psig	37.5 ps ig	02/N2	0 to 120	60 to 120	14.7 psi, 2 psi min	+0.1 psid	50 MS
1.127	Avionic Bay Delta P	1 1	-2 to 2 psid	22.5 psig	37.5 psig	02/N2	0 to 120	60 to 120	14.7 psi, 2 psi min	+0.1 psid	50 MS
1.128	Avionic Bay Delta P	1	-2 to 2 psid	22.5 psig	37.5 psig	02/N2	0 to 120	60 to 120	14.7 psi, 2 psi min	+0.1 psid	50 MS
1.190	Cabin Total Pressure	2	0 to 30 psia	22.5 psig	37.5 psig	02/N2	0 to 120	60 to 120	14.7 psi, 2 psi min	±3% F.S.	50 MS
2.100	Fan Delta P	2	0-10 In. H20	22.5 psig	37.5 psig	02/N2	70 to 100	60 to 120	14.7 psi, 2 psi min	±3% F.S.	50 MS
2.101	Debris Trap Delta P	1 1	0-2 In. H20	22.5 psig	37.5 psig	02/N2	70 to 100	60 to 120	14.7 psi, 2 psi min	±3% F.S.	50 MS
3.104	Secondary Pump Inlet Pressure	1	0-50 psig	45 psig	75 psig	Water	130 max	60 to 120	14.7 psi, 2 psi min	±3% F.S.	50 MS
3.105	Primary Pump Inlet Pressure	1	0-50 psig	45 psig	75 psig	Water	130 max	60 to 120	14.7 psi, 2 psi min	±3% F.S.	50 MS
3.150	Primary Water Pump Delta P	1	0 to 60 psid	110 psig	190 psig	Water	30 to 100	60 to 120	14.7 psi, 2 psi min	±3% F.S.	50 MS
3.151	Secondary Pump Delta P	1 1	0 to 60 psid	110 psig	190 psig	Water	30 to 100	60 to 120	14.7 psi, 2 psi min	±3% F.S.	50 MS
3.152	Avionics Bay-1 Fan Delta P	2	0-10 In. H20	22.5 psig	37.5 psig	02/N2	130 max	60 to 130	14.7 psi, 2 psi min	±3% F.S.	50 MS
3.153	Avionics Bay-2 Fan Delta P	2	0-10 In. H20	22.5 psig	37.5 ps ig	02/N2	130 max	60 to 130	14.7 psi, 2 psi min	±3% F.S.	50 MS
3.154	Avionics Bay-3 Fan Delta P	2	0-10 In. H20	22.5 psig	37.5 psig	02/N2	130 max	60 to 130	14.7 psi, 2 psi min	±3% F.S.	50 MS
4.100	Water Pressure (Primary Instr)	1	0-50 psig	32.5 psig	62.5 psig	Water	130 max	60 to 120	14.7 psi, 2 psi min	±3% F.S.	50 MS
7.100	Primary Pump Package Inlet Pressure	1	0-300 psig	375 psig	625 psig	F-21	30 to 100	0 to 160	Vacuum	±3% F.S.	50 MS
7.101	Secondary Pump Package Inlet Pressure	1	0-300 psig	375 psig	625 psig	F-21	30 to 100	0 to 160	Vacuum	±3% F.S.	50 MS
7.150	Primary Pump Package Delta P	1	0 to 80 psid	375 psig	625 psig	F-21	30 to 100	0 to 160	Vacuum	±3% F.S.	50 MS
7.151	Secondary Pump Package Delta P	1	0 to 80 psid	375 psig	625 psig	F-21	30 to 100	0 to 160	Vacuum	±3% F.S.	50 MS
7.152	Ammonia Tank Pressure (Pri)	1	0-1000 psig	1500 psig	2500 psig	NH3	0 to 160	0 to 160	Vacuum	±3% F.S.	50 MS
7.153	Ammonia Tank Pressure (Sec)	1	0-1000 psig	1500 psig	2500 psig	NH3	0 to 160	0 to 160	Vacuum	±3% F.S.	50 MS
7.154	Ammonia Manifold Pressure	1	0-200 psig	300 psig	500 psiq	NH3	0 to 160	0 to 160	Vacuum	±3% F.S.	50 MS

SECTION 4

TEMPERATURE TRANSDUCERS

TRANSDUCER EVALUATION (WBS 1.0, SOW 3.2.1)

Table 4-I lists all of the temperature sensors that were used in the ECS of the Apollo command service module. Failure and design evaluation reports have been prepared for each of the sensors. These reports are contained in the Appendix with the appropriate page number and report number referenced on Table 4-I.

All of the sensors listed in Table 4-I employ thermistors as the temperature sensing element except for the sensors that are described in Report 72-8537-I5. The thermistors were supplied to AiResearch by Fenwal Electronics, Inc., Framingham, Massachusetts, in accordance with AiResearch specification control drawings.

Thermistors are thermal resistors, or resistors with a high negative temperature coefficient of resistance. This is opposite to the effect of temperature changes on metals. Thermistors are semiconductors of ceramic material made by sintering mixtures of metallic oxides such as manganese, nickel, cobalt, copper and uranium. The thermistor is one of the simplest and most versatile components available. Its unique characteristics permit straightforward solutions to many sensing, measurement and control problems which would otherwise require elaborate equipment and complex circuitry.

Thermistors are near-ideal components mechanically. Small in size (some bead types are smaller in diameter than the period at the end of this sentence), their space requirements are negligible for most applications. They are extremely rugged, stable, and they demonstrate the reliability and extended life common to many semiconductor products.

Beads are made by forming small elipsoids of thermistor material on two parallel, fine wires about 0.010 in. apart. The material is sintered at high temperature and the leads become embedded tightly in the beads making good electrical contact inside the thermistors. Beads are usually coated with glass for protection. They are used where small size, fast response, high precision, stability and temperatures to $600^{\circ}F$ are required. Resistance values of 100 ohms to over 10 megohms can be obtained in beads ranging from 0.006 in. to 0.100 in. diameter.

RESISTANCE - TEMPERATURE CHARACTERISTICS

The resistance of a thermistor is solely a function of its absolute temperature whether the source of heat is external or internal, or both. Thus, a thermistor responds to changes in environmental temperature and also to changes in internal temperature caused by passage of current through its resistance material (self-heating).

TABLE 4-1
APOLLO CSM TEMPERATURE TRANSDUCERS

Unit Operating		Identification							Design Data				Performance Data				
Temperature					Uni	t Outline	Manuf	acturer		Pres	sure	1	Time Transduce		ansducer l	Jnits	
Range in Apollo CSM, O _F	Title/Application	Media	ltem Number	Specifica- tion AiResearch	Page	AiResearch Report Number	Name	Part Number	Sensing Element	Proof, psig	Burst, psig	Weight,	Con- stant, sec	Sup- plied	Rejected	Rejec- tion Rate, %	Rem a rks
25 to 75	Glycol Temperature Sensor	Glycol	2.23 CSM	820920	2-4	72-8537-13	AiResearch	820920-2	Thermistor and Electronics	90	150	0.38	6	71	29	40.8	Bridge excitation voltage 2.7 ±0.5 vrms, 300 Hz, squ. type wave, 140 ma max.
25 to 75	Glycol Temperature Sensor	Glycol	2.23 CSM	820920	2-4	72-8537-13	AiResearch	820920-3	Thermistor and Electronics	90	150	0.38	6 \$,,	29	40.8	Bridge excitation voltage 2.7 ±0.5 vrms, 300 Hz, squ. type wave, 140 ma max.
25 to 75	Glycol Temperature Sensor	Glycol	2.23 CSM	836172	2-3	72-8537-13	AiResearch	836172-1	Thermistor, Coil and Electronics	90	150	0.38	6	22	0	0	Bridge excitation voltage 2.7 ±0.5 vrms, 300 Hz, squ. type wave, 140 ma max.
20 to 70	Glycol Temperature Sensor	Glycol	2.45 CSM	836684-1	4-24	72-8537-12	Fenwal	K1200 A	Thermistor	150	200	0.07	İ	25	0	0	
20 to 70	Glycol Temperature Sensor	Glycol	2.45 CSM	820980	4-26	72-8537-12	AiResearch	820980-2	Thermistor	90	150	0.1	120	32	2	6.25	
40 to 100	Glycol Temperature Sensor	Glycol	2.47 CSM	836684-2	4- 24	72-8537-12	Fenwa1	K1201 A	Thermistor	150	200	0.07		96	1	1.04	
40 to 100	Glycol Temperature Sensor	Glycol	2.47 CSM	820980	4-26	72-8537-12	AiResearch	820980-4	Thermistor	90	150	0.1	120	92	19	20.65	
40 to 100	Glycol Temperature Sensor	Glycol	2.50 CSM	836684-2	4-24	72-8537-12	Fenwal	K1201A	Thermistor	150	200	0.07					Performance information of this unit is included in Item No. 2.47, PN 836684-2
40 to 100	Glycol Temperature Sensor	Glycol	2.50 CSM	820980	4- 26	72-8537-12	AiResearch	820980-4	Thermistor	90	150	0.1	120				Performance information of this unit is included in Item No. 2.47, PN 820980-4
0 to 212	Wick Temperature Sensor	Water	2.49 CSM	836250	3-11	72-8537-12	AiResearch	836250-1	Thermistor	35 psia		0.1	0.5	89	4	4.5	
70 to 100	Cabin Temperature Anticipator	Cabin Gas	3.6 CSM	820110	5-3	72-8537-12	AiResearch	820110-3	Thermistor			0.1	8	47	4	8.51	
70 to 80	Cabin Temperature Sensor	Cabin Gas	3.8 CSM	820964	5 - 2	72-8537-12	AiResearch	820964-1	Thermistor			0.05	8	35	o	0	
20 to 95	Suit Supply Inlet Temperature Sensor	0xygen	7.17 CSM	836950	4-4	72 -8537- 15	AiResearch	836950-1	Coil and Electronics	6	10	0.2	6	34	6	17.6	Bridge excitation voltage 2.7 ±0.5 vrms, 300 Hz, squ. type wave. 140 ma max.
20 to 95	Steam Duct Temperature Sensor	Steam	8.22 CSM	836950	4-4	72-8 53 7 - 15	AiResearch	8 3 695 0- 2	Coil and Electronics			0.2	6	31	2	6.45	Bridge excitation voltage 2.7 ±0.5 vrms, 300 Hz, squ. type wave, 140 ma max.
-50 to 100	Radiator Outlet Temperature Sensor	Glycol	8.23 CSM	836058	3-3	72-85 37- 15	AiResearch	836058-1	Coil and Electronics	90	150	0.3	6 }	45	14	31.1	Bridge excitation voltage 2.7 ±0.02 vrms, 300 Hz, squ. type wave, 140 ma max.
-50 to 100	Radiator Outlet Temperature Sensor	Glycol	8.23 CSM	836058	3-3	72-8537 - 15	AiResearch	836058-2	Coil and Electronics	90	150	0.3	6)	(F	14),,,	Bridge excitation voltage 2.7 ±0.02 vrms, 300 Hz, squ. type wave, 140 ma max.
20 to 95	Cabin Temperature Transducer	Cabin Gas	9.11 CSM	836930	2~3	72-8537-14	AiResearch	836930-1	Thermistor and Electronics	,		0.2	10	37	6	16.21	Output signal proportional to sensed temperature, 'O' vdc at 40°F and 5 vdc at 125°F

The unique aspect of a thermistor's resistance versus temperature characteristic is its very high coefficient of change of resistance with temperature. This is typically 3 to 5% per degree Centigrade as compared with about 0.4% for platinum. Consequently, it is an ideal temperature transducer, sensitive to small temperature changes and requiring less amplification.

A common transducer power supply was provided for the temperature sensors installed in the Apollo CSM. The performance characteristics for the power supply are shown below.

TEMPERATURE TRANSDUCER POWER SUPPLY (Apollo PN 836066)

Purpose

The temperature transducer power supply furnishes dc operating power and square-wave-type excitation voltage to the amplifier assemblies of the CSM temperature signal amplifiers.

<u>Description</u>

The power supply is hermetically sealed. Solid-state devices are used to increase reliability and reduce power requirements. The power supply is of redundant design, having two identical sections.

Each section comprises a voltage regulator stage, a saturable-reactor-type static-inverter stage, and a differential-amplifier-type feedback circuit to control the voltage regulator. The voltage of the 28-vdc power is applied to the input of the static inverter and also to the temperature transducer amplifiers. The static inverter operates at 300 Hz and design parameters are such that +18-vdc power at the input of the stage produces a 5.4-v peak-to-peak square-wave-type (2.7 vrms) signal at one secondary winding of the inverter transformer. This signal is supplied to the temperature signal amplifiers for use as excitation voltage.

A second winding on the transformer controls a transistor switch used to sample the 5.4-v square-wave-type (2.7 vrms) output for voltage controlling purposes. This sample voltage is applied to one input of a differential amplifier stage. A stabilized reference voltage is applied to the other input of the differential amplifier. This reference voltage is developed in a zener diode filter network from the 28-vdc input power. The outputs from the differential amplifier are amplified in a second differential amplifier stage and then applied to a differential control amplifier, where the control signal for the voltage regulator stage is developed. This control signal corrects the input voltage to the static inverter to maintain an exact 5.4-v peak-to-peak square-wave (2.7 vrms) output.

The regulated +18-vdc power furnished by the power supply is used in the signal amplifier stages. The 5.4-v peak-to-peak (2.7 vrms) 300 Hz, square wave excitation voltage produced by the power supply is used in the chopper-demodulator stage of the temperature signal amplifier assemblies.

Output voltages

2.7 \pm 0.02 vrms, 300 (\pm 30, \pm 100) Hz, sq waves at 700 ma max normal load

current

18.0 \pm 1.0 vdc supply voltage at

165 ma max

-0.5 \pm 0.2 vdc bias voltage at 30 ma max normal load current

Electrical power requirements

Input voltage, vdc

28

Input power, watts

10.7 (max) at 28 +2, -3 vdc

Weight, 1b

1.5

Envelope

See Figure 4-1

A common temperature sensor amplifier was used in the ECS of the Apollo CSM. The performance characteristics of the amplifier are tabulated below:

TEMPERATURE SIGNAL AMPLIFIER (Apollo PN 836056)

Purpose

The power required to operate each of the instrumentation temperature sensors is provided by the amplifier. The sensor output signal is then fed back into the amplifier where it is amplified and then transmitted to telemetry.

Performance and Design Data

Input signal 0 to 29.5 mv rms, 300 Hz.

square-type wave from

instrumentation temp sensor

Output signal O at O input, 5 vdc output across

30,000 ohms external load with 29.5 mv rms, 300 Hz, square-type wave input. Output is proportional

to input

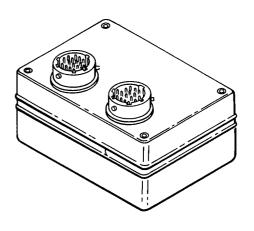
Output signal error Output signal error shall not

exceed $\pm 0.5\%$ ($\pm 0.025v$) of full scale from 0% to 100% of input

Output ripple, mv rms 10 (max)

Input impedance, ohms 270 ± 2.7





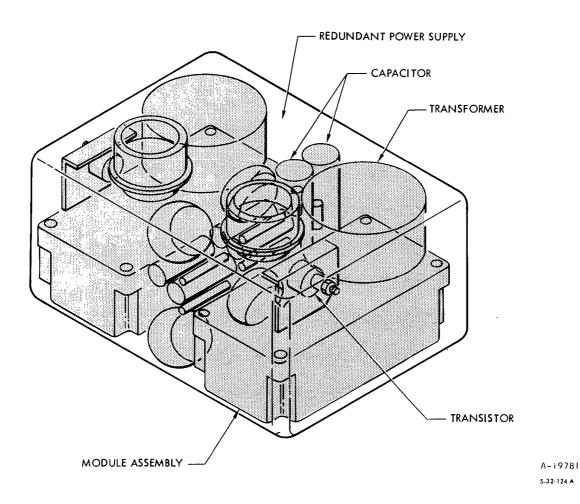


Figure 4-1. Temperature Transducer Power Supply

Output impedance, ohms 400 (max)

Load resistance, ohms 10,000 min; 30,000 nominal

Electrical power requirements

Signal excitation 2.7 ±0.02 vrms, 300 (+30, -45) Hz,

square-type wave at 140 ma

Supply, vdc 18.0 ± 1.0 at 33 ma

Bias, vdc -0.5 ± 0.2 at 6 ma

Weight, 1b 0.3

Envelope See Figure 4-2

DESIGN CONCEPT (WBS 2.0, SOW 3.2.2)

The failure and design evaluation reports contained in AiResearch Reports 72-8537-12, -13, -14 and -15, describe the history of failures that were experienced during the course of the Apollo program and also describe changes that were made to reduce or eliminate the rejections. The resultant failure rate is sufficiently low to be considered acceptable for these units. Design criteria in the form of a training program relative to assembly and test are recommended to further reduce the rejection rate.

VERIFICATION TESTING (WBS 3.0, SOW 3.2.3)

The temperature sensors tabulated in Table 4-I were not selected for corrective design/development during the course of this program; consequently, no verification testing was specified.

DESIGN CRITERIA (WBS 4.0, SOW 3.2.4)

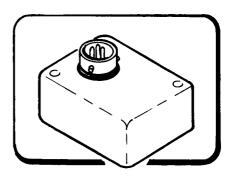
Design criteria appropriate to each of the part numbered temperature sensors listed in Table 4-1 are contained in the AiResearch reports that were prepared during the failure and design evaluation of the temperature sensors. These reports are contained in the Appendix.

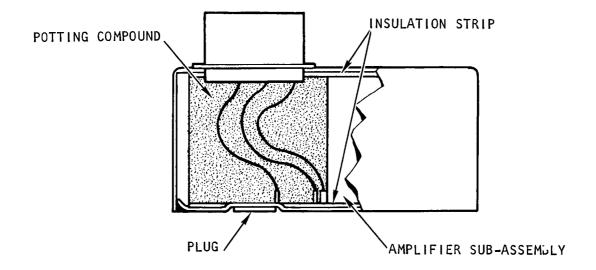
A review of the temperature sensor requirements for the Shuttle ECS has been made by the AiResearch Manufacturing Company. These requirements are contained in Table 4-2.

UNRESOLVED PROBLEM

This section describes the temperature measuring sensors and transducers that were used in the ECS of the Apollo CSM. The GFE failure reports provided the basis for the failure and design information reports that were published during the course of this program; however, reports were not published on the temperature transducers that were used in the environmental







S- 77113

Figure 4-2. Temperature Sensor Amplifier



TABLE 4-2
TEMPERATURE SENSORS REQUIREMENTS FOR SHUTTLE ECS

	Transducer Identification						•	Flight Environment		
SSV I tem	Part Description	Qty Per System	Operating Temperature Range, OF	Proof, psig	Burst, psig	Fluid Media	Normal Temperature, OF	Temperature, OF	Pressure	
1.200	02 Manifold Temperature	1	-75 to 175	1500	2500	02	-75 to 175	60 to 120	14.7 psi, 2 psi min	
1.201	02 Manifold Temperature	1	-75 to 175	1500	2500	02	-75 to 175	60 to 120	14.7 psi, 2 psi min	
3.255	Interchanger Outlet (Primary)	1	0 to 200	22.5	37.5	02/N2	45 to 65	0 to 160	Vacuum	
3.256	Evaporator Outlet (Primary)	1	0 to 100	22.5	37.5	02/N2	35 to 65	60 to 120	14.7 psi, 2 psi min	
3.257	Interchanger Outlet (Secondary)	1	0 to 200	22.5	37.5	02/N2	45 to 65	0 to 160	Vacuum	
3.258	Evaporator Outlet (Secondary)	1	0 to 100	22.5	37.5	02/N2	35 to 65	60 to 120	14.7 psi, 2 psi mir	
3.259	Evaporator Exit Temp (Secondary)	ļ 1	0 to 100	22.5	37.5	02/N2	35 to 65	60 to 120	14.7 psi, 2 psi mir	
3.260	Evaporator Exit Temp (Primary)	1	0 to 100	22.5	37.5	02/N2	35 to 65	60 to 120	14.7 psi, 2 psi mir	
3.290	Cabin Temp	1	0 to 120	22.5	37.5	02/N2	60 to 80	60 to 120	14.7 psi, 2 psi mir	
3.3	Cabin Temp	1	0 to 120	22.5	37.5	02/N2	60 to 80	60 to 120	14.7 psi, 2 psi mir	
4.200	Water Nozzle Temp Sensor	1	0 to 100	22.5	37.5	02/N2	0 to 100	60 to 120	14.7 psi, 2 psi mir	
7.10	Control Temp Sensor	2	0 to 250	22.5	37.5	02/N2	30 to 60	0 to 160	Vacuum	
7.250	Radiator Inlet Temp (Primary)	1	0 to 250	22.5	37.5	02/N2	0 to 210	0 to 160	Vacuum	
7.251	Interchanger Inlet Temp (Primary)	1	0 to 250	22.5	37.5	02/N2	30 to 200	0 to 160	Vacuum	
7.252	Interchanger Inlet Temp (Secondary)	1	0 to 250	22.5	37.5	02/N2	0 to 200	0 to 160 .	Vacuum	
7.253	Radiator Inlet Temp (Secondary)	1	0 to 250	22.5	37.5	02/N2	0 to 200	0 to 160	Vacuum	
7.256	GSE HX Outlet Temperature (Secondary)	1	0 to 250	22.5	37.5	F-21	30 to 185	0 to 160	Vacuum	
7.257	GSE HX Outlet Temperature (Primary)	1	0 to 250	22.5	37.5	F-21	0 to 160	0 to 160	Vacuum	
7.258	Primary F-21 Boiler Outlet Temp	1	0 to 200	22.5	37.5	F-21	0 to 160	0 to 160	Vacuum	
7.259	Secondary F-21 Boiler Outlet Temp	1	0 to 200	22.5	37.5	F-21	0 to 160	0 to 160	Vacuum	

control system for the LM and PLSS. Technical information regarding these sensors was solicited from the manufacturers; however, the information received was not sufficiently complete to permit a thorough evaluation to be made. A follow-up effort to obtain more information from the manufacturers of the LM and PLSS temperature sensors is recommended. This information when supplemented by tests and analyses conducted on sensors that were supplied by NASA will enable failure and design evaluation reports to be prepared including the formulation of design criteria for reducing or eliminating chronic failure modes. A follow-on effort of this type has been proposed to NASA under separate cover.

SECTION 5

FLOW TRANSDUCERS

TRANSDUCER EVALUATION (WBS 1.0, SOW 3.2.1)

The flow transducer monitors the inflow of oxygen into the cabin to satisfy the crew metabolic needs and to make up the loss of cabin gas caused by overboard cabin leakage. The flow transducer also closes a switch which causes a warning light to become illuminated if a higher than normal inflow rate occurs due to excess cabin leakage.

AiResearch Report 72-8537-22, "Report on Failure and Design Evaluation of Apollo ECS Oxygen Flow Transducer," contained in the Appendix shows that approximately 46 percent of the flow transducers was rejected for problems giving cause for the recommendation to redesign the unit.

The oxygen flow transducer used in the Apollo CSM (Figure 5-1) measures the flow rate of the oxygen gas by heat transfer principles. The wire-wound heating element and resistance thermometers are contained in dual 90-degree tubular probes (see Figures 5-2 and 5-3) with the sensing ends located side by side in the main flow stream. This design is very difficult to fabricate and assemble because the heater and thermometer resistance coils, including the wire leads, must be routed through the small tubular probes. The ends of the probes are sealed by soft solder after the installation is completed. The difficulty of installing the heater and thermometer coils inside the small diameter probes frequently is manifested in development of heat transfer problems causing poor stability of the output signal. The problem is compounded by the difficulty of inspecting the miniature, hidden coils after assembly is completed.

Discussions with the manufacturer of the oxygen flow transducer (Tylan Corporation) indicated that this unit will not be available for application beyond the Apollo program. The growth in performance requirements imposed on this unit during the Apollo program resulted in extremely tight packaging. Tylan Corporation personnel stated that a portion of the subassembly is considered a blind assembly making in-step inspection impractical. They further stated that when sufficient subassembly has been accomplished to reach a test milestone, if an error was found, the subassembly was not reworkable, and therefore, had to be completely redone. This was the major cause for the high price of the unit. Personnel of the Tylan Corporation recommended that the oxygen flow transducer be redesigned to take advantage of the techniques used in a unit that has been sold commercially over the past four years. This unit employs a similar concept for flow measurement in a configuration that is relatively easy to assemble, inspect and test. A statement of work presented in Exhibit 5A was negotiated with the Tylan Corporation for the purpose of converting the commercial flow transducer to a flight-type design. AiResearch awarded the Tylan Corporation a subcontract in October 1972 to repackage the commercial transducer into an aerospace-type unit, correct the "g" sensitivity

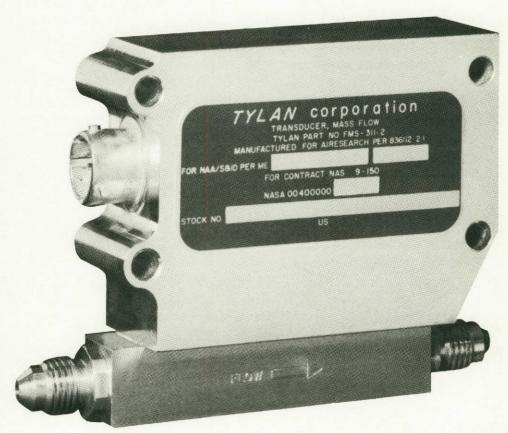


Figure 5-1. Apollo CSM Oxygen Flow Transducer

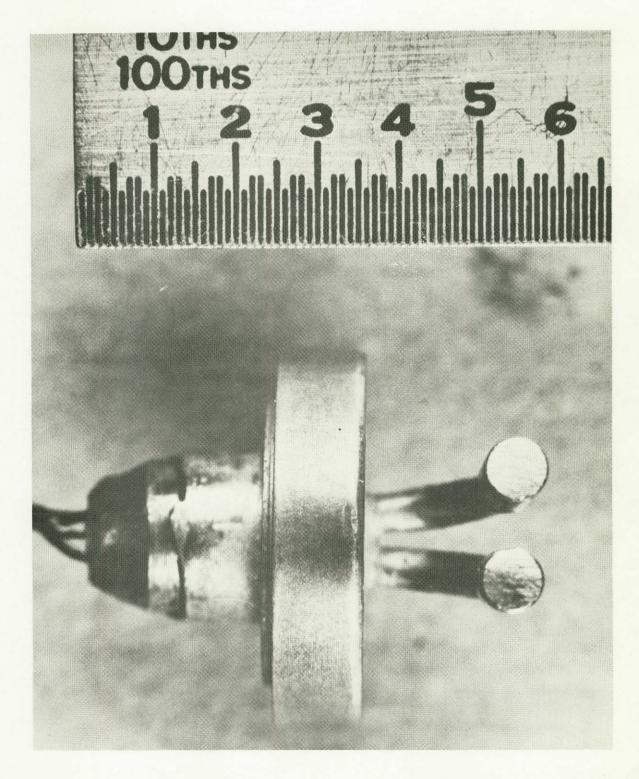


Figure 5-2: Apollo CSM 0₂ Flow Sensing Element



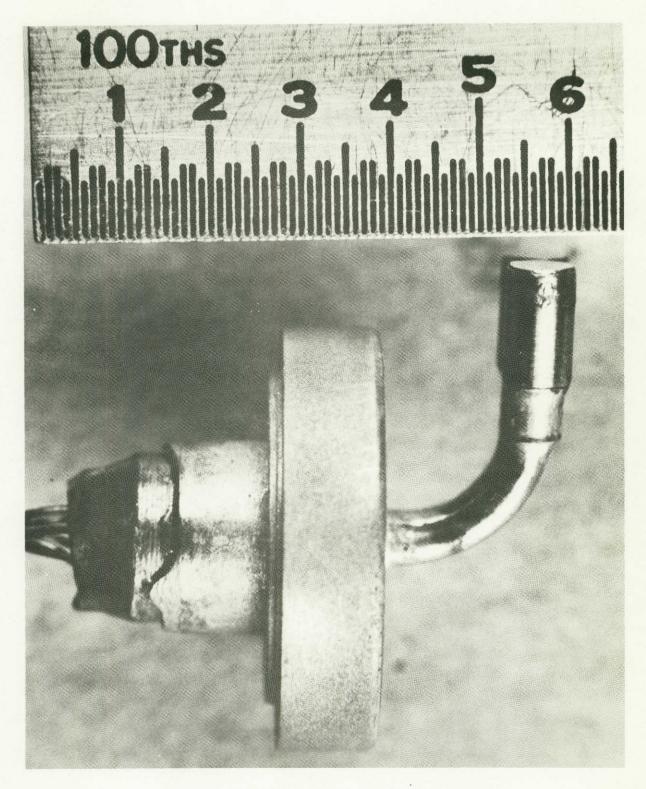


Figure 5-3. Apollo CSM 0₂ Flow Sensing Element



of the sensing element and perform a vibration test of the sensor portion only, in accordance with SSV vibration requirements.

DESIGN CONCEPT (WBS 2.0, SOW 3.2.2)

The improved technique for measuring oxygen flow developed by Tylan for their commercial unit is shown in Figure 5-4. It measures the mass flow rate of the oxygen by heat transfer principles. A small portion of the oxygen gas flowing through the transducer is forced to flow through the sensor which consists of a small diameter capillary tube mounted across a laminar-flow bypass in the main flow line. The ΔP of the sensor and bypass is approximately 5 to 7 inches of water at full-scale flow rate.

The sensor is wound with a heater coil in the middle and a resistance thermometer is wound around the tube on both sides of the heater. A few milliwatts of heat applied by the heater raises the gas stream temperature slightly, changing the relative reading of the two thermometers. The design parameters are such that the temperature difference signal between the resistance thermometers is directly proportional to flow and is also linear. The reading is not affected by changes in gas pressure or temperature within specific ranges. This construction has several distinct advantages for space flight applications, all of which relate to the fact that the sensor elements are on the outside of the sensing tube.

- 1. There is no exposure of the elements to the gas in the tube, hence, no erosion or corrosion problems.
- 2. There are no electrical feed-throughs, so the flow passage has outstanding leak integrity.
- 3. Fabrication and inspection are facilitated, so quality control and reliability are enhanced.

The sensor is deliberately made small to achieve fast response and minimum power consumption; therefore, only a fraction of the total flow passes through the sensor. The greater portion of the flow passes through a bypass which is thermodynamically similar to the sensor and gives a constant bypass ratio under all extremes of operation. The use of the flow transducer in widely different flow range applications, involves bypass modification only; the sensor and signal conditioner are not changed.

Coordination meetings between AiResearch and the Tylan Corporation were held during the course of the subcontracted program to identify the problem statement for the new flow transducer with special emphasis placed on the Shuttle ECS requirements and review of progress and performance of the following tasks:

Task 1--Performance of a heat transfer analysis on the sensor to determine the tradeoffs in response, g-sensitivity and sensor gain as a function of the supporting insulation necessary for vibration survival.

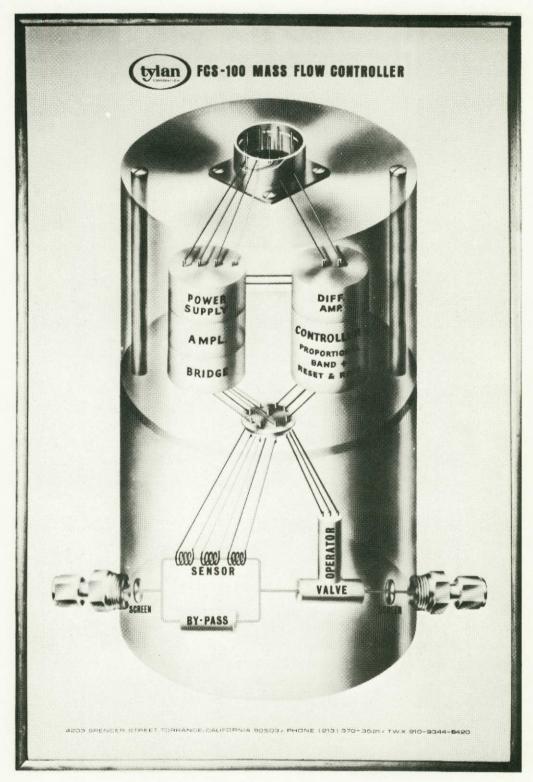


Figure 5-4. Commercial Mass Flow Controller



Task 2--Fabrication of a prototype sensor section using existing hardware and the subsequent testing of g-sensitivity, temperature stability, response and vibration survival.

Task 3--Determination of the input-output parameters, built-in-test capability and the required circuitry for preventing damage due to misapplication of the input power.

Task 4--Design, breadboard and test of the electronic circuit required to operate with the modified sensor to meet the desired performance specifications.

Task 5--Identify and prescribe mechanical features of the flight transducer to ensure compliance with Shuttle performance and environmental requirements.

Task 6--Preliminary package design resulting in a proposed outline drawing.

The following paragraphs supply descriptive information that amplifies the above tasks.

Sensor Development (Task 1)

Figure 5-5 is a photograph of the sensor portion only for the new oxygen flow transducer. Two heavy sections are attached to each end of a 0.010-in. diameter capillary tube. The heavy sections install in two counterbored holes located on either side of a laminar flow bypass in the main oxygen flow line. The ΔP of the bypass is approximately 5 to 7 in. of water which forces a proportionate amount of flow through the capillary tube. The sensing element (capillary tube assembly) is wound with a heater coil in the middle and a resistance thermometer is wound around the tube on either side of the heater. The heater and thermometer wires are routed through plastic supports on each end of the U-tube.

The sensor measures flow by heat transfer principles. A few milliwatts of heat applied by the heater raises the gas stream temperature slightly, changing the relative readings of the two thermometers. In one "g", the heat rises vertically intersecting the sensor assembly in a given plane. As the sensor assembly is rotated, the heat continues to rise vertically, but intersects a different portion of the sensor causing a drastic change in the sensor output. A thermal analysis has been prepared by Tylan; this analysis shows that by maintaining a small air gap around the sensor and a specified amount of insulation located outside of the air gap, the "g" sensitivity can be virtually eliminated.

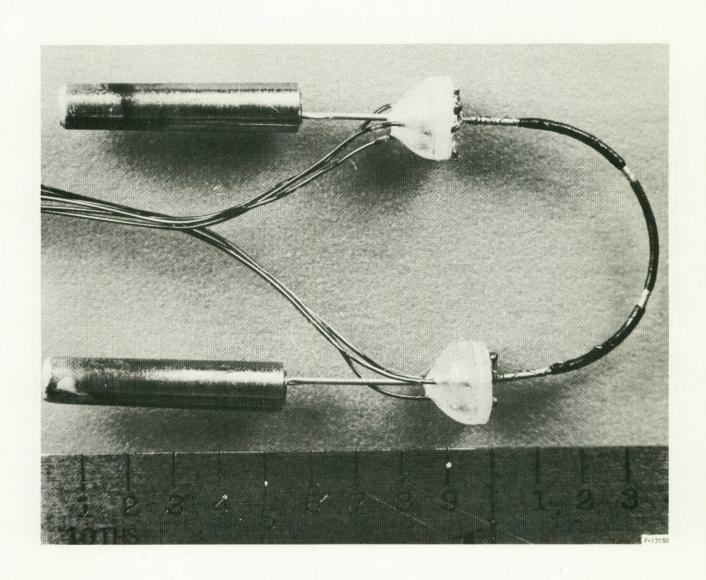


Figure 5-5. Oxygen Flow Sensor

Guidelines developed during heat transfer analysis showed that the primary consideration is the steady-state solution which shows that the insulation should be optimized primarily to have minimum heat transfer (small thermal conductivity of insulation material). This will result in a minimum reduction of sensor gain.

The optimum insulator is a vacuum while second best would be a gas with just enough solid in it to stop convection (foams, mats, honeycombs). Argon is better than air, but would diffuse from a foam unless contained.

It is desirable to maintain the smallest practical air gap between the insulation and the sensor because this gives the least g-sensitivity with a reasonably small heat transfer coefficient.

In summary, the best material would be a low-density foam with good insulating properties clamped onto the sensor to give a minimum (but finite) air gap and rigid enough to support the sensing tube during vibration.

Results of Sensor Tests (Task 2)

Preliminary g-sensitivity, gain, and response tests were run on two styles of modified sensors and several types of insulating methods and materials to determine an optimum configuration. The test results (see data sheets 1 through 17, Exhibit 5B) were found to verify the conclusions made from the heat transfer analysis. Simplicity and ease of manufacture were taken into consideration in selecting the optimum configuration used for the final environmental testing.

NOTE: The term, "doghouse", in the data sheets refers to an insulation enclosure shaped like a doghouse. This enclosure was placed over the sensor to isolate the test article from room air currents, etc. The flight design will incorporate insulation and hermetic sealing as determined necessary by these breadboard tests.

The final configuration consisted of a type B sensor, taped between two 1/8-in. blocks of beaded polystyrene foam, which was enclosed in a metal can for mechanical support. All of the final tests were run on this configuration using the breadboard electronics. The tests and test results follow.

1. G-sensitivity (Data Sheet No. 1F, Exhibit 5B)

With the flow set to give an output signal of 5.00 vdc, the unit was rotated around both axes to determine the shift due to attitude. The maximum shift in output voltage occurred at 90 deg along the pitch axis and was found to be no greater than 0.01 vdc (± 0.2 percent f.s.).

2. Response (Data Sheet No. 1F, Exhibit 5B)

Response curves were run by producing step changes in flow from 10 to 100 percent and 100 to 10 percent full scale flow while recording the output voltage versus time. The worst-case time response was found to be from 100 to 10 percent which had a first-order time constant (to 63 percent of the change) of 4.0 sec and a time constant of 25 sec to be within 2 percent of final value. An electronic lead circuit was added and the tests were repeated with the result that, although the first-order time constant was reduced to 0.25 sec, a 15 percent overshoot resulted which had a settling time to within 2 percent of final value of 25 sec. Since this response curve could only be advantageous in a feedback control system, it was decided that the additional complexity was not warranted in this application.

3. Linearity (Data Sheet No. 2F, Exhibit 5B)

With the full scale output set at 1.0 lb/hr (arbitrarily determined by the adjustment of the bypass), the electronic linearity adjustment was calibrated to give 2.50 vdc output at 0.5 lb/hr. A curve of output voltage versus flow rate was run and the linearity was seen to be within ± 0.4 percent full scale over the flow range. Separate tests run on the electronics shown that the adjustment was capable of linearizing up to a ± 5 percent nonlinearity. Nominal sensor nonlinearity is ± 2 percent.

4. Supply Voltage Sensitivity (Data Sheet No. 2F, Exhibit 5B)

With the flow adjusted to give 5.00 vdc output, the supply voltages were varied from 14 to 16 vdc and the output voltage was seen to remain constant within ± 0.6 percent full scale.

5. Vibration (Data Sheet No. 3F, Exhibit 5B and Exhibit 5C)

A calibration curve was run of output voltage versus flow and the sensor assembly was then subjected to random vibration (for a reduced time duration). The overall sensor resistance was monitored during vibration testing and was observed to remain constant. The calibration curve was rerun after vibration and the output versus flow was seen to repeat the pre-vibration data within ± 0.2 percent full scale from 0 to 5.00 vdc.

6. Temperature Stability - Sensor Only (Data Sheet No. 4F, Exhibit 5B)

Output voltage versus flow rate was run at 0° F, 70° F and 160° F with the bypass plugged and the calibration was seen to be stable to within ± 2 percent.

7. Temperature Stability with 1.0 lb/hr Bypass (Data Sheet No. 5F, Exhibit 5B)

Output voltage versus flow rate was run at 0° F, 70° F, 120° F and 160° F with a bypass and the calibration was noted to be stable to within ±6 percent worst



case. (Since existing hardware was used, a marginal bypass design was necessary due to the undersized bore of the bypass port. In the proposed package design, allowance has been made for adequate sizing of the bypass port to allow for a proper bypass design which should exhibit better flow spitting characteristics over the required temperature range and thus improve the temperature stability of the complete unit.) During the temperature tests, the electronics were held at room ambient temperature while the flow sensor assembly and gas were stabilized in an environmental chamber to the noted temperatures.

The proposed installation of the oxygen flow transducer in the Shuttle ECS shows the transducer installed in a line that may flow either oxygen or nitrogen depending on the demands established by the 2-gas control. An analysis was made to determine what effect the alternate flow of oxygen or nitrogen would have on the output signal of the transducer. Tests were run to verify the analysis and the results of both the analysis and the tests showed that the indicated flow rate would be different by no more than 0.5 percent because of the similar characteristics of nitrogen and oxygen.

Electronic Circuit Design Considerations (Task 3)

Guidelines established prior to the development of the electronic circuit included requirements pertinent to the Shuttle vehicle. These guidelines were:

- Simple design
- Require no maintenance or refurbinshment for 100 or more launches
- Require little or no ground checkout; such checkout to be simple
- Be unaffected by long quiescent periods in space environment
- Be economically produced
- Be lightweight
- Consume minimum electrical power

During the circuit analysis several design features were made mandatory to accommodate the requirements established by the Shuttle guidelines. These design features are given in the paragraphs that follow.

Design a circuit such that the end products can withstand an inadvertent application of 32 vdc to the 0-5 vdc output pins and also a reversal of polarity on the input power pins.

The circuit shall incorporate a switch that is activated when the flow of oxygen or nitrogen exceeds "normal." The purpose of this switch is to illuminate

a warning light on the pilot's panel in the event cabin or system leakage exceeds specified limits. The vehicle 28 vdc electrical power system shall be used for energizing the warning lamp.

Incorporate built-in-test equipment (BITE) to permit all the circuitry between the input and output to be checked while the transducer is installed in the vehicle.

Design the circuitry in the transducer to interface with a separate power supply that is common for any other transducers on Shuttle. The various reasons for a separate power supply are described in the following:

- (a) The power supply complexity and failure rate is greater than that of the flow transducer. The manufacturing cost of the transducer, however, will be much higher than the power supply because of its mechanical parts and specialized calibration testing. Economics of operation and repair will therefore result from separating the power supply failures from the transducer.
- (b) Redundant separate power supplies can supply multiple transducers, whereas integral power supplies would require the same redundancy per transducer to achieve similar reliability. Cost, complexity, size and weight would suffer.
- (c) Since power levels are low, the combining of numerous small power supplies into fewer larger power supplies will result in savings of size, weight and complexity.
- (d) The removal of the power supply converter from the transducer case eliminates the major source of EMI problems from the transducer. This is of considerable importance to reliability and to development costs.

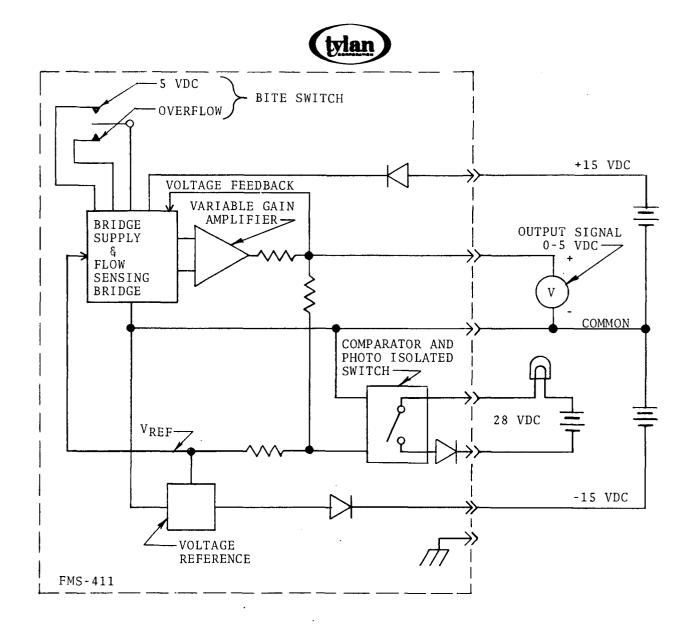
Electronic Circuit Analysis and Test (Task 4)

The transducer electronic circuit diagram shown in Figure 5-6 includes amplification and associated signal conditioning, an isolated solid-state switch output for overflow indication and BITE for quantitative checking of zero, full scale, and overflow output signals. It does not include power supply isolation, but is designed to operate from an isolated ±15 vdc supply. Final power supply cleanup is included so that the specifications on the external power supply are eased. EMI protection is also included, although filtering problems are greatly reduced by the use of the separate power supply isolation and the fact that the entire transducer uses only low-frequency, low impedance signals and interface connections.

Built-in-test capability is accomplished by the use of one spring-loaded, 3-position switch which functions as follows:

(a) Normal position: output voltage = 0 ± 0.15 vdc at no flow which is normal operation.





BLOCK DIAGRAM

Figure 5-6. Electronic Circuit Block Diagram.



- (b) Momentary left: output voltage = 5.0 ±0.15 vdc. The flow sensor bridge is unbalanced a precise amount, and the sensor, reference circuitry and amplifier are all checked simultaneously.
- (c) Momentary right: output voltage +6.25 ±0.5 vdc and the overflow warning light illuminates. The flow sensor bridge is further unbalanced to actuate the overflow warning circuit to verify its operation.

The circuit can easily be protected from any combination of misapplication of input power by the use of diodes and current limiting resistors.

The electronic circuit was breadboarded as shown in Figure 5-7 for use in conjunction with the tests run on the sensing element. Several iterations were made to the circuit to achieve the desired design features. In addition, an electronic lead circuit was added which reduced the response time of the sensor to 0.5 sec. It was concluded from test results that the additional complexity of the lead circuit was not warranted because a satisfactory response time (6 sec) could be achieved without the electronic lead circuit.

The electronic breadboard was required during development and environmental testing of the sensing element; however, the circuit was not subjected to any of the test environments because of the nature of the breadboard packaging and because the circuit employs highly developed state-of-the-art components. Environmental testing of the circuit will be meaningful on a prototype unit that is designed and packaged in accordance with production type drawings.

Transducer Mechanical Features (Task 5)

The Shuttle cabin holds 150 lb of oxygen and nitrogen when the cabin is pressurized to 14.7 psia. Oxygen gas is selected by the two-gas control at the start of cabin repressurization until a partial pressure of oxygen (PO_2) of 3.1 psia is achieved for a total of 35 lb of oxygen. Nitrogen gas is then selected by the two-gas control until 14.7 ± 0.2 psia is achieved for a total of 115 lb of nitrogen.

The flow transducer is installed in the atmosphere repressurization line, therefore, it is required to flow 150 lb/hr of oxygen or nitrogen at a maximum allowable ΔP of 10 psi. The normal oxygen supply pressure is 100 psi and the pressure is 140 psi when nitrogen is flowing.

The oxygen/nitrogen flow transducer is designed to monitor flow rates in the range of 0 to 2 lb/hr. Only a fraction of the flow passes through the sensing element of the transducer, thus achieving fast response and minimum power consumption. The greater portion of this flow passes through a bypass which is thermodynamically similar to the sensor and gives a constant bypass ratio under all normal extremes of operation.

While the pressure drop of the flow transducer is low during normal operation, it may be excessive at a very high overflow; therefore, provision has been



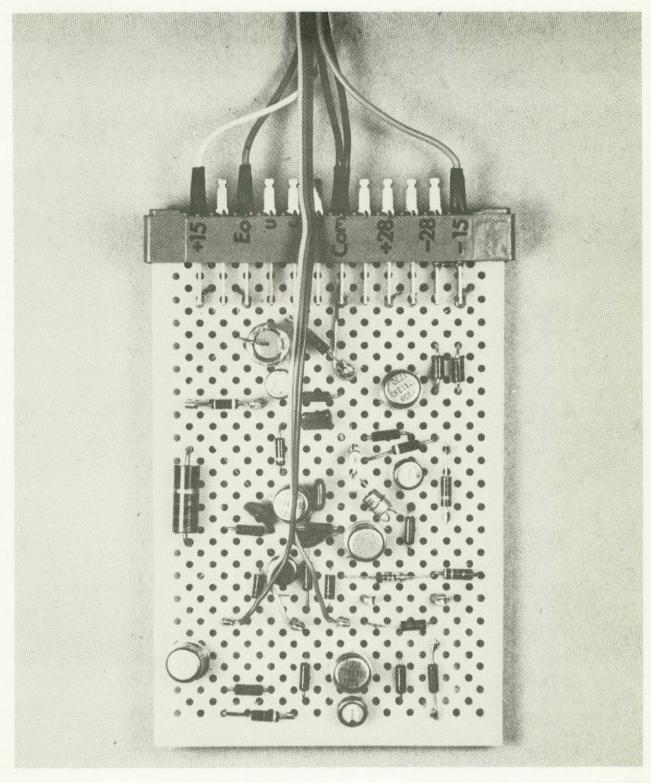


Figure 5-7. Breadboard Electronics Circuit for the ${\rm 0_2/N_2}$ Flow Transducer

made for the addition of an external bypass relief valve. This valve would be closed at all flow rates in the normal sensing range, but would open when the pressure drop becomes excessive during high overflow conditions. Because of the rather large spread between normal maximum pressure drop and overflow pressure drop (1.0 to 10.0 psid), the pressure relief valve problem statement is considered to be rather simple.

The cartridge type relief valve is identical to a relief valve that has been used in the Gemini environmental control system. The housing for the relief valve is shown by dashed lines on outline drawing FMS 411. The inlet and outlet ports of the relief valve are sealed by static 0-rings at the interface surface between the flow transducer and the relief valve.

As an alternate, a separate relief valve may be installed in the Shuttle ECS such that its flow is parallel to the flow transducer. This method, however, requires extra fittings to be used which results in more weight and volume and a greater possibility for leakage.

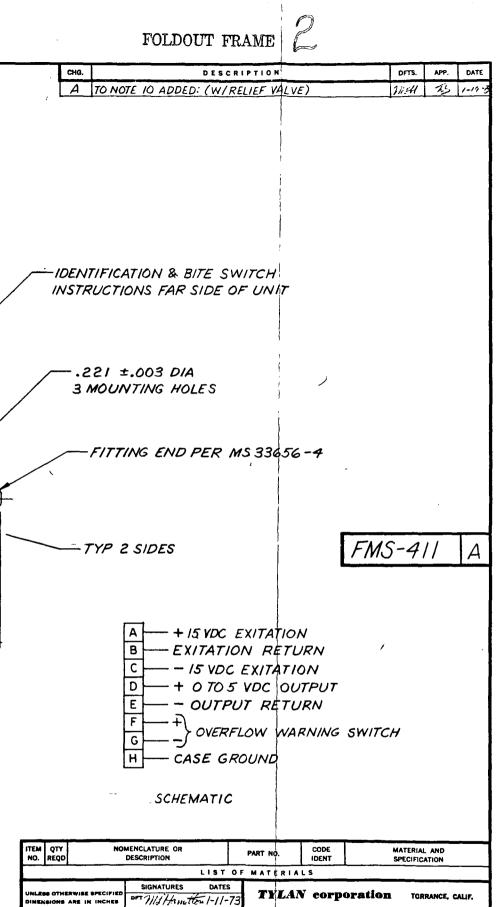
Stainless steel (type 316) is used for the flow passage, sensor, bypass, fittings and all other parts wetted by the working fluid. The signal conditioner case is aluminum, locally plated to receive the solder-mount connector. Interfaces between the case and cover and between the case and flow section are 0-ring-sealed. The MS 33656 fittings are also 0-ring-sealed in the flow housing. The mounting holes for the unit are a part of the cover; this part is inexpensive to replace if damaged by excessive handling.

Flow Transducer Package Outline (Task 6)

A layout drawing was prepared and reviewed jointly by AiResearch and Tylan personnel. The breadboard modules provided the basis for the general arrangement of the transducer. The component part sizes and interfacing techniques demonstrated on the breadboard were translated into a production design with emphasis on making the transducer easy to manufacture, assemble, inspect and test. The density of the electronic package was made similar to other recently developed electronic packages and is in conformance with the Shuttle guidelines. Several iterations were made to the layout drawing as a result of the design review culminating in the transducer outline drawing FMS 411. The overall size of the 2.0 lb/hr transducer, including a larger electrical connector and the addition of a BITE switch, is approximately the same size as the 1.0 lb/hr oxygen flow transducer used in the Apollo CSM.

VERIFICATION TESTING (WBS 3.0, SOW 3.2.3)

The verification tests conducted on the oxygen/nitrogen flow transducer breadboard modules are described in this section under the heading Design Concept because of the iterations during analyses, design, breadboard fabrication and verification testing.



INCREASING FLOW

7. ACCURACY: ±3% FULL SCALE FROM 40° TO 110°F, ±10% FULL SCALE AT -20°F & +165°F

8. OVERFLOW WARNING: SOLID STATE SWITCH CLOSURE AT 2.3 TO 2.8 LB / HR WITH

2.93 -

FL'OW__

3.8

.40 – .20 –

2.875

-70

 $\bigoplus_{i \in A} \widehat{A}_i$

-05.

BITE SWITCH

BENDIX PTIH-12-8P(101)

PRESSURE RELIEF VALVE-

9

CONNECTOR

2.531

- 6. OUTPUT SIGNAL: 0 TO 5 VDC OVER THE FLOW RANGE
- 5. MAXIMUM PRESSURE DROP: 1.0 PSI AT 2.0 LB/HR FLOW
 10.0 PSI AT 150 LB/HR FLOW (WITH RELIEF VALVE)
- 4. LINE PRESSURE: 80 TO 160 PSIG

--- .60 |

-1.10 --

4.25

5.25

- 3. TEMPERATURE RANGE: -20°F TO +165°F
- 2. FLOW RANGE: OTO 2.0 LB/HR
- I. FLOW MEDIUM: GASEOUS OXYGEN OR NITROGEN

(9) PRESSURE RELIEF VALVE & NOT A PART OF FMS - 411

NOTES: UNLESS OTHERWISE SPECIFIED

NO.	QTY REQD		NOMENCLATURE OR DESCRIPTION			.	CODE	MATERIAL AND SPECIFICATION			
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TOLERANCES ON DECIMALS: X ± 1 XX ± .03 XXX ± .03 ON ANGLES ± ½ BREAK SHARP EDGES .010 MAX. SURFACE FINISH 63 RNS HEXT ASSY F/NAL USED ON F/NAL		.1 .03	APP 75C	PLOWMETER							
		EDGES .010 MAX.	APP	L	, 201, 112, 121						
			DEGR ACTIVITY APP		Č	_	IDENT NO. 4260	FM	5-4//		Ā
			OTHER ACTIVITY AP	SCALE:	1//	wr: /	602	SHEET /	OF /	; `	

DESIGN CRITERIA (WBS 4.0, SOW 3.2.4)

The oxygen/nitrogen flow transducer is an outgrowth of the Apollo CSM oxygen flow transducer produced by Tylan Corporation (see Figure 5-1). The earlier unit was difficult to manufacture and troubled with stability problems locked in by an early design freeze, but otherwise showed a good reliability record on all of the Apollo lunar flights. About 70 units were made.

The proposed flowmeter is more closely related in sensor design to an industrial unit which has been in production for four years. This sensor is used on mass flowmeters, mass flow controllers and vaporizer controllers for many kinds of hard-to-handle gases. Tylan flow equipment using these sensors see daily workhorse production usage in the semiconductor industry throughout the free world. Approximately 2500 units are in use in the U.S., Japan and Europe, measuring and controlling the flow of hydrogen, oxygen, helium, silane, arsine, phosphine, anhydrous HCI gas and many other gases.

CONCLUSIONS

Based on the analyses and test results obtained during the development program, the feasibility of successfully producing a reliable oxygen/nitrogen flow transducer for space shuttle application has been established. The primary concerns of g-sensitivity, response, temperature stability and vibration survival appear to present no particular problems that cannot be solved by a sound electromechanical design.

The performance and design data of Table 5-1 summarize the characteristics of the oxygen/nitrogen flow transducer developed during this study program.

RECOMMENDATIONS FOR FUTURE WORK

The following is recommended for a continuing development of the oxygen/nitrogen flow transducer:

- 1. Design and fabrication of a prototype unit per the proposed outline drawing (FMS 411).
- 2. Circuit analysis (worst case stress and error).
- 3. Performance tests of the prototype including:
 - (a) Calibration at -20° F, 40° F, 75° , 110° F, 165° F
 - (b) BITE functions
 - (c) Power supply sensitivity
 - (d) Attitude sensitivity
 - (e) Dynamic response
 - (f) Survival of incorrect connections
 - (g) Vibration, operating



TABLE 5-1

PERFORMANCE AND DESIGN DATA

Input power

+15 vdc ± 1 vdc, 25 ma max -15 vdc ± 1 vdc, 25 ma max

The circuit is protected so that the end product can withstand an inadvertent application of 32 vdc to any connector pins in any combination for a minimum period of one minute.

Flow range (oxygen or nitrogen)

O to 2 lb/hr to be equivalent to 0-5 vdc

The oxygen flow transducer installs in the SSV ECS in a line that may flow either oxygen or nitrogen depending on the level of the PO_2 in the cabin. The indicated flow when nitrogen is flowing will be different by no more than 1/2% because of the similar characteristics of nitrogen and oxygen.

A spring-loaded, 3-position switch will check all of the circuitry between the plus and minus I5 vdc input and 0-5 vdc output. With the BITE switch activated and no oxygen flowing, the output of the transducer shall read 5 vdc, and with the switch in the normal position, the output shall read 0 vdc. Alternate actuation of the BITE switch tests the overflow warning.

Response time

6 seconds max (to 63% of final value following step change in flow rate)

Output signal

0 to 5 vdc linear over flow range

Output ripple

25 mv max

Output impedance

10 ohms max (5K min load)

Accuracy

 $\pm 3\%$ f.s., 40° F to 110° F $\pm 10\%$ f.s., -20° F to 165° F

Temperature range

 -20° F to $+165^{\circ}$ F

High flow for switch point of panel warning light

2.3 to 2.8 lb/hr

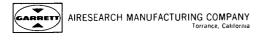


TABLE 5-I (Continued)

Overflow switch rating

100 ma at 28 vdc

A solid-state photo-isolator switch closes when the flow of oxygen or nitrogen exceeds "normal." The purpose of the switch is to illuminate a warning light on the pilot's panel in the event cabin or system leakage exceeds specified limits. The vehicle 28 vdc electrical power system shall be used for energizing the warning lamp.

A second position on the BITE switch is incorporated for checking the photo-isolator circuit.

Maximum overflow requirement for cabin repressurization

*150 lb/hr

*The SSV cabin holds 150 lb of oxygen and nitrogen when the cabin is pressurized to 14.7 psia. Oxygen gas is selected by the two gas control at the start of cabin repressurization until a partial pressure of oxygen (PO₂) of 3.1 psia is achieved for a total of 35 lb of oxygen. Nitrogen gas is then selected by the two-gas control unit 14.7 ±0.2 psia is achieved for a total of 115 lb of nitrogen.

Pressure range (supply)

80 to 160 psig

Pressure drop (max)

1.0 psid at 2.0 lb/hr
10.0 psid at 150 lb/hr*

Weight

16.0 oz (max) 24.0 oz (max*

*With high-flow relief valve added

Electrical connector (6 pins plus I pin for case ground)

AiResearch Part No. 223-022-9016

EMI

Per MIL-STD-461 and 462

Environmental

Per AiResearch Document No. SC 633000

Envelope

See Drawing FMS 411



EXHIBIT 5A

OXYGEN FLOWMETER MODIFICATION STUDY STATEMENT OF WORK

EXHIBIT 5A

OXYGEN FLOWMETER MODIFICATION STUDY STATEMENT OF WORK

PUPROSE

1.1 OBJECTIVE

The objective of this statement of work (SOW) is to describe the effort required to modify an existing oxygen flowmeter design for space shuttle application.

1.2 END PRODUCT

The end product of this effort will be (a) test results, (b) a preliminary flowmeter package design, and (c) a final report.

1.3 BACKGROUND

The effort described in this SOW is in support of an environmental control system (ECS) transducer development study for NASA, Manned Spacecraft Center, under Contract No. NAS 9-12452. See AiResearch request for Quotation No. 1387-2, dated 15 June 1972 for further background information, Attachment 1. It seeks to determine the utility of an existing flowmeter, suitably modified for space shuttle application. See Tylan letter 2184 for further background on the flowmeter.

2. SCOPE

2.1 GENERAL

The contractor will provide the necessary resources to modify the oxygen flow transducer and perform the necessary tests and analyses per the technical requirements section of this SOW.

2.2 PROGRAM SCHEDULE

The contractor will comply with the schedule presented in Figure 1.

3. TECHNICAL REQUIREMENTS

3.1 GENERAL

The contractor will respond to the technical requirements described in this section.

3.2 SPECIFICATION DEVELOPMENT

3.2.1 Environmental

Typical spacecraft environmental system specifications are included as Attachments 2 and 3 to this SOW.

3.2.2 Configuration

Configuration specification including provisions for mounting and connections and size and weight will be determined jointly by AiResearch and the contractor.

Materials specification are per Attachments 2 and 3 for the sensor package and will be determined for the breadboard electronics package.

3.2.3 Interface

Interface considerations including power supply interconnections and computer and outputs connections to provide built-in-test capability will be determined by AiResearch and the contractor. Tylan will define and provide input-output parameters for normal and failure conditions for each of the functional blocks.

3.3 TRANSDUCER MODIFICATIONS AND TESTS

Modified sensors will be tested for g-sensitivity, temperature stability and response by the contractor. The breadboard signal conditioner will be used during these tests but need not be subjected to the transducer environment.

Modified sensors will be subjected to the launch vibration equipment level vibration specification per Figure 3 of Attachment 2 except that durations may be reduced.

3.4 PRELIMINARY PACKAGING DESIGN

The results of the preliminary packaging design will include drawings and descriptions of accessibility, sealing and space allocation. A layout drawing showing complete packaging will be provided up to but not including the power supply.

3.5 FINAL REPORT

A final report will be prepared by the contractor which includes the following items as a minimum.

3.5.1 Proposed Specifications

3.5.2 Outline Drawing

3.5.3 Results of Analyses

3.5.4 Results of Tests, Including Photographs



3.5.5 Conclusions

3.5.6 Recommendations for Future Work

4. COORDINATION MEETINGS

A minimum of three coordination meetings will be held between AiResearch and the contractor, as indicated on the program schedule. With the exception of the first meeting, each will include a detailed status report by the contractor regarding the current attainment of program objectives. Specific interested parties from AiResearch and NASA may witness tests, examine parts, review circuits, and otherwise technically monitor the proprietary portion of Tylan's effort which cannot be publicly revealed.



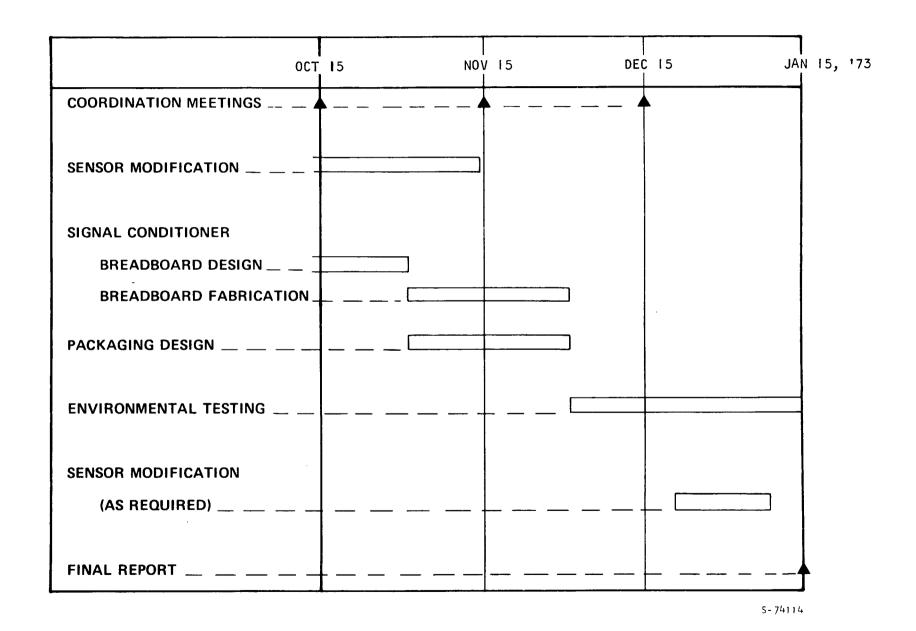


Figure 1. Program Schedule

EXHIBIT 5B SENSOR TEST DATA SHEETS



TYLAN CORP. DATA SHEET / 3046 Sensor Response and g-Sensitivity

Date	11-8-72
Part	NO. NR
Repor	t No.

Job No. 3046	
Tested By Perry	
Q.C. NIR	

- 1. Sensor Configuration: TYPE B-BARE W/BEAPED POLYSTYRENE COVER.
 (DORNON-FR 100) W/ DOG HOUSE.
- 2. Current Thru Sensor, Eo= 5.00v (Is): 12.8 ma
- 3. Risetime: 10 to 98% (.500 to 4.85v): 1) Sec. To 63%(3.33v): 3 sec.
- 4. Falltime: 100 to 12% (5.00 to .600): 00 sec. to 63%(2.33v): 3 sec.
- 5. g- sensitivity, Eo= 4.99 (sensor Perpendicular to Horizon)

Pitch Axis: Sensor 30° to Left of Perpendicular 486 × %-1.7

Sensor 30° to Right of Perpendicular 5.09 × %+2.0

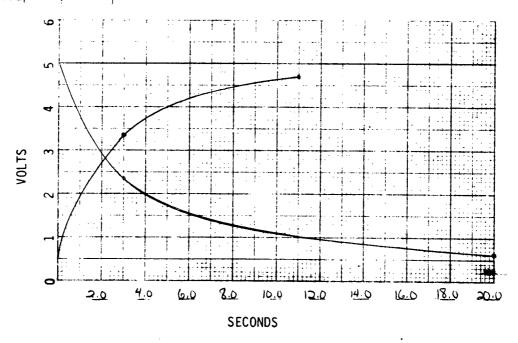
Roll Axis: Sensor 30° to Left of Perpendicular 4.99 × % 0

(outlet side) Sensor 30° to Right of Perpendicular 5.03 % +0.8

6. Resistance Values of:

R₁₂ 750 2 R₁ 20 K R₂ 19.81 K

7. Graph to and te





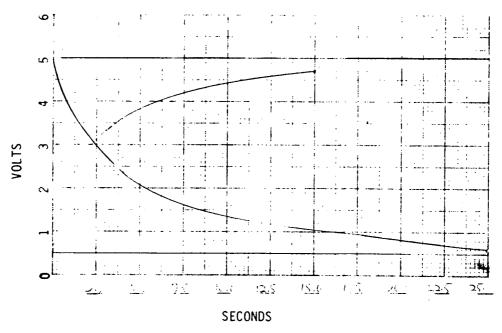
TYLAN CORP. DATA SHEET 2 3046 Sensor Response and g-Sensitivity

Par	$\begin{array}{cccccccccccccccccccccccccccccccccccc$	
1.	Sensor Configuration: TIDE B - DIDERED IN TOLYUR CTURNE FORM. 18 1940	
2.	Current Thru Sensor, Eo= 5.00v (I _s): 14.6 mg	
3.	Risetime: 10 to 98% (.500 to 4.85v): 15 sac. To 63%(3.33v): 3 sac.	
4.	Falltime: 100 to 12% (5.00 to .600): 25 sec. to 63%(2.33v): 4 356.	
5.	g- sensitivity, Eo= 499 (sensor Perpendicular to Horizon)	

6. Resistance Values of: $R_{12} = 630 - 6$ $R_{11} = 20 \times 6$ $R_{21} = 19.73 \times 6$

Pitch Axis: Sensor 30° to Left of Perpendicular 4.5% v Sensor 30° to Right of Perpendicular 5.26 v Roll Axis: Sensor 30° to Left of Perpendicular 4.99 v (outlet side) Sensor 30° to Right of Perpendicular 5.06 v

7. Graph t_r and t_f



5.4



TYLAN CORP. DATA SHEET 3 3046 Sensor Response and g-Sensitivity

Par	t No. NIR ort No. 1	Job No. 3046 Tested By Dezad Q.C. N R
1.	Sensor Configuration: TYPE B GARE WITH BELDED Dely	STUREDA CLUSA
2.	Current Thru Sensor, Eo= 5.00v (I _S): 29 mc.	
3.	Risetime: 10 to 98% (.500 to 4.85v):To	63%(3.33v): <u>3.22.</u>
4.	Falltime: 100 to 12% (5.00 to .600):to	63%(2.33v): <u>3 3/c</u> .
5.	g- sensitivity, Eo= is (sensor Perpendicular	to Horizon)
	Pitch Axis: Sensor 30° to Left of Perpendicular n.9% Sensor 30° to Right of Perpendicular 5.03 Roll Axis: Sensor 30° to Left of Perpendicular 4.99 (outlet side) Sensor 30° to Right of Perpendicular 4.99	%-0.7 %-0.₹ %-0.₹ %-0
6.	Resistance Values of: $\begin{array}{c} R_{12} \xrightarrow{7.8\%} \\ R_{1} \xrightarrow{\sim} C \\ R_{2} \xrightarrow{19.5\%} C \end{array}$	
7.	Graph t, and tz	
	VOLTS 3 4 5 6	

SECONDS



TYLAN CORP. DATA SHEET \mathcal{L} 3046 Sensor Response and g-Sensitivity

Date	11-8-72	
Part	NO. NR	
Repor	rt No. /	

Job No.	3046	
Tested I	By PERRY	
Q.C. NI		

1. Sensor Configuration: TYPE B-HTAPE COVERNOE THE SENSOR. W/DOGHOUSE.

2. Current Thru Sensor, Eo= 5.00v (Is): 14.9 ma.

3. Risetime: 10 to 98% (.500 to 4.85v): 13 Sec. To 63%(3.33v): 3 Sec.

4. Falltime: 100 to 12% (5.00 to .600): 16 sec. to 63%(2.33v): 4 sec.

5. g- sensitivity, Eo= 4.99 (sensor Perpendicular to Horizon)

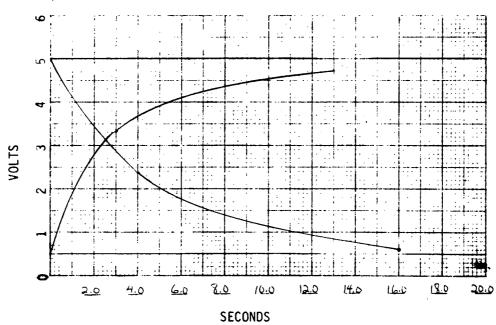
Pitch Axis: Sensor 30° to Left of Perpendicular 4.60 %-7.9
Sensor 30° to Right of Perpendicular 5.40 %+8.2

Roll Axis: Sensor 30° to Left of Perpendicular 4.9% %-0.3

(outlet side) Sensor 30° to Right of Perpendicular 5.09 %+2.0

6. Resistance Values of: R₁₂ 630 R₁ 2010

R₁ 201C R₂ 19.81 K





TYLAN CORP. DATA SHEET 5 3046 Sensor Response and g-Sensitivity

Date	11-8.	72	
Part	No. N	R	
Repor	t No.		

Job No.	3046	
Tested	By DERRY	
Q.C. NI		

1. Sensor Configuration: TYPE A, BARE WITH POLYURETHANK Fram Sciglifly BELOW THE SENSOR. W/ DOGHOUSE

2. Current Thru Sensor, Eo= 5.00v (Is): 14.4 ma.

3. Risetime: 10 to 98% (.500 to 4.85v): 15°_{500} . To 63%(3.33v): 35°_{500} .

4. Falltime: 100 to 12% (5.00 to .600): 23 sec. to 63%(2.33v): 4 sec.

5. g- ::sensitivity, Eo= $\frac{5.13}{}$ (sensor Perpendicular to Horizon)

Pitch Axis: Sensor 30° to Left of Perpendicular 4.55 % %-11.4

Sensor 30° to Right of Perpendicular 5.56 %+3.3

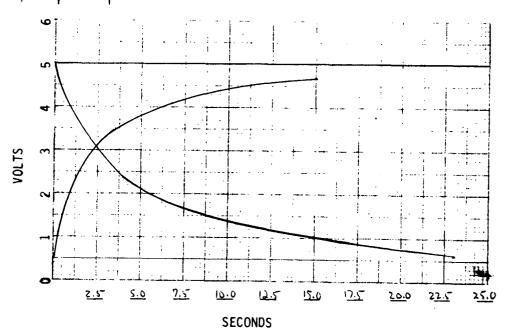
Roll Axis: Sensor 30° to Left of Perpendicular 5.09 %-1.0

(outlet side) Sensor 30° to Right of Perpendicular 5.15 % %+0.3

6. Resistance Values of:

R₁₂ 5452 R₁ 20K R₂ 20K

7. Graph t_r and t_f





TYLAN CORP. DATA SHEET 6 3046 Sensor Response and g-Sensitivity

Date	11-8-72
Part -	NO. NIR
Repor	t No. [

Job No.	3046	
Tested	By PORRY	
Q.C. NL	R	

1. Sensor Configuration: TYPE A - DIPPED IN POLYUTETHINE FORM. WI DOG HOWS

2. Current Thru Sensor, Eo= 5.00v (I_S): 15.6 ms.

3. Risetime: 10 to 98% (.500 to 4.85v): 40 sec. To 63%(3.33v): 9 sec.

4. Falltime: 100 to 12% (5.00 to .600): 45 sec to 63%(2.33v): 9 sec.

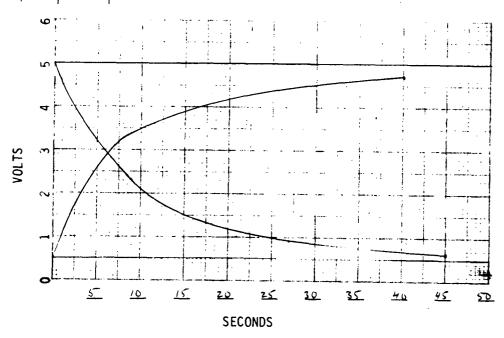
5. g- sensitivity, Eo= 5.00v (sensor Perpendicular to Horizon)

Pitch Axis: Sensor 30° to Left of Perpendicular 4.65 % %-7.0 Sensor 30° to Right of Perpendicular 5.26 % %+5.2 Roll Axis: Sensor 30° to Left of Perpendicular 4.97 %-0.6 (outlet side) Sensor 30° to Right of Perpendicular 5.03 % %+0.6

6. Resistance Values of:

R₁₂ 5542 R₁ 19.87 K R₂ 20 K

7. Graph t_r and t_f





TYLAN CORP. DATA SHEET > 3046 Sensor Response and g-Sensitivity

Date	<u> 11 - 8 - 7</u>	a
Part -	NO. NIR	
	rt No.	

Job No.	3046	
Tested	By PERRY	
Q.C. ~/		

1. Sensor Configuration: TYPE A - HTAPE COVERING SENSOR WITH BEADED POLYSTYRENE COVER. W/DOGHOUSE

2. Current Thru Sensor, Eo= 5.00v (Is): 13.4 ma.

3. Risetime: 10 to 98% (.500 to 4.85v): 2.2 sec. To 63%(3.33v): 55ec.

4. Falltime: 100 to 12% (5.00 to .600): 35_{390} to 63%(2.33v): $\frac{7}{280}$

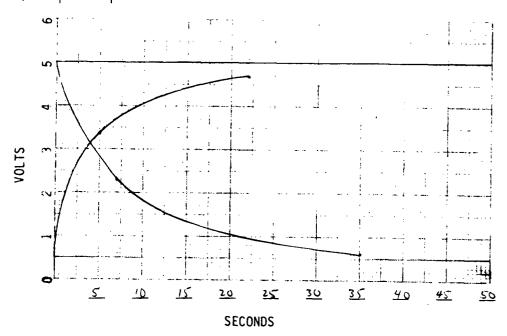
5. g- .sensitivity, Eo= 5.14 (sensor Perpendicular to Horizon)

Pitch Axis: Sensor 30° to Left of Perpendicular 4,85 % % -8.5 Sensor 30° to Right of Perpendicular 5.30 % +3.1 Roll Axis: Sensor 30° to Left of Perpendicular 5.11 % % -1.0 (outlet side) Sensor 30° to Right of Perpendicular 5.16 % % +9.3

6. Resistance Values of:

R₁₂ <u>545 2</u> R₁ 20 K R₂ 19.81 K

7. Graph t_r and t_f





TYLAN CORP. DATA SHEET & 3046 Sensor Response and g-Sensitivity

Date	11-8-72	
Part	No. Nr.	
	t No. 1	

Job No. 3046
Tested By Perry
Q.C. N/R

1. Sensor Configuration: TYPE A BARE W/ BEADED POLYSTYRENG COWER W/ DOKHOUSE

2. Current Thru Sensor, Eo= 5.00v (I_s): 13.3 ma

3. Risetime: 10 to 98% (.500 to 4.85v): 17 sec. To 63%(3.33v): 4/56c.

4. Falltime: 100 to 12% (5.00 to .600): 35 sec to 63%(2.33v): 5 sec

5. g- sensitivity, Eo= <u>5.00</u> (sensor Perpandicular to Horizon)

Pitch Axis: Sensor 30° to Left of Perpendicular 5.04v % -.6

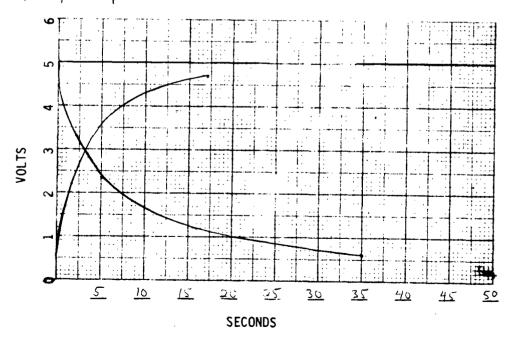
Sensor 30° to Right of Perpendicular 5.10v % +.5

Roll Axis: Sensor 30° to Left of Perpendicular 5.07 % 0

(outlet side) Sensor 30° to Right of Perpendicular 5.07 % 0

6. Resistance Values of:

R₁₂ 7002 R₁ 19.8 K R₂ 20.0 K





TYLAN CORP. DATA SHEET 9 3046 Sensor Response and g-Sensitivity

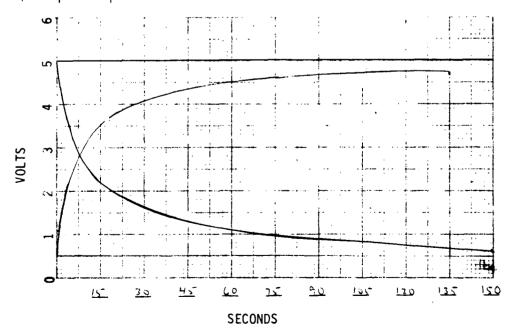
Date 11-8-72	
Part No. NIR	
Report No.	

	3046
ested	By PERRY
).C	NIR

Pitch Axis: Sensor 30° to Left of Perpendicular 4.99 % 6
Sensor 30° to Right of Perpendicular 4.99 % 6
Roll Axis: Sensor 30° to Left of Perpendicular 4.99 % 6
(outlet side) Sensor 30° to Right of Perpendicular 4.99 % 6

6. Resistance Values of:

R₁₂ 554 ~ R₁ 19.91 K R₂ 200K





TYLAN CORP. DATA SHEET /O 3046 Sensor Response and g-Sensitivity

Date	11-8	-72	
Part	No. N	R	
Repor	rt No.	7	

Job No	3046	
Tested \overline{E}	y PERRY	
Q.C. N/		

- 1. Sensor Configuration: TYPE A POLYURATHAME DIPPED WITH POLYSTYRENE COVER W/DOGHOUSE
- 2. Current Thru Sensor, Eo= 5.00v (Is): 15.3 ma
- 3. Risetime: 10 to 98% (.500 to 4.85v): 45 sec. To 63%(3.33v): 7 sec.
- 4. Falltime: 100 to 12% (5.00 to .600): 55 SATE. to 63%(2.33v): 8 Sac.
- 5. g- sensitivity, Eo= 5.00 (sensor Perpendicular to Horizon)

Pitch Axis: Sensor 30° to Left of Perpendicular 4.6) % %-7.8

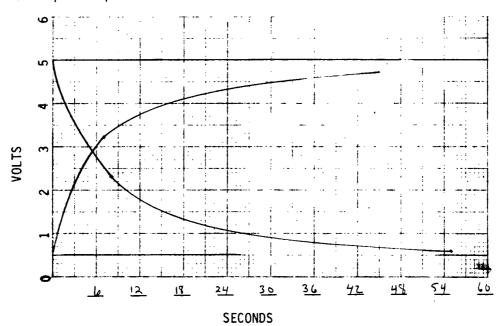
Sensor 30° to Right of Perpendicular 5.24 % + 4.8

Roll Axis: Sensor 30° to Left of Perpendicular 4.98 % -0.4

[outlet side] Sensor 30° to Right of Perpendicular 5.02 % + 0.4

6. Resistance Values of:

R₁₂ 554-2 R₁ 20K R₂ 20K





TYLAN CORP. DATA SHEET // 3046 Sensor Response and g-Sensitivity

Date	<u>11-7-72</u>	
Part	No. N/R	
Repor	rt No. /	

Job No. 3046
Tested By PERRY
Q.C. N/R

١.	Sensor Configuration: TYPE A-	CAKE WITH Doghouse	

2. Current Thru Sensor, Eo= 5.00v (Is): 12.6 ma

3. Risetime: 10 to 98% (.500 to 4.85v): 7 sec. To 63%(3.33v): 3 sec.

4. Falltime: 100 to 12% (5.00 to .600): 14 set to 63%(2.33v): 4 set

5. g- ∴sensitivity, Eo= 5.67 (sensor Perpendicular to Horizon)

Pitch Axis: Sensor 30° to Left of Perpendicular 4.36 % -14
Sensor 30° to Right of Perpendicular 5.66 % +11.6

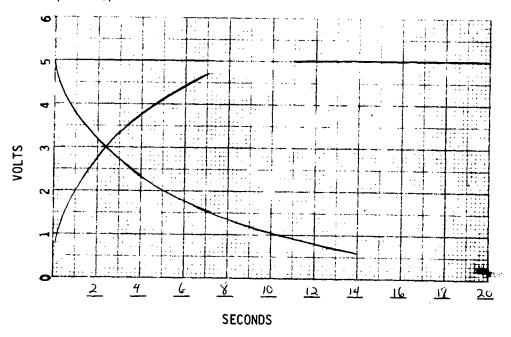
Roll Axis: Sensor 30° to Left of Perpendicular 4.97 % -18

(outlet side) Sensor 30° to Right "of Perpendicular 5.13 % +1.5%

6. Resistance Values of:

R₁₂ 700 ~ R₁ 20 K R₂ 20 K

7. Graph tr and tf





TYLAN CORP. DATA SHEET /2 3046 Sensor Response and g-Sensitivity

Date 11-8-72	Job No 3046
Part No. N/R	Tested By Pagey
Report No. /	Q.C.N/R

1. Sensor Configuration: TYPE A - WITH HTAPE COVERING THE SENSOR.
WIDDGHOUSE.

2. Current Thru Sensor, Eo≈ 5.00v (I_S): 13.5 ma

3. Risetime: 10 to 98% (.500 to 4.85v): 15 soc. To 63%(3.33v): 4 soc.

4. Falltime: 100 to 12% (5.00 to .600): 22 set. to 63%(2.33v): 6 sec.

5. g- sensitivity, Eo= <u>ς.οη</u> (sensor Perpendicular to Horizon)

Pitch Axis: Sensor 30° to Left of Perpendicular 4.60 % -9.3

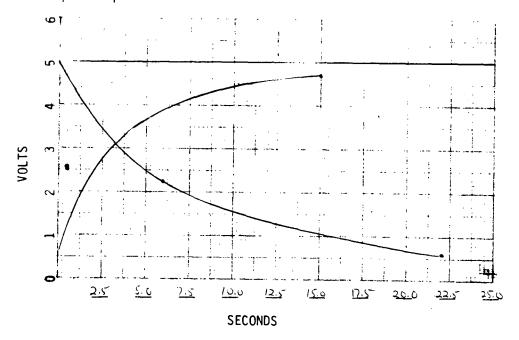
Sensor 30° to Right of Perpendicular 5.60 % + 10.4

Roll Axis: Sensor 30° to Left of Perpendicular 5.04 % -0.6

(outlet side) Sensor 30° to Right of Perpendicular 5.23 % + 3.1

6. Resistance Values of: $R_{12} = 545 - R_{1} = 20 \times R_{2} = 19.87 \times R_{2}$

7. Graph tr and tf





TYLAN CORP. DATA SHEET /3 3046 Sensor Response and g-Sensitivity

Date 11-8-72	
Part No. NIK	
Report No.	

Job No. 3046
Tested By Perry
Q.C. NR

1. Sensor Configuration: TYPEB- HTAPE WITH POLYSTYRENE CONER. W/ DOGHOUSE

2. Current Thru Sensor, Eo= 5.00v (Is): 15.0 m.

3. Risetime: 10 to 98% (.500 to 4.85v): 17 sec. To 63%(3.33v): 4 sec.

4. Falltime: 100 to 12% (5.00 to .600): 30 sec. to 63%(2.33v): 4 sec.

5. g- sensitivity, Eo= <u>5.6 マッ</u> (sensor Perpandicular to Horizon)

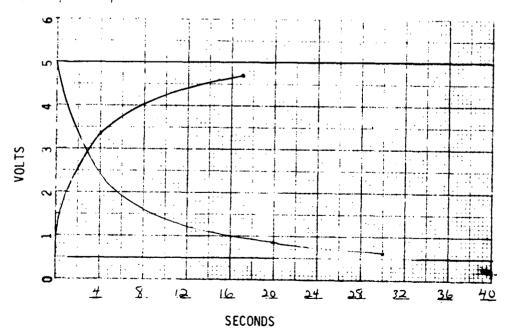
Pitch Axis: Sensor 30° to Left of Perpendicular 5.00 % -0.4
Sensor 30° to Right of Perpendicular 5.00 % % -0.4

Roll Axis: Sensor 30° to Left of Perpendicular 5.01 % 0

(outlet side) Sensor 30° to Right of Perpendicular 5.01 % 0

6. Resistance Values of:

R₁₂ <u>C30</u> <u>2</u> R₁ <u>201</u> <u>201</u> <u>R₂ 19.81k</u>





TYLAN CORP. DATA SHEET 14 3046 Sensor Response and g-Sensitivity

Date 11-8-72	
Part No. N/R	
Report No. 1	

Job No. 3046
Tested By Presy
Q.C. NIR

1. Sensor Configuration: TYPE B - BARE WDOGHOULE

2. Current Thru Sensor, Eo= 5.00v (I_s): 12.8 ma.

3. Risetime: 10 to 98% (.500 to 4.85v): 6 sec. To 63%(3.33v): 3 sec.

4. Falltime: 100 to 12% (5.00 to .600): / 0 sec. to 63%(2.33v): 3 sec.

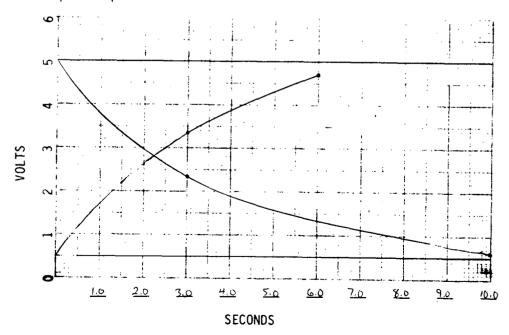
5. g- sensitivity, Eo= 4.99 (sensor Perpendicular to Horizon)

Pitch Axis: Sensor 30° to Left of Perpendicular 4.91 % -1.7 Sensor 30° to Right of Perpendicular 5.44 % +9.9 Roll Axis: Sensor 30° to Left of Perpendicular 4.91 % -1.7 (outlet side) Sensor 30° to Right of Perpendicular 5.01 % +9.4

6. Resistance Values of:

R₁₂ 677 2 R₁ 20 K R₂ 19.811

7. Graph tr and tf





TYLAN CORP. DATA SHEET 15 3046 Sensor Response and g-Sensitivity

Date	11-8-72
Part	No. N/R
Repor	t No. I

Job No3	
Tested By	PERRY
Q.C. NIR	

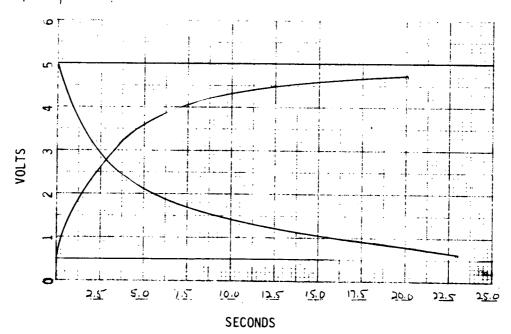
- 1. Sensor Configuration: TYPE B-DIPPED IN POLYUR STRANG FORM WITH A POLYSTYRENE COVER. W/ DOCHOUSE
- 2. Current Thru Sensor, Eo= 5.00v (I_S): 14.7 ma.
- 3. Risetime: 10 to 98% (.500 to 4.85v): 20 To 63%(3.33v): 4
- 4. Falltime: 100 to 12% (5.00 to .600): 23 to 63%(2.33v): 4
- 5. g- sensitivity, Eo= 4.9分。 (sensor Perpendicular to Horizon)

Pitch Axis: Sensor 30° to Left of Perpendicular 4.60 % - 7.7Sensor 30° to Right of Perpendicular 9.9 % + 9.2Roll Axis: Sensor 30° to Left of Perpendicular 9.9 % - 9.2(outlet side) Sensor 30° to Right of Perpendicular 9.9 % - 9.2

6. Resistance Values of:

R₁₂ 630 R₁ 200 R₂ 19731

7. Graph t_i and t_f



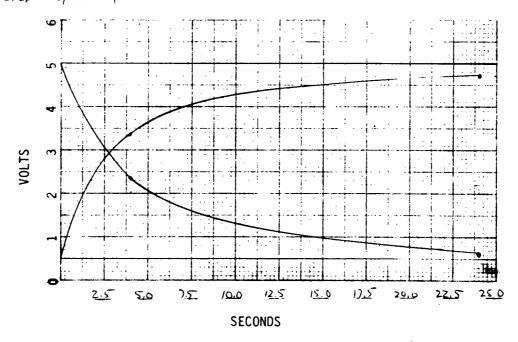


TYLAN CORP. DATA SHEET /6 3046 Sensor Response and g-Sensitivity

Par	$\begin{array}{cccccccccccccccccccccccccccccccccccc$
۱.	Sensor Configuration: TYDE B - Next FELT INSULATION :18 1200. 4. CONFRED WITH POLYSTYRENE. Wy DORHOUSE
2.	Current Thru Sensor, Eo= 5.00v (I _S): 70Lv. 13.4ma
3.	Risetime: 10 to 98% (.500 to 4.85v): 24 sec. To 63%(3.33v): 4
4.	Falltime: 100 to 12% (5.00 to .600): 2 4 sec. to 63%(2.33v): 4
5.	g- sensitivity, Eo= 5.00 (sensor Perpendicular to Horizon)
	Pitch Axis: Sensor 30° to Left of Perpendicular 4.99 % Sensor 30° to Right of Perpendicular 4.99 % Roll Axis: Sensor 30° to Left of Perpendicular 4.99 % (outlet side) Sensor 30° to Right of Perpendicular 4.99 %

7. Graph t_c and t_f

6: Resistance Values of:





TYLAN CORP. DATA SHEET /7 3046 Sensor Response and g-Sensitivity

Date	11-9-72	
Part	NO. NIR	
	t No. /	

Job No. 3046
Tested By Perry
Q.C. N/R

1. Sensor Configuration: TYPE B - HEAT FELT INSULATION - LELD IN PLACE
By H-TAPE AROUND THE SIDES AND ACRES THE TOP. W/ Doghouse.

2. Current Thru Sensor, Eo= 5.00v (I_s) : 7.31 12.1 mg.

4. Falltime: 100 to 12% (5.00 to .600): 25_{sac} to 63%(2.33v): 3

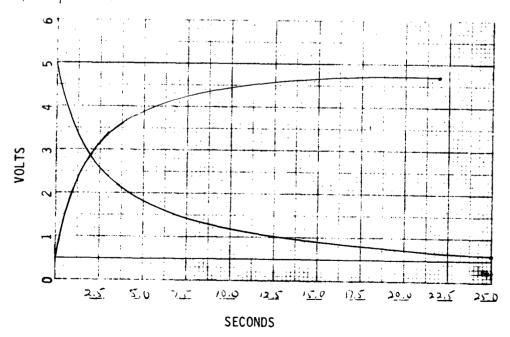
5. g- sensitivity, Eo= 4.98 (sensor Perpandicular to Horizon)

<u>Pitch Axis</u> : Sensor 30 ⁰ to Left of Perpendicular	4.93	6-1.090
Sensor 300 to Right of Perpendicular	4.99	6+0.2%
Roll Axis: Sensor 300 to Left of Perpendicular	4.97	6 -0.2%
(outlet side) Sensor 300 to Right of Perpendicular	4.97	6 + 0.290

6. Resistance Values of:

R ₁₂	657-r
R1	20K
R ₂	20K

7. Graph t_r and t_f





TYLAN CORP. DATA SHEET ** No. 1F 3046 Sensor Response and g-Sensitivity

Date	Jan	<u> </u>	1973	
			Protot	y pe
			046-1	

Job No.		30	46		
[ested]	Ву	R.	F,	Blair	
).C.				_	

1.	Sensor Configuration: Final - Type B taped between 1/8" blocks at	_
	braded Polystycene town, enclosed in metal can	

2. Current Thru Sensor, Eo= 5.00v (I_S): 10.0 ma

3. Risetime: 10 to 98% (.500 to 4.85v): 20 500 To 63%(3.33v): 3.0 500

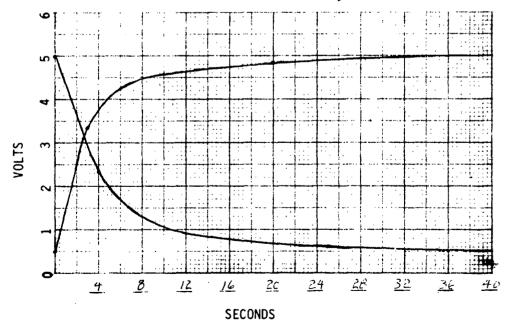
4. Falltime: 100 to 12% (5.00 to .600): 25 sec. to 63%(2.33v): 4.0 sec.

5. g- sensitivity, Eo= 5.00 (sensor Perpendicular to Horizon)

Pitch Axis: Sensor 30° to Left of Perpendicular 5.C1 % +0.2
Sensor 30° to Right of Perpendicular 4.97 % -0.2
Roll Axis: Sensor 30° to Left of Perpendicular 5.C0 % 0
(outlet side) Sensor 30° to Right of Perpendicular 5.C0 % 0

6. Resistance Values of:

7. Graph tr and to Bypass installed to give is = 1.016/nr @ Es = 5.0 VDC





Specimen <u>Flow Sensor</u>
Date <u>Dec 16, 1972</u>
Part No. <u>FHS-411 Prototype</u>
Serial No.

Job No. 3046 Report No. R-3046-1 Specimen Temp. 65°F Amb. Temp. 65°F

Test Title: Linearity & Supply Voltage Sensitivity $\mathring{\omega}$ + 15.0 + 14.0 + 16.0 + 15.0 + 15.0 + + Es VDC 16/nr 02 -15.0 -15.0 -14.0 -16.0 $-\hat{Es}$ - 15,0 8 10 11 NO. 0,00 0.00 2 0,20 0.98 3 0,40 1.99 0.50 2.50 0.60 3.00 0.80 4,00 4.97 5.00 5.00 5,00 5,02 1.00 1,25 6.03 1,50 6.94 10 11 12 **GENERAL TEST NOTES:**

Bread board	Electronics	used w	ith amp	lifier gain	<i>≈ 50</i>	Linear ity	adjusted	at 0.50 161	hr
to give			•			,	•		

Bypass made of 6 layers 20 micron s.s. screen, ID = 0.19", OD = 0.26"

Specimen Passed	Tested By 17 F Blair Date: 12-16-72	
Specimen Failed	Witness Date:	
N.O.D. Written	Sheet Noofof	







Specimen	Flow So	eusor
Date Da	Jan	2 8 3 1973
Part No.	FM5-411	Prototype
Serial No	•	

Approved

Job No. 3046 Report No. R - 3046-1 Specimen Temp. 60-65°F Amb. Temp.

Test Title: Calibration Before & After Vibration See AETL Report EO- VOC Afte Before $\mathring{\omega}$ Vibration 16/hr 02 Vibration 1/3/73 1/2/73 7 9 6 8 - 10 11 NO. 1 0.0 0,00 0.01 2 0,25 1,23 1,23 3 2,58 2,57 0.50 3,89 0.75 3.89 5,12 5:13 1.00 1,25 6.13 6.16 7 8 9 10 11 12 **GENERAL TEST NOTES:** · Vibrated Prototype Sensor per Fig. 3 of Shuttle Environmental Requirements 10 minutes duration each axis. The sensor resistance was monitored during vibration and was seen to be constant at 652 ohms (Ru+Ro). · Electronics not adjusted between tests. · Bypass was 14 layers 20 micron screen, 0.14 ID x 0.30 OD x 0.88 Long. Specimen Passed Tested By R. F. Blair Date: 1-3-73 Witness Date: Specimen Failed _____ Sheet No. N.O.D. Written ___

72-8537-1 Page 58-20





Specimen Flow Sensor

Date 12/17/72 12/30/72

Part No. FMS-411 Prototype

Serial No.

Job No. 3046

Report No. R-3046-1

Specimen Temp. Noted

Amb. Temp. 70°F

	Test Tit	tle: Ca	librati	ou VS	Temp	eratu	re - 3	Sensor	only	(Bypa	iss Plug	19 ed)
C	ώ sccm 0₁	70%	0°F	Eo-		Gas	& Spec	imon	emp,			
NO.		1	2	3	4	5	6	7	8	9	10	11
1	0	0.00		-0.01								
2	2,5	2.67		2.67		Sensu.	insular	ed with	1/8" Hs	ick He	at Felt	# 1260 F
3	5,0	4.91		4.98			sed in					
4												
5							-					
6	0	0.00	-0,01	-0.05	0,00)						
7	3, 5	2.72	2.74	2.72	2.72	Final	Configur	atión -	Polysty	rene Bl	ack insul	atión
8	7.0	5,03	5,05	5,13	5,01	enclo	sed in	metal	can			
9		_										
10								<u> </u>	<u> </u>			
11		,		ļ			ļ					
12		j										
GENE		As meas						eries u	with te	st uni	+	
•	45 minute star	bilizatio	u time	s at e	each to	empera	ture.					
-	Cooling rate =	5°F/m	inute	Heat	ing rat	Le = -	40°F/	minute			·	
•	Electronic Linear											
	Result: (Calibration	on sta	able w	sithin ±	2% f,	s, frou	n 0°F	+0 /	160°F		
				S	pecimen Pas	sed		Tested	By 77	F. Blair	Date: <u>/2/</u>	30/72
				S	pecimen Fail	ed		Witness			Date:	
				N	.O.D. Written			She et N	٥		of	



Specimen Flow Seusov

Date 12/20/72 - 12/31/72

Part No. FMS-411 Prototype

Serial No.

Report No. R-3046-1
Specimen Temp. Noted
Amb. Temp. 70°F

Test Title: Calibration vs Temperature - with 1 16/hr Bypass Eu-VDC $\dot{\omega}$ 1b/hr 02 Gas & Specimen Temp 70°F 0 0°F 160°F OF 70°F 120°F NO. 10 11 0,0 0.00 0.00 12-20-72 0,01 2 0,50 2,49 2.57 2,61 3 5,00 5,20 5,18 1.00 0.0 -0.01 0,00 0.00 12-21-72 6 0.50 2.53 2.59 2.59 7 1.00 5.06 5,25 5,14 8 9 -0,04 0.0 0.00 -0,02 -0,01 0.00 12-31-72 10 0.50 2.50 2.48 2.58 2.55 2.47 11 4,95 5,27 4.95 1.00 5.00 5,19 12 GENERAL TEST NOTES: @ Measured with Voloflow system · Bypass made of 14 layers 20 micron 55 screen . 14 ID x ,30 OD x ,88 long Stabilization times at each temperature = 45 minutes minimum Cooling rate = 5°F/min, Heating rate = 40°F/minute Result: Calibration Stable within + 5% fis. from 0 to 160°F Tested By 7. A. Blair Date: 12-31-72 Specimen Passed Witness Date: Specimen Failed _____ Sheet No. N.O.D. Written Approved

EXHIBIT 5C VIBRATION TEST REPORT



Report No. 5330-0777

P. O. No. 721447

Date: 8 January 1973

5 Page Report

TESTED FOR

Tylan Corporation 4203 Spencer Street Torrance, California 90503

TEST ITEM

Sensor, Part Number FMS-411

TEST PERFORMED

Random Vibration

REFERENCES

Figure Number 3, Shuttle Requirements

TEST EQUIPMENT

AETL No.	Manufacturer	Instrument
D10L D11L D13L D113L D140L D148L D167L D168L	M.B. Electronics M.B. Electronics M.B. Electronics Moseley Ballantine Labs Unholtz Dickie Spectral Dynamics Spectral Dynamics	Vibration Exciter, M/N C-60 Amplifier, M/N T452 Control Console, M/N T388 X-Y Recorder, M/N 2D-2A True RMS Voltmeter, M/N 320 Charge Amplifier, M/N D11MGV-8 Ensemble Averager, M/N SD301 Real Time Analyzer, M/N SD301A
D532V E250L	Endevco Corp. M.E. Electronics	Accelerometer, M/N 2215E Elapsed Time Meter, M/N N220A

TEST PROCEDURES AND TEST RESULTS

The specimen was installed in a test fixture and was subjected to ten minutes of random vibration in each of the three major orthogonal axes over the frequency range of 20 to 2000 Hz at the following intensities:

Frequency (Hz)	<u>Intensity</u>
20 - 250 250 - 500	6 db/octave rise 0.25 g ² /Hz
500 - 2000 Overall Acceleration:	6 db/octave rolloff





Report No. 5330-0777 Date: 8 January 1973

TEST PROCEDURES AND TEST RESULTS (Cont.)

Visual examination at the completion of testing in each axis revealed no damage or other adverse effects. The PSD plots are presented in this report.

Official SEAL

2

KARL G. SCHMIDT NOTAGY PUBLIC CALIFORNIA IGN ARICLES COUNTY My Commission expires Sept. 22, 1973

STATE OF CALIFORNIA COUNTY OF LOS ANGELES ("DEANE HELLER, Project Manager

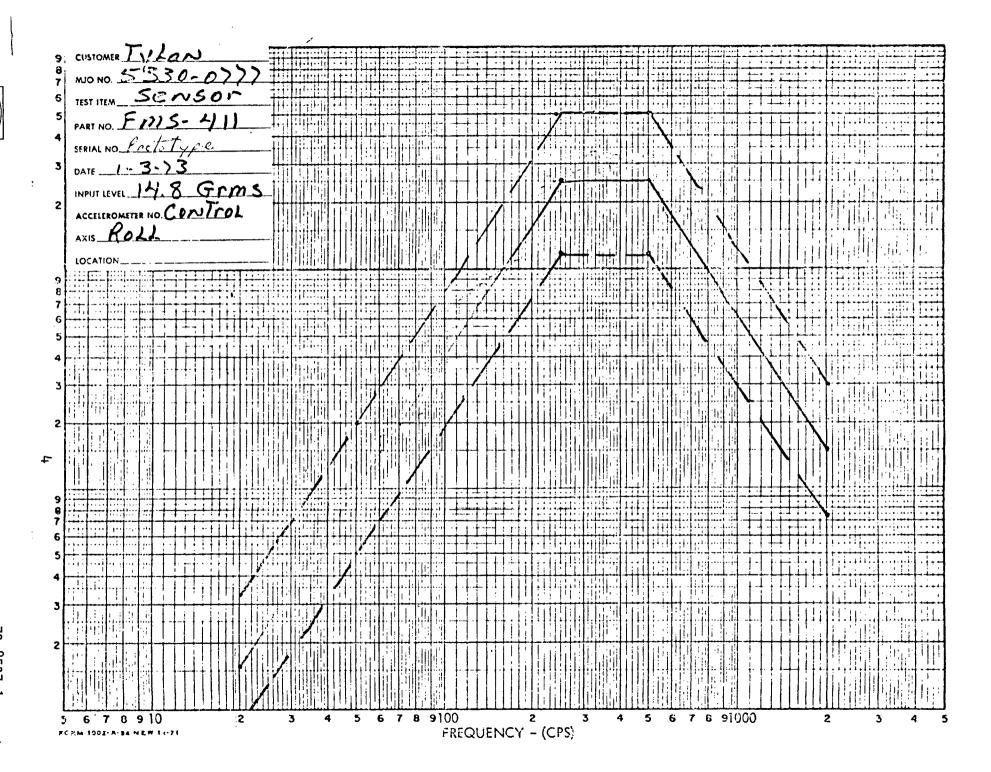
deposes and says. That the information contained in this report is the result of complete and callefully conducted tests and is to the best of his knowledge frue and correct in all respects.

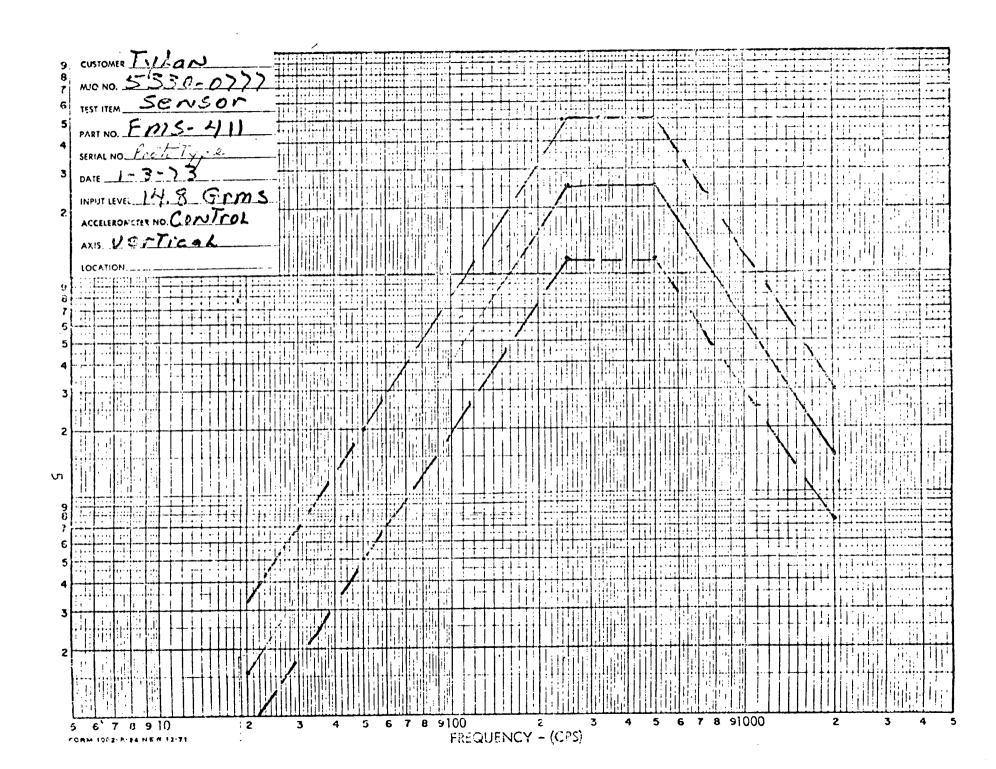
Public in and for the County of Los Angeles, State of California. day of January 19 73

FOR OUR MUTUAL PROTECTION. THE USE OF THIS REPORT, COMPLETE OR IN CAPILETA ADVERTISING OR PUBLICITY MUST RECEIVE OUR WRITTEN APPROVAL, THIS FEROAT SIGN OF MOT IMPLY GENERAL APPROVAL BUT APPLIES ONLY TO THE INVESTIGATION REPORTED.









SECTION 6

SPEED SENSORS

Centrifugal water separators were used in the LM ECS to remove entrained water droplets from the suit loop gases. The performance of the separators was dependent on proper rotational speed. At high speeds, the water that is collected in the separator trough splashes, causing some to be carried downstream and into the suits. A variable reluctance speed sensor was made integral with the separator to monitor rotational speed.

The GFE trouble reports that were furnished to AiResearch at the start of the ECS transducer study contained only one failure report logged against the speed sensor. Discussions with NASA personnel indicated that the speed sensor was highly reliable; consequently, a failure and design evaluation of the sensor and signal conditioner was not made during the course of this study.

Performance and design data on the speed sensor are listed below.

Speed sensor type The speed sensor is an angular velocity

transducer used to develop a frequency signal proportional to the angular velocity of the water separator.

H. S. Part No. SV 593257

Airpax Part No. 086-111-0008

Spec, weight 1.5 ounces

Construction Environmentally sealed electronics

Output voltage 2.86 mv/ips surface speed with 0.010

in. min. qap

Output inductance 20 mh max.

Gap width 0.010 in. min.

Output resistance 200 ohms max.

SECTION 7

PRESSURE SWITCHES

The evaluation of the GFE failure reports has identified malfunctions in the pressure-actuated switches that were used in the Apollo environmental control systems for the LM and PLSS. The switches are briefly described in Table 7-1.

The failure information has been logged on failure evaluation forms and also has been compiled on separate matrixes as illustrated in Figures 2-2 and 2-3 in Section 2 of this report. AiResearch corresponded with the manufacturers of the switches; however, only minimal data has been received. Specific failure and design evaluation reports were not prepared on the pressure switches because of priorities that were established by the Contract Technical Monitor to develop corrective concepts on one or two transducers in lieu of a continuing data search.

Preliminary definition of the instrumentation on the Shuttle ECS indicates that pressure switches are not needed; however, application for pressure switches may exist on other subsystems on Shuttle; therefore, it is recommended that additional study be conducted on the pressure switches listed in Table 7-1 to define and correct the component parts that were responsible for the chronic failure modes.

TABLE 7-1

PRESSURE SWITCH DESCRIPTIONS

LM No. LSC-330-124 Fan Differential Pressure Switch

Specification No.

SVHS 2335

H.S. Part No.

SV 707755

Hydra-Electric Part No.

S 72169

Operation

When the pressure rise across the suit circuit fan drops below 6 in. of water, the switch provides a closed circuit to illuminate a cabin

warning light.

Switch actuates on increasing pressure by 9 in. of water

System pressure

3.5 psia to 20.5 psia

Proof pressure

3.5 psia to 20.5 psia

Differential

22.9 in. of water, max.

Applied to high and low ports simultaneously

6 psi

Operating temperature

0 to 160°F

Electrical rating

I amp at 28 vdc

LM No. LSC-330-218 Coolant Pump ΔP Switch

Specification No.

SVHS 2338/2757

H.S. Part Nos.

SV 715520/SV 718707

Hydra-Electric Part No.

8161

Operation

When the glycol pump pressure drops to 3.0 psid, the switch closes a circuit to activate a cabin warning light and initiates a sequence which switches from Pump No. I in the primary loop to Pump No. 2. The contacts open where pump pressure rise exceeds 7 psid.

Differential pressure

40 psid

Proof pressure

60 psiq



TABLE 7-I (Continued)

Burst pressure

90 psig

Operating temperature

0 to 160°F

Electrical rating

I amp at 28 vdc

LM No. LSC-330-323 Cabin Pressure Switch

Specification No.

SVHS 3253/3477

H.S. Part Nos.

SV 716278/SV 731734/SV 731969

Century Electronics and Instruments, Inc. Part No.

92C115

Operation

When cabin pressure drops to 4.45-3.70 psia, the switch closes a circuit to open the cabin repressurization solenoid valve, activates a cabin warning light and starts the sequence that closes the suit circuit diverter to the cabin. Switch contacts open when cabin pressure rises to 4.4-

5.0 psia

Electrical rating

Current

1.5 amps max

Voltage

25 to 31.5 volts

PLSS No. 204 PGA Differential Pressure Switch

Specification No.

SVHS 4312

H.S. Part No.

SV 714170

Bourns Part No.

2004414701

Operation

Senses pressure differential between ambient and suit pressure, used to provide an input signal to an alarm

system

Operating pressure

3.4 to 4.05 psid

Switch closure

3.4 to 3.10 psig

Switch opening

3.10 to 3.40 psid

Operating temperature

40 to 85°F



TABLE 7-I (Continued)

PLSS No. 239 Feedwater Pressure Transducer and Switch

Specification No. SVHS 3867

H.S. Part No. SV 718788

Bourns Part No. 284419301

Operation A pressure-sensing bellows actuating

a potentiometer wiper element senses water pressure in the feedwater line and develops a signal for input to

the telemetry system

Operating pressure 21 psia to 10 mm Hg

Excitation Potentiometer excited by 5 vdc

Resistance Total of potentiometer is 2000 ohms

Signal output Linear 0 to 5 volt output into 100,000

ohm load for 0-5 psia input pressure

Switch actuation I.2 to I.7 psia

Current capacity 10 ma

SECTION 8

VALVE POSITION INDICATING SWITCHES

AiResearch Report 72-8537-51 in the Appendix describes an evaluation of the operational characteristics and reported failures of precision switches as part of the ECS transducer development program. The precision switches are position indicating and control switch assemblies used to indicate the position of ECS component controls and to control electrical power to other ECS components. The valve position indicating (VPI) switch assemblies develop a switch closure (or opening) as an input to the telemetry system.

A review of the VPI and control switch requirements show them to be unique to the Lunar Module ECS. Failure reports recorded against the next assembly valves were reviewed to isolate the failure reports that pertained to the precision VPI switches.

TRANSDUCER EVALUATION (WBS 1.0, SOW 3.2.1)

Section 3 of AiResearch Report 72-8537-51, "Report on Failure and Design Evaluation of Apollo ECS Valve Position Indicator Switches" describes the failure evaluation that was conducted on the VPI switches.

DESIGN CONCEPT (WBS 2.0, SOW 3.2.2)

Design recommendations governing the next assembly interfaces and suggested redesign of the VPI switches is contained in Section 4 of AiResearch Report 72-8537-51.

VERIFICATION TESTING (WBS 3.0, SOW 3.2.3)

Specific verification tests were not run on the VPI switches during the course of this study. The study of the Apollo VPI switches was limited to a data search in accordance with discussions and agreements reached with the NASA-MSC Contract Technical Monitor.

DESIGN CRITERIA (WBS 4.0, SOW 3.2.4)

Design criteria was formulated during the failure and design evaluation of the VPI switches. The design criteria is contained in Section 4 of AiResearch Report 72-8537-51.

APPENDIX

FAILURE AND DESIGN EVALUATION OF APOLLO ECS TRANSDUCERS

AiResearch conducted a study of transducers used in the Apollo environmental control systems for the CSM, LM, and PLSS. The failure analyses of approximately 800 trouble reports, supplemented by a review of the transducer specifications and system schematics, resulted in identification of generic types of transducers; these types are pressure, temperature, flow, speed, pressure switch, and position switch. Failure and design evaluation reports were prepared during the course of this study. The reports contained in this appendix are listed below by document number, title, and generic type.

Document Number	Document Title	Transducer Generic Type
72-8537-2, Rev. 1	Report on Failure and Design Evaluation of Apollo ECS Pressure Transducers, Variable- Reluctance Twisted Bourdon Tube Type	Pressure
72-8537-3, Rev. 2	Report on Failure and Design Evaluation of Apollo ECS Pressure Transducers, Variable-Reluctance Diaphragm with Electronics Type	Pressure
72-8537-12, Rev.1	Report on Failure and Design Evaluation of Apollo ECS Temperature Sensors, Thermistor Type	Temperature
72-8537-13, Rev. 1	Report on Failure and Design Evaluation of Apollo ECS Temperature Sensor, Thermistor Bead and Coil Type	Temperature
72-8537-14, Rev. 1	Report on Failure and Design Evaluation of Apollo ECS Cabin Temperature Sensor, Thermistor with Electronics Type	Temperature
72-8537-15, Rev. 1	Report on Failure and Design Evaluation of Apollo ECS Temperature Sensors, Coil with Electronics Type	Temperature
72-8537-22, Rev. 1	Report on Failure and Design Evaluation of Apollo ECS Oxygen Flow Transducer Temperature Sensor with Electronics Type	Flow
72-8537-51, Rev. 1	Report on Failure and Design Evaluation of Apollo ECS Valve Position Indicator Switches	Position Switch



AIRESEARCH MANUFACTURING COMPANY

Los Angeles, California

REPORT ON FAILURE AND DESIGN EVALUATION OF APOLLO ECS PRESSURE TRANSDUCERS VARIABLE-RELUCTANCE TWISTED BOURDON TUBE TYPE CONTRACT NO. NAS 9-12452

72-8537-2, Rev. I

February 10, 1973

Prepared by A. Saginian/H. Louie

APPROVED:

R. E. Vesque Program Manager

APPROVED.:

√. Brudnicki

Principal Investigator

NASA MANNED SPACECRAFT CENTER HOUSTON, TEXAS 77058

ABSTRACT

This report presents the results of a failure and design evaluation study conducted on the Apollo ECS transducers, the generic group of variable-reluctance twisted Bourdon tube type pressure transducers. The study was conducted for NASA-MSC by the AiResearch Manufacturing Company, a division of The Garrett Corporation under Contract NAS9-12452.

The study purpose was to evaluate the integrity of design of this type transducer. Failure information is presented and summarized pertaining to six different transducer part numbers. A failure matrix is presented which describes the failure mode, type, mechanism, cause, and problem areas for 84 failures out of a lot total of 296 units.

The integrity of the design was confirmed. Recommendations are made to reduce the failure rate from the current level of 26 percent.

CONTENTS

Section		<u>Page</u>
I	INTRODUCTION	1-1
2	DESCRIPTION, FAILURE SUMMARY, AND RECOMMENDATIONS FOR VARIABLE-RELUCTANCE, TWISTED BOURDON TUBE PRESSURE TRANSDUCERS	2-1
	Description and Operation	2-1
	Failure Summary	2 - 5
	Recommendations	2-13
3	WATER-GLYCOL PUMP PRESSURE TRANSDUCER (AIRESEARCH PN 836130)	3-1
	Purpose and Description	3-1
	Performance and Design Data	3-1
	Failure and Design Review	3-1
4	WATER-GLYCOL QUANTITY TRANSDUCER (AIRESEARCH PN 837026-I)	4-1
	Purpose and Description	4-1
	Performance and Design Data	4-1
	Failure and Design Review	4-1
5	CABIN PRESSURE TRANSDUCER (AIRESEARCH PN 836132)	5-1
	Purpose and Description	5-1
	Performance and Design Data	5-1
	Failure and Design Review	5-1
6	SUIT SUPPLY OR CABIN PRESSURE TRANSDUCER (AIRESEARCH PN 837044)	6-1
	Purpose and Description	6-1
	Performance and Design Data	6-1
	Failure and Design Review	6-1

CONTENTS (Continued)

Section	•	<u>Page</u>
7	OXYGEN SUPPLY PRESSURE TRANSDUCER (AIRESEARCH PN 837016-1)	7-1
	Purpose and Description	7-1
	Performance and Design Data	7-1
	Failure and Design Review	7-1
8	WATER-GLYCOL PUMP PRESSURE TRANSDUCER (AIRESEARCH PN 837008-I)	8-1
	Purpose and Description	8-1
	Performance and Design Review	8-1

SECTION I

INTRODUCTION

This report presents a summary of failure data of the generic group of variable-reluctance, twisted Bourdon tube type pressure transducers. This type is one of several pressure transducer types, which are described and categorized in AiResearch Report No. 72-8537-1. Six transducers were evaluated and are presented for discussion; however, the last one (AiResearch PN 837008-1) has been superseded by AiResearch PN 836130.

All of the transducer applications described in this report are with respect to Apollo environmental control subsystem (ECS) functions. They may be typically used in the command service module (CSM), lunar excursion module (LEM), or portable life support subsystem (PLSS) designs.

The transducers which are summarized are, by AiResearch part number:

PN 836130

PN 837026

PN 836132

PN 837044

PN 837016

PN 837008

Detailed failure data on each of these transducers are presented in Sections 3 through 8 of this report. Section 2 presents summary, descriptive information, and recommendations on all aspects common to the group, thus avoiding excessive repetition. Differences in the transducer design for this group are primarily due to differences in the pressure ranges of applications.

The results of the failure evaluation for each transducer were combined into a single failure matrix of 84 failures, presenting a useful statistical picture for this transducer type. A notable observation is that the great majority of the failures is due to human error and hence potentially preventable with no reflection on the design integrity.

SECTION 2

DESCRIPTION, FAILURE SUMMARY, AND RECOMMENDATIONS FOR VARIABLE-RELUCTANCE,
TWISTED BOURDON TUBE PRESSURE TRANSDUCERS

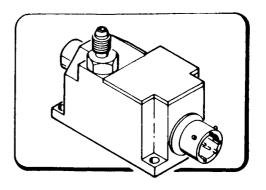
DESCRIPTION AND OPERATION

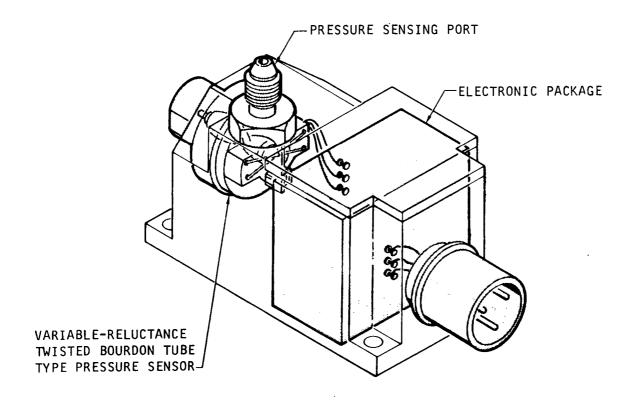
An isometric of a typical variable-reluctance twisted Bourdon tube pressure transducer is shown in Figure 2-1. The outline drawing is given in Figure 2-2. The transducer utilizes a Bourdon tube for the pressure-responsive element which is fabricated from tubing flattened into a non-circular cross section and twisted along its length. Axial rotation of the unrestrained end of the Bourdon tube is caused by a change in internal pressure. The tube deforms elastically until the stresses created in the tube balance forces arising from a pressure change. Increasing pressure tends to return the flattened cross section to its original circular shape. Opposing compressive and tensile stresses create a bending moment that tends to change the curvature of the tube.

Four types of Bourdon tubes commonly used are plain, spiral, helical, and twisted. Each is shown in Figure 2-3 with various cross sections used in their design. The twisted tube maintains a straight centerline along the length of the tube, but is twisted about the centerline at a uniform rate. The opening of the tube due to internal pressure causes the tube to unwind some finite angle about the tube centerline. The change in tube length is negligible. Different angles of twist alter the angular rotation for any given length of tube.

A variable reluctance-type transducer operates on the principle of electromagnetic induction, which produces an electric current (or voltage) by the movement of a conductor through a magnetic field. It consists of a sensing element Bourdon tube, a magnetic core, an armature to complete the magnetic circuit, and two or four inductance coils. A typical two-coil unit is shown in Figure 2-4. The armature is fastened to the twisted Bourdon tube and rotates in proportion to the pressure. The rotation changes the air gap, causing a change in the circuit inductance. The inductance coils are represented in the bridge circuit (Figure 2-4). Generally, the output is sufficiently high that amplification is unnecessary, but the output of the bridge may be doubled by adding an E-core opposite the one shown, creating a four-arm circuit. Any inductance change can be used to modulate the amplitude of a carrier voltage, or change the oscillator frequency. A schematic diagram of the instrumentation system for a variable reluctance transducer is shown in Figure 2-5.

The transducer electronics are powered by a 28-vdc supply. The output signal is in the range of zero to 5 vdc and is proportional to the magnitude of the sensed pressure. This signal is used for ground checkout, for crew visual information, and for telemetry data to be transmitted to a ground station.





A-11013

Figure 2-1. Typical Pressure Transducer



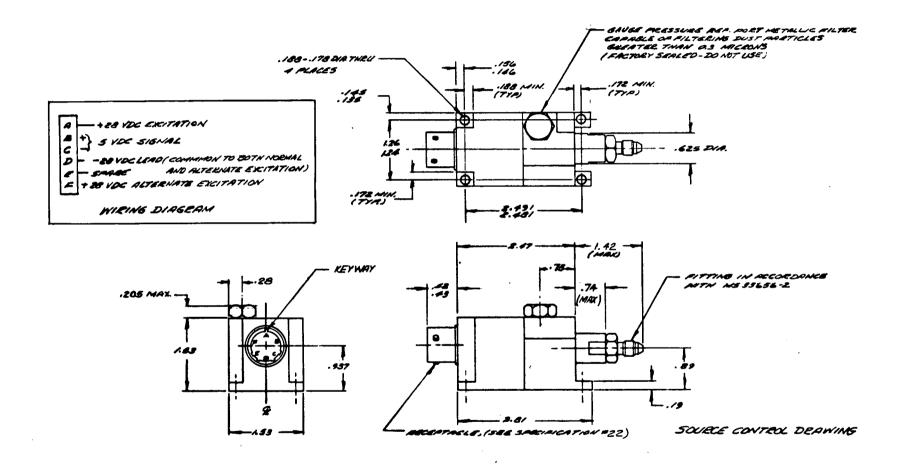


Figure 2-2. Typical Pressure Transducer Outline

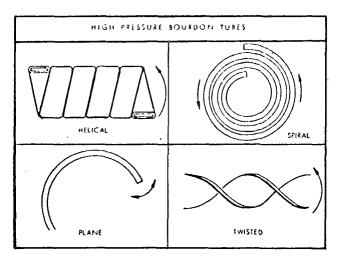


Figure 2-3. Bourdon Tube Designs

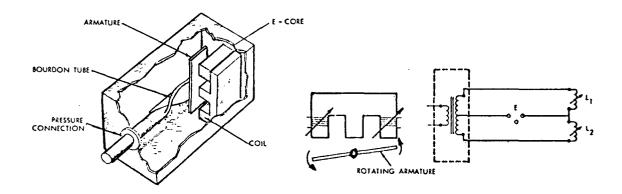


Figure 2-4. Variable Reluctance Transducer and Electrical Circuit

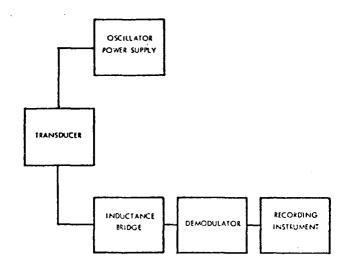


Figure 2-5. Schematic Diagram for a Reluctance Transducer System

FAILURE SUMMARY

A total of 91 failure reports, furnished by NASA-MSC, were reviewed. The results of 84 of these reports are summarized in the failure matrix shown in Figure 2-6. Seven failure reports, all written against PN 837008, were excluded from this total summary matrix because this part number has been superseded by PN 836130. The matrix in Figure 2-6 is a summation of the individual matrixes presented in turn for each transducer application in this report.

Seventy-six (90 percent) of the failures were judged to be due to human error. Thirty-two (38 percent) of these failures were caused by overpressurization and fourteen (17 percent) by misconnection of input potential to the output terminals.

It was observed, through tests, that the twisted Bourdon tube sensing element is sensitive to pressure spikes. However, laboratory tests of the transducer assembly have shown that no perceptible permanent distortion occurs when the pressure is increased slowly. Figures 2-7 and 2-8 show a typical resultant shift of the armature when the unit was subjected to physical shock or excessive pressure. Note the position of the armature which is attached to the unrestrained end of the Bourdon tube. In the case of Figure 2-8, this particular transducer had shifted positive approximately 300 millivolts over the entire range. Post failure tests conducted at Whittaker Corporation were summarized on AiResearch Trouble Reports Nos. 16668 and 19199, respectively, with the results quoted as follows:

"The unit was subjected to extensive temp-cycle test (100 hr) to ascertain if the electronics package was stable. There were no further shifts in performance. The transducer was subsequently disassembled and the sensor section inspected. There was visible evidence of a slight distortion in the Bourdon tube. See attached photo [Figure 2-7]. Such distortion can result from physical shock as from mishandling or overpressurization. There was no external evidence of mishandling such as case damage. However, mishandling either at the vendor's facility prior to shipment or at AiResearch prior to test is considered the most likely cause, since the unit failed the initial calibration test point at AiResearch prior to application of any pressure.

Upon verification of the reported discrepancy of subject glycol pump outlet pressure transducer, the unit was disassembled for analysis at Whittaker Corporation.

A physical offset of the armature, relative to the coils, was immediately noticed (see attached photo [Figure 2-8]). This armature is a part of the pressure sensing "Bourdon Tube," and in this case, the said tube was permanently deformed resulting in a closed gap. This condition is normally seen when a pressure is applied to the tube but will recover the initial gap when relieved of the pressure. Further physical



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Figure 2-6. Variable-Reluctance Twisted Bourdon Tube Type Transducer Failure Matrix

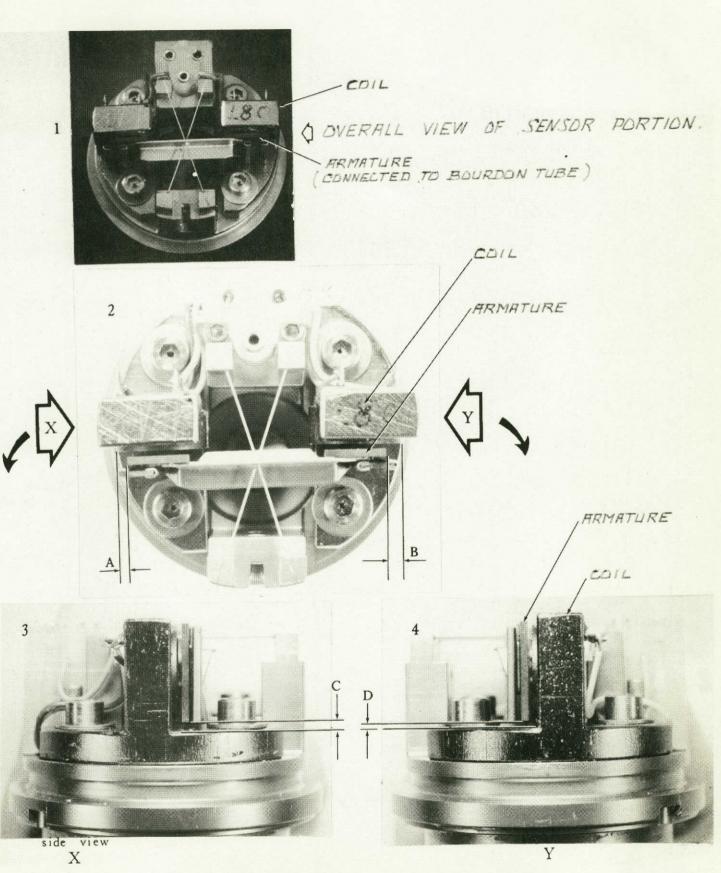
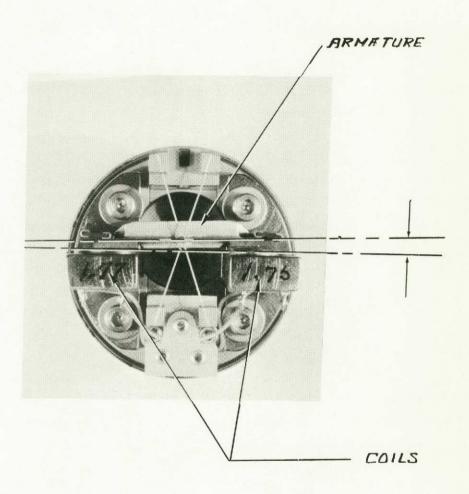


Figure 2-7. CSM, Glycol Pump Pressure Transducer Showing Shift of Armature

F-15860





(NOTE DISLOCATED ARMATURE)

F-15859

Figure 2-8. CSM, Glycol Pump Pressure Transducer Showing Dislocated Armature

inspection of the Bourdon tube portion revealed that a bright spot existed on the transition area (inside the tube). This is a likely indication that it was struck by some hard object, distorting the original shape of the tube. The most probable place this could happen is during the final cleaning process where a person could attempt to clean the Bourdon tube by using a needle or other tool. It is noted that the unit was operating properly prior to final cleaning and failed the first test following cleanup. Investigation of the procedures uncovered that no detail steps are provided to the cleaning vendor by Whittaker for this configuration. It was concluded that this type of discrepancy can be prevented by proper communication between Whittaker and Cemarc (cleaning contractor)."

Although this pressure transducer was found to be sensitive to pressure surges or a pressure spike, the following test data show the unit to be quite capable of withstanding overpressure when applied slowly.

"Four 836130 transducers were calibrated in the range of zero to 60 psig and then incrementally overpressurized from 60 psig to 250 psig. Calibration was performed after each pressure exposure to determine whether a shift had occurred. Zero shifts were apparent on two transducers, SN 9 and SN 33, after exposure to 100 psig. These transducers had a substantial shift; SN 33 had 2 psig and SN 9 had 3 psig after exposure to 230 psig. SN 8 exhibited essentially no shift until after exposure to 100 psig and had an ultimate shift of one (I) psig after the application of 250 psig. SN 25 exhibited no shift to all pressure applications up to 250 psig. Recalibration of the zero point verified that the shift was a linear displacement of the calibration curve."

A review of the failure matrix of Figure 2-6 indicates that there is no basic and chronic problem area for this transducer type. This conclusion is based on the following comments which are grouped according to problem area.

Non-Specific Problem Area

- (a) There was no information given on the failure report which was not analyzed.
- (b) Two failures were not confirmed and the responsibility of the reports belongs to their initiators.
- (c) The seven random failures include only one human-induced failure and six failures of electronic components.

Since six of the random failures were registered against electronic components, it is evident that a more critical judgement should be exercised in the choice of electronic components.

Final Installation

Only one unit failed by overpressurization in the final installation. This can be considered a random human error.

Engineering

- (a) There were four design problems, the sources of which have since been eliminated.
- (b) There were seven qualification-test-induced failures, six of which are of recurring type.

A problem source exists in test equipment and procedure which must be eliminated.

Test Equipment and Handling

- (a) There were three failures of test equipment which have no reflection on the integrity of the transducers.
- (b) There were eight induced failures by mishandling.

A problem source exists in handling which must be eliminated.

Manufacturing

- (a) One failure was due to poor planning.
- (b) Three failures in fabrication were due to processing error.
- (c) Sixteen failures in assembly were largely due to overpressurization during assembly tests.
- (d) One failure in sensing mechanism was due to inspection.
- (e) Twenty-nine failures in testing were due to test errors.

A problem source exists in testing equipment and procedure which must be eliminated.

Transducer Problem Area Evaluation

None of the problem areas mentioned above indicate a design problem. Therefore, the conclusion is that the transducer design is trouble-free and is recommended to be considered for future applications.

Failure Distribution

Figure 2-9 illustrates the distribution of failures according to problem area, and Figure 2-10 illustrates this distribution after design change which will eliminate the recurrence of engineering-error-related failures.

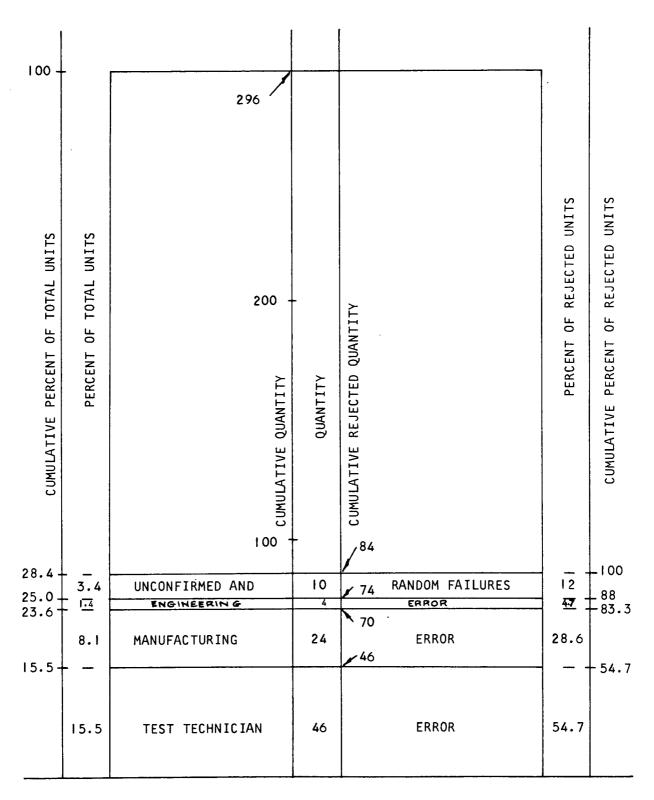


Figure 2-9. Distribution of Failures According to Problem Area

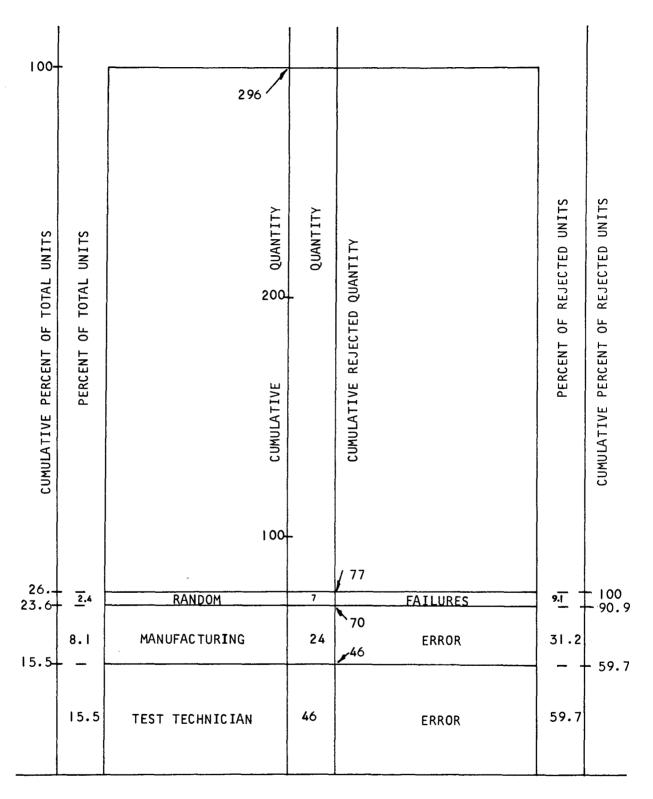


Figure 2-10. Distribution of Failures After Elimination of Engineering Errors

Twenty-six percent of the total population of 296 units were rejected. Of this, more than half were caused by test technician errors and all but seven were potentially avoidable. While the recurrence of random failures (representing a two-to-three-percent failure rate) can be prevented, definitive action to eliminate problem sources from manufacturing and test can be taken.

RECOMMENDATIONS

Most failure reports on variable-reluctance twisted Bourdon tube transducers were the result of overpressurization in the form of a pressure spike or a physical shock. Both of these had resulted in a permanent distortion of the pressure-sensing Bourdon tube. The second highest number of failures was the result of misconnection of the 28-vdc input power supply to the transducer output terminals by the test technician. As a result, the following recommendations are made with respect to design, test, and handling criteria:

Design Criteria

- (a) Aging of the Bourdon tube pressure-sensing element on the order of six months with a simultaneous burn-in cycle on the overall transducer should be considered to verify stability of the pressure-sensing element and the electronics. A burn-in test consisting of a cyclic temperature from ambient to +135°F was made mandatory during the course of the Apollo Program and was effective on all transducers manufactured in accordance with 836130-2.
- (b) Incorporate diodes in the electrical output circuitry such that the application of 28 vdc to the 0-5 vdc output pins does not cause any damage to the transducer.
- (c) Incorporate a readily replaceable burst disc or blowout plug such that the application of pressure spikes or surges could not overpressurize and hence deform the sensing mechanism.
- (d) It is desirable to select transducers with an allowable operating pressure limit 20 to 25 percent above normal working pressure to allow for transient conditions and to aid in trouble-shooting and determining the extent of inadvertent overpressurizations.

Test Criteria

- (a) Pressure relief valves that are vented to ambient should be installed in ATP test setups, GSE filling and purging systems, and in the next assembly in which the transducer is installed to prevent pressure spikes.
- (b) ATP test setup equipment should be color coded to clearly denote transducer electrical input power leads of 28 vdc and output signal leads of 0-5 vdc to avoid the possibility of damage to the transducer caused by interchanging the leads.

(c) ATP and QTP documents should be reviewed and amended as necessary to minimize the possiblity of inadvertent overpressurization of the sensing element and misconnection of input and output power leads.

Handling Criteria

- (a) The transducer should be appropriately packaged to withstand shock loads when packaged of 30 g's intensity for II ±1 milliseconds applied along three mutually perpendicular axes.
- (b) Planning documents should be reviewed and amended as necessary to minimize the possibility of induced failure in the forms of damage, contamination, and incorrect process.

SECTION 3

WATER GLYCOL PUMP PRESSURE TRANSDUCER (AIRESEARCH PN 836130)

PURPOSE AND DESCRIPTION

The water-glycol pump pressure transducer measures the static pressure of the water-glycol coolant at the outlet of the pump assembly by sensing the pressure and generating a proportional electrical signal. This signal is used for ground check out, for the crew's visual information via an indicator, and for telemetry data to be transmitted to a ground station, and serves as an indication of water-glycol pump performance.

The transducer utilizes a Bourdon tube for the pressure-responsive element and a combination of a magnetic core, an armature (which completes the magnetic circuit), and inductance coils for translation of the physical motion into a proportional electrical signal.

PERFORMANCE AND DESIGN DATA

Table 3-1 lists performance and design data for this transducer.

FAILURE AND DESIGN REVIEW

Table 3-2 is a summary of the 21 failure reports which were reviewed for this transducer evaluation. The information indicated in Table 3-2 is summarized in the failure matrix of Figure 3-1. This and the other failure matrixes, subsequently presented in this report, were used as inputs to the summary matrix shown in Figure 2-6.

Nineteen of the total of 21 reported failures were caused by human errors. The other two were caused by (I) contamination during assembly, and (2) customer mistakes during final installations. Two of the failures included in the human error category were caused by engineering design error. The failure source of the engineering error has since been eliminated by design change.

Eight of the human-caused failures resulted from inadvertent overpressurization of the ECS coolant subsystem. Sensitivity of the Bourdon tube to pressure spikes and to inadvertent overpressurization is the mechanism of these eight failures. Laboratory tests have proved that such inadvertent pressure variations cause permanent distortion in the Bourdon tube.

Figure 3-2 shows the distribution of the failures according to the sources of problems. Figure 3-3 shows the distribution of the current failures after the redesign that removed the engineering error from the list of problem sources. The remaining current problem sources include (I) test technician errors (responsible for 52.6 percent of the failures) and (2) manufacturing and handling errors (responsible for 42.1 percent of the failures). These failures, which account for 94.7 percent of all failures, are potentially

TABLE 3-1

PERFORMANCE AND DESIGN DATA FOR PN 836130

Electrical power requirements

Input voltage, vdc 24 to 32

Excitation current, ma 25 (max.)

Operating pressure range, psig 0 to 60

Operating temperature range, ⁰F 35 to 160

Accuracy, psig $\pm 1.5 (\pm 0.125 \text{ v})$

Time constant of response Minimum

Output signal O v at O psig to 5 vdc at 60

psig. Output signal shall not exceed 6.4 v in the event of

overpressurization

Output ripple Ripple component of output

signal shall not exceed 10 mv

rms

Load resistance, ohms 30,000

Output impedance, ohms 500 (max.)

Sensed fluid Water-glycol solution per

SS-1070-R

Proof pressure, psig 90 at 70°F

Burst pressure, psig 150 at 70°F

Sensing port MS33656-2 (1/8-in. OD tube)

External leakage 1.3×10^{-4} cc/hr water-glycol

max. with 60 psia internal

pressure at 70° F



TABLE 3-2

GLYCOL PUMP PRESSURE TRANSDUCER FAILURE EVALUATION

TRANSDUCER	APPLICATION	ON <u>Glyc</u>	ol Pump Pre	essure Tran	sducer	Т	RANSDUCER TYPE Pre	essure Differential		
BASIC PART	NUMBER	8361	30			0	PERATING PRINCIPLE <u>Var</u>		sted Bourdon Tube	
TRANSDUCER	MANUF	Whit	taker (Pace	e-Wiancko)				60 psi		
TROUBLE RE	PORT SOURC	E AiRe	search/Nort	th American	Rockwell	м	EASUREMENT MEDIAWat	er-Glycol per AiRese	earch Report SS-1070-R	
PART NUMBER	SERIAL NUMBER	FAILURE DATE	T/R NUMBER	FAILURE TYPE	FAILURE MODE	FAILURE MECHANISM	FAILURE CAUSE	PROBLEM AREA	CORRECTIVE ACTION	COMMENTS
836130-1	50019	6-1-66	A/R 9917-9	Human	Shift	Bourdon tube	Cleaning processes	C-38 Cleaning	Improve cleaning procedure	
836130-1	50004	2-17-67	A/R 306 -9	Human	Shift	Electric output circuit	28 vdc applied to 5 vdc output leads	Testing ATP	Color code electric test box	Re-educate test technicians
836130-1	50015	3-23-67	A/R II 354 - 9	Human	Shift	Bourdon tube	Suspect over- pressurization spike of I-I/2 times proof	Testing	Procedures reviewed and found accept-able	
836130-1	50025	7-26-67	A/R 15438	Human	Shift	Bourdon tube/ E-core	Unit shows damage of being dropped or hit	Handling	None	Source of damage was indeterminate
836130-1	50021	12-19-67	A/R 16530-9	Human	Shift .	Bourdon tube/ E-core	Suspect mis- handling	Handling	None	Next assy pump was returned by NR for damaged tubes leading to the transducers
836130-2	50034	4-25-68	A/R 17680	Human	Shift	Bourdon tube distorted	Suspect over- pressurization	Testing	None	to the transducers
836130-1	50016	7-12-68	A/R I 6663	Human	Shift	Bourdon tube distorted	Suspect over- pressurization	Testing		
836130-1	50055	7-19-68	A/R 16668 - 9	Human	Shift	Bourdon tube distorted	Handling shocks	Handling	None	
836130-2	50055	7-26-68	A/R 16668	Human	Shift	Bourdon tube distorted	Suspect over- pressurization	Testing		



TABLE 3-2 (Continued)

I KANSDUCEK	APPLICATION	ON <u>Glyco</u>	ol Pump Pre	ssure Trans	sducer	TR	ANSDUCER TYPE P	ressure Differentia	<u>a </u>	
BASIC PART	NUMBER	8361.	30			OP	ERATING PRINCIPLE <u>V</u>	ariable Reluctance-	Twisted Bourdon Tube	
TRANSDUCER	MANUF	Whit	taker (Pace	-Wiancko)		ME/	ASUREMENT RANGEO	-60 psi		
TROUBLE RE	PORT SOURC	E AiRes	search/North	American	Rockwell	ME	ASUREMENT MEDIAW	<u>ater-Glycol per Ail</u>	Research Report SS-1070	-R
PART NUMBER	SERIAL NUMBER	FAILURE DATE	T/R NUMBER	FAILURE TYPE	FAILURE MODE	FAILURE MECHANISM	FAILURE CAUSE	PROBLEM AREA	CORRECTIVE ACTION	COMMENTS
836130-2	50017	8-19-68	A/R 17794 ~ 9	Elec.	Shift	E-core package	Minor shift during burn-in cycle	Random	None	Burn-in is run to screen out this type failure
836130-2	50040	9-19-68	NR 9438-2	Human	Shift	Bourdon tube	Unit over- pressurized during system test	NR testing	None	System over-pressure could not be verified
836 30-	50057	10-3-68	A/R 19199 - 9	Human	Shift	Bourdon tube	Struck by mech. object during cleaning	C-38 Cleaning	Incorporate in- structions in cleaning procedure	Cleaning vendor is Cemarc
836130-1	50016	10-13-68	A/R 19195	Mech.	Shift	Pressure sensing mechanism	Contamination	Manufacturing assembly	None	
836130-1	50020	11-7-68	NR 60878	Human	Shift		Unit over- pressurized during system test	Testing		
836130-1	50021	11-7-68	NR 60875	Human	Shift		Unit over- pressurized during system test	Testing		
836130-2	50063	12-5-68	A/R 19132	Human	High output ripple	Shorted transistor and two diodes	Input power applied to output pins	Testing	Use electric con- nector on test equipment was banana jacks	
836130-2	50037		A/R 19174	Human	Leakage	Welded joint	Cracked weld	Manufacturing inspection	Port replaced	·
836130-2	50035	6-3-69	A/R 19181	Human	Shift	Variation in test equipment	Test equipment tolerance	Engineering	Recalibrate unit	



FOLDOUT FRAME

Table 3-2 (Continued)

RANSDUCER	APPLICATION	ONG1	ycol Pump P	ressure Tra	ansducer	TR	ANSDUCER TYPE	Pressure Differential		
BASIC PART	NUMBER	83	6130			OP	ERATING PRINCIPLE	Variable Reluctance-T	wisted Bourdon Tube	
TRANSDUCER	MANUF	Wh	<u>ittaker (Pa</u>	ce-Wiancko)	ME	ASUREMENT RANGE	0-60 psi		
TROUBLE REI	PORT SOURC	E Ai	Research/No	rth Americ	an Rockwell	ME	ASUREMENT MEDIA	Water-Glycol per AiRe	search Report SS-1070-R	
PART NUMBER	SERIAL NUMBER	FAILURE DATE	T/R NUMBER	FAILURE TYPE	FAILURE MODE	FAILURE MECHANISM	FAILURE CAUSE	PROBLEM AREA	CORRECTIVE ACTION	COMMENTS
836130-2	50036	6-10-69	A/R 19182-9	Human	Shift	Variation in test equipment	Test equipment tolerance	Testing	Recalibrate unit	
836130	50030	11-14-69	NR PFI 08522	Human	Shift	Bourdon tube overstressed	Unit over- pressurized	(Testing) human	Relief valves added to coolant loops	
836130-2	0028	11-24-69	A/R 20328-0	Human	Shi ft	Bourdon tube overstressed	Unit over- pressurized	(Testing) human	Personnel cautioned	
										
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PERCENT	NO OUTPUT	SHIFT	LOW OUTPUT	TUATUO HƏIH	FIXED OUTPUT	LOW RESISTANCE	LEAKAGE		EKKALIU	KIPPLE	DRIFT	PEELING				NONE	HUMAN	ELECTRICAL	MECHANICAL	EL	.EC		MEC	HAI	NIC	AL												NG A							
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Figure 3-1. Glycol Pump Pressure Transducer Failure Matrix

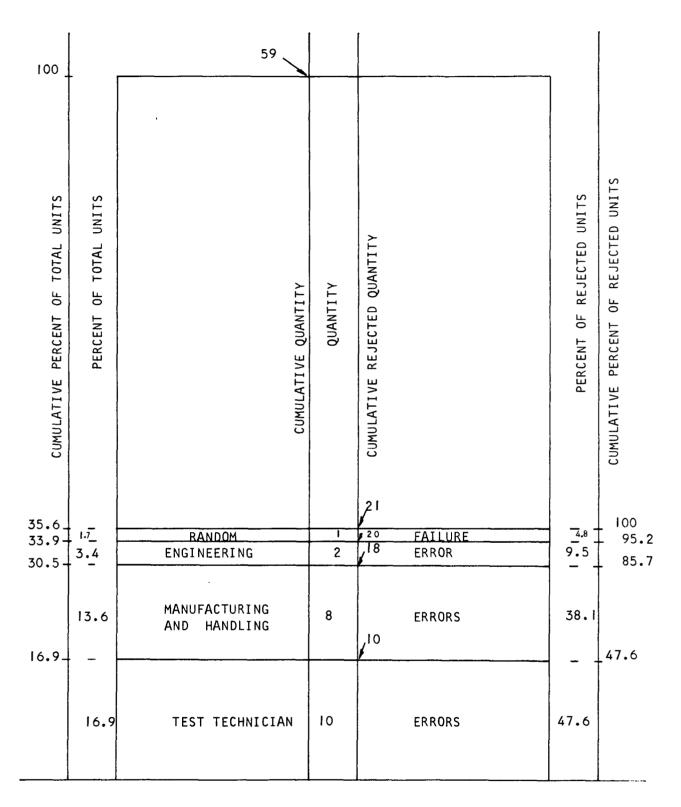


Figure 3-2. Distribution of Failures According to Problem Area

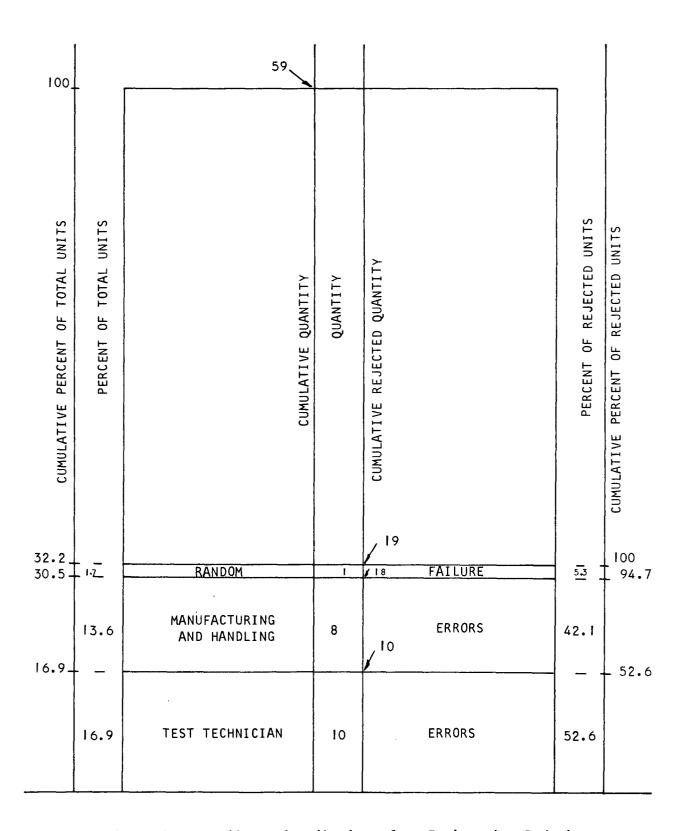


Figure 3-3. Failure Distribution after Engineering Redesign



avoidable. Recommendations for actions that will drastically reduce the quantity of failures resulting from these problem areas are summarized in Section 2 of this report.

SECTION 4

WATER GLYCOL QUANTITY TRANSDUCER (AIRESEARCH PN 837026)

PURPOSE AND DESCRIPTION

The water-glycol quantity transducer measures the volume of water-glycol stored in the accumulator. Depending on the volume of water-glycol stored in the accumulator, a differential pressure across the bellows of the accumulator is sensed by the transducer and a proportional electrical signal generated. This signal is used for telemetry purposes.

The transducer utilizes a Bourdon tube for the pressure-responsive element and a combination of a magnetic core, an armature (which completes the magnetic circuit), and inductance coils for the translation of physical motion into a proportional electrical signal.

PERFORMANCE AND DESIGN DATA

Table 4-I lists performance and design data for this transducer.

FAILURE AND DESIGN REVIEW

Table 4-2 is a summary of the 32 failure reports which were reviewed for this transducer evaluation. The information indicated in Table 4-2 has been summarized in the failure matrix of Figure 4-1.

Twenty-nine of the total of 32 reported failures were random electrical failures.

Twelve of the human-caused failures resulted from inadvertent overpressurization of the transducer. Seven of the remaining failures resulted from misconnection of input leads to the output terminals. Among the remaining ten failure reports, two failures were unconfirmed, two were caused by test equipment failure, and six others were caused by errors at various stages of the production process. Figures 4-2 and 4-3 illustrate typical failures caused by errors in production processing.

Figure 4-4 shows the distribution of the failures according to the sources of problems. The two unconfirmed failure reports are not included in this histogram. The current problem sources include (I) test technician errors, responsible for 63.3 percent of the failures, and (2) manufacturing and other errors, responsible for 26.7 percent of the failures. These failures, which account for 90 percent of all failures, are potentially avoidable. Recommendations for actions that will drastically reduce the quantity of failures resulting from these problem areas are summarized in Section 2 of this report.

TABLE 4-1

PERFORMANCE AND DESIGN DATA FOR PN 837026

Electrical power requirements

Input voltage, vdc 28 ± 4

Excitation current, ma 35 (max.)

Accuracy, psig $\pm 0.5 (\pm 0.7 \text{ cu in.})$

Quantity range, cu in. 0 to 35

Operating pressure range, psig 0 to 25

Operating temperature range, ^oF

Liquid side 35 to 160

Gas side 0 to 150

Time constant Within 30 ms

Output signal O volts at O psig to 5 vdc at

25 psig. Output signal shall

not exceed 6.5 vdc.

Output ripple Ripple component of output

signal shall not exceed 10 mv

rms

Output resistance, ohms 30,000

Output impedance, ohms 500 (max.)

Proof pressure, psig 37.5

Burst pressure, psig 62.5

External leakage Zero with 25 psig internal

pressure

Environmental conditions Per AiResearch Report SS-1060-R;

Type I equipment

Weight, 1b 0.6

Electrical connector Per MIL-C-26482C

FOLDOUT FRAME

TABLE 4-2

GLYCOL ACCUMULATOR QUANTITY TRANSDUCER FAILURE EVALUATION

TRANSDUCER	APPLICATI	ON Glyco	l Accumulate	or Quantity	Transducer	TRA	NSDUCER TYPE Pressure	e Differential	i	
BASIC PART	NUMBER	837028	5 - 5-1						nd Variable Reluctance	
TRANSDUCER	MANUF	AiRese	earch			MEA	SUREMENT RANGE 0-25	5 PSI Differential		
TROUBLE REP	ORT SOURC	E NR Spa	ace Div. and	d/or AiRese	arch Mfg. Co.			er Glycol		
PART NUMBER	SERIAL NUMBER	FAILURE DATE	T/R · NUMBER	FAILURE TYPE	FAILURE MODE	FAILURE MECHANISM	FAILURE CAUSE	PROBLEM AREA	CORRECTIVE ACTION	COMMENTS
837026-1	50059	6-8-69	AR18748	Elec	Output too low (Shift)	Transistor burnt out	Testing (Burn-in tests)	None Purpose of test	None	Purpose of burn-in test is to detect defective components.
837026-5-1	50059	2-17-69	AR19153	Elec	Output ripple	(Suspect) Transistor burnt out	Unknown	Random	Part was rejected for flight use	Failure cause could not be duplicated and failure can be detect during burn in
837026-5-1	50054	9-19-68	A117262	Human	Output too high	Deformation	Part over- pressurized	Testing	None	E-core okay Bourdon tube over- stressed
837026-5-1	50038	8-6-68	ARIOO8I	Human	Output too low	Output transistor and diode burnt out	Input power applied to output	Manufacturing	None	Wiring crossed during mfg. assembly result-ing in misapplication of power during test.
837026-5-I	50013	7-18-68	AR16671	Human	Output too high	Bourdon tube damaged	Mishandling	Manufacturing	None	Physical evidence of mishandling evident.
837026-5-1	50027	4-26-68	AR17681	Human	None		NO FAIL	URE		Test equipment mal- function causing burn- in temp. for 5 min. Part is satisfactory.
837026-4-1	50030	2-22-68	AR I 6566	Human	Low insulation resistance	Internal wire short	Improper installa- tion	Manufacturing	None - except Reliability Group will survey part	Low IR does not degrade test performance
837026-4-1	50023	6-12-67	AR8880	Human	Low insulation resistance	Contamination	Mishandling	Cleaning damage	None - Supplier QC adequate for contamination control.	This failure does not effect performance of transducer.
837026-4-1	50023	3-23-67	AR8899	Human	Low insulation resistance	Contamination	Mishandling	Testing	None	



FOLDOUT FRAME

TABLE 4-2 (Continued)

TRANSDUCER	APPLICATI	ON Glyco	1 Accumulat	or Quantit	Transducer	TRA	ANSDUCER TYPE Pressur	re Differential		
BASIC PART 1	NUMBER	83702	6-5-1		···				nd Variable Reluctance	
TRANSDUCER	MANUF	AiRes	earch			ME <i>F</i>	ASUREMENT RANGEO-2	5 PSI Differential		
ROUBLE REP	ORT SOURC	E NR Sp	ace Div. an	d/or AiRes	search Mfg. Co.	ME <i>A</i>	ASUREMENT MEDIAWat	er Glycol		
PART NUMBER	SERIAL NUMBER	FAILURE DATE	T/R NUMBER	FAILURE TYPE	FAILURE MODE	FAILURE MECHANISM	FAILURE CAUSE	PROBLEM AREA	CORRECTIVE ACTION	COMMENTS
837026-4-1	50-003 and 50-005	2-17-67	AR13062	Human	Output too high (Shift)	Wires crossed	Input power applied to output	Manufacturing	All technicians reeducated on proper assembly of part	
837026-4-1	50011 and 50014	11-11-66	ARI 2036	Human	Output too high (Shift)	Wires crossed	Input power applied to output	Manufacturing	Surveillance pro- gram has been initi- ated between Vendor and AiResearch.	
837026-4-1	50004	10-21-66	AR11384	Human	Output too high (Shift)	Wires crossed	Input power applied to output	Manufacturing	Surveillance pro- gram has been initi- ated between Vendor and AiResearch.	
837026-4-1	50036	9-30-66	AR11324	Human	Output too high (Shift)	Wires crossed	Input power applied to output	Manufacturing	Surveillance pro- gram has been initi- ated between Vendor and AiResearch.	
837026-4-1	50007	8-9-66	REPOR	NOT	LEGIBLE.	NOTAIRESE	ARCH REPOR	т.		
837026-4-1	50007	8-6-66	AR6632	Human	Shift	Variation in test equipment	Test equipment tolerance	Testing	Test set-up correct and part passed test.	
837036-1-1	9196	2~27-66	AR10748	Human	Shift	Stabilization	Part "set" changing calibration	Manufacturing or design	Mfg. process changed to add cycling test to cause part to "set" so that stablization shift. is prevented.	
837026-4-1	50039	7-12-66	AR10351	Human	Shift	Deformation	Overpressurized	Testing	Mfg. procedure re- vised so that part is not test out of sequence allowing it to be overpress.	Proof pressure should be performed prior to first assembly and calibration
837026-4-1	50030 and 50031	7-11-66	AR10217	Human	Output too high (Shift)	Deformation	Overpressurized	·Testing	Mfg. procedure re- vised so that part is not test out of sequence allowing it to be overpress.	Proof pressure should be performed prior to first assembly and calibration



TABLE 4-2 (Continued)

TRANSDUCER	APPLICATI	ON Glyc	ol Accumula	itor Quanti	ty Transducer		TRANSDUCER TYPE Pre	essure Differential		
BASIC PART			26-5-1				· · · · · · · · · · · · · · · · · · ·	Twisted Bourdon Tube ar	nd Variable Reluctance	
TRANSDUCER	MANUF.	AiRe	search				MEASUREMENT RANGE	0-25 PSI Differential		
TROUBLE REP	ORT SOURC	E NR S	pace Div. a	nd/or AiRe	search Mfg. Co.		MEASUREMENT MEDIA	Water Glycol		
PART NUMBER	SERIAL NUMBER	FAILURE DATE	T/R NUMBER	FAILURE TYPE	FAILURE MODE	FAILURE MECHANISM	FAILURE CAUSE	PROBLEM AREA	CORRECTIVE ACTION	COMMENTS
837026-4-1	50032	7-11-66	AR10216	Human	Output too high (Shift)	Deformation	Overpressurized	Mfg Testing	Mfg. procedure re- vised so part is not tested out of seq. so that is out of calib. When proofed	Proof pressure should be performed prior to final assembly and calibration
837026-4-1	50040, 50035, and 50038	7-11-66	AR10213	Human	Output too high (Shift)	Deformation	Overpressurized	Mfg Testing	Mfg. procedure re- vised so part is not tested out of seq. so that is out of calib. when proofed	Proof pressure should be performed prior to final assembly and calibration
837026-4-1	50019, 50027, and 50023	7-11-66	AR9932	Human	Output too high (Shift)	Deformation	Overpressurized	Mfg Testing	rested out of seq.	Proof pressure should be performed prior to final assembly and calibration
837026-4-1	50031	7-2-66	AR9262	Human	Output too high (Shift)	Deformation	0verpressurized	Mfg. Testing	Mfg. procedure re- vised so part is not tested out of seq. so that is out of calib. when proofed	Proof pressure should be performed prior to final assembly and calibration
837026-4-1	50026	7-1-66	AR9261	Human	Output too high (Shift)	Deformation	Overpressurized	Mfg Testing	Mfg. procedure re- vised so part is not tested out of seg. so that is out of calib. when proofed	Proof pressure should be performed prior to final assembly and calibration
837026-4-1	50011 and 50018	6-6-66	AR9939	Human	Output too high (Shift)	Deformation	0verpressurized	Mfg Testing	Mfg. procedure re- vised so part is not tested out of seq. so that is out of calib. when proofed	Proof pressure should be performed prior to final assembly and calibration
837026-4-1	50010 and 50015	5-28-66	AR9983	Human	Output too high (Shift)	Deformation	Overpressurized	Mfg Testing	Mfg. procedure re- vised so part is not tested out of seg. so that is out of calib. when proofed	Proof pressure should be performed prior to final assembly and calibration
837026-4-1	50002	5-22-66	AR9905	UN	CONFIRMED	Deformation	0verpressurized	Mfg Testing	Mfg. procedure re- vised so part is not tested out of seq. so that is out of calib. when proofed	Proof pressure should be performed prior to final assembly and calibration
837026-4-1	50008	5-11-66	AR9196	Human	Output too high (Shift)	Deformation	Overpressurized	Mfg Testing	Mfa. procedure re-	Proof pressure should be performed prior to final assembly and calibration



FOLDOUT FRAME

TABLE 4-2 (Continued)

TRANSDUCER A	APPLICATIO	ON Glyco	l Accumulato	r Quantit	y Transducer	TRA	ANSDUCER TYPE Press	ure Differential		
BASIC PART N	IUMBER	83702	6-5-1					isted Bour d on Tube and	Variable Reluctance	
TRANSDUCER N	MANUF.	Ai Res	earch					25 PSI Differential		
TROUBLE REPO	ORT SOURCE	NR Sp	ace Div. and	/or AiRes	earch Mfg. Co.		· · · · · · · · · · · · · · · · · · ·	ter Glycol		
PART NUMBER	SERIAL NUMBER	FAILURE DATE	T/R NUMBER	FAILURE TYPE	FAILURE MODE	FAILURE MECHANISM	FAILURE CAUSE	PROBLEM AREA	CORRECTIVE ACTION	COMMENTS
837026-4-1	50004	5-11-66	AR9176	Human	Output too high	Deformation	Overpressurized	Mfg. Testing	rfg. procedure re- vised so that part is not tested out of seq. so that it is out of calib. when it is proofed.	
837026-3-1	0002	9-1-65	AR6132	Human	Output too high	Transistor shorted	Input power applied to output	l _	None	
837026-3-1	69-201	5-20-65	AR6058	Human	Output too high	Transistor shorted	Input power applied to output	Testing	None	
837026-3-1	0002	3-29-65	AR4770	Human	Output too high (Shift)	Pressure sensing mechanism	Improperly adjusted	Manufacturing	None	During mfg locking cement was improperly applied allowing adj screw to loosen changing set point.
837026-2	69-201	2-4-65	AR4472	Elec	Fixed output	Output transistor	Unknown	Testing	None	The second secon

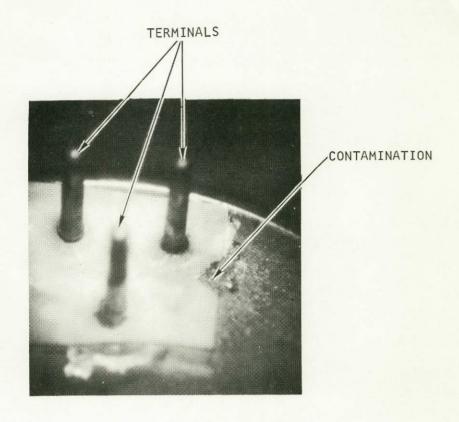


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PERCENT	NO OUTPUT		LOW OUTPUT	HIGH OUTPUT	FIXED OUTPUT	LOW RESISTANCE	LEAKAGE	FRRATIC	241747	RIPPLE	DRIFI	PEELING			T N C N		HUMAN	ELECTRICAL	MECHANICAL	EL			CHA MEC		NIC	AL									ITI(PROBLEM AREA
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<u> </u>			-	İ												T																									RECEIVING INSPECTION (TEST AND EQUIPMENT) INSTALLATIO
																																									INSTALLATION
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																				NEGO	Tach	ואסהט	FROZEN	OVERPRESSURIZED	LEAKAGE	DAMAGED	UNKNOWN	-	FAI			SDEGRADED	S PROCESS	MATERIAL	CONTAMINATION	DAMAGED	TEST EQUIPMENT	NOT ANALYZED	1		Figure 4-1. AiResearch PN 837 Block II ECS Comp



Block II ECS Component Water Glycol Quantity Transducer Failure Matrix



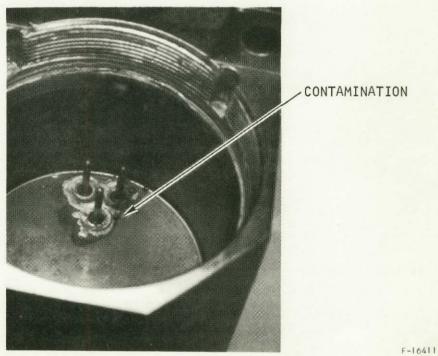
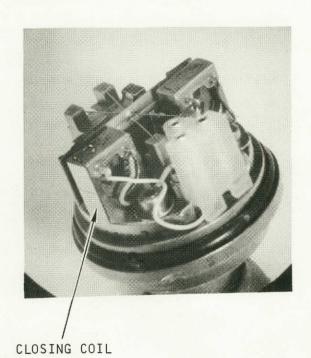
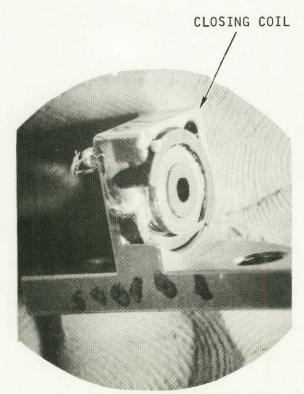
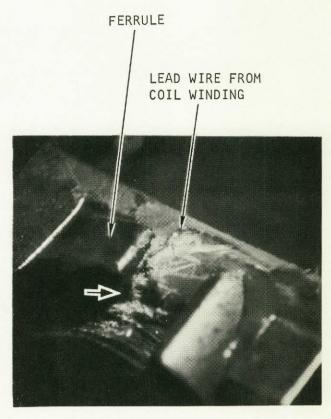


Figure 4-2. Water-Glycol Quantity Transducer Failure Report Sample

AIRESEARCH MANUFACTURING COMPANY
Torrance, California







CLOSING COIL (20 X)
(LEAD WIRE MAKING CONTACT TO
FERRULE NEAR THE COIL WINDING)

F-16410

Figure 4-3. Water-Glycol Quantity Transducer Failure Report Sample

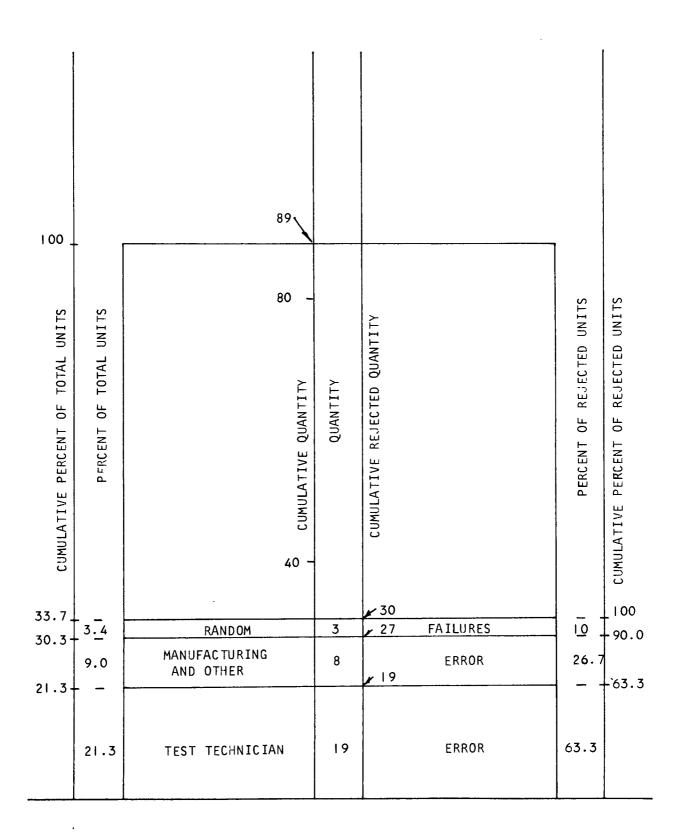


Figure 4-4. Distribution of Failures According to Problem Area

SECTION 5

CABIN PRESSURE TRANSDUCER (AIRESEARCH PN 836132)

PURPOSE AND DESCRIPTION

The cabin pressure transducer measures the static pressure of the cabin gases by sensing the pressure and generating a proportional electrical signal. This signal is used for ground checkout, for the crew's visual information via an indicator, and for telemetry data to be transmitted to a ground station, and serves as an indication of the performance of the cabin pressure regulator.

The transducer utilizes a Bourdon tube for the pressure-responsive element and a combination of a magnetic core, an armature (which completes the magnetic circuit), and inductance coils for the translation of physical motion into a proportional electrical signal.

PERFORMANCE AND DESIGN DATA

Table 5-1 presents performance and design data for this transducer.

FAILURE AND DESIGN REVIEW

Table 5-2 is a summary of the two failure reports which were reviewed for this transducer evaluation. Because of the very low quantity of the failures, a special matrix was not constructed. The information indicated in Table 5-2 has been directly transferred to a histogram in Figure 5-1. This figure shows that both of the failures were caused by human errors and hence are potentially avoidable. Recommendations for actions that will eliminate failures from these problem areas are summarized in Section 2 of this report.

TABLE 5-1

PERFORMANCE AND DESIGN DATA FOR PN 836132

Electrical power requirements

Input voltage, vdc 28 per SS-1070

Excitation current, ma 25 (max.)

Operating pressure range, psia 0 to 17

Operating temperature range, ^oF 0 to 150

Accuracy, psia $\pm 0.425 (\pm 0.125 \text{ v})$

Time constant of output signal Minimum

Output signal Proportional to sensed pressure.

O v at O psia to 5 vdc at 17 psia. Output signal shall not exceed 6.5 v in the event of

overpressurization.

Output ripple, mv rms 10 (max.)

Output load, ohms 30,000

Output impedance, ohms 500 (max.)

Pressure sensing port Per MS 33656-4 (1/4in. OD tube)

Proof pressure, psia 25.5 at 70°F

Burst pressure, psia 43 at 70°F

External leakage 6×10^{-6} lb/hr 0_2 max. when

pressurized to 4 psiq at 70°F

Weight, lb 0.5

OLDOUT FRAME

TABLE 5-2

CABIN ABSOLUTE PRESSURE TRANSDUCER FAILURE EVALUATION

TRANSDUCER	APPLICATIO	N <u>Apo</u>	llo ECS, Cab	in Abs. P	ress.	T	RANSDUCER TYPE Pressu	ıre Transducer				
BASIC PART I							PERATING PRINCIPLE TV					
TRANSDUCER	MANUF	Whittake	r (PN 600265)			ASUREMENT RANGE O-					
TROUBLE REP	ORT SOURCE	E AiRese	arch/North A	merican R	ockwell			reathing Oxygen				:
PART NUMBER	SERIAL NUMBER	FAILURE DATE	T/R NUMBER	FAILURE TYPE	FAILURE MODE	FAILURE MECHANISM	FAILURE CAUSE	PROBLEM AREA		CORRECTIVE ACTION	COMMEN	TS
836132-2-1	50026	1-20-71	22400 (NR)	Human	Output high	Pressure sensing mechanism	0verpressurized	Manufacturing	No	ne	E-pack wire s bowed.	lightly
ME449-0095- 0021	500004	11-15-68	60921 (NR)	Unknown	Output high	Pressure sensing mechanism	Suspect overpressure	Unknown	No	ne	Bourdon tube v	was not



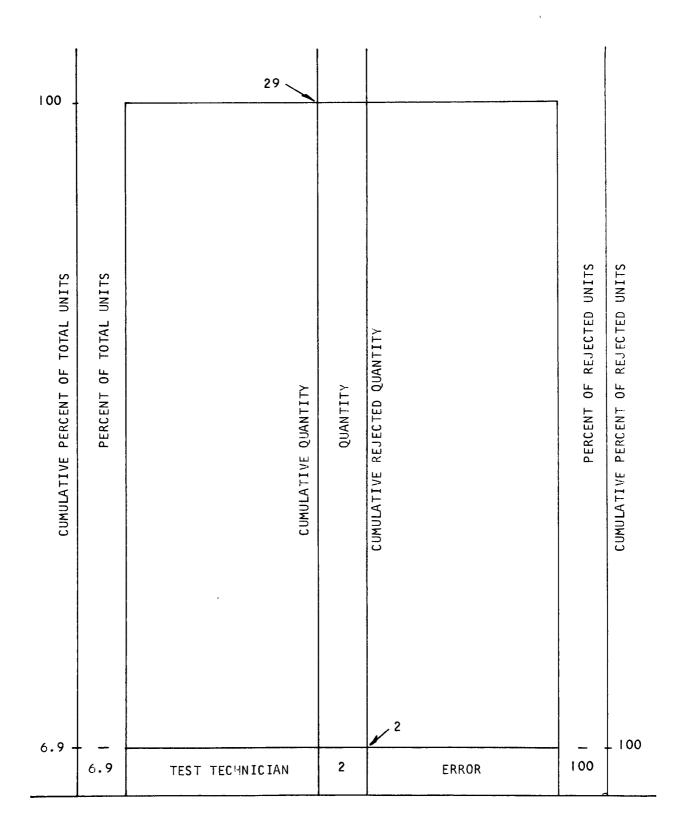


Figure 5-1. Distribution of Failures



SUIT-SUPPLY AND CABIN PRESSURE TRANSDUCER (AIRESEARCH PN 837044)

PURPOSE AND DESCRIPTION

The pressure transducer is used as follows:

- (a) To measure the static pressure of the gases flowing through the suit-supply inlet manifold just prior to entering the pressure suits.
- (b) To measure the static pressure of the cabin gases. The gas pressure serves as an indication of the performance of the cabin pressure regulator.

The measurement is accomplished by sensing the pressure and generating a proportional electrical signal.

The transducer utilizes a Bourdon tube for the pressure-responsive element and a combination of a magnetic core, an armature (which completes the magnetic circuit), and inductance coils for translation of the physical motion into a proportional electrical signal.

PERFORMANCE AND DESIGN DATA

Table 6-I presents the performance and design data for this transducer.

FAILURE AND DESIGN REVIEW

Table 6-2 is a summary of the 19 failure reports which were reviewed for this transducer evaluation. The information included in Table 6-2 has been summarized in the failure matrix of Figure 6-1. Seventeen of the total of 19 reported failures were caused by human errors. The other two were random electrical failures.

Eight of the human-caused failures resulted from inadvertent overpressurization of the transducer. Sensitivity of the Bourdon tubes to pressure spikes is the mechanism of these failures. One of the failures had not been analyzed. Two failures were caused by misconnection of the input power leads to the output terminals. One unit shorted out because of assembly errors. Three units were rejected because of fabrication process errors. One rejection was caused by the choice of wrong material in the test equipment. One unit was rejected because it was damaged in handling. There were two random electrical failures.

Figure 6-2 shows the distribution of the failures according to the sources of problems. These problem sources include (I) test technician errors (responsible for 52.6 percent of failures), and (2) manufacturing and handling errors (responsible for 31.5 percent of failures). These failures, which account for

TABLE 6-1

PERFORMANCE AND DESIGN DATA FOR PN 837044

Electrical power requirements

Input voltage, vdc 28 ±4

Excitation current, ma 35 (max.)

Operating pressure range, psia 0 to 17

Accuracy, psia ±0.34

Time constant of output signal Within 30 ms

Output signal O v at O psia, 5 vdc at 17 psia.

Output signal shall not exceed 6.5 v in the event of overpres-

surization.

Output ripple, mv rms 10 (max.)

Output load, ohms 30,000

Output impedance, ohms 500 (max.)

Proof pressure, psia 25.5 at 70°F

Burst pressure, psia 43 at 70°F

Weight, 1b 0.6

FOLDOUT FRAME

TABLE 6-2

SUIT INLET AND CABIN PRESSURE TRANSDUCER FAILURE EVALUATION

TRANSDUCER A	APPLICATIO	ON Suit	Inlet and C	abin Press	ure Transducer	TRA	NSDUCER TYPE Press	sure		
BASIC PART N	IUMBER A/	R No. 8370	044, Whittal	ker No. 60	0245 and 600247	OPE	RATING PRINCIPLE Var	iable Reluctance-Twis	ted Bourdon Tube	
TRANSDUCER 1	MANUF. Wh	ittaker-Wi	i anko			MEAS	SUREMENT RANGE			
TROUBLE REPO	ORT SOURCE	AiResea	erch			MEA:	SUREMENT MEDIA		, 	
PART NUMBER	SERIAL NUMBER	FAILURE DATE	T/R NUMBER	FAILURE TYPE	FAILURE MODE	FAILURE MECHANISM	FAILURE CAUSE	PROBLEM AREA	CORRECTIVE ACTION	COMMENTS
837044 - I	70248	11/6/64	4289	Human	Calibration Shift	Distortion of sense mechanism	Overpressure	Testing	None	
837044-1-1	69213	4/13/65	5895	Human	Explosion in test setup	-	-	Testing	-	Failure did not relate to unit. Unit was good.
837044-3-1	0018	4/22/65	5805	Human	Plating peeling off unit	-	Improper surface preparation prior to plating	Manufacturing	Properly prepare surface	
837044-4-1	50001	5/4/66	9168	Human	Calibration Shift	-	Unit thought to be overpressurized during cleaning	Manufacturing	Revise cleaning procedure	
837044-4-1	50002	5/12/66	8440	Human	Calibration Shift	-	Unit thought to be overpressurized during cleaning	Manufacturing	Revise cleaning procedure	
837044-4-1	50001	5/18/66	9901	Human	Calibration Shift	~	Unknown. Thought to be cleaning procedure.	Manufacturing	Add more calibration checks before, dur- ling and after cleaning	·
837044-4-1	50008	5/28/66	9952	Human	No output	Failed transistor	Input voltage applied to output circuit	Testing	None	
837044-4-1	50012	6/7/66	9918	Human	Calibration Shift	Distortion of sense mechanism	Overpressure during cleaning	Manufacturing	Revise cleaning procedure	
837044-4-1	50016	7/2/66	9263	Human	Calibration Shift	Distortion of sense mechanism	Overpressure during cleaning	Manufacturi ng	Revise cleaning procedure	

FOLDOUT FRAME

TABLE 6-2 (Continued)

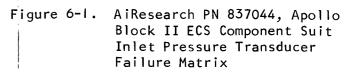
TRANSDUCER	APPLICATION	ON <u>Suit</u>	Inlet Pres	sure Trans	ducer	TRA	NSDUCER TYPE Press	sure		
BASIC PART	NUMBER	A/R No. 837	7044, Whitt	aker No. (500245	OPE	RATING PRINCIPLE			
TRANSDUCER							SUREMENT RANGE			-
TROUBLE REF	ORT SOURC	E AiResea	erch			MEA	SUREMENT MEDIA			
PART NUMBER	SERIAL NUMBER	FAILURE DATE	T/R NUMBER	FAILURE TYPE	FAILURE MODE	FAILURE MECHANISM	FAILURE CAUSE	PROBLEM AREA	CORRECTIVE ACTION	COMMENTS
837044-3-1	0012	7/14/66	10047	Human	Drift	Defective capacitor	Excessive stress applied to lead during assembly	Manufacturing	Caution production personnel	
837044-4-1	50006	7/26/66	10745	Human	Calibration Shift	Distortion of sense mechanism	Overpressure during cleaning	Manufacturing	Revise cleaning procedure	
837044-3-1	0013	9/19/66	11139	Elec	Erratic output	Failed (shorted) capacitor	Unknown	-	None	Probably random failure
837044-4-I	50010	10/28/66	12006	Human	Calibration Shift	-	-	-	-	Unit failure not analyzed
837044-4-I	50018	3/16/67	12253	Elec	Drift	Failed zener diode	Unknown	-	None	Probably random failure
837044-5-1	50020	10/27/67	16501	Human	No output	Failed electrical components	Input voltage applied to output terminals	Testing	Color code electrical connectors	
837044-5	50007	12/8/67	16525	Human	Calibration Shift	Housing of unit distorted	Installing over a burr in test fixture	Testing	None	
837044-5-1	50031	1/9/68	19144	Human	Full output	Shorted terminals on circuit board	Human error during potting operation	Manufacturing	None	
837044 - 5 - I	50006	11/14/69	N/A No. PAC 3-350	Human	Erratic Operation	Particles of nickle plate and lunar dust contaminating unit	Poor internal plating	Manufacturing	Add filtering to transducer line	



TABLE 6-2 (Continued)

TRANSDUCER	APPLICATI	ON Suit	Inlet Press	ure Transe	ducer	TRA	NSDUCER TYPE Pressu	ıre		
			044, Whittal	ker No. 60	00245	OPE	RATING PRINCIPLE			
TRANSDUCER	MANUF. Wh	nittaker-Wi	anko			MEA	SUREMENT RANGE			
TROUBLE REP	ORT SOURC	EAiRes	search	· · · · · · · · · · · · · · · · · · ·		MEA	SUREMENT MEDIA			
PART NUMBER	SERIAL NUMBER	FAILURE DATE	T/R NUMBER	FAILURE TYPE	FAILURE MODE	FAILURE MECHANISM	FAILURE CAUSE	PROBLEM AREA	CORRECTIVE ACTION	COMMENTS
37044-5-1	50002	4/11/70	NA No. PAC 3-365	Human	Output Shift	Particles of nickle plate contaminating unit	Inadequate cleaning of unit.	Manufacturing	Clean all units while disassembled. Assemble in clean room.	
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PERCENT	NO OUTPUT	SHIFT	LOW OUTPUT	HIGH OUTPUT	FIXED OUTPUT	LOW RESISTANCE	LEAKAGE	ERRATIC	PIDDIE	אזור רב	DRIFT	PEELING				NONE	LIMANI	NC LOL	MECHANICAL	EL	EC.		ME	ECH/	ANI	CAL						NAL NSM															
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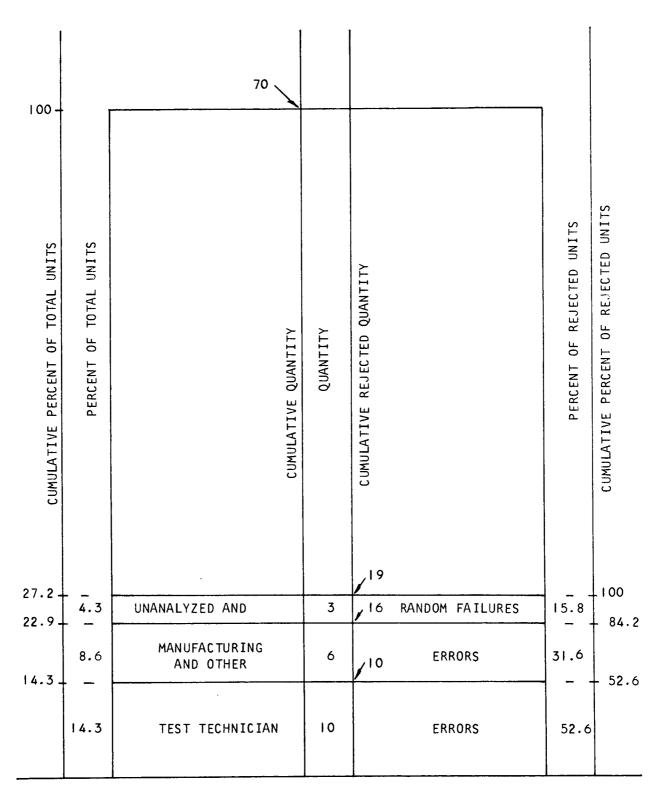


Figure 6-2. Distribution of Failures According to Problem Area



84.2 percent of all failures, are potentially avoidable. Recommendations for actions that will drastically reduce the quantity of failures resulting from these problem areas are summarized in Section 2 of this report.

OXYGEN SUPPLY PRESSURE TRANSDUCER (AIRESEARCH PN 837016)

PURPOSE AND DESCRIPTION

The oxygen supply pressure transducer measures the static pressure in the oxygen supply line by sensing the pressure and generating a proportional electrical signal. This signal is used for ground checkout, for the crew's visual information (via an indicator) and for telemetry data to be transmitted to a ground station. This measurement is taken at a point just upstream of the demand pressure regulator and relief valve.

The transducer utilizes a Bourdon tube for the pressure-responsive element and a combination of a magnetic core, an armature (which completes the magnetic circuit), and inductance coils for translation of the physical motion into a proportional electrical signal.

PERFORMANCE AND DESIGN DATA

Table 7-I lists performance and design data for this transducer.

FAILURE AND DESIGN REVIEW

Table 7-2 is a summary of the IO failure reports which were reviewed for this transducer evaluation. The information indicated in Table 7-2 has been summarized in the failure matrix of Figure 7-1.

Nine of the total of 10 reported failures were caused by human errors. The remaining one was due to random electrical failure.

Two of the human-caused failures resulted from inadvertent overpressurization of the transducer. Three of the remaining failures resulted from misconnection of the input power leads to the output terminals. Two failures were caused by poor assembly practices, and two more failures were caused by the wrong choice of material by engineering. There was one random electrical failure.

Figure 7-2 shows the distribution of the failures according to the sources of problems. Figure 7-3 shows the distribution of the current failures after the redesign that removed the engineering error from the list of problem sources. The remaining current problem sources include (I) test technician error (responsible for 62.5 percent of failures), and (2) maufacturing and handling errors (responsible for 25 percent of failures). These failures, which account for 87.5 percent of all failures, are potentially avoidable. Recommendations for actions that will drastically reduce the quantity of failures resulting from these problem sources are summarized in Section 2 of this report.

TABLE 7-1

PERFORMANCE AND DESIGN DATA FOR PN 837016

Electrical power requirements

Input voltage, vdc 28 ±4

Excitation current, ma 35 (max.)

Operating pressure range, psig 0 to 150

Accuracy, psig ±3.0

Time constant of response Within 30 ms (to 63.2 percent

of applied step pressure input)

Output signal O v at O psig to 5 vdc at 150

psig. Output signal shall not exceed 6.5 v in event of over-

pressurization.

Output supply, mv rms 10 (max.)

Output load, ohms 30,000

Output impedance, ohms 500 (max)

Proof pressure, psig 225 at 70°F

Burst pressure, psig 375 at 70°F

External leakage, 1b/hr 6 x 10^{-6} with 150 psig

internal pressure

Electrical connector Per MIL-C-26482-C

Weight, lb 0.6

TABLE 7-2

OLDOUT FRAME

OXYGEN PRESSURE TRANSDUCER FAILURE EVALUATION

TRANSDUCER	APPLICATIO	ONA	pollo ECS 0 ₂	Pressure	Transducer	TRA	NSDUCER TYPE <u>Pressu</u>	re Transducer Variab	le Rei	uctance	
			(AiResearch				RATING PRINCIPLE				
TRANSDUCER- I	MANUF	Pace Wia	ncko (54628-	1)		MEA	SUREMENT RANGEO to	150 psig		·	
TROUBLE REPO	ORT SOURC	E AiRes	earch/North	American	Rockwell	MEA	SUREMENT MEDIA0x	ygen (gaseous)			
PART NUMBER	SERIAL NUMBER	FAILURE DATE	T/R NUMBER	FAILURE TYPE	FAILURE MODE	FAILURE MECHANISM	FAILURE CAUSE	PROBLEM AREA		CORRECTIVE ACTION	COMMENTS
837016-1	0007	2-29-68	16571	Human	Shift to no output	Electronic package	Input power applied to output	Testing	None	- Block I part	Shorted diode
837016-2-1	50008	8-29-67	15159	Human	High output	Pressure sensing mechanism	Overpressurized	Testing		- Test equip-	
						mechanism			ment	correct earlier	
837016-2-1	50017	8-25-67	14620	Human	High output	Electronics package	Input power applied to output	Test	rewo misa	equipment rked to prevent pplication or during test	
837016-2-1	50003	8-24-67	14618	Human	High output	Electronics package	Input power applied to output	Test	rewo misa	equipment rked to prevent pplication or r during test	
837016	50014	8-22-67	15477	Human	High output	Pressure sensing mechanism	Overpressurized	Test equipment	to o	y valve allowed verpressurize test revised	Deformed Bourdon tube
837016-2	50006	2-21-67	13065	Elect.	High output	Electronics package	Shorted transformer	Unknown	Acce fail	pted as a random ure	
837016-1	70243	I - 28 - 67	12076	Human	Shift	Electronics package	Out tolerance caused by resistor	Design		ace carbon stor with film	
837016-1	00001	9-16-66	NR 27061	Human	Shift		Out tolerance caused by resistor	Design		ce carbon stor with film	
837016-1	0009	9-12-66	10986	Human	High Output	Electronics package	Resistor wired improperly	Manufacturi ng	proce	nbly and test dures incorpo- to preclude lem	
837016-1	50001	8-23-66	10933	Human	High output	Electronics package	Resistor wired improperly	Manufacturing	proce	mbly and test edures incorpo- to preclude lem	





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			F	UT	PUT	TANCE														S E N ME C		NG NIS	M							c t c	MAI		ND.		ONT	N.C					; ;		PROBLEM AREA
PERCENT	NO OUTPUT		LOW OUTPUT	HIGH OUTPUT	FIXED OUTPUT	LOW RESISTANCE	LEAKAGE	ERRATIC	KI PPLE	DRIFT	PEELING			NONE	HIMAN		ELECTRICAL	MECHANICAL	LE(С.	1	1EC	HAN	IIC	AL.					TRA	NSM	ISS	ION	N M	ON I ECH	NG IAN I	SM	ט					
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	BINC CO																																										Figure 7-1. AiResearch PN 837016, Apo Block II ECS Component Ox Supply Pressure Transduce Failure Matrix



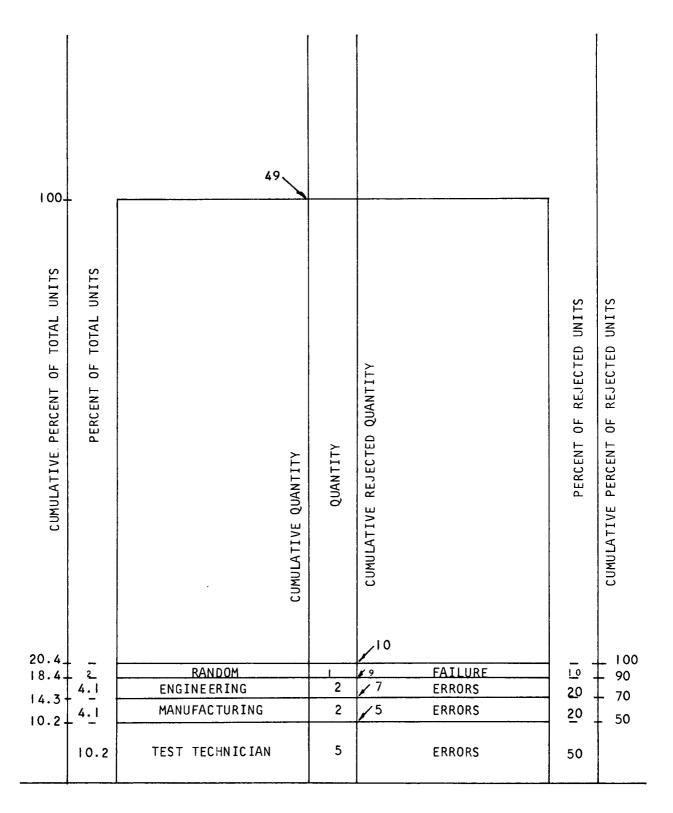


Figure 7-2. Distribution of Failures According to Problem Area



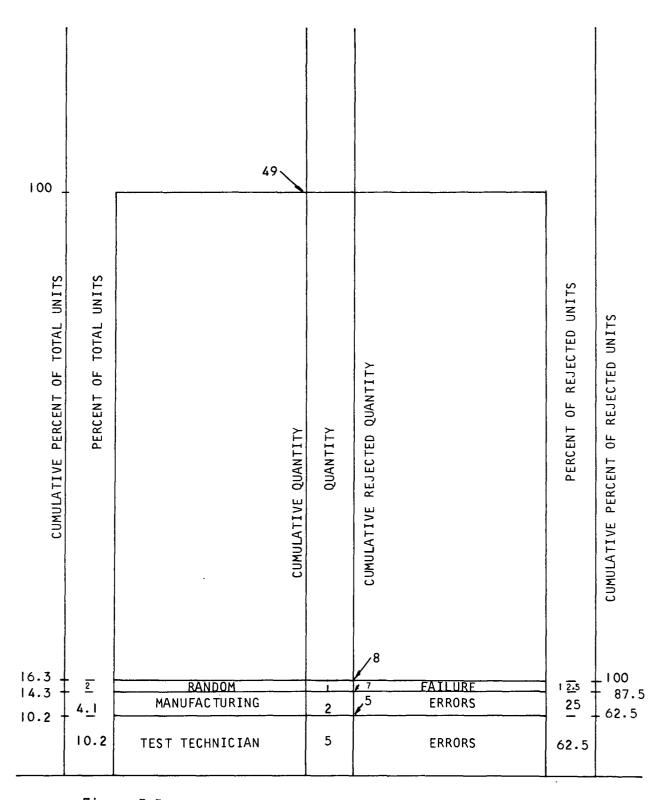


Figure 7-3. Distribution of Failures After Correction of Engineering Design



WATER GLYCOL PUMP PRESSURE TRANSDUCER (AIRESEARCH PN 837008)

PURPOSE AND DESCRIPTION

This pressure transducer is identical in application to water-glycol pump pressure transducer, PN 836130, described in Section 3 of this report. Since a large portion of the failures (approximately 72 percent) occurred in manufacturing assembly, the unit was replaced by PN 836130. AiResearch recommends that this item be closed, and that PN 836130 be used as the reference transducer.

PERFORMANCE AND DESIGN REVIEW

Table 8-I is a summary of the 7 failure reports reviewed. All 7 of the failures were human-caused. Figure 8-I presents the matrix of these failures. This summary of failures is presented for record purpose only.

TABLE 8-1

FOLDOUT FRAME

)

WATER-GLYCOL ACCUMULATOR QUANTITY TRANSDUCER FAILURE EVALUATION

TRANSDUCER A	PPLICATION	ON <u>Wa</u>	ter-Glycol A	ccumulato	r Quantity	TR/	ANSDUCER TYPE Press	Transducer		
BASIC PART N	UMBER	837008	(AiResearc	:h)			ERATING PRINCIPLE _Twis			
TRANSDUCER M	ANUF	Whittal	ker (Pace-Wi	ancko) (P	N 54626-I)	ME <i>A</i>	SUREMENT RANGE 0 to	o 60 psia	!	
TROUBLE REPO	RT SOURC	E AiRe	search or No	rth Ameri	can Rockwell	ME <i>F</i>	ASUREMENT MEDIAWate	er glycol		
PART NUMBER	SERIAL NUMBER	FAILURE DATE	T/R NUMBER	FAILURE TYPE	FAILURE MODE	FAILURE MECHANISM	FAILURE CAUSE	PROBLEM AREA	CORRECTIVE ACTION	COMMENTS
837008-2	50007	11-22-67	A/R 16900-0	Human	Shift	Minute leak in reference chamber	Leak path could not be determined	Manufacturing	Helium leak check all Apollo Blk II units (mass spec)	This failure was on an early Apollo Blk I unit
837008-2	50004	11-20-67	A/R 16805-0	Human	Shift	None found	Suspected NR test equipment was bad	NR test	Mark unit "not for flight use"	Failure could not be duplicated by A/R and Whittaker
837008-2	50006	11-13-66	A/R 12041-9	Elec.	Shift	Failed capacitor	Random	Manufacturing	None	
837008-2	50010	5-28-66	A/R 9951-9	Human	No output.	Open junction at transistor	Open circuit	Manufacturing technician error	None	First occurrence
337008-2	50005	7-5-66	A/R 9166-9	Human	Shi ft	Not determined	Used for wrong application	Manufacturing assembly	Revised blueprint to clarify xducer vs application	
837008-2	50007		A/R 9165-9	Human	Leakage	O-ring seal on banjo fitting defective	Excessive torque was applied to banjo fitting	Test	Proper torque was specified on vendor printnone-	
837008-2		2-19-65	A/R 5034	Human	Diode voltage high	Added jumper wire	Added jumper wire was not done to print	Manufacturing	Personnel notified	
							·			·



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PERCENT	NO OUTPUT		LOW OUTPUT	HIGH OUTPUT	FIXED OUTPUT	LOW RESISTANCE	LEAKAGE	ERRATIC	RIPPIF	DRIET		PEEL ING		NONF		HUMAN	ELECTRICAL	MECHANICAI	ELE	с.	М	IE C H	ļAN	ICA	ıL				Т	RAN	ISMI	[SS]	ON	MEC	CHAN	IISI	M						·
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Figure 8-1. AiResearch PN 837008, Apollo Block I ECS Component Glycol Pump Transducer Failure Matrix



AIRESEARCH MANUFACTURING COMPANY

Los Angeles, California

REPORT ON FAILURE AND DESIGN EVALUATION OF APOLLO ECS PRESSURE TRANSDUCERS, VARIABLE RELUCTANCE-DIAPHRAGM WITH ELECTRONICS TYPE

CONTRACT NO. NAS 9-12452

72-8537-3, Rev. 2

February 10, 1973

Prepared by A. Saginian

APPROVED:

R. E. Vesque Program Manager

F F KU V EU

Principal Investigator

Prepared for NASA MANNED SPACECRAFT CENTER HOUSTON, TEXAS 77058

ABSTRACT

This report presents the results for a failure and design evaluation study conducted on the Apollo ECS pressure transducers, the generic group of variable reluctance-diaphragm with electronics type pressure transducers. The study was conducted for NASA-MSC by the AiResearch Manufacturing Company, a division of the Garrett Corporation under Contract NASA-12452.

The study purpose was to evaluate the integrity of design of this type transducer. Failure information is presented and summarized pertaining to 3 transducer design groups comprising 5 different transducer part numbers.

These designs have had chronic calibration and stabilization problems. Design and supplier changes have not resolved this problem. Other types of pressure transducers should be studied for possible substitution in similar applications.

CONTENTS

<u>Section</u>		Page
1	INTRODUCTION	1-1
2	STEAM DUCT PRESSURE TRANSDUCER	2-1
3	SUIT COMPRESSOR DIFFERENTIAL PRESSURE TRANSDUCER	3-1
4	BACK PRESSURE TRANSUDCER	4-1

INTRODUCTION

This report presents a summary of failure data of the generic group of variable reluctance-diaphragm with electronics type pressure transducers, one of several pressure transducer types that are described and categorized in AiResearch Report No. 72-8537-1. Five variable reluctance-diaphragm with electronics pressure transducers were evaluated in three different configuration groups; (1) steam duct pressure transducer, (2) suit compressor differential pressure transducer, and (3) back pressure transducer.

All five part numbers were designed for Apollo ECS application. Requirement for back pressure transducer PN 836114, was eliminated from the system and the use of this transducer was discontinued. Two transducers were designed for suit compressor differential pressure sensing function where PN 836705 supersedes PN 837054; however, the superseded part number was never implemented in any system. Two transducers were designed for steam duct pressure sensing function where PN 837036 supersedes PN 836706.

The pressure transducer that are evaluated and summarized in this report are by AiResearch part number:

<u>PN</u>	Nomenclature
837036	Steam Duct Pressure Transducer
836706	Steam Duct Pressure Transducer
837054	Suit Compressor Differential Pressure Transducer
836114	Back Pressure Transducer

Detailed failure data on each of these pressure transducers are presented in Section 2 through 4 of this report. Each one of these three sections presents discriptive information, failure summary, and recommendations that apply to the transducer evaluated in that section. Differences in the transducer design configurations within these three groups are primarly due to differences in the intended transducer locations and media of application.



SUIT COMPRESSOR DIFFERENTIAL PRESSURE TRANSDUCER

(AiResearch PN 837054 and PN 836705)

INTRODUCTION

The initial design of suit compressor differential pressure transducer PN 837054 has been implemented in Apollo ECS Block I and Block II. Because of numerous rejections as a result of unit instability this design was superseded by PN 836705 which has not been implemented in any system.

PURPOSE AND DESCRIPTION

The suit compressor differential pressure transducer in its Apollo application measures the gas pressure rise developed by the suit compressor. The pressure rise serves as an indication of suit compressor performance. The pressure sensing ports of the transducer are connected to the suit circuit ducting at a point upstream of the suit compressors and at a point downstream of the suit compressor check valves.

The transducer is powered by the 28 vdc supply of the spacecraft and operates over a differential pressure range of 0 to 25 in. H₂0. An electrical signal (0 to 5 vdc) proportional to the differential pressure across the suit compressor is provided by the transducer. This signal is used for ground checkout, for the crews visual information, via an indicator and for telemetry data to be transmitted to a ground station.

The transducer essentially converts a signal corresponding to the sensed differential pressure into a proportioned electrical signal.

PERFORMANCE AND DESIGN DATA

Table 2-1 presents the performance and design data for these differential pressure transducers. The data are identical for both of these designs. Figure 2-1 presents a typical isometric drawing of these transducers. Figure 2-2 presents the outline drawing of the current transducer design PN 836705. Engineering design error on PN 837054 was the problem source for 65 rejections in a total population of 51 units which represents a rejection rate of 127 percent. This high rejection rate motivated the effort for PN 836705 which was not implemented in the system and has two rejections in a total propulation of 11 units for a rejection rate of 18 percent.

FAILURE AND DESIGN REVIEW

Initial Design (PN 837054)

Table 2-2 is a summary of 65 failure reports written against PN 837054. Sixty three (63) units (97 percent) were rejected because of instability and two units (3 percent) because of attitude sensitivity.

Current Design (PN 836705)

Table 2-3 is a summary of two failure reports written against PN 836705.

The reason for both of these rejections were ripple and shift caused by engineering error in design.

RECOMMENDATIONS

Both of these designs have been in trouble from the beginning; design revisions and changes have not eliminated the instability problem. It is recommended that other transducer designs be studied as possible substitution in this or similar applications.

TABLE 2-1

PERFORMANCE AND DESIGN DATA FOR PN 837054 AND PN 836705

Performance Requirements:

- a. Operating differential pressure range: 0 to 25 in. water differential. (0.18 to 0.903 psi)
- b. Accuracy ±0.5 in. water (also refer to h)
- c. Time Constant of Output Signal: Within 30 ms
- d. Output signal: 0 vdc at 0 in. water to 5 vdc at 25 in. water.

 Output signal shall not exceed 6.5v in the event of overpressurization
- e. Output ripple: Ripple component of output signal shall not exceed 10 mv peak to peak
- f. Output load: 30,000 ohms
- q. Output impedance: 500 ohms max
- h. Environmental error band: Output signal error resulting from the combined effects of nonlinearity, repeatability, and input voltage fluctuation during any rational combination of environmental conditions specified in AiResearch Report SS-1060-R, shall not exceed ±2.0 percent (±0.10 v) of full scale from 0 to 100 percent of differential pressure range.

Structural Requirements:

- a. Proof pressure:
 - (1) Case: $7.5 \text{ psig at } 70^{\circ} \text{F}$
 - (2) Differential: $37.5 \text{ in. H}_2\text{O}$ at 70°F
- b. Burst pressure:
 - (1) Case: $12.5 \text{ psig at } 70^{\circ} \text{F}$
 - (2) Differential: 62.5 in. H_2O at $70^{\circ}F$

Leakage:

- a. External: Oxygen leakage rate shall not exceed 6 x 10^{-6} lb/hr with 5 psia internal pressure and 10^{-4} torr external pressure.
- b. Internal: Zero at 25 in, water differential

TABLE 2-1 Cont.

<u>Electrical Power Requirements:</u>

a. Input voltage: 28 ±4 vdc

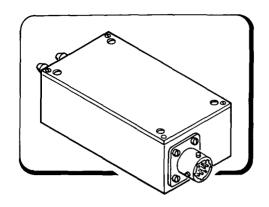
b. input current: 35 ma max

Environmental Conditions: Per AiResearch Report SS-1060-R

Installation Envelope: Per AiResearch Drawing 837054

Weight: 0.6 lb

Electrical Connector: In accordance with MIL-C-26482-C



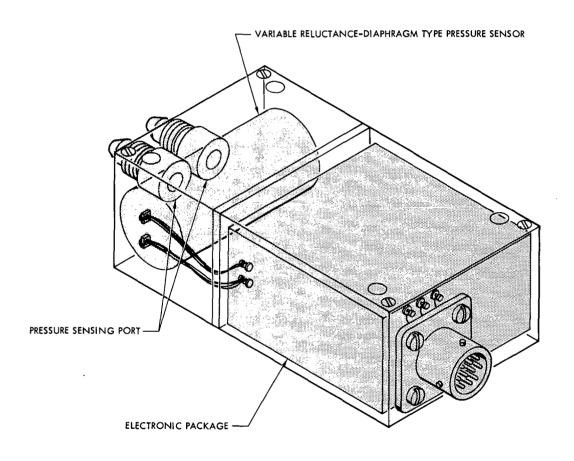


Figure 2-1. Isometric Drawing of a Typical Suit Differential Pressure Transducer

S- 32 135

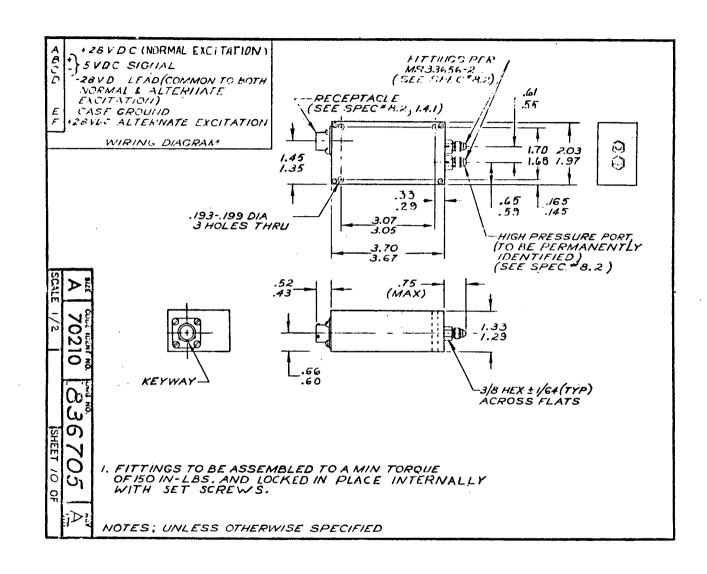


Figure 2-2. Outline Drawing of Current Suit Differential Pressure Transducer

LDOUT FRAME

TABLE 2-2

DIFFERENTIAL PRESSURE TRANSDUCER FAILURE EVALUATION

TRANSDUCER	APPLICATIO	ON Suit	Compressor	∆P Xducer		TR/	ANSDUCER TYPE Pro	essure		
BASIC PART I	NUMBER	A/R 8	37054			OP1	ERATING PRINCIPLE Va	riable Reluctance-Di	agram with Electronics	
TRANSDUCER	MANUF	Cons	olidated Con	trols Cor	poration	ME.A	ASUREMENT RANGE 0	- 25 in. Water		
TROUBLE REP	ORT SOURCE	E Nort	th American	and AiRese	earch		SUREMENT MEDIAGas			
PART NUMBER	SERIAL NUMBER	FAILURE DATE	T/R NUMBER	FAILURE TYPE	FAILURE MODE	FAILURE MECHANISM	FAILURE CAUSE	PROBLEM AREA	CORRECTIVE ACTION	COMMENTS
837054-3	00400- 0008163	12.6-68	NR A137257	Human	Setpoint Shift	Electronic instability and unstable sensing diaphragm	Unit over pressurized	Des i gn	Alert Test Person- sonel to follow the OCP's	This xducer is sensitive to over-pressurization
837054-3	9792	8-26-68	A/R 19107-0	Human	Setpoint shift	Instability	Inadequate design	Design	Improved cleaning and handling proce- dures	EDCP 1572 submitted and rejected by NR
837054-3	9976	7-24-68	NR AR16677	Human	Setpoint shift	Instability		Design		
837054-3-1	9976	7-14-68	A/R 16677-0	Human	Setpoint shift	Electronic instability		Design	Returned to vendor	
837054-3	9975	7-14-68	A/R 16665	Human	Setpoint shift	Electronic instability		Design		
837054-	9233	7-3-68	A/R 16645	Human	Shift	Attitude sensitive		Des ign	Return to vendor	
837054	8161	7-2-68	A/R 16647	Human	Shift	Electronic instability		Des i gn	Return to vendor	
837054-3	8157	7-1-68	A/R 16646	Human	Shift	Electronic instability		Des i gn	Return to vendor	
837054-3	8164	6-29-68	A/R 16644	Human	Shift	Electronic instabiltiy		Des i gn	Return to vendor	



72-8537-3 Page 2-7, Rev. 2

TABLE 2-2 (Continued)



DIFFERENTIAL PRESSURE TRANSDUCER FAILURE EVALUATION

LKANSDUCER	APPLICATION	ONSui	t Compress	or ∆P Xduc	er		TRANSDUCER TYPE	Pressure			
BASIC PART NUMBER A/R 837054							OPERATING PRINCIPLE	Variable Reluctance - Diagram with Electronics			
ΓRANSDUCER	MANUF	Consoli	dated Cont	rols Corpo	ration		MEASUREMENT RANGE				
TROUBLE REF	PORT SOURC	E N	lorth Americ	can and Ail	Research		MEASUREMENT MEDIA	Gas			
PART NUMBER	SERIAL NUMBER	FAILURE DATE	T/R NUMBER	FAILURE TYPE	FAILURE MODE	FAILURE MECHANISM	FAILURE CAUSE	PROBLEM AREA	CORRECTIVE ACTION	COMMENTS	
837054-2	8158	6-3-68	A/R 16638	Human	Electronic instability			Design	Return to vendor		
837054-2	9221	5-28-68	A/R 16656-9	Human	Electronic instability		·	Design	Return to vendor		
837054-2	8162	5-22-68	A/R 16634-9	Human	Low insulation resistance			Design	Return to Vendor		
837054-2	8910	5-8-68	A/R 16625-0	Human	Shift			Design	Return to vendor		
837054-1	9791	4-5-68	A/R 17667	Human	Shift	,		Design	Return to vendor		
837054-3	9192	4-15-68	A/R 17674	Human	Shift			· Des i gn	Return to vendor		
837054-3	9232	4-12-68	A/R 17672	Human	Shift			Des i gn	Return to vendor		
837054-2	8157	12-28-67	7 A/R 16539-0	Human	Shift			Des i gn	Return to vendor		
837054-2	8910	12-28-67	/ A/R 16539-0	Human	Shift			Des i gn	Return to vendor		



72-8537-3 Page 2-8 ,Rev.1

TABLE 2-2 (Continued)

OLDOUT FRAME

DIFFERENTIAL PRESSURE TRANSDUCER FAILURE EVALUATION

TRANSDUCER	APPLICATIO	ON Su	it Compress	or ∆P Xduc	cer	TRA	NSDUCER TYPE	Pressure	i	
BASIC PART N	NUMBER	A/R 8370	54			OPE	RATING PRINCIPLE	Variable Reluctance	- Diagram with Electro	ni cs
TRANSDUCER	MANUF	Consol	idated Cont	rols Corpo	ration	MEA	SUREMENT RANGE	0 - 25 in. Water		
TROUBLE REP	ORT SOURC	ENort	h American	and AiRese	earch	MEA	SUREMENT MEDIA	Gas		
PART NUMBER	SERIAL NUMBER	FAILURE DATE	T/R NUMBER	FAILURE TYPE	FAILURE MODE	FAILURE MECHANISM	FAILURE CAUSE	PROBLEM AREA	CORRECTIVE ACTION	COMMENTS
837054-2	8164	12-28-67	A/R 16533-0	Human	Shift			Des i gn 1	Return to vendor	,
837054-2	8161	8-11-67	A/R 1547 0 -0	Human	Low insulation resistance			Des i gn	Return to vendor	
837054-1	8912	8-11-67	A/R 15469-0	Human	Shift	Attitude sensitive		Des i gn	Return to vendor	
837054-2	9220	8-10-67	A/R 15472-0	Human	Shift			Des i gn	Return to vendor	
837054		43 Repts		Human	Shift	,		Deign		43 trouble reports not tabulated common problem
		·								
							·			
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72-8537-3 Page 2-9 ,Rev.1

LDOUT FRAME

TABLE 2-3

DIFFERENTIAL PRESSURE TRANSDUCER FAILURE EVALUATION

TRANSDUCER	APPLICATION	ON Sui	t ∆P Xducer				TRANSDUCER TYPE	Pressure				
BASIC PART N	IUMBER	83670	5				OPERATING PRINCIPLE Variable Reluctance - Diagram with Electronics					
TRANSDUCER	MANUF	Pace W	i anck o				MEASUREMENT RANGE	0 - 25 in. Water	1	•		
TROUBLE REP	ORT SOURCE	E Nor	th American	and AiRes	earch		MEASUREMENT MEDIA	Gas	i			
PART NUMBER	SERIAL NUMBER	FAILURE DATE	T/R NUMBER	FAILURE TYPE	FAILURE MODE	FAILURE MECHANISM	FAILURE CAUSE	PROBLEM AREA	CORRECTIVE ACTION	COMMENTS		
836705-1	0006	10-3-69	A/R 20304-0	Elec	Excessive output ripple			Design				
836705-1	0005	10-3-69	A/R 20305-0	Elec	Shift							
									!			
·												
•												
							·					



STEAM DUCT PRESSURE TRANSDUCER (AiResearch PN 837036 and PN 836706)

INTRODUCTION

The initial design of steam duct pressure transducer PN 837036 was implemented on the Apollo Block I and Block II ECS.

Because of numerous failures this design was superseded by a new design, PN 836706, which was implemented on Apollo Block II ECS. Each of these designs is analyzed in this section.

PURPOSE AND DESCRIPTION

The pressure transducer, in the Apollo ECS application, measures the static pressure of the fluid in the glycol and suit evaporator steam discharge duct. The fluid pressure serves as an indication of the effectiveness of the evaporative cooling process in the ECS. The transducer is located in the steam discharge duct immediately downstream of the junction of the glycol evaporator and the suit evaporator outlets. This transducer converts a signal corresponding to the sensed pressure into a proportional electrical signal used for telemetry purposes or visual display.

The transducer is powered by the 28 vdc supply of the spacecraft and operates over a range of 0.05 to 0.25 psia. An electrical signal (0 to 5 vdc) proportional to the absolute pressure of the fluid is provided by the transducer.

PERFORMANCE AND DESIGN DATA

Table 3-1 presents the performance and design data for these transducers. The data are identical for both of these designs. Figure 3-1 presents a typical isolmetric drawing of these transducers. Figure 3-2 presents the outline drawing of the current transducer design PN 836706. Numerous rejections at qualification and acceptance test level motivated the effort for PN 836706. The new unit has had less rejections at test level; however, this new design has 17 rejections in a total population of 42 units which represents a rejection rate of 40 percent.

Page 3-1, Rev. 1

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Los Angeles, California

FAILURE AND DESIGN REVIEW

Initial Design (PN 837036)

Table 3-2 is a summary of two failure reports written against 77 units of PN 837036. One rejection was caused by calibration of test equipment, and the second rejection cause was not determined because the failure was not analyzed. However, this unit has been very troublesome and has accumulated unaccounted number of rejections at ATP and QTP levels. These numerous rejections were the basic reason for design and supplier change.

Current Design (PN 836706)

Table 3-3 is a summary of 17 failure reports written against 42 units of PN 836706 which represents a rejection rate of 40.5 percent. The two units (11.7 percent) were rejected because of design problems. Five units (29.4 percent) were rejected because contamination, damage, and overtorque suffered in assembly. Five units (29.4 percent) were rejected because of misconnection and installation problems during testing. One unit (5.9 percent) was rejected because of test equipment failure while the unit had not failed. Three units (17.7 percent) were rejected because of contamination and overpressurization suffered during LOX cleaning. One unit was rejected for oscillation but the failure was not confirmed. These information is presented in Figure 3-3 failure matrix. Only two of the failures which were the result of design error are unavoidable.

RECOMMENDATIONS

Both of these designs have been in trouble from the beginning; design revisions and changes have not eliminated the calibration instability problem. It is recommended that other transducer designs be studied as possible substitution in this or similar applications.

TABLE 3-1

PERFORMANCE AND DESIGN DATA FOR PN 837036 and PN 836706

Performance Requirements:

- a. Operating pressure range: 0.05 to 0.25 psia.
- b. Accurancy: ± 0.004 osi (also refer to h)
- c. Time constant of output signal: Within 30 ms (to 63.2 percent of applied step change in pressure)
- d. Output signal: Ov at 0.05 psia to 5.0vdc at 0.25 psia. Output signal shall not exceed 6.5v in the event of overpressurization.
- e. Output ripple: Ripple component of output signal shall not exceed 10 mv peak to peak
- f. Output load: 30,000 ohms
- q. Output impedance: 500 ohms max
- h. Environmental error band: Output signal error resulting from the combined effects of non-linearity, repeatability, and input voltage fluctuation during any rational combination of environmental conditions specified in AiResearch Report SS-1060-R, shall not exceed ±2.0 percent (±0.10v) of full scale from 0 to 100 percent of pressure range for temperatures between 0°F and 150°F. For temperatures between 150°F and 200°F, the output signal shall not exceed ±3.0 percent of full scale.

Structural Requirements:

- a. Proof pressure: 22.5 psia at 70° F
- b. Burst pressure: 37.5 psia at 70°F

<u>Leakage:</u> Zero with 20.7 psia external pressure and 14.7 psia internal pressure

Electrical Power Requirements:

- a. Input voltage: 28 ±4 vdc
- b. Excitation current: 35 ma max

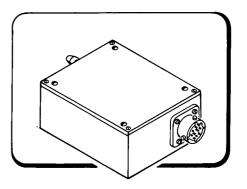
<u>Environmental Conditions:</u> Per AiResearch Report: SS-1060-R: Type I equipment

Installation Envelope: Per AiResearch Drawing 837036

Weight: 0.9 lb

Electrical Connector: in accordance with MIL-C-26482C





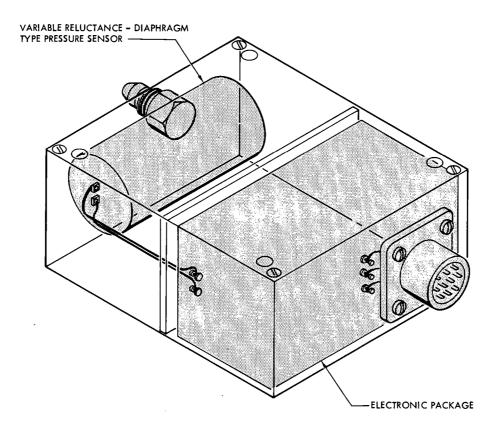


Figure 3-1. Isometric Drawing of a Typical Steam Duct Pressure Transducer

S-32·125

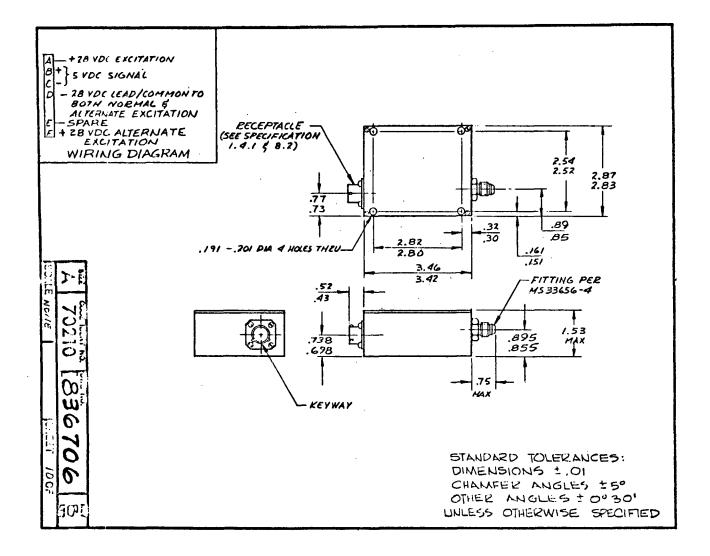


Figure 3-2. Outline Drawing of Current Steam Duct Pressure Transducer

TABLE 3-2

STEAM DUCT PRESSURE TRANSDUCER FAILURE EVALUATION

TRANSDUCER	APPLICATION	ON <u>Evapo</u>	orator Steam	Duct Pres	ssure Xducer	TI	RANSDUCER TYPE Press	ure Xducer	:	
BASIC PART N						0	PERATING PRINCIPLEVa	ariable Reluctance	- Diagram with Electronic	.s
TRANSDUCER	1ANUF	AiResearch	n (Pace Wian	iko to 836	5706-2-1)	ME	ASUREMENT RANGE0	.05 to 0.25 psia		
TROUBLE REPO	ORT SOURC	E AiRe	esearch Mfg	Co/North A	American Aviation	ME	ASUREMENT MEDIAS1	team		
PART NUMBER	SERIAL NUMBER	FAILURE DATE	T/R NUMBER	FAILURE TYPE	FAILURE MODE	FAILURE MECHANISM	FAILURE CAUSE	PROBLEM AREA	CORRECTIVE ACTION	COMMENTS
837036-4-1	9214	11-30-67	A/R 16521	Human	Output to high	None	Variation in test equipment	Accept test	Test gage recalib- rated and part passed test	d
837036-1-1	9783	1-24-68	A/R 16540		Not analyzed since	837036-2 supersedes	837036-1-1			
		·								
							·			
	·						·			

FOLDOUT FRAME

TABLE 3-3

STEAM DUCT PRESSURE TRANSDUCER FAILURE EVALUATION

				·						
TRANSDUCER	APPLICATION	ONIte	m 8.17 Evap	oorator St	eam Duct Pressure Xdu	cer TRA	NSDUCER TYPE Pressu	re Xducer		
BASIC PART I	NUMBER <u>8</u>	36706-2				OPE	RATING PRINCIPLE Va	riable Reluctance -	- Diagram with Electroni	cs
TRANSDUCER	MANUF	AiResearc	h (630033-2	-1 Pace Wi	ancko Div Wittaker)	MEA	SUREMENT RANGE 0-5	vdc proportional to	press, 0 vdc = 0.05 ps	ia = 5 vdc - 0.25 psig
TROUBLE REP	ORT SOURC	E AiRes	earch Mfg Co	o/North Am	erican Rockwell		SUREMENT MEDIA	Water/Steam		
PART NUMBER	SERIAL NUMBER	FAILURE DATE	T/R NUMBER	FAILURE TYPE	FAILURE MODE	FAILURE MECHANISM	FAILURE CAUSE	PROBLEM AREA	CORRECTIVE	COMMENTS
836706-2	50034	5-18-70	AR 15703	Human	Shift (output high)	Pressure sensor	Contamination	Manufacturing	Addition cleaning operations and inspection added to prevent contaminatio	defect
836706-2-1	50035	3-19-70	AR 17773	Human	Shift output low	Distortion	Overtorqued	Manufacturing	Personnel cautioned about proper installation	Overtorquing or pressure fitting disturbed housing causing rated shift
836706-2	50038	4-29-69	AR 18776	Human:	Intermittent	Soldered (jointed)	Shorted (under light pressure)	Manufacturing	None -considered isolated	Short caused by solder splash on pins causing intermittent condition
836706-2	50026	11-4-68	AR 113103	Human	Oscillation	Electronic output package	Transistor gain out of tolerance for circuit design	Design		Transistor unstable in region of ATP test. Gai range is too large part must be selected
836706-2	50017	10-1-68	AR 17785	Human	Low output (shift)	Electronic output package	Input power applied to output	Acceptance test	Placards added to test equipment to ca personnel against over	
836706-2	50010	9-27-68	AR 19113	Human	Output too high (shift)	Electronic output package	Input power applied to output	Acceptance test	Vendor has revised procedure to test input diode and Zener prior to assembly	
836706-2	50010	7-2-68	AR 16660	Human	Fixed output	Pressure sensing mechanism	Contamination	Manufacturing	Vendor required to improve cleaning and handling. All parts cleaned per Air C-39	Process
836706-2-1	50006	7-17-69	AR 14634	Human	No output	Electronic output package	Input power applied to output	Acceptance test	None	Excessive voltage applied to transmitter.
836706-2	50007	7-8-68	AR 16649	Human	Output low (shift)	Pressure sensing mechanism	De s ign	Manufacturing	Dimensional change made to 0-ring grove to allow pro- per assembly	Shift due to output tolerance condition; causing load insufficie squash allowance



STEAM DUCT PRESSURE TRANSDUCER FAILURE EVALUATION

TRANSDUCER .	APPLICATI	ON <u>Evapo</u>	orator Steam	m Duct Pre	ssure Xducer	TR	ANSDUCER TYPE Pressu	re Xducer		
BASIC PART I	NUMBER	836706-2	(630033-2-1	Pace Wian	cko)	OP	ERATING PRINCIPLE	/ariable Reluctance -	Diagram with Electron	nics
TRANSDUCER	MANUF	Pace Wia	encko for A	iResearch		ME/	ASUREMENT RANGE 0-5 vd	c proportional to pres	ssure, $0 \text{ vdc} = 0.05 \text{ p}$	sia - 5 vdc = 0.25 psia
TROUBLE REP	ORT SOURC	EA	Research M	fg Co and	North American Rockw	rell ME	ASUREMENT MEDIA	Stema	'	
PART NUMBER	SERIAL NUMBER	FAILURE DATE	T/R NUMBER	FAILURE TYPE	FAILURE MODE	FAILURE MECHANISM	FAILURE CAUSE	PROBLEM AREA	CORRECTIVE ACTION	COMMENTS
836706-2	50002	4-3-68	AR 17662	Human .	High output	Pressure sensing mechanism	Contamination	LOX cleaning	Cleaning procedures revised to prevent re-occurence of failure	
836706-2	50027	7-5-68	AR 17768	Human	Low output	Pressure	Contamination	Manufacturing	Wittaker has been made aware of pro- blem and has improved QC	Brazing flux left in part causing diaphragmestruction
848400-9-1	58-110	6-30-68	AR 15150	Human	Low output	None	Improper test instruction	Acceptance test	Air has revised ATP to include larger tolerance because of system changes	parameter change which
836706-2	50004	6-2-68	AR 16637	Human	Oscillating voltage (intermittent)	Electronic package	Unknown	Unknown	Replaced package and part passed test	E-pack fault could not be determined
836706-2-1	50003	5-25-68	AR 17553	Human	Output too high EMI frequency	Electronics package	Poor installation	Acceptance test setup qualification	Test rerun with unit properly installed no fail	
836706-2-1	50001	4-22-68	AR 17679	Human	Low output	Electronic (Poor installation		Supplier has revised welding procedure (schedule) to proclude failure	
836706-2	50004	4-4-68	AR 17682	Hụman	Output too high	Pressure sensing mechanism	Overpressurized		Functional test added after cleaning and verify performan	
836706-2	50006	4-3-68	AR 17663	Human	Output too high	Pressure sensing mechanism	Overpressurization	_	Surveillance initiate on part by AiResearch Reliability group	



72-8537-3 Page 3-8, Rev.1

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																				DES IGN	CONTAMINATION	OVERPRESSURIZED		INSTALLATION	OVERTOROHE	CHORTER	DESIGN	MISCONNECTED	I'II SCOMMECT ED								UNKNOWN	NO FAILURE	Figure 3-3. Steam D Transducer Failure M	uct Pressure atrix
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SECTION 4

BACK PRESSURE TRANSDUCER (AiResearch PN 836114)

INTRODUCTION

The back pressure transducer was implemented in the initial stages of Apollo ECS as an obsolute pressure switch that sensed the pressure in the glycol evaporator steam discharge duct. The transducer functioned as a safety device to prevent the steam discharge pressure from falling below 5 mm Hg. The requirement of this transducer in the Apollo Block II ECS was eliminated, and the production of this transducer was discontinued. The available data on this transducer is presented in this section for the foundation and it is recommended that the analysis of this transducer not be continued.

DESCRIPTION

The back pressure sensor consists of a variable reluctance absolute pressure transducer and a solid state switch circuitry to switch the control signal from the glycol evaporator controller. The switch is open at pressures above 5.0 mm Hg and below 3.5 mm Hg, and is closed between 5.0 mm Hg and 3.5 mm Hg.

FAILURE AND DESIGN REVIEW

Figure 4-1 presents the isometric drawing of this pressure transducer. Table 4-2 is a summary of 19 failure reports written against 20 units out of a population of 39 units of PN 836114 representing a rejection rate of 51.3 percent. One unit (5 percent) was rejected because excessive voltage applied during testing shorted the electronic circuitry. Four units (20 percent) were rejected because units did not stabilize. The remaining rejected sixteen units (75 percent) were not analyzed because this item was deleted from the ECS.

PERFORMANCE AND DESIGN DATA

Table 4-1 presents the performance and design data for this pressure transducer.

TABLE 4-1

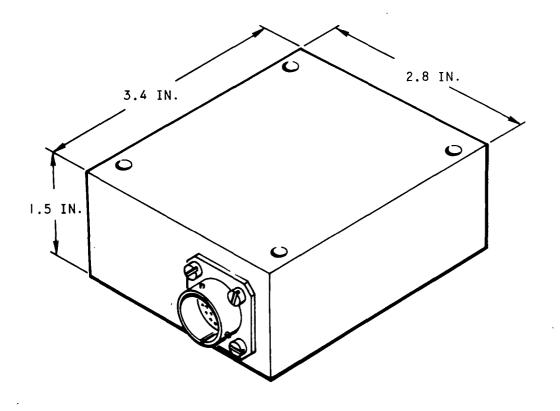
PERFORMANCE AND DESIGN DATA FOR BACK PRESSURE TRANSDUCER PN 836114

Operating pressure	0 - 15 psia
Proof pressure	21 ps ia
Burst pressure	30 psia
Leakage, external to internal	6×10^{-6} lb/hr with 6 psig differential
Operating voltage	28 +2, -3 v dc
Operating current	50 milliamp
Switch activation - decreasing	5.0 ± 0.2 mm Hg, close
pressure	3.5 ± 0.2 mm Hg, open
Switch activation - increasing	3.5 ± 0.2 mm Hg, close
pressure	5.0 ± 0.2 mm Hg, open
Switch voltage	5.0 volts dc
Switch current	5.0 milliamp
Switch voltage drop	0.2 millivolt
Pressure port	33656-4
Power requirement	50 ma max at 28 +2, -3 vdc
External leakage	6×10^{-6} lb/hr 0_2 max with 6 psi Δ P
Electrical connector	AiResearch Comm Std 223-022-9009 or 223-021-9009
Envelope	$3.50 \times 2.90 \times 1.60$
Weight	0.6 16

QUALIFICATION STATUS

This back-pressure sensor is a qualified Block II Apollo component.





A-19235

Figure 4-1. Isometric Drawing of Back Pressure Transducer

BACK PRESSURE TRANSDUCER FAILURE EVALUATION

TRANSDUCER A	PPLICATI	ON ESC Ap	ollo Steam	Duct Pres	sure Switch	TR	ANSDUCER TYPE Pressure	e Switch		
BASIC PART N	UMBER 8	36114				OP	ERATING PRINCIPLE			
TRANSDUCER N	MANUF						ASUREMENT RANGE			
TROUBLE REPO							SUREMENT MEDIA			
PART NUMBER	SERIAL NUMBER	FAILURE DATE	T/R NUMBER	FAILURE TYPE	FAILURE MODE	FAILURE MECHANISM	FAILURE CAUSE	PROBLEM AREA	CORRECTIVE ACTION	COMMENTS
836114-1-1	9278	10-12-66	11342	Mech	Shift	Pressure sensing mechanism	Part not stabilized	Manufacturing	None - due to signal reocurring failure	Part deleted from ECU
836114-1-1	9286	10-11-66	11337	Mech	Closed	Unknown	Unknown	Unknown	Unknown	
836114-1-1	9271	9-24-66	11314	Unknown	High current consumation	Unknown	Unknown	Unknown	Unknown	
836114-1-1	9280	9-16-66	11035	Unknown	Low output	Unknown	Unknown	Unknown	Unknown	
836114-1-1	9279	9-1-66	10223	Unknown	Low output	Unknown	Unknown	Unknown	Unknown	
836114-1-1	9271	8-5-66	10249	Human	Shift	Shorted transistor	Excessive voltage applied to part	Testing	Nome - parts have previously been color code to prevent this	·
836114-1-1	9274	8-1-66	10755	Unknown	Output high	Unknown	Unknown	Unknown	Unknown	
836114-1-1	9261	7-8-66	9607	Mech	Shift	Pressure sensing mechanism	Part not stabilized	Manufacturing	Vendor will pres- sure cycle part to achieve stable operation	
836114-1-1	9 2 66	6-24-66	10395	Mech	Shift	Pressure sensing mechanism	Part not stabilized	Manufacturing	Vendor will pres- sure cycle part to achieve stable operation	·
836114-1-1	9263	6-23-66	10394	Mech	Shift	Pressure sensing	Part not stabilized	Manufacturing	Vendor will pres-	

mechanism



72-8537-3 Page 4-4 ,Rev.1

sure cycle part to achieve stable

operation

OLDOUT FRAME

TABLE 4-2 (Continued)

TRANSDUCER	APPLICATI	ON ECS A	oollo Steam	Duct Pre	ssure SW		RANSDUCER TYPE Pressui	re Switch	1	
BASIC PART N		6114	•						:	
TRANSDUCER	MANUF								1	•
TROUBLE REP							EASUREMENT MEDIA			
PART NUMBER	SERIAL NUMBER	FAILURE DATE	T/R NUMBER	FAILURE TYPE	FAILURE MODE	FAILURE MECHANISM	FAILURE CAUSE	PROBLEM AREA	CORRECTIVE ACTION	COMMENTS
836114-1-1	9264	5-9-67	14196	Mech	0pen	Unknown	Unknown	Unknown	Part deleted from ECU	Part deleted no fail- ure analysis performed
836114-1-1	9279	5-12-67	14168	Mech	0pen	Unknown	Unknown	Unknown	Part deleted from ECU	Part deleted no fail- ure analysis performed
836114-1 - 1	9295	11-23-66	11943	Mech	Out of calibration	Unknown	Unknown	Unknown	Part deleted from ECU	Part deleted no fail- ure analysis performed
836114-1-1	9294	11-21-66	11937	Mech	0pen	Unknown	Unknown	Unknown	Part deleted from ECU	Part deleted no fail- ure analysis performed
836114-1-1	9264	11-13-66	12042	Mech	Shift	Unknown	Unknown	Unknown	Part deleted from ECU	Part deleted no fail- ure analysis performed
836114-1-1	9279	11-2-66	12017	Mech	Out of calibration	Unknown	Unknown	Unknown	Part deleted from ECU	Part deleted no fail- ure analysis performed
836114-1-1	9272	10-25-66	11399	Mech	Output too high	· Unknown	Unknown	Unknown	Part deleted from ECU	Part deleted no fail- ure analysis performed
836114-1-1	9284	10-20-66	1183	Mech	0pen	Unknown	Unknown	Unknown	Part deleted from ECU	Part deleted no fail- ure analysis performed
836114-1-1	9288 and 9289	10-15-66	11370	Mech	Output high	Unknown	Unknown	Unknown	Part deleted from	Part deleted no fail- ure analysis performed





AIRESEARCH MANUFACTURING COMPANY

Los Angeles, California

REPORT ON FAILURE AND DESIGN EVALUATION OF APOLLO ECS TEMPERATURE SENSORS,
THERMISTOR TYPE
CONTRACT NO. NAS 9-12452

72-8537-12, Rev. |

February 10, 1973

Prepared by A. Saginian

APPROVED:

Program Manager

APPROVED,

Brudnicki ، کر ،

Principal Investigator

NASA MANNED SPACECRAFT CENTER HOUSTON, TEXAS 77058

ABSTRACT

This report presents the results of a failure and design evaluation study conducted on the Apollo ECS temperature sensors, the generic group of bead-type thermistor temperature sensors. The study was conducted for NASA-MSC by the AiResearch Manufacturing Company, a division of The Garrett Corporation under Contract NAS9-12452.

The study purpose was to evaluate the integrity of design of this type sensor. Failure information is presented and summarized pertaining to three sensor design groups comprising eight different sensor part numbers. A failure matrix is presented which describes the failure mode, type, mechanism, cause, and problem areas for nine failures out of a lot total of 267 units.

The integrity of each of the three designs was confirmed. Recommendations are made to reduce the failure rate from the current level of 3.0 percent.

CONTENTS

Section		Page
1	INTRODUCTION	1-1
2	DESCRIPTION, FAILURE SUMMARY, AND RECOMMENDATIONS FOR BEAD-TYPE THERMISTOR TEMPERATURE SENSORS	2-1
	Description	2-1
	Failure Summary	2-4
	Recommendations	2-7
3	GLYCOL EVAPORATOR WICK TEMPERATURE SENSORS (AIRESEARCH PN 820972 AND PN 836250)	3-1
	Introduction	3-1
	Purpose and Description	3-1
	Performance and Design Data	3-1
	Failure and Design Review	3-1
4	WATER-GLYCOL TEMPERATURE SENSORS (AIRESEARCH PN'S 820918, 820980, 836684)	4-1
	Introduction	4-1
	Purpose and Description	4-1
	Rejection Summary	4-1
	Performance and Design Data	4-1
	Failure and Design Review	4-13
5 .	CABIN TEMPERATURE SENSORS AND CABIN TEMPERATURE ANTICIPATOR (AIRESEARCH PN'S 820100, 820964, 820110)	5-1
	Introduction	5-1
	Purpose and Description	5-1
	Rejection Summary	5-10
	Performance and Design Data	5-10
	Failure and Design Review	5-10

SECTION 1

INTRODUCTION

This report presents a summary of failure data of the generic group of bead-type thermistor temperature sensors, one of several temperature sensor types that are described and categorized in AiResearch Report No. 72-8537-1. Eight bead-type thermistor temperature sensors were evaluated in three different configuration groups: (1) glycol evaporator wick temperature sensors, (2) water-glycol temperature sensors, and (3) cabin temperature sensors.

All temperature sensors evaluated in this report have been used in the Apollo environmental control system (ECS). In general, they may be used to perform any other temperature sensing function with similar requirements.

The temperature sensors that are evaluated and summarized in this report are, by AiResearch part number:

PN	Nomenclature
820972-2	Glycol Evaporator Wick Temperature Sensor
836250-1	Glycol Evaporator Wick Temperature Sensor
820918-1	Water-Glycol Temperature Sensor
820918-2	Water-Glycol Temperature Sensor
820980-1	Water-Glycol Temperature Sensor
820980-2	Water-Glycol Temperature Sensor
820880-3	Water-Glycol Temperature Sensor
820980-4	Water-Glycol Temperature Sensor
836684-1	Water-Glycol Temperature Sensor
836684-2	Water-Glycol Temperature Sensor
820110-3	Cabin Temperature Anticipator
820100-1	Cabin Temperature Sensor
820964-1	Cabin Temperature Sensor

Detailed failure data on each of these temperature sensors are presented in Sections 3 through 5 of this report. Section 2 presents descriptive information, a failure summary, and recommendations that apply to each of the three sensor groups. Differences in the sensor design configurations within these three groups are primarily due to differences in the intended sensor locations and media of application.

SECTION 2

DESCRIPTION, FAILURE SUMMARY, AND RECOMMENDATIONS FOR BEAD-TYPE THERMISTOR TEMPERATURE SENSORS

DESCRIPTION

Thermistors are "thermal resistors"--resistors that exhibit a high negative temperature coefficient of ohmic resistance. As the temperature of the thermistor increases, the thermistor resistance decreases, and as its temperature decreases, its resistance increases. (This is the opposite of the effect of temperature changes on metals.) Thermistors are semiconductors constructed of ceramic material made by sintering mixtures of metallic oxides such as those of manganese, nickel, cobalt, copper, iron, and uranium. Their electrical characteristics may be controlled by varying the type of oxide used and the physical size and configuration of the thermistor.

A typical thermistor resistance vs temperature characteristic curve is shown in Figure 2-1. A typical glass-sealed, dual-bead thermistor temperature sensor probe is illustrated in Figure 2-2. This sensor utilizes a dual-bead thermistor for the temperature-sensitive element.

The thermistor forms discussed herein include:

Beads--A bead is made by forming a small ellipsoid of thermistor material on two fine, parallel wires about 0.010 in. apart. The material is sintered at high temperature and the leads become embedded tightly in the bead, making good electrical contact inside the thermistor material. Beads may be coated with glass for protection or mounted in evacuated or gas-filled bulbs. Resistance values of 300 ohms to over 100 megohms can be obtained in beads ranging in diameter from 0.006 in. to 0.100 in.

Probes--A probe is made by sealing a bead-type thermistor into the tip of a solid glass rod of up to 0.100-in. diameter and 0.25 in. to 2 in. long.

This report evaluates sensors (consisting of one or more thermistor beads) that sense by direct contact the temperature of the media in which they are placed. The thermistor is connected through lead wires and a connector to a temperature control to form one leg of a temperature-sensing bridge circuit. Variation in temperature causes a change in the resistance of the thermistor and thus causes the bridge circuit to unbalance. The bridge circuit remains unbalanced as long as there is a temperature variation. The unbalanced bridge circuit produces a signal which is processed by separate equipment in accordance with the requirements of the thermistor application.

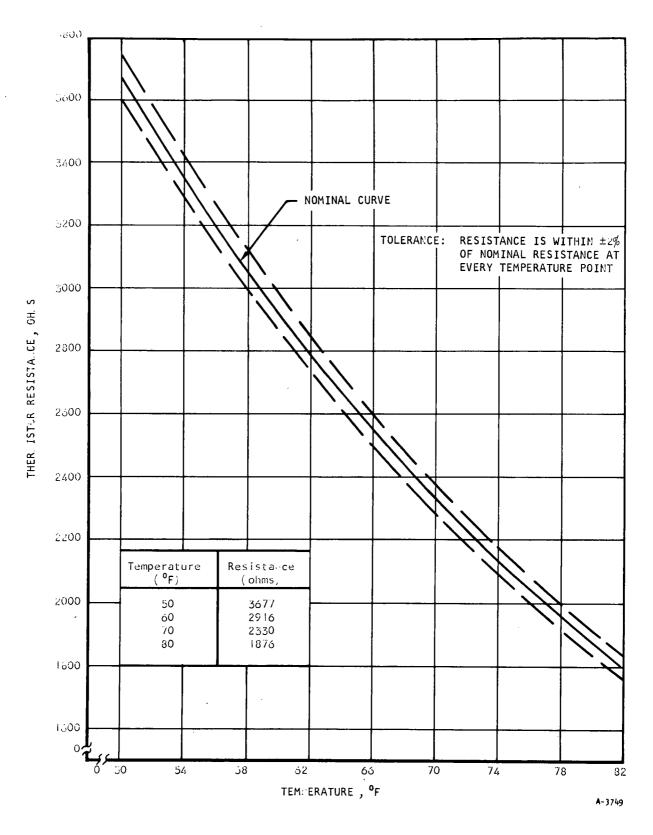


Figure 2-1. Typical Thermistor Resistance-Temperature Curve



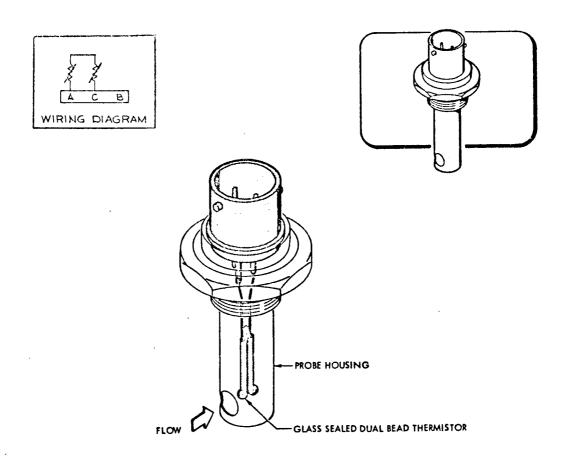


Figure 2-2. Glass-Sealed Dual-Bead Thermistor Temperature Sensor

FAILURE SUMMARY

Detailed failure analyses and summaries of each of the three temperature sensor groups evaluated in this report are presented in Sections 3 through 5 of this report. Each sensor group analysis presents the reliability data on the evaluation of each design configuration from the preliminary concept to the final design applied in the Apollo Block II ECS. Most of the trouble sources were removed from the problem area list during the process of design evaluation and modification; therefore, only the failure data on the current design configurations are analyzed in this section.

The current designs of the thermistor temperature sensors used in the Apollo Block II ECS include:

PN	Nomenclature
836250-1	Water-Glycol Wick Temperature Sensor
836684-1	Water-Glycol Temperature Sensor
836684-2	Water-Glycol Temperature Sensor
820964-1	Cabin Temperature Sensor
820110-3	Cabin Temperature Anticipator

All these temperature sensors, regardless of the quantity of the thermistors employed in each design, have the same principle of operation. Therefore, design data on individual units are combined to present the general value and reliability of the hardware in its temperature sensing application.

Nine failure reports, written against these part numbers and furnished by NASA-MSC, were reviewed. The results of these reports are summarized in the failure matrix shown in Figure 2-3. This matrix is a summation of the individual matrixes presented in turn for each of these five temperature sensors. Eight (89 percent) of the failures were determined to be due to human error and one (11 percent) due to random failure.

Figure 2-4 presents the relationship of these failures with respect to the total population of temperature sensors. A total of nine failures from a population of 267 units represents a rejection rate of 3.0 percent. Eight of the rejections, being due to human error, are potentially avoidable; therefore, the unavoidable rejection rate for one unanalyzed failure is 0.3 percent.

A review of the failure matrix of Figure 2-3 indicates that there is no basic and chronic problem area for this type of temperature sensor. This conclusion is based on the following observations on the failure matrix.



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Figure 2-3. AiResearch Current Thermistor Type
Temperature Sensor Failure Matrix

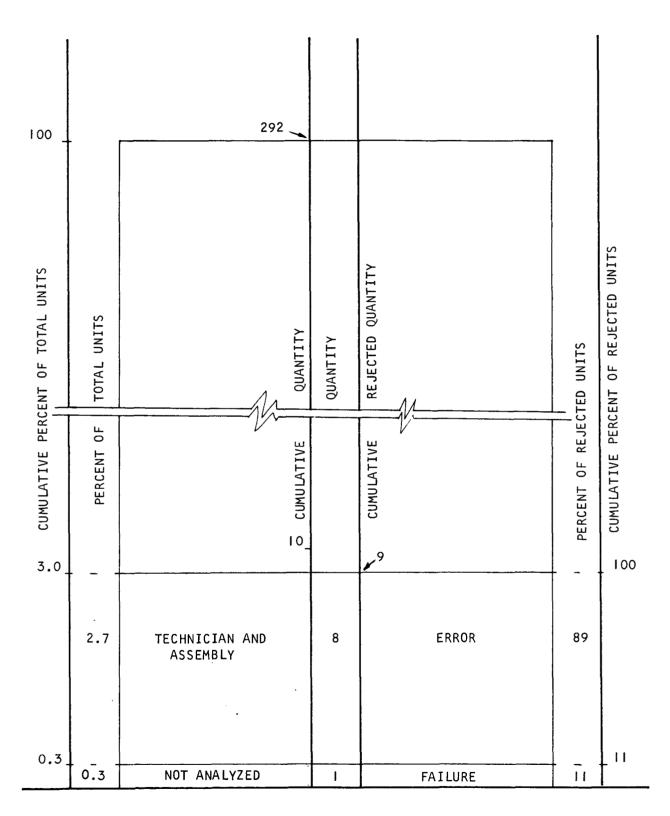


Figure 2-4. Distribution of Failures According to Problem Area for the Current Temperature Sensors

Non-Specific Problem Area

There was no information concerning the failure cause of the sensor in the failure report which was not analyzed.

Three failures were not confirmed and the responsibility of the reports belongs to their initiator.

Because three of the failures reported were not confirmed it is proper to retrain the laboratory technicians in the use of lab equipment and conduct of tests at scheduled intervals.

Manufacturing

Five failures were attributed to poor assembly practices.

A retraining program was conducted and the failure source was eliminated. It may be advisable to conduct retraining programs at scheduled intervals to keep personnel abreast of new techniques and skilled on the acquired knowledge.

RECOMMENDATIONS

Most of the failures reported on the current designs of the temperature sensors were the result of poor soldering and assembly practices. The remaining reports had three unconfirmed failures and one unit was scrapped before analysis. The design changes have already eliminated most of the previous problem sources. The following recommendations, based on the current design problems, are made to minimize the possibility of future rejections because of current problems.

Manufacturing Criteria

Provide detailed assembly and operations instructions to eliminate poor soldering.

Retrain assembly personnel at scheduled intervals.

Testing Criteria

Provide detailed test equipment checkout procedures.

Retrain test personnel at scheduled intervals.

Usage

Use the superseding designs which are trouble free.

SECTION 3

GLYCOL EVAPORATOR WICK TEMPERATURE SENSORS (AIRESEARCH PN 820972 AND PN 836250)

INTRODUCTION

The initial design of glycol evaporator wick temperature sensor PN 820970 was implemented on the Apollo Block I ECS. Because of numerous leakage problems this design was superseded by a new design, PN 836250, which was implemented on the Apollo Block II ECS. Each of these designs is analyzed in this section—the initial design is briefly reviewed and the superseding design is reviewed in detail.

PURPOSE AND DESCRIPTION

The wick temperature sensor senses the temperature of the wick in the water evaporator and thus detects whether the wick is wet or dry. The wick temperature sensor consists of a normal thermistor circuit and a redundant thermistor circuit. Each thermistor circuit consists of two thermistor probes connected in series. The thermistors are all connected by lead wires to a hermetic electrical connector.

PERFORMANCE AND DESIGN DATA

Table 3-1 presents the performance and design data for these temperature sensors. These data are identical for both of the designs. Engineering design error on PN 820972 was the problem source for 26 rejections in a total population of 65 units which represents a rejection rate of 40 percent. This high rejection rate motivated the design effort for PN 836250 which was approved as a new part for the Apollo Block II ECS. Four units of this new design were rejected because of poor potting adhesion. This assembly problem was detected immediately and an adhesive application training program was conducted which eliminated the problem source. The new design has a total population of 89 units, and 4 rejections represent a rejection rate of 4.5 percent. Figure 3-1 presents this information in a histogram. It is notable that there were no random failures, and all the rejections both in the intital and final designs were potentially avoidable.

FAILURE AND DESIGN REVIEW

Initial Design (PN 820972)

Table 3-2 is a summary of 12 failure reports written against 28 units of this sensor. Two of these failure reports were in error. The remaining 10 failure reports contained information on 26 rejected units which were reviewed for the evaluation of this sensor. The outline drawing of PN 820972 is presented in Figure 3-2 for reference. The information indicated

TABLE 3-1

Thermistor resistance 7901 +19 ohms at 47°F

PERFORMANCE AND DESIGN DATA FOR PN'S 836250 AND 820972

 4002 ± 13 ohms at 77° F

 2482 ± 10 ohms at 100° F

Sensor time constant 0.50 sec in still oil

Operating pressure 0 to 15 psia

Proof pressure 25 psia

Low pressure 1×10^{-4} mm Hg abs

Operating temperature 0° to 212° F

Working media Water and low-pressure steam

Electrical connector AiResearch commercial standard

223-025-9013

Weight 0.1 lb

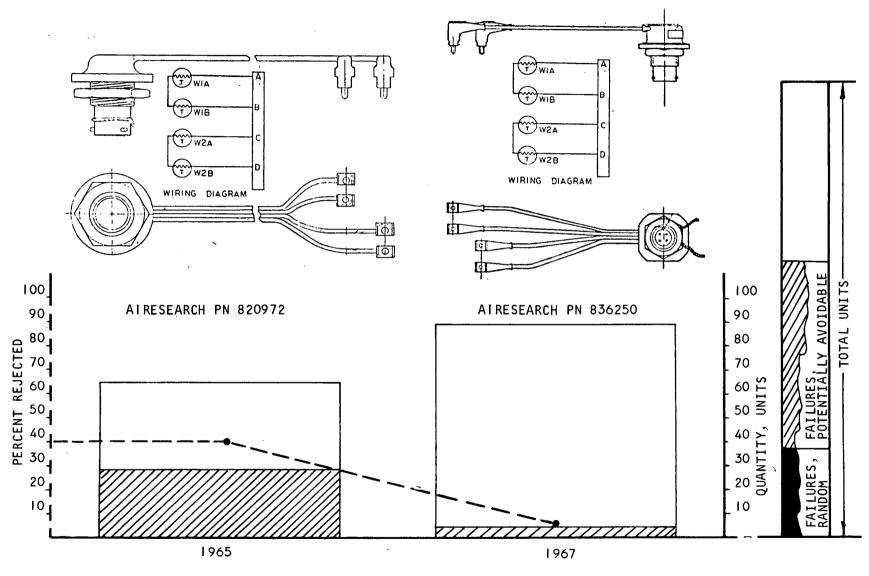


Figure 3-1. Glycol Evaporator Wick Temperature Sensor Population and Rejection Quantity Histogram in Chronological Order of Design

TABLE 3-2

FOLDOUT FRAME

GLYCOL EVAPORATOR WICK TEMPERATURE SENSOR FAILURE EVALUATION

TRANSDUCER	APPLICATIO	N Glyc	ol Evaporat	tor Wick Te	emperature Sensor	TRA	ANSDUCER TYPET	emperature		
BASIC PART	NUMBER	8209	72 (Page 1	of 2)		OPE	RATING PRINCIPLE T	hermistor		
TRANSDUCER	MANUF.	Fenw	al Electron	nics		MEA	SUREMENT RANGE 4	7 - 100°Ė		
TROUBLE REP	ORT SOURCE	AiRe	search			MEA	SUREMENT MEDIA G	lycol		
PART NUMBER	SERIAL NUMBER	FAILURE DATE	T/R NUMBER	FAILURE TYPE	FAILURE MODE	FAILURE MECHANISM	FAILURE CAUSE	PROBLEM AREA	CORRECTIVE ACTION	COMMENTS
820972-2-1	2,3,4,5 7,8,9,10 11,13,14 15	10-3-66	11331	Human	Low insulation resistance	Leakage at potting interface	Poor potting adhesion at suspected potted interfaces	Design	Redesign to metal clad potted unit	Redesigned unit designation 836250-1-1 will be used on Block II ECS
820972-2-1	31, 35	10-13-66	11362	Human	Low insulation resistance					Units scrapped
820972-1-1	37, 38	10-13-66	11363	Human	Low insulation resistance		Potting techniques	Design	Redesign to metal clad potted unit	Unit replaced with -2 configuration using improved potting
820972-2-1	9	11-11-66	12038	Human	Low insulation resistance	Leakage at potting interface	Poor potting adhesion at suspected potted interfaces	Design	Redesign to metal clad potted unit	Redesigned unit designation 836250-1-1 will be used on Block II ECS
820972-2-2	16	11-29-66	11946	Human	Low insulation resistance	Leakage at potting interface	Poor potting adhesion at suspected potted interfaces	Design	Redesign to metal clad potted unit	Redesigned unit designation 836250-1-1 will be used on Block II ECS
820972-2-1	25	12-14-66	11993	Human	Low insulation resistance	Leakage at potting interface	Poor potting adhe- sion at suspected potted interfaces	Design	Redesign to metal clad potted unit	Redesigned unit designation 836250-1-1 will be used on Block II ECS
820972-2	43, 44, 45	12-21-66	12550	Human	Low insulation resistance	Leakage at potting interface	Poor potting adhesion at suspected potted interfaces	Design	Redesign to metal clad potted unit	Redesigned unit designation 836250-1-1 will be used on Block II ECS
820972-2	44	1-11-67	7825	NOT A QU	AL FAILURE. THIS WAS	MISREPORTED				
820972-1-1	33	2-15-67	8868	Human	Low insulation resistance	Leakage at potting interface	Poor potting adhession at suspected potted interfaces	Design	Redesign to metal clad potted unit	Redesigned unit designation 836250-1-1 will be used on Block II ECS





TABLE 3-2 (Continued)

TRANSDUCER A	\PPLICATIO	ONGlyc	ol Evaporato	or Wick Te	emperature Sensor	TRA	NSDUCER TYPE	Temperature			
			72 (Page 2 d					Thermistor			
TRANSDUCER 1	MANUF	Fenw	al Electroni	cs		MEA:	SUREMENT RANGE	47 - 100°F			
TROUBLE REPO	ORT SOURC	E <u>AiRe</u>	search			MEA	SUREMENT MEDIA	Glycol			
PART NUMBER	SERIAL NUMBER	FAILURE DATE	T/R NUMBER	FAILURE TYPE	FAILURE MODE	FAILURE MECHANISM	FAILURE CAUSE	PROBLEM AREA		CORRECTIVE ACTION	COMMENTS
820972-2-1	54, 56	2-15-67	13045	Human	Low insulation resistance	Leakage at potting interface	Poor potting adhesion at suspected potted interfaces	Design	Re	its scrapped. designed to metal ad potted unit	Redesigned unit desig- nation 836250-1-1 will be used on Block II ECS
820972-2	24	2-20-67	13063		Not reportable, not	t a n acceptance test					
820972-2-1	12	3-23-67	8872	Human	Low insulation resistance	Leakage at potting interface	Poor potting adhesion at suspected potted interfaces	Design		design to metal ad potted unit	Redesigned unit desig- nation 836250-1-1 will be used on Block II ECS
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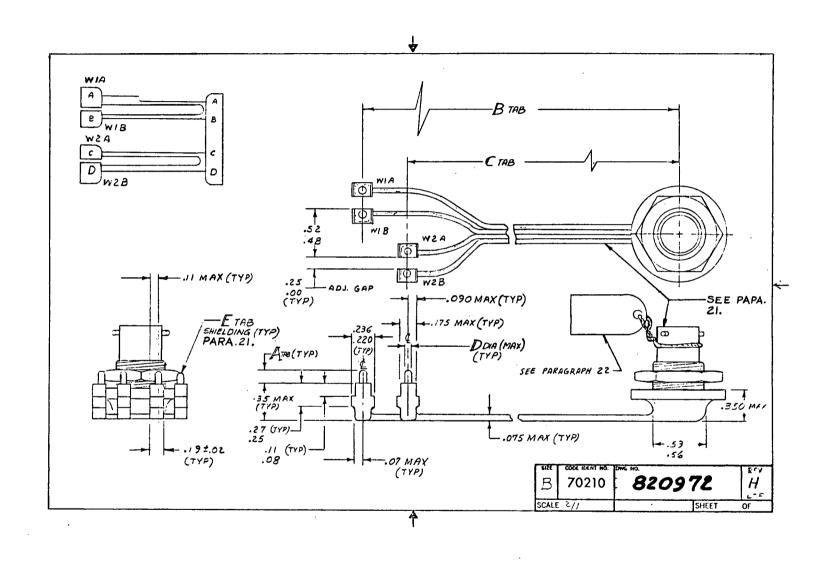


Figure 3-2. Outline of Wick Temperature Sensor

in Table 3-2 is summarized in the failure matrix of Figure 3-3. The histogram of Figure 3-4 presents the distribution of failures according to problem area.

The basic problem with this initial design was leakage caused by poor potting adhesion. The design change to a metal-clad potted unit eliminated this problem source.

Because this design has been superseded, it is recommended that the analysis of this design be discontinued. The notable information gained from this analysis is that thermistor probes should be well protected and, if necessary, metal-clad potted to prevent leakage failure.

Current Design (PN 836250)

Table 3-3 is a summary of four failure reports which were reviewed for the evaluation of this sensor which supersedes PN 820972. The outline drawing of PN 836250 is presented in Figure 3-5 for reference. The information indicated in Table 3-3 is summarized in the failure matrix of Figure 3-6. The histogram of Figure 3-7 presents the distribution of failures according to problem area.

The basic early problem with the current design was leakage caused by poor potting adhesion. The assembly adhesive application training program conducted at the time of these failures eliminated this problem source.

This is a design of proven integrity and, with assembly personnel who are well trained in up-to-date techniques of assembly and application procedures, the only failure source should be random failures.



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Figure 3-3. AiResearch PN 820972, Apollo Block I ECS Item No. 2.49 Wick Temperature Sensor Failure Matrix

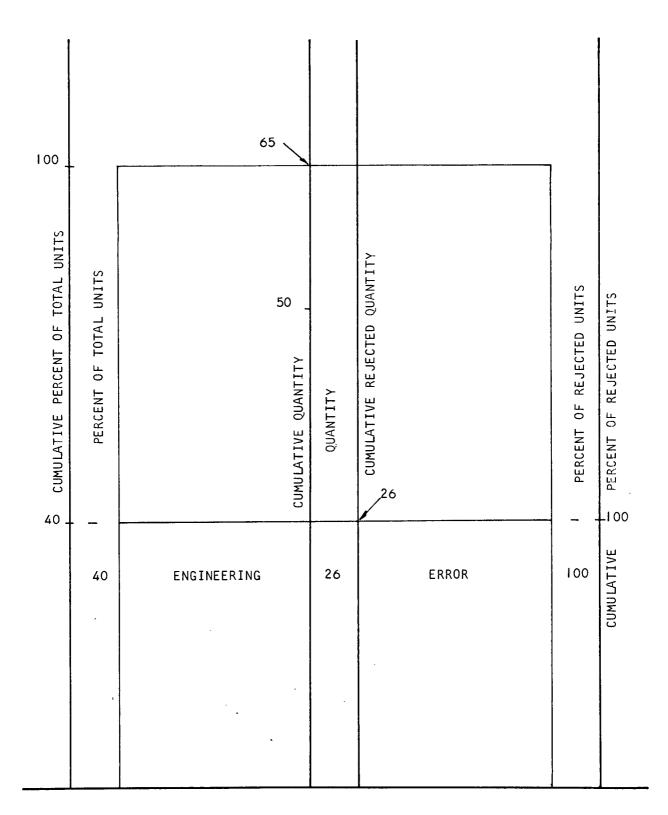


Figure 3-4. Distribution of Failures According to Problem Area

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GLYCOL EVAPORATOR WICK TEMPERATURE SENSOR FAILURE EVALUATION

TRANSDUCER A	APPLICATIO	N Glyc	ol Evaporate	or Wick Te	mperature Sensor	TRA	NSDUCER TYPETe	emperature		
BASIC PART N	IUMBER	8362	250			0PE	RATING PRINCIPLETh	nermistor		
TRANSDUCER N	MANUF	AiRe	search			MEAS	SUREMENT RANGE47	7 - 100°F		
TROUBLE REPO	ORT SOURCE	EAiRe	esearch			MEA:	SUREMENT MEDIAWa	ater Glycol	1	
PART NUMBER	SERIAL NUMBER	FAILURE DATE	T/R NUMBER	FAILURE TYPE	FAILURE MODE	FAILURE MECHANISM	FAILURE CAUSE	PROBLEM AREA	CORRECTIVE ACTION	COMMENTS
836250-1	87-139	9-29-67	15176	Human	Low insulation resistance	Leakage at potting interface	Poor potting adhe- sion at suspected potted interfaces	Design	Q.C. and production alerted	
836250-1	118-199	4-3-69	19161	Human	Low insulation resistance	Leakage at potting interface	Poor potting adhe- sion at suspected potted interfaces	Design	Retraining of assembly personnel	
836250-1	118-203	4-8-69	19163	Human	Low insulation resistance	Leakage at potting interface	Poor potting adhersion at suspected potted interfaces	Design	Retraining of assembly personnel	
836250-1	188-204	4-8-69	19164	Human	Low insulation resistance	Leakage at potting interface	Poor potting adhesion at suspected potted interfaces	Design	Retraining of assembly personnel	
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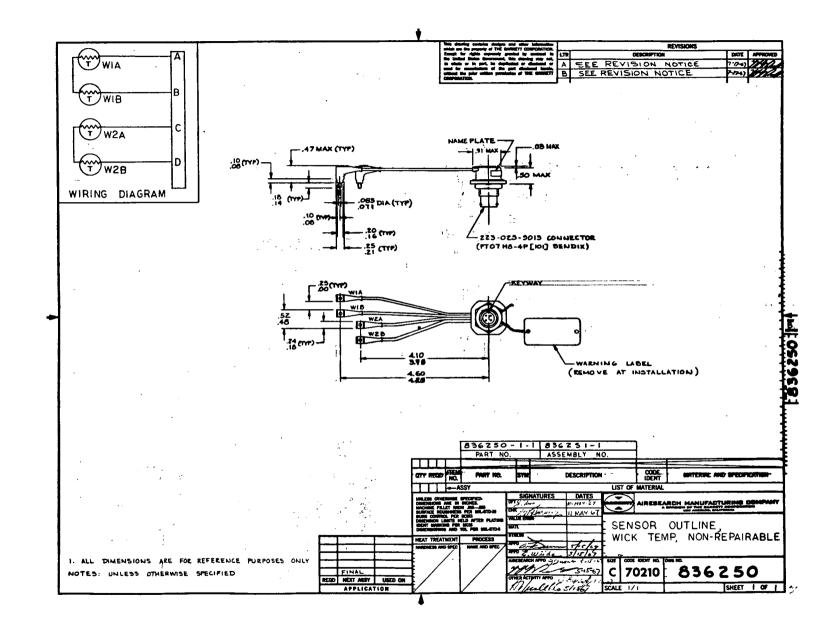


Figure 3-5. Outline of Wick Temperature Sensor

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Figure 3-6. AiResearch PN 836250, Apollo Block II ECS Item No. 2.49 Wick Temperature Sensor Failure Matrix

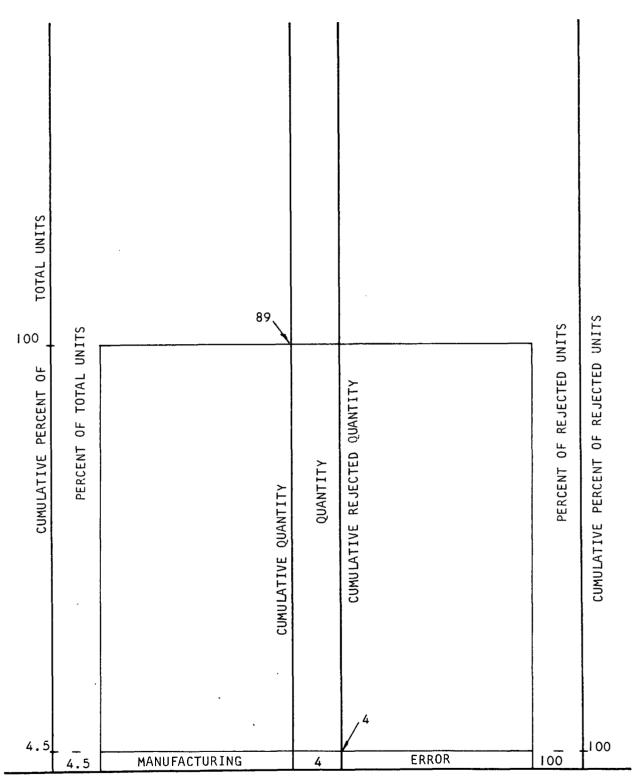


Figure 3-7. Distribution of Failures According to Problem Area

SECTION 4

WATER-GLYCOL TEMPERATURE SENSORS (AIRESEARCH PN'S 820918, 820980, 836684)

INTRODUCTION

Three different designs and a total of eight different variations of water-glycol temperature sensors were designed for three different applications. The basic principle of operation in all designs and their variations is the same; the only differences are in the resistivity of the probes and the series-parallel arrangements. The initial design, which is no longer in use, is reviewed in brief. More emphasis is placed on the reviews of the second and third designs, which are approved Apollo Block II components. Figure 4-1 presents the typical configuration of a water-glycol temperature sensor. Figure 4-2 presents the quantity and rejection histogram of each design of these sensors in their chronological order of design. This figure also includes the series-parallel arrangement of the thermistor beads of each design variation. Evaluation of each of these eight configurations is presented at the end of this section.

PURPOSE AND DESCRIPTION

The water-glycol temperature sensor is used to sense the temperature of water-glycol coolant and exhibits a change in resistance in accordance with change in temperature. These units consist of a metal housing containing two or more thermistor probes, one of which is in operation and the rest of which are in standby redundancy. The operating thermistor forms one leg of a resistance bridge in the control circuitry which compares the sensed temperature to a reference temperature, and initiates the control function accordingly.

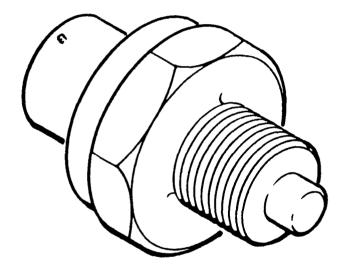
REJECTION SUMMARY

Figure 4-3 presents the failure matrix of all the failures in all eight different configurations of the water-glycol temperature sensor. The information indicated in this matrix is summarized in the histogram of Figure 4-4. This histogram indicates two random failures for 6.6 percent of the total rejections. The remaining 93.4 percent of the rejections are caused by handling, assembly, and engineering errors; all are potentially avoidable.

PERFORMANCE AND DESIGN DATA

Initial Designs

The performance and design data for initial designs PN's 820918-1, 820918-2, 820980-1, 820980-2, 820980-3, and 820980-4 are presented in Table 4-1 through 4-6.



A-11828

Figure 4-1. Typical Configuration of Water-Glycol Temperature Sensor



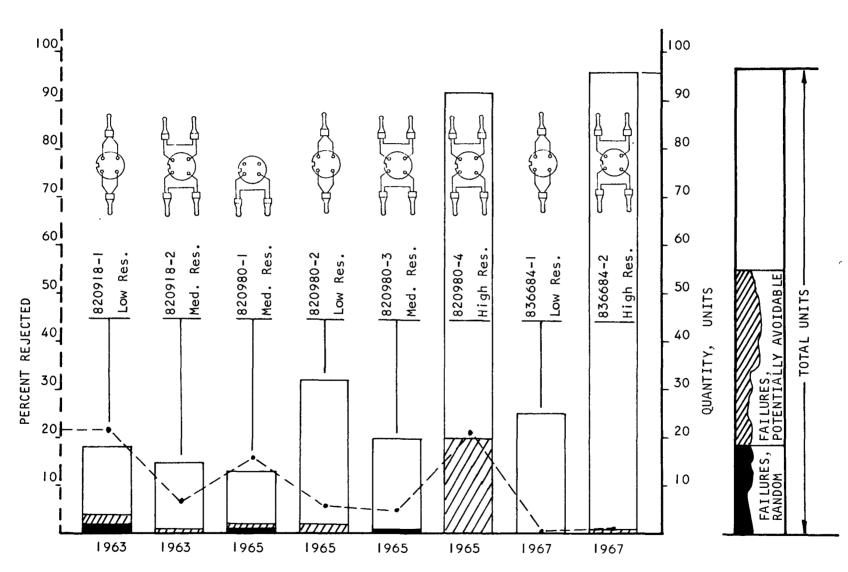


Figure 4-2. Water-Glycol Temperature Sensor Population and Rejection Quantity
Histogram in Chronological Order of Design

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Figure 4-3. Water-Ġlycol Temperature Sensor Failure Matrix

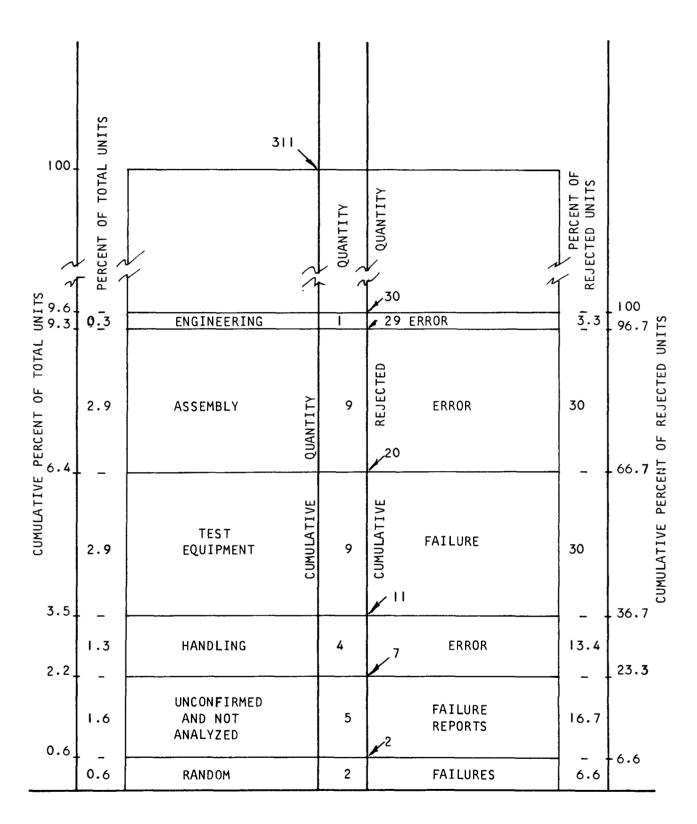


Figure 4-4. Distribution of Failures According to Problem Area

PERFORMANCE AND DESIGN DATA FOR PN 820918-1 (Initial Design)

Performance requirements

- (a) Thermistor resistance: Resistance is 1822 ohms $\pm 2\%$ at 45° F
- (b) Time constant: 2 min when exposed to 200 lb/hr water-glycol flow rate

Operating pressures:

- (a) Normal: 21 psig
- (b) Max.: 60 psig
- (c) Pressure drop across sensor: 0.5 in. water max. at 200 lb/hr glycol flow rate

Structural requirements:

- (a) Proof pressure: 90 psig
- (b) Burst pressure: 150 psig

External leakage: Zero with 60 psig internal pressure

Fittings: Per MS-33656-6, Style E

Environmental conditions: As specified in AiResearch Specification

SS-1060-R; Type I equipment

Installation envelope: Per AiResearch Drawing 820918

Weight: 0.1 lb

Electrical connector: In accordance with MIL-C-26482C and gold-plated

PERFORMANCE AND DESIGN DATA FOR PN 820918-2 (Initial Design)

Performance requirements:

(a) Thermistor resistance: $3677 \text{ ohms } \pm 2\% \text{ at } 50^{\circ}\text{F}$ 2916 ohms $\pm 2\%$ at 60°F

2916 ohms $\pm 2\%$ at 60°F 2330 ohms $\pm 2\%$ at 70°F 1876 ohms $\pm 2\%$ at 80°F

(b) Time constant: 2 min when exposed to 200 lb/hr water-glycol

flow rate

Operating pressures:

(a) Normal: 21 psig

(b) Max.: 60 psig

(c) Pressure drop across sensor: 0.5 in. water max. at 200 lb/hr

water-glycol flow rate and 45°F

temperature

Structural requirements:

(a) Proof pressure: 90 psig

(b) Burst pressure: 150 psig

External leakage: Zero with 60 psig water-glycol pressure

Environmental conditions: Per AiResearch Report SS-1060-R; Type I

equipment

Installation envelope: Per AiResearch Drawing 820918

Weight: 0.1 lb

Electrical connector: Per MIL-C-26482C and gold-plated

PERFORMANCE AND DESIGN DATA FOR PN 820980-1 (Initial Design)

End fittings

Per MS33656-6

Operating pressure

60 psig maximum

Proof pressure

90 psig

Burst pressure

150 psig

External leakage

 1.3×10^{-4} cc/hr water-glycol with 60 psig at 70° F

Weight

0.1 1b

Envelope

3.6 by 3.5 by 2.0 in.

Sensor resistance (each)

4670 ohms $\pm 1\%$ at 40° F 2001 ohms $\pm 1\%$ at 77° F 413.6 ohms $\pm 1\%$ at 160° F

Time constant

2 min when exposed to 200 lb/hr

water-glycol flow rate

PERFORMANCE AND DESIGN DATA FOR PN 820980-2 (Initial Design)

\	
End fittings	Per MS33656-6
Operating pressure	60 psig
Proof pressure	90 psig
Burst pressure	150 psig
External leakage	1.3 x 10 ⁻⁴ cc/hr water-glycol with 60 psig at 70 [°] F
Weight	0.1 lb
Envelope	3.6 by 3.5 by 2.0 in.
Sensor resistance (each)	3296 +280 ohms at 20°F 2614 +139 ohms at 30°F 2084 +51 ohms at 40°F 1860 +28 ohms at 45°F 1663 +42 ohms at 50°F 1336 +58 ohms at 60°F 1082 +66 ohms at 70°F
Time constant	2 min when exposed to 200 lb/hr water-glycol flow rate
Qualification status	This glycol temperature sensor is a qualified Block II Apollo component.

PERFORMANCE AND DESIGN DATA FOR PN 820980-3 (Initial Design)

Per MS33656-6 End fittings

60 psig maximum Operating pressure

Proof pressure 90 psig

Burst pressure 150 psig

 1.3×10^{-4} cc/hr water-glycol with 60 psig at 70° F External leakage

Weight 0.1 lb

3.6 by 3.5 by 2.0 in. Envelope

Sensor resistance (each)

 $4670 \text{ ohms } \pm 1\% \text{ at } 40^{\circ}\text{F}$ $2001 \text{ ohms } \pm 1\% \text{ at } 77^{\circ}\text{F}$ $413.6 \text{ ohms } \pm 1\% \text{ at } 160^{\circ}\text{F}$

Time constant 2 min when exposed to 200 lb/hr

water-glycol flow rate

PERFORMANCE AND DESIGN DATA FOR PN 820980-4 (Initial Design)

Per MS33656-6 End fittings 60 psig maximum Operating pressure Proof pressure 90 psig 150 psig Burst pressure 1.3×10^{-4} cc/hr water-glycol with 60 psig at 70° F External leakage 0.1 16 Weight Envelope 3.6 by 3.5 by 2.0 in. 9356 ±117 ohms at 40°F 7355 ±92 ohms at 50°F 5835 ±73 ohms at 60°F 4661 ±58 ohms at 70°F 3752 ±47 ohms at 80°F 3041 ±38 ohms at 90°F 2482 ±31 ohms at 100°F Sensor resistance (each) Time constant

2 min when exposed to 200 lb/hr

water-glycol flow rate

Oualification status The glycol temperature sensor

is a qualified Block II Apollo

component.

Current Designs

The performance and design data for current designs PN's 836684-1 and 836684-2 are presented in Tables 4-7 and 4-8.

TABLE 4-7

PERFORMANCE AND DESIGN DATA FOR PN 836684-1 (Current Design)

Connector	AiResearch 223-022-9007
Proof pressure	150 psig
Burst pressure	200 psig
Sensor resistance	1860 <u>+</u> 19 ohms at 45°F

TABLE 4-8

PERFORMANCE AND DESIGN DATA FOR PN 836684-2 (Current Design)

Connector	AiResearch 223-022-9007
Proof pressure	150 psig
Burst pressure	200 psig
Sensor resistance	9356 ± 94 ohms at 40° F 4661 ± 47 ohms at 70° F 2482 ± 25 ohms at 100° F

FAILURE AND DESIGN REVIEW

Initial Designs

1. Water-Glycol Temperature Sensor PN 820918-1

Table 4-9 is a summary of the four failure reports that were reviewed for this sensor evaluation. Two of the reports were determined to be due to test equipment errors and two reports were related to random failure of seals. Figure 4-5 summarizes this information in the failure matrix. Recommendations for actions that will reduce the quantity of rejections stemming from human errors are summarized in Section 2 of this report.

2. Water-Glycol Temperature Sensor, PN 820918-2

Table 4-10 is a summary of the only failure report that was reviewed for the evaluation of this sensor. The only problem was low insulation resistance caused by excessive use of potting compound which pressed the lead wire to the housing. Recommendations of actions that will reduce the quantity of this type of failures are presented in Section 2 of this report.

3. Water-Glycol Temperature Sensor, PN 820980-1

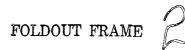
Table 4-11 is a summary of the two failure reports that were reviewed for the evaluation of this sensor. One unit was scrapped without analysis of the failed item. The second unit exhibited low insulation resistance because of water leakage into the case, which resulted from a defective solder joint in the thermistor-to-case seal. Recommendations of actions that will reduce the quantity of this type of failures are presented in Section 2 of this report.

4. Water-Glycol Temperature Sensor, PN 820980-2

Table 4-12 is a summary of the two failure reports that were reviewed for the evaluation of this sensor. One failure report was not relevant to the sensor and the rejection was found to be caused by a faulty battery in the test equipment. The second failure report was written on a unit with low resistance, which was caused by water leakage into the thermistor as a result of a crack caused by mishandling. Recommendations of actions that will reduce the quantity of such rejections and failures are presented in Section 2 of this report.

5. Water-Glycol Temperature Sensor, PN 820980-3

Table 4-13 is a summary of the only failure reported on this part number; however, the unit was scrapped before failure analysis was performed. Since this design is not being implemented and has been superseded, it is recommended that no further investigation be performed on this design.



TRANSDUCER A	APPLICATIO	ON Glyc	ol Temperatu	ure Sensor			TRANSDUCER TYPE Te	emperature	1.	
BASIC PART N	IUMBER	8209	18-1			 	OPERATING PRINCIPLETh	nermistor		
TRANSDUCER N	MANUF.	AiRe	search Mfg.	Co.				O - 80°F		
TROUBLE REPO	ORT SOURCE	E AiRe	search				MEASUREMENT MEDIAGI	lycol		
PART NUMBER	SERIAL NUMBER	FAILURE DATE	T/R NUMBER	FAILURE TYPE	FAILURE MODE	FAILURE MECHANISM	FAILURE CAUSE	PROBLEM AREA	CORRECTIVE ACTION	COMMENTS
820918-1-1	24-107	6-18-64	3370	Human	Drift	Faulty test equipment	Out-of-calibration test gages	Testing equipment	Replace faulty test equipment	Unit was good
820918-1-1	44-113	4-7-65	4785	Mech	Connector packing ("O" ring) damage	Isolated case				This packing was lost prior to analysis
820918-1-1	44-112	4-7-65	4785	Mech	Connector packing ("O" ring) damage	Isolated case				
820918-1-1	44-113	4-13-65	5890	Human	Explosion in test set-up	No		Not confirmed failure		Failure did not relate to unit. Unit was good.
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Figure 4-5. PN 820918-1 Failure Matrix





TRANSDUCER	APPLICATI	ON <u>Glycc</u>	ol Temperatu	re Sensor		TR	ANSDUCER TYPETempe	rature	1	
BASIC PART	NUMBER	820918-2				OF	PERATING PRINCIPLE	hermistor		
TRANSDUCER	MANUF	AiResearc	h Manufactu	ring Co.		ME	ASUREMENT RANGE50	- 80°F		·
TROUBLE REF	ORT SOURC	E <u>AiRese</u>	arch		y		ASUREMENT MEDIAGlyc	01		
PART NUMBER	SERIAL NUMBER	FAILURE DATE	T/R NUMBER	FAILURE TYPE	FAILURE MODE	FAILURE MECHANISM	FAILURE CAUSE	PROBLEM AREA	CORRECTIVE ACTION	COMMENTS
820918-2	24-105	6/18/64	3435	Human	Low insulation resistance	Potting compound provided a low resistance path wire to case	Excessive potting compound used in assembly	Manufacturing, assembly	Use a measured amount of potting compound	
										-

FOLDOUT FRAM

TABLE 4-11

TRANSDUCER	APPLICATIO	ON <u>Glyc</u>	ol Temperato	<u>ıre Sensor</u>		TR/	ANSDUCER TYPE <u>Temper</u>	ature			
BASIC PART N							RATING PRINCIPLET				
TRANSDUCER	MANUF	AiResea	rch Manufac	turing Co.			SUREMENT RANGE 40 -				· · ·
TROUBLE REP							SUREMENT MEDIAGly				
PART NUMBER	SERIAL NUMBER	FAILURE DATE	T/R NUMBER	FAILURE TYPE	FAILURE MODE	FAILURE MECHANISM	FAILURE CAUSE	PROBLEM AREA		CORRECTIVE ACTION	COMMENTS
820980-1	65-106	1/18/66	8234	Elect.	Drift						Unit scrapped with no failure analysis performed
820980-1	65-103	10/17/66	11372	Human	Low insulation resistance	Water leakage into sensor case	Defective solder joint in thermistor- to-case seal	Manufacturing	gly	90 psig water- col test during sembly	
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FOLDOUT FRAME

Water-Glycol Temperature Sensor Failure Evaluation

TRANSDUCER	APPLICATI	ONG1	ycol Tempera	ture Sens	or	TR	ANSDUCER TYPETe	emperature		·
BASIC PART	NUMBER	820980-	2				ERATING PRINCIPLE			
TRANSDUCER	MANUF	AiRe	search Manuf	facturing	Co.	,	ASUREMENT RANGE <u>40</u>			
TROUBLE REP	ORT SOURC	E Ai	Research				ASUREMENT MEDIAGly			
PART NUMBER	SERIAL NUMBER	FAILURE DATE	T/R NUMBER	FAILURE TYPE	FAILURE MODE	FAILURE MECHANISM	FAILURE CAUSE	PROBLEM AREA	CORRECTIVE ACTION	COMMENTS
820980-2	16-113	2/16/72	13058	Human	Low insulation resistance	Water leakage into thermistor encapsulation	Cracked thermistor bead	Hand1ing	Add notes to assembly instruc- tion on fragility	
820980-2	76-137	7/29/67	15442	Human	Drift	Failed test setup	Failed battery	Testing, ATP	Replace battery	Unit was good
					·					
								,		



WATER-GLYCOL TEMPERATURE SENSOR FAILURE EVALUATION

TRANSDUCER A	APPLICATION	ON	Glycol Te	emperature	Sensor	TR/	ANSDUCER TYPE Temp	erature		
BASIC PART N	IUMBER	820980-	3				ERATING PRINCIPLE	Thermistor		
TRANSDUCER I	MANUF	AiResearc	h Manufactu	ring Co.	·····	ME.A	SUREMENT RANGE40	- 100°F		<u> </u>
TROUBLE REP							SUREMENT MEDIA	Glycol		
PART NUMBER	SERIAL NUMBER	FAILURE DATE	T/R NUMBER	FAILURE TYPE	FAILURE MODE	FAILURE MECHANISM	FAILURE CAUSE	PROBLEM AREA	CORRECTIVE ACTION	COMMENTS
820980-3-1	65-112	11/29/65	7483	Elect.	Drift					Unit scrapped with no analysis performed
					·					



72-8537-12 Page 4-19

6. Water-Glycol Temperature Sensor, PN 820980-4

Table 4-14 is a summary of 12 failure reports written against 19 units that were reviewed for evaluation of this sensor. The information indicated in Table 4-14 is summarized in the failure matrix of Figure 4-6. One of the units was scrapped before failure analysis was performed. One failure was not confirmed. Four units had cracked beads as a result of mishandling. Seven units were rejected because of faulty test equipment. Five units were rejected because of water leakage as a result of poor soldering. Finally, one unit was rejected because of contamination as a result of inadequate posttesting cleaning instructions in the qualification test procedures. All of the test rejections are potentially avoidable, and recommendations for actions that will reduce drastically the quantity of such rejections is presented in Section 2 of this report.

Current Designs

1. Water-Glycol Temperature Sensor, PN 836684-1

This design does not have any failure report supplied by NASA for evaluation. This design, a qualified Block II Apollo component, is a good one for its specific application. An altered copy of the outline drawing of this temperature sensor is shown in Figure 4-7.

2. Water-Glycol Temperature Sensor, PN 836684-2

Table 4-15 is a summary of the only NASA-supplied failure report on this temperature sensor that was reviewed for evaluation of this sensor. Failure was caused by an inadequate solder joint. A single failure in a total population of 96 units is equivalent to a rejection rate of 1.04 percent. This design, a qualified Block II Apollo component, is a good one for its specific application. An altered copy of the outline drawing of this temperature sensor is shown in Figure 4-8.

FOLDOUT FRAME 2

WATER-GLYCOL TEMPERATURE SENSOR FAILURE EVALUATION

TRANSDUCER	APPLICATI	ON Glyo	col Tempera	ture Senso	<u> </u>	TR/	ANSDUCER TYPE Te	mperature		
BASIC PART 1	NUMBER	8209	980-4 (Page	I of 2)			ERATING PRINCIPLETh	ermistor		
TRANSDUCER	MANUF	AiRe	esearch Man	ufacturing	Company	ME <i>A</i>	SUREMENT RANGE 40	- 100°F		•
TROUBLE REP	ORT SOURC	E AiRe	esearch			ME <i>A</i>	ASUREMENT MEDIAG1	ycol		
PART NUMBER	SERIAL NUMBER	FAILURE DATE	T/R NUMBER	FAILURE TYPE	FAILURE MODE	FAILURE MECHANISM	FAILURE CAUSE	PROBLEM AREA	CORRECTIVE ACTION	COMMENTS
820980-4-1	46-130	5-18-66	9197	Human	Failed high	-	-	-	-	Trouble report analysidoes not relate to failure
820980-4-1	46-148	8-31-66	8845	Human	Low insulation resistance	Water leakage into sensor case	Solder pinhole in thermistor-to-case seal	Manufacturing	Clean and pressure test all solder seals	Leaks were sealed with flux during initial testing
820980-4-1	46-154	10-3-66	11330	Human	Low insulation resistance	Water leakage into thermistor encapsu- lation	Cracked thermistor bead	Handling	None	
820980-4-1	46-171	10-3-66	11330	Human	Low insulation resistance	Water leakage into sensor case	Cracks in solder thermistor-to-case seal	Manufacturing	Clean and inspect all solder seals	
820980-4-1	46-188	10-6-66	11334	Human	Low insulation resistance	Water leakage into sensor case	Cold solder joint in thermistor-to-case seal	Manufacturing	Clean and inspect all solder seals	
820980-4-1	46-189	10-6-66	11334	Human	Low insulation resistance	Water leakage into sensor case	Cold solder joint in thermistor-to-case seal	Manufacturing	Clean and inspect all solder seals	·
820980-4-1	46-153	10-14-66	11365	Human	Low insulation resistance	Water leakage into sensor case	Cracked thermistor bead	Handling	None	
820980-4-1	46-163	10-14-66	11365	Human	Low insulation resistance	Water leakage into sensor case	Cold solder joint in thermistor-to-case seal	Manufacturing	Add low temperature and proof pressure tests during assem- bly	
820980-4-1	46-170	10-22-66	11391	Human	Low insulation resistance	-	-	-	-	Unit scrapped prior to performing analysis



72-8537-12 Page 4-21

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. Appendix on a constant

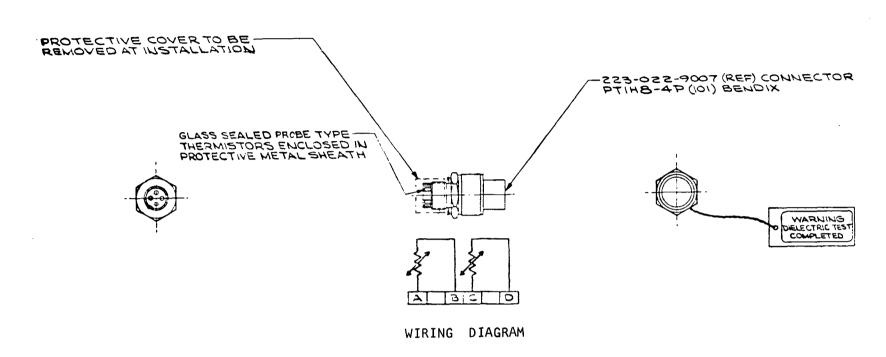
TABLE 4-14 (Continued)

RANSDUCER A	APPLICATION		ycol Temper			TRA	NSDUCER TYPE	Temperature		
ASIC PART N	NUMBER	82	0980-4 (Pag	ge 2 of 2)		OPE	RATING PRINCIPLE	Thermistor		
RANSDUCER N	MANUF	Ai	Resarch Mar	nufacturing	Company	MEA	SUREMENT RANGE	40 - 100°F		
ROUBLE REPO	ORT SOURC	E Ai	Research			MEA	SUREMENT MEDIA	Glycol		
PART NUMBER	SERIAL NUMBER	FAILURE DATE	T/R NUMBER	FAILURE TYPE	FAILURE MODE	FAILURE MECHANISM	FAILURE CAUSE	PROBLEM AREA	CORRECTIVE ACTION	COMMENTS
820980-4-1	46-146	2-14-67	13099	Human	Low insulation resistance	Water leakage into thermistor encapsu- lation	Cracked thermistor bead	Handling	Add notes to assembly instructions on fragility	
820980-4-1	46-150	3-23-67	8871	Human	Low insulation resistance	Contamination of connector	Connector contam- ination during testing	QTP procedure design	None	No failure
820980-4-1	46-196 46-198 46-199 46-200	7-27-67	15439	Human	Drift	Failed test setup	Failed battery in test setup	Testing, ATP	Replace battery	Units were good
820980-4-1	46-142 46-179 46-185	7-29-67	15441	Human	Drift	Failed test setup	Failed battery in test setup	Testing, ATP	Replace battery	Units were good
820980-4-1	46-172	7-29-67	15440	Human	Low insulation resistance	Water leakage into thermistor encapsulation	Cracked thermistor bead	Handling	Add notes to assembly instructions on fragility	
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										78 -								F	AIL	URE																					
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Figure 4-6. PN 820980 4 Failure Matrix





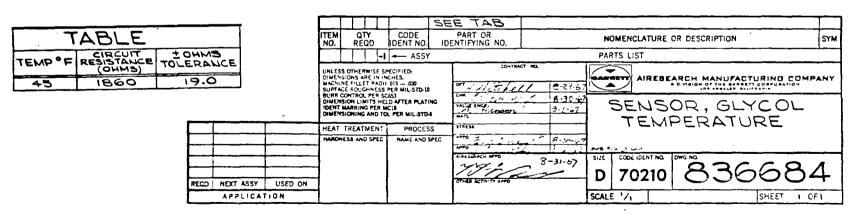


Figure 4-7. Outline Drawing of the Water-Glycol Temperature Sensor PN 836684-1

OLDOUT FRAME

TABLE 4-15

TRANSDUCER APPLICATION Glycol Temperature Sensor TRANSDUCER TYPE Temperature																
BASIC PART							RATING PRINCIPLE		,							
TRANSDUCER	MANUF	Fenwal E	lectronics (Corp.			SUREMENT RANGE		1							
TROUBLE REP	ORT SOURC	E <u>Air</u>	esearch			MEA	UREMENT MEDIA Glycol									
PART NUMBER	SERIAL NUMBER	FAILURE DATE	T/R NUMBER	FAILURE TYPE	FAILURE MODE	FAILURE MECHANISM	FAILURE CAUSE	PROBLEM AREA	CORRECTIVE ACTION	COMMENTS						
836684-2	36	11/17/68	16846	Elec.	Intermittent output	Poor lead conductor connection	Inadequate solder joint	Manufacturing	Add inspection of soldered connections							
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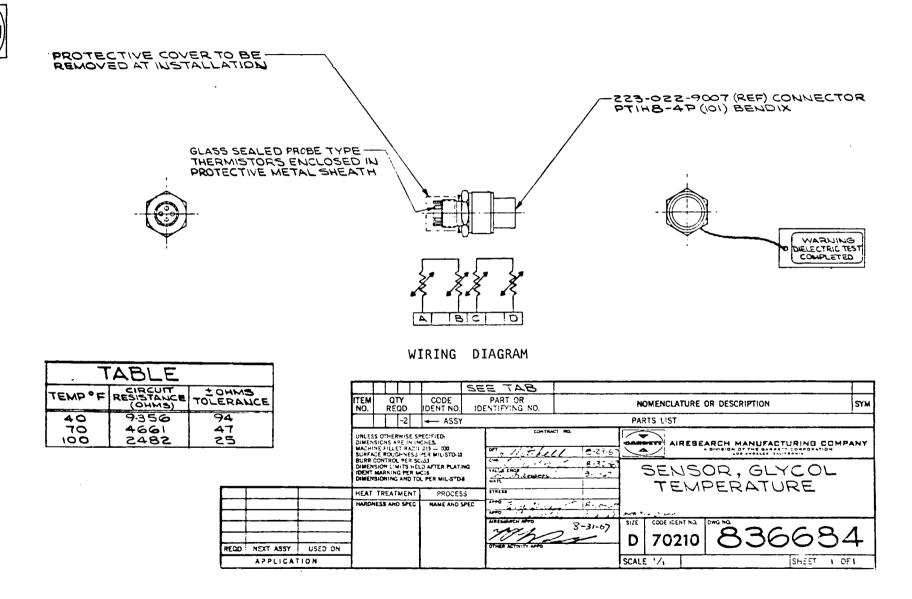


Figure 4-8. Outline Drawing of the Water-Glycol Temperature Sensor PN 836684-2

SECTION 5

CABIN TEMPERATURE SENSORS AND CABIN TEMPERATURE ANTICIPATOR (AIRESEARCH PN's 820100, 820964, 820110)

INTRODUCTION

The three part numbers listed above have identical functions and their design and performance specifications are very similar. The initial design of the cabin temperature sensor, PN 820100, which was an Apollo Block I ECS component, was replaced by a new design, PN 820964, in the Block II. The physical characteristics of the housing of these two sensors are different; however, their functions and principle of operation are identical. The temperature anticipator, PN 820110, also is very similar to the initial design of cabin temperature sensor PN 820100.

PURPOSE AND DESCRIPTION

Cabin Temperature Sensor

The cabin temperature sensor senses the gas temperature near the inlet of the cabin heat exchanger. This information is used by the cabin temperature control subsystem for temperature regulation.

Each sensor consists of a metal probe containing a glass-sealed, dual-bead thermistor. An outline drawing of the current design, PN 820964-1 is presented in Figure 5-1 for reference.

Cabin Temperature Anticipator

The cabin temperature anticipator senses the temperature of the gases at the outlet duct of the cabin heat exchanger. The anticipator reduces the amount of temperature overshoot and improves the dynamic characteristics of the cabin temperature control subsystem.

The anticipator consists of a metal probe, containing two glass-sealed, dual-bead thermistors. One thermistor is thermally lagged by encapsulation in a metal slug, while the other is in direct contact with the cabin air. An outline drawing of the current design, PN 820110, is presented in Figure 5-2 for reference.

The thermistors are connected to the cabin temperature controller to form two branches of a temperature-rate-of-change resistance bridge. The resistance ratio produced by the two thermistors corresponds to the rate of temperature change occurring at the cabin heat exchanger outlet. The change in thermistor resistance unbalances the bridge, causing an error rate of change signal to be produced. The error rate of change signal improves the dynamic performance of the cabin temperature subsystem.

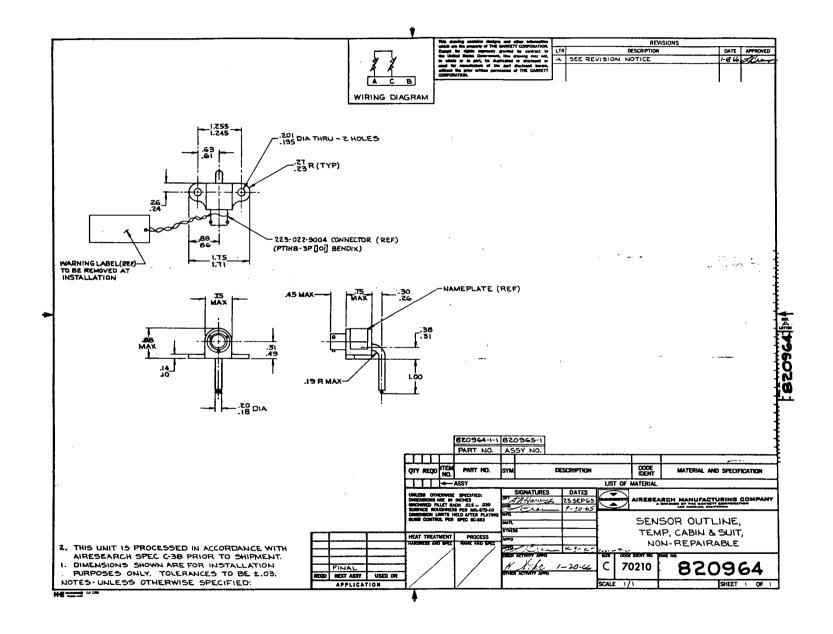


Figure 5-1. Outline Drawing of Cabin Temperature Sensor PN 820964-1

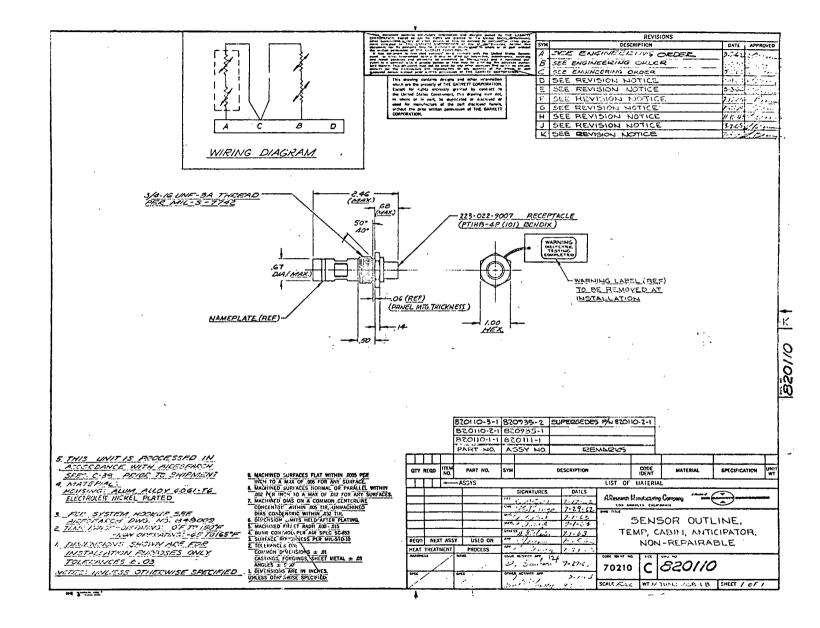


Figure 5-2. Outline Drawing of Cabin Temperature Anticipator

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Anticipator, AiResearch PN's 820100, 820969 and 820110, Failure Matrix

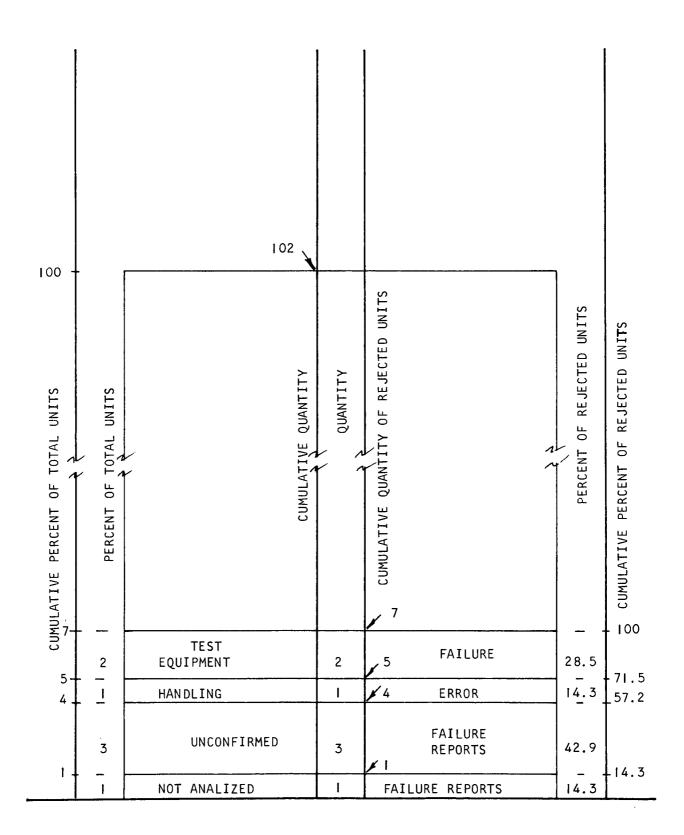


Figure 5-4. Distribution of Failures According to Problem Area for the Cabin Temperature Sensor and Anticipator



PERFORMANCE AND DESIGN DATA FOR PN 820100-1 (Initial Design)

Performance Requirements:

(a) Thermistor resistance: 3677 ohms $\begin{array}{c} +2 \% \text{ at } 50^{\circ}\text{F} \\ 2916 \text{ ohms } \\ +2 \% \text{ at } 60^{\circ}\text{F} \\ 2330 \text{ ohms } \\ +2 \% \text{ at } 70^{\circ}\text{F} \\ 1876 \text{ ohms } \\ +2 \% \text{ at } 80^{\circ}\text{F} \\ \end{array}$

(b) Time constant: 6 sec max. when exposed to 35 cfm airflow rate.

Environmental Conditions: Per AiResearch Report SS-1060-R; Type I equipment.

Installation Envelope: Per AiResearch Drawing 820100.

Design:

(a) Weight: 0.1 lb.

- (b) Thermistor: Bead type with a high negative temperature coefficient of resistance. Thermistor enclosed in end of glass cylinder.
- (c) Mounting provision: The sensor probe is threaded for installation in the inlet air duct of the cabin heat exchanger.

Electrical Connector: Per MIL-C-26482C and gold-plated.

PERFORMANCE AND DESIGN DATA FOR PN 820964-1

2330 ohms +2% at 70°F 2230 ohms +2% at 72°F 2135 ohms +2% at 74°F 2045 ohms +2% at 76°F 1959 ohms +2% at 78°F 1923 ohms +2% at 80°F
8 sec max. to reach 63.2% of applied ΔT when exposed to 35 cfm airflow rate at 14.7 psia in a 3-in. duct
Bead type with a high negative temp coefficient of resistance. Therm- istor enclosed in end of a glass cylinder
The sensor probe is threaded for installation in the inlet air duct of the cabin heat exchanger
Per MIL-C-26482C and gold-plated
0.05
0.9 in. dia by 2.16 in. long
The cabin temperature sensor is a qualified Apollo Block II item

PERFORMANCE AND DESIGN DATA FOR PN 820110-3

Performance Requirements:

(a) Thermistor resistance: 3672 ohms +2% at 50° F 2916 ohms +2% at 60° F

2330 ohms $\pm 2\%$ at 70° F 1876 ohms $\pm 2\%$ at 80° F

(b) Time constants: 8 sec max to reach 63.2 percent of applied ΔT when

exposed to 20 cfm airflow rate at 14.7 psia in a

3-in. dia duct

Thermally lagged thermistor, min: 4.0 ±1.0

Unlagged thermistor, sec: 6 max.

Environmental Conditions: Per AiResearch Report SS-1060-R; Type I

equipment.

Installation Envelope: Per AiResearch Drawing 820110.

Design:

- (a) Weight: 0.1 lb
- (b) Thermistor: Bead type with a high negative temperature coefficient of resistance. Thermistor enclosed in end of glass cylinder.
- (c) Mounting provision: The anticipator probe is threaded for Installation on the outlet air duct of the cabin heat exchanger.

Electrical Connector: Per MIL-C-26482C

FOLDOUT FRAME

CABIN TEMPERATURE SENSOR FAILURE EVALUATION

TRANSDUCER	TRANSDUCER APPLICATION Cabin Temperature Sensor TRANSDUCER TYPE Temperature													
BASIC PART 1	NUMBER	82010	00				ERATING PRINCIPLE The	rmistor						
TRANSDUCER	MANUF	AiRes	earch			ME.A	SUREMENT RANGE50-	80°F						
TROUBLE REP	ORT SOURCE	E AiRes	earch				ASUREMENT MEDIACab							
PART NUMBER	SERIAL NUMBER	FAILURE DATE	T/R NUMBER	FAILURE TYPE	FAILURE MODE	FAILURE MECHANISM	FAILURE CAUSE	PROBLEM AREA	CORRECTIVE ACTION	COMMENTS				
820100-1	93-103	7/1/64	3145	Human	Test setup explosion		Heater coil insula- tion breakdown due to heat	Testing	Revise test setup	Unit was good				
820100-1	93-106	7/1/64	3146	Human	Test Setup explosion		Heater coil insula- tion breakdown due to heat	Testing	Revise test setup	Unit was good				
820100-1-2	65-116	9/27/65	6143	Human	Sensor shield damaged	Damaged by tech- nician's wrench	Unit being used during test set buildup	Handling	Use dummy unit during buildup					
,														

REJECTION SUMMARY

Figure 5-3 presents a matrix of all failure reports written against these three parts. The same information is presented in the histogram of Figure 5-4. Of the total of seven failure reports, two reports were concerned with test equipment failure, one report was written on a damaged unit, the failures indicated in three other reports were not confirmed, and one unit was scrapped before failure analysis was performed. Assuming the scrapped unit was actually a failed item, this type of temperature sensors exhibited a failure rate of one percent; the rest were avoidable.

PERFORMANCE AND DESIGN DATA

Performance and design data for cabin temperature sensors PN's 820100-1 (initial design) and 820964 (current design) are presented in Tables 5-1 and 5-2, respectively. Table 5-3 presents performance and design data for cabin temperature anticipator PN 820110-3.

FAILURE AND DESIGN REVIEW

Cabin Temperature Sensor PN 820100-1 (Initial Design)

Table 5-4 is a summary of three failure reports supplied by NASA-MSC, which were reviewed for evaluation of this sensor. Two of the reports were determined to have resulted from test equipment failure resulting in damage to the sensors. The other report described damage inflicted on the sensor housing by mishandling. All three reported cases were potentially avoidable. Figure 5-5 summarizes this information in the failure matrix. Since this sensor has been superseded, it is recommended that no further evaluation of it be made.

Cabin Temperature Sensor PN 820964-1 (Current Design)

No failure report was supplied by NASA-MSC for evaluation of this part. This part number supersedes the previous PN 820100-1 and is a very good component in its application.

Cabin Temperature Anticipator PN 820110 (Current Design)

Table 5-5 is a summary of four failure reports supplied by NASA-MSC, which were reviewed for this sensor evaluation. Three of the reported failures were not confirmed and one unit was scrapped after four consecutive failures before failure analysis was performed. Figure 5-6 summarizes this information in the failure matrix. The one failed item out of a total population of 47 units represents a rejection rate of 2.1 percent.



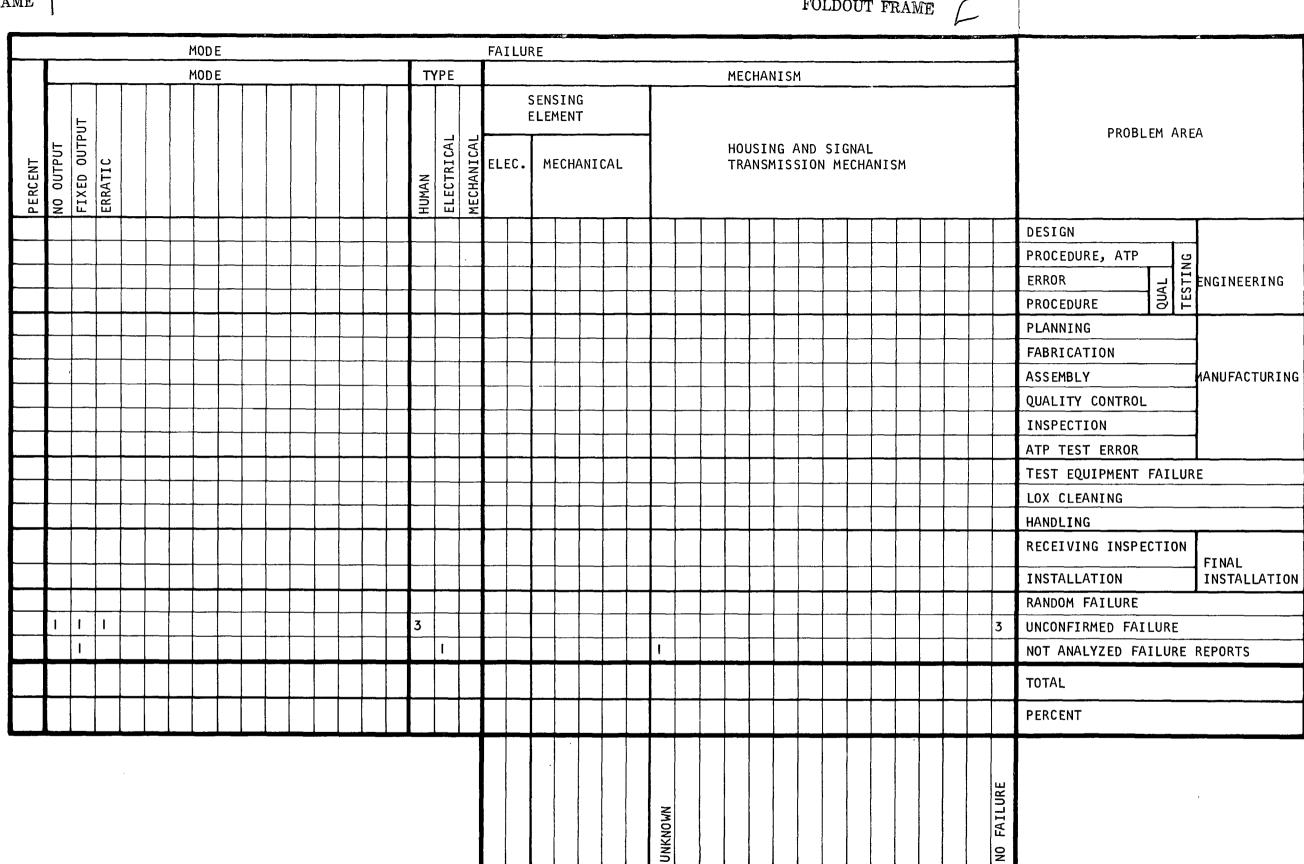
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																			Į													F/	41L	URE	CA	USE			-				Figure 5-5. Cabin PN 820 Matrix	1100-1, Failure



2

CABIN TEMPERATURE ANTICIPATOR FAILURE MATRIX

TRANSDUCER /	APPLICATION	ON Cabi	n Temperatu	re Anticip	eator (Sensor)		TRANSDUCER TYPE Tem	perature Sensor	+	
BASIC PART N	IUMBER	820	110-3-1				OPERATING PRINCIPLE Th			
TRANSDUCER I	MANUF.	AiR	esearch				MEASUREMENT RANGE 50		1	
TROUBLE REP	·	Λ: D	esearch					ectric Current		
PART NUMBER	SERIAL NUMBER	FAILURE DATE	T/R NUMBER	FAILURE TYPE	FAILURE MODE	FAILURE MECHANISM	FAILURE CAUSE	PROBLEM AREA	CORRECTIVE ACTION	COMMENTS
820110-3-1	26-140	9-23-66	11088	Elect.	Continuous Output	Unknown	Unknown	Unknown	None	Unit was scrapped after the fourth failure
820110-3-1	26-140	7-28-66	10718	Human	No output	Unknown	Unknown	Unknown	None	Failure not confirmed
820110-3-1	26-140	5-31-66	9273	Human	Continuous Output	Unknown	Un known	Unknown	None	Failure not confirmed
820110-3-1	26-140	4-25-66	8711	Human	Erratic	Unknown	Unknown	Unknown	None	Failure not confirmed



FAILURE CAUSE



Figure 5-6. Cabin Temperature Anticipator Failure Matrix



AIRESEARCH MANUFACTURING COMPANY

Los Angeles, California

REPORT ON FAILURE AND DESIGN EVALUATION OF APOLLO ECS TEMPERATURE SENSOR, THERMISTOR BEAD AND COIL TYPE

CONTRACT NO. NAS 9-12452

72-8537-13, Rev. I

February 10, 1973

Prepared by A. Saginian

APPROVED:

R. E. Vesque Y Program Manager

PPROVED 1/2

pr. J. Brudnicki

Principal Investigator

Prepared for

NASA MANNED SPACECRAFT CENTER HOUSTON, TEXAS 77058

ABSTRACT

This report presents the results of a failure and design evaluation study conducted on the Apollo ECS transducers, the generic group of the combination of thermistor bead and coil type temperature sensors. The study was conducted for NASA-MSC by the AiResearch Manufacturing Company, a division of The Garrett Corporation under Contract NAS9-12452.

The study purpose was to evaluate the integrity of design of this type temperature sensor. Failure information is presented and summarized pertaining to two different transducer part numbers. A failure matrix is presented which describes the failure mode, type, mechanism, cause, and problem areas. for failures.

The integrity of the superseding design was confirmed. Recommendations are made to reduce the rejection rate of human induced failures.

CONTENTS

Section		Page
I	INTRODUCTION	1-1
2 .	DESCRIPTION, FAILURE SUMMARY, AND RECOMMENDA-	2-1
	TIONS FOR THERMISTOR BEAD AND COIL TYPE	
	TEMPERATURE SENSORS	
	Introduction	2-1
	Purpose and Description	2-1
	Performance and Design Data	2-1
	Failure and Design Review	2-1
	Recommendations	2-2

INTRODUCTION

This report presents a summary of failure data of the generic group of the combination of bead-type thermistor and coil temperature sensors, one of several temperature sensor types that are described and categorized in AiResearch Report No. 72-8537-1. Four bead-type thermistor temperature sensors were evaluated.

All temperature sensors evaluated in this report have been used in the Apollo environmental control system (ECS). In general, they may be used to perform any other temperature sensing function with similar requirements.

The temperature sensors that are evaluated and summarized in this report are, by AiResearch part number:

PN	<u>Nomenclature</u>
820920-1	Glycol Temperature Sensor
820920-2	Glycol Temperature Sensor
820920-3	Glycol Temperature Sensor
836172-1	Glycol Temperature Sensor

Detailed failure data, a summary, and descriptive information on each of these temperature sensors are presented in Section 2 of this report.

DESCRIPTION, FAILURE SUMMARY, AND RECOMMENDATIONS FOR THE COMBINATION OF THERMISTOR BEAD AND COIL TYPE TEMPERATURE SENSORS

INTRODUCTION

The initial design of glycol temperature sensor PN 820920-2 was implemented on the Apollo Block I and Block II ECS. Because of numerous failures this design was superseded by a new design, PN 836172, which was implemented on Apollo Block II ECS. Each of these designs is analyzed in this section.

PURPOSE AND DESCRIPTION

The outline of the current glycol temperature sensor which is a combination of thermistor bead and coil type sensor is presented in Figure 2-1. Subject glycol temperature sensor senses the temperature of the water-glycol coolant at the outlet of the glycol evaporator. The unit consists of a metal housing containing two glass-sealed thermistors, a coil type sensing element, a resistance-bridge circuit, and a transformer coupled output circuit.

The two glass-sealed thermistors, one of which is standby redundant, operate in conjunction with the backpressure control. The operating thermistor forms one leg of a resistance bridge in the control.

The coil type sensing element, which has a positive coefficient of resistance, forms the measured branch of the resistance-bridge circuit of this unit and is used for instrumentation purposes. The resultant signal is transmitted to the associated inflight temperature sensor amplifier through the transformer coupled output circuit of the glycol temperature sensor. This signal is amplified and the amplifier output signal is used for telemetry purposes.

PERFORMANCE AND DESIGN DATA

Table 2-1 presents the performance and design data for these temperature sensors. These data are identical for both of the designs. Human errors in design, assembly, testing, and handling of PN 820920 was the problem source for 29 rejections in a total population of 71 units which represents a rejection rate of 40.8 percent. This high rejection rate motivated the design effort for PN 836172 which was approved as a new part of the Apollo Block II ECS. There has been no reported failed unit of this new design which has a total population of 22 units.

FAILURE AND DESIGN REVIEW

Initial Design (PN 820920)

Table 2-2 is a summary of 30 failure reports written against 29 units of PN 820920. One of these failure reports was duplicating the information presented in another failure report. Six of the rejections (20 percent) were



caused by engineering design error. Twelve units were rejected (41.4 percent) because of assembly errors. Four rejections (13.8 percent) were caused by ATP test errors. Three units were rejected (13.3 percent) because of test equipment failure. One unit was damaged in handling (3.5 percent) and three units were scrapped before failure analysis were performed. These information is presented in Figure 2-2 failure matrix.

Current Design (PN 836172)

There have been no failures in PN 836172 which replaces PN 820920. This is a design of proven integrity and, with assembly personnel who are well trained in up-to-date techniques of assembly, test, and application procedures the only failure source should be random failures.

RECOMMENDATIONS

Since the design problems of this temperature sensor were resolved and eliminated in the new design only the following recommendations are made to prevent human induced failures.

Manufacturing Criteria

- (a) Provide detailed assembly and operations instructions to eliminate poor soldering and calibration problems
- (b) Retrain assembly personnel at scheduled intervals.

Testing Criteria

- (a) Provide detailed test equipment checkout procedures.
- (b) Retrain test personnel at schedule intervals.

Usage

Use the superseding design which is trouble free.



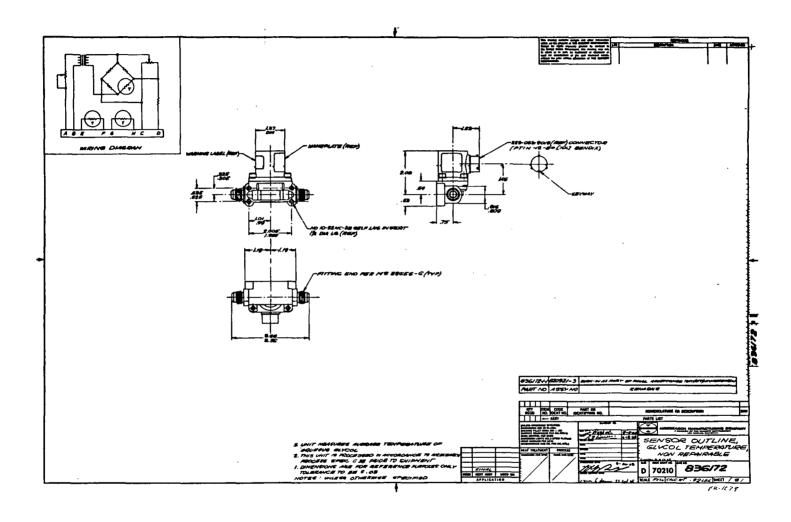


Figure 2-1. Outline Drawing of Glycol Temperature Sensor

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																																					PROCEDURE	
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																																					FABRICATION	
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	Ī														Î																						QUALITY CONTROL	MANUFACTURING
																																		i			INSPECTION	
13.8	4										\top	Ī	4																							4	ATP TEST ERROR	
10.	1	T	\top	2								1	3																							3	TEST EQUIPMENT FAILUR	E
				T				1																													LOX CLEANING	
3.5	1			+							\neg	1	1						1																		HANDLING	
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Figure 2-2. Thermistor Bead and Coil Type
Temperature Sensor Failure Matrix

TABLE 2-1

PERFORMANCE AND DESIGN DATA FOR PNs 820920 AND 836172

Performance Requirements

- a. Thermistors:
 - (I) Resistance: 4220 ohms $\pm 2.0\%$ at 45° F only
 - (2) Time constant: Six sec max when exposed to 200 lb/hr water-glycol flow rate
- b. Instrumentation part of sensor:
 - (I) Operating temperature range: 25°F to 75°F
 - (2) Accuracy: ± 0.75 °F ($\pm 1.5\%$ of total operating range)
 - (3) Output signal: Proportional to sensed temperature. Zero at $25^{\circ}F$ and 59 mv peak-to-peak sq wave (with 260 ± 2.6 ohm load) at $75^{\circ}F$
 - (4) Output impedance: 200 ohms max
 - (5) Time constant: Same as thermistor time constant
 - (6) Bridge excitation voltage: 5.4 ±0.1v peak-to-peak, 300 cps, sq wave at 140 ma
 - (7) Power dissipation of sensing element: 46 mw max

Operating Pressure

- a. Normal: 21 Psig (relative to cabin)
- b. Max: 60 psig (relative to cabin)
- c. Pressure drop across sensor: 0.50 in. water max at flow rate0.50 in. water max at flow rate

TABLE 2-I (Continued)

Structural Requirements:

a. Proof pressure: 90 psig

b. Burst pressure: 150 psig

External Leakage: Zero with 60 psig internal pressure

Environmental Conditions: Per AiResearch Specification SS-1060-R; Type I

equipment

Installation Envelope: Per outline Drawing 820920

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TRANSDUCER	APPLICATI	ON WATER	-GLYCOL TEMP	PERATURE		TRA	NSDUCER TYPE TEMPER	ATURE		
BASIC PART	NUMBER	820920	(PAGE I C)F 4)		OPE	RATING PRINCIPLETH	IERMISTOR		
TRANSDUCER	MANUF. A	IRESEARCH	·····			MEA	SUREMENT RANGE			· ·
TROUBLE REP	ORT SOURC	EAIRE	SEARCH			MEA	SUREMENT MEDIAWA	TER-GLYCOL		
PART NUMBER	SERIAL NUMBER	FAILURE DATE	T/R NUMBER	FAILURE TYPE	FAILURE MODE	FAILURE MECHANISM	FAILURE CAUSE	PROBLEM AREA	CORRECTIVE	COMMENTS
820920-1	14-106	1/4/65	5048	Human	Drift	ATP Test procedure not followed	Technician error	Testing	Re-emphasize test procedure to test personnel	Unit was good
820920-1	14-106	1/14/65	4766	Human	Drift	Metal cap which en- capsulates the thermistor bead con- ducts too much heat.		Design	Design revised	
820920-2-1	45-114	8/23/65	7008	Mech	Excessive external leakage	External leak from port connection	Defective "0" ring packings in assembly	Design	Replace packings	Blind assy. Fault found during leak check.
820920-2-1	45-113	8/23/65	7425	Human	Excessive external leakage	External leak from port connection	Damaged "O" ring	Design	Replace packings	Blind assy. Fault found during leak check.
820920-2-1	45-113	9/23/65	7499	Human	Excessive external leakage	External leak from port connection	Contamination	Design, blind assy	Replace packings	Blind assy. Fault found during leak check.
820920-2-1	85-120	2/21/66	8416	Human	Excessive external leakage	External leak from port connection	Damaged "O" ring	Design, blind assy	Replace packings	Blind assy. Fault found during leak check.
820920-2-1	85-120	7/21/66	10737	Human	Excessive external leakage	-	-	-	-	No teardown analysis performed on unit. Unit scrapped
820920-2-1	46-156	8/17/66	10268	Human	Low insulation resistance	-	-	-	-	No teardown analysis performed on unit. Unit scrapped
820920-2-1	46-154	9/8/66	10976	Human	Excessive external leakage	External leak from port connection	Defective "O" ring packings	manufacturing/ design	Replace packings	Blind assy. Fault found during ATP leak check.



TRANSDUCER	APPLICATI	ON				TR	ANSDUCER TYPE			
BASIC PART I	NUMBER _ 8	20920 CONT	r'D (PAGE 2	0F 4)						
TRANSDUCER	MANUF									•
TROUBLE REP							ASUREMENT MEDIA			
PART NUMBER	SERIAL NUMBER	FAILURE DATE	T/R NUMBER	FAILURE TYPE	FAILURE MODE	FAILURE MECHANISM	FAILURE CAUSE	PROBLEM AREA	CORRECTIVE ACTION	COMMENTS
820920-2-1	85-123	9/12/66	11029	Human	Drift	-	-	-	-	Unit scrapped prior to reliability analysis
820920-2-1	46-137	9/15/66	11046	Human	Out of calibration	-	Unit's original calibration done incorrectly	Manufacturing	Re-calibrate unit.	
820920-2-1	46-144	10/10/66	11336	Human	Out of calibration	-	Unit's original calibration done incorrectly	Manufacturing	Re-calibrate unit.	
820920-2-1	46-153	10/25/66	11397	Human	Out of calibration	-	Unit's original calibration done incorrectly	Manufacturing	Re-calibrate unit	
820920-2-1	46-159	10/26/66	11398	Human	Out of calibration	-	Unit's original calibration done incorrectly	Manufacturing	Re-calibrate unit.	
820920-2-1	46-138	10/27/66	12004	Human	Drift	Failed test setup	Battery in test setup failed	Testing	Replace battery in test setup	Unit was good
820920-2-1	46-153	11/30/66	11953	Human	Low insulation resistance	Fluid was able to enter unit	Defective hermetic seal	Manufacturing	Add more stringent in-process testing.	
820920-2-1	106-174	12/22/66	12554	Human	Drift	Cracked thermistor glass bead	Mishandling	Handling	-	
820920-2-1	106-167	12/28/66	12558	-	-	-	-	-	-	Refer to TR 14169



- - -

TRANSDUCER	APPLICATI	ON				TRA	ANSDUCER TYPE			
BASIC PART										
							SUREMENT RANGE			
TROUBLE REP							SUREMENT MEDIA			
PART NUMBER	SERIAL NUMBER	FAILURE DATE	T/R NUMBER	FAILURE TYPE	FAILURE MODE	FAILURE MECHANISM	FAILURE CAUSE	PROBLEM AREA	CORRECTIVE ACTION	COMMENTS
820920-2-1	85-126	3/24/67	13717	Human	Low insulation resistance		Faulty solder joint, which acts as seal.	Manufacturing	Evaluate other methods of producting this unit	
820920-2-1	46-158	4/19/67	14161	Human	Low insulation resistance	Leak between mandrel and housing	Faulty solder joint, which acts as seal.	Manufacturing	Evaluate other methods of produc-ing this unit.	Found during re-test of all units to find units with faulty sealing.
820920-2-1	106-167	5/12/67	14169	Human	Drift	Unit incorrectly calibrated.	Thermission element out of tolerance and unit incorrectly calibrated	Manufacturing	Use more accurate calibration equipt. and re-educate personnel.	
820920-2-1	46-131	10/20/67	15114	Human	Out of calibration	Unit incorrectly calibrated.	Unit incorrectly calibrated	Manufacturing	Use more accurate calibration equipt. and re-educate personnel.	
820920-3-1	106-164	5/2/68	16623	Human	Out of calibration	Test equipt. fault	Weak battery in test equipt	Testing	None	Unit was good
820920 - 3-1	-	6/10/68	15148	Human	Out of calibration	Test equipt fault	Capacitor used in calib. equipt. was loading output	Testing	Revise test equipment	Unit was good
820920-3-1	85-125	7/12/68	16664	Human	Low insulation resistance	Leakage into unit	Faulty solder seal	Manufacturing	None. Fault found during re-test with revised procedures.	Unit was being upgraded to -3-1
820920-3-1	85-121	7/26/68	16699	Human	Low insulation resistance	Leakage into unit	Faulty solder seal	Manufacturing	None. Fault found during re-test with revised procedures.	Unit was being upgraded to -3-I
820920-3-1		7/30/68	16679	Human	Failed to high output	Failed open therm- istor to lead wire joint	Faulty weld of lead wire	Manufacturing	None. Random fail- ure.	
									· · · · · · · · · · · · · · · · · · ·	

TRANSDUCER	APPLICATI	ON				Т	RANSDUCER TYPE		·	
BASIC PART N	NUMBER8	820920 CON	IT'D (PAGE 4	4 OF 4)			PERATING PRINCIPLE			
TRANSDUCER	MANUF						EASUREMENT RANGE		1	
TROUBLE REP							EASUREMENT MEDIA			
PART NUMBER	SERIAL NUMBER	FAILURE DATE	T/R NUMBER	FAILURE TYPE	FAILURE MODE	FAILURE MECHANISM	FAILURE CAUSE	PROBLEM AREA	CORRECTIVE	COMMENTS
820920-3-1	106-170	4/17/68	-	Human	Drift	-	Changed test methods from initial cali- bration	_	Re-calibrate unit.	Unit was good when tested with old method.
820920 -3- I	106-166	4/18/68	17676	Human	Drift	-	Changed test methods from initial cali- bration	-	Re-calibrate unit	Unit was good when tested with old method.
820920 - 3-I	106-165	4/17/68	17685	Human	Drift	-	Changed test methods from initial cali- bration	-	Re-calibrate unit	Unit was good when tested with old method.
			· · · · · · · · · · · · · · · · · · ·							
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AIRESEARCH MANUFACTURING COMPANY

Los Angeles, California

REPORT ON FAILURE AND DESIGN EVALUATION OF

APOLLO ECS CABIN TEMPERATURE SENSOR, THERMISTOR WITH ELECTRONICS TYPE

CONTRACT NO. NAS 9-12452

72-8537-14, Rev. I

February 10, 1973

Prepared by A. Saginian

APPROVED :

R. E. Vesque

Program Manager

APPROVED

. Brudnicki

Principal Investigator

Prepared for

NASA MANNED SPACECRAFT CENTER HOUSTON, TEXAS 77058

ABSTRACT

This report presents the results of a failure and design evaluation study conducted on Apollo ECS transducers, the generic group of the combination of thermistor bead with electronics type temperature sensors. This study was conducted for NASA-MSC by the AiResearch Manufacturing Company, a division of The Garrett Corporation under Contract NAS 9-12452.

The study purpose was to evaluate the integrity of design of this type temperature sensor. Failure information is presented and summarized. A failure matrix is presented which describes the failure mode, type, mechanism, cause, and problem areas, for failures.

The integrity of the final design configuration was confirmed. Recommendations are made for actions which will reduce the quantity of rejections resulting from human errors.

CONTENTS

Section		Page
1	INTRODUCTION	1-1
2	DESCRIPTION, FAILURE SUMMARY, AND RECOMMENDATIONS FOR THERMISTOR BEAD WITH ELECTRONICS TYPE TEMPERATURE SENSOR	2-1
	Introduction	2-1
	Purpose and Description	2-1
	Performance and Design Data	2-1
	Qualification Status	2-1
	Failure and Design Review	2-1
	Recommendations	2-3

INTRODUCTION

This report presents a summary of failure data of the generic group of bead-type thermistors with electronics, one of several temperature sensor types that are described and categorized in AiResearch Report No. 72-8537-1.

The temperature sensor evaluated in this report was used in the Apollo environmental control system (ECS). This temperature sensor may be used to perform any other temperature sensing function with similar requirement.

The temperature sensor which is evaluated and summarized in this report is the Apollo cabin temperature sensor, PN 836930. Detailed failure data, a summary, and description information on this temperature sensor are presented in Section 2 of this report.

DESCRIPTION, FAILURE SUMMARY, AND RECOMMENDATIONS FOR THERMISTOR BEAD WITH ELECTRONICS TYPE TEMPERATURE SENSOR

INTRODUCTION

The initial design of cabin temperature sensor PN 836064 was implemented on the Apollo Block I ECS. This sensor, which had a coil type sensing element, was replaced by a new design, PN 836930, which was implemented on Apollo Block II ECS. The new design is analyzed in this section. The previous design, which utilizes a coil type sensing element is analyzed with the other coil type sensors in a separate report.

PURPOSE AND DESCRIPTION

A typical isometric drawing of the current cabin temperature sensor is presented in Figure 2-1. This sensor senses the cabin temperature at the inlet duct of cabin heat exchanger. The unit consists of a metal housing containing power supply, temperature sensing element, and signal conditioner. The temperature sensing element consists of two series bead thermistors mounted at the end of a probe. An internal power supply provides the necessary operating voltages and isolates the unit from 28-vdc spacecraft power. The signal conditioner converts sensing element current changes (due to resistance changes) into an output voltage for telemetry or visual display.

PERFORMANCE AND DESIGN DATA

Table 2-1 presents the performance and design data for these temperature sensors.

QUALIFICATION STATUS

The cabin temperature sensor is a qualified Block II Apollo component.

FAILURE AND DESIGN REVIEW

Table 2-2 is a summary of eight failure reports written against the -1 and -3 versions of PN 836930. The -3 version design is identical to the -1. The only difference between the -1 and the -3 is that the -3 acceptance test procedure includes a burn-in instruction over and above the ATP requirement of the -1 version. Human errors in design, manufacturing and handling were the problem sources for the eight rejections in a population of 38 units which represents a rejection rate of 21 percent.

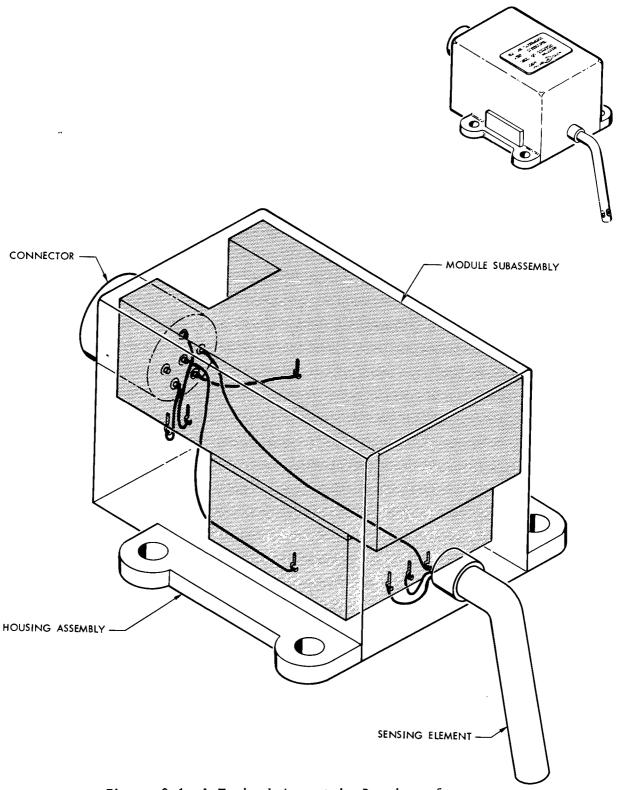


Figure 2-1. A Typical Isometric Drawing of Thermistor Bead With Electronics Temperature Transducer.

A-19700 s-32-250



TABLE 2-1

PERFORMANCE AND DESIGN DATA FOR PN 836930-1

Output signal Proportional to sensed temperature

0 v at 40° F and 5 vdc at 125° F

Accuracy ±2.5 percent of full scale output

 $(\pm 0.125 \text{ vdc})$ at 60° F to 80° F

 ± 5 percent of full scale output (± 0.25 vdc at 40° F to 60° F and

80°F to 125°F

Response time 10 sec max to 63.7 percent of total

change in 20 cfm air flow at 14.7

psia in 3 in. dia duct

Output impedance 500 ohms maximum

Load resistance 30,000 ±6000 ohms

Power consumption 80 ma max at 28 +2, -3 vdc

Weight, 1b 0.2

Two of the eight rejections (25 percent) were caused by design error. The unit was redesigned; and the problem area was eliminated. Four of the rejections (50 percent) were caused by erroneous assembly. The assembly MOT was revised; and the problem area was eliminated. One unit made a poor connection (12.5 percent) because of contamination. One unit was rejected (12.5 percent) because of a design criteria that is not evident in installation but produces a misleading signal on the test stand.

RECOMMENDATIONS

Since the design and manufacturing problems of this temperature sensor were resolved and eliminated in the development process of the unit, only the following recommendations are made to prevent human induced failures.

Manufacturing Criteria

- a. Provide detailed and up-to-date assembly and operations instructions to eliminate assembly problems.
- b. Retrain assembly personnel at scheduled intervals.

Design Criteria

Provide better protection for the probe to eliminate accidental damage.





CABIN TEMPERATURE TRANSDUCER FAILURE EVALUATION

TRANSDUCER	APPLICATION	ON CABIN	TEMPERATURE	E SENSOR		TRAI	NSDUCER TYPE TEMPE	RATURE	1	
BASIC PART					····· ,				LICO	
TRANSDUCER			СН					ERMISTOR WITH ELECTRON 125°F, 0 - 29 mv RMS	!	•
TROUBLE REP							SUREMENT MEDIA GAS		,	
PART NUMBER	SERIAL NUMBER	FAILURE DATE	T/R NUMBER	FAILURE TYPE	FAILURE MODE	FAILURE MECHANISM	FAILURE CAUSE	PROBLEM AREA	CORRECTIVE ACTION	COMMENTS
836930-3	108-135	11/27/68	19130	Human	Low insulation resistance	Short	Bad assembly	Manufacturing	Assembly not revised	
836930-3	36-109	1/15/69	NAA 61062	Human	Circuit breaker trips	Input diodes shorted	Erroneous assembly	Manufacturing	None	
836930-I	36-103	6-16-68	NAA A 91329	Human	Unstable	Burned	Overheated by heat gun	Manufacturing	None	
836930-1	37-126	6-21-68	NAA A 91338-B	Human	Low temp. reading	Insufficient base current	Resistor	Design	None	Once installed the low temp condition will never occur
836930-1	37-125	3-20-68	16613	Human	Inresponsive to temp. change	Low current draw	Bad connection	Manufacturing Q.C.	Q.C. notified	
836930-1	37-123	5-31-67	14179	Human	Low output	Low resistance	Low power	Engineering	Unit redesigned	
836930-1	37-124	5-31-67	14178	Human	High current output	Low resistance	Low power	Engineering	Unit redesigned	
836930-1	36-103	6-14-66	10382	Human	Low insulation resistance	Bad connection	Contamination	Manufacturing procedures	None	



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PERCENT	LOW RESISTANCE	C.B. TRIP	UNSTABLE	LOW OUTPUT	FIXED OUTPUT	HIGH OUTPUT							HUMAN	I A OT GT OF 1 P	MECHANIC	E	LEC.		MEC	(AH	NICA	AL —									I ME(217			
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12.5					1								ı					T																		1		RECEIVING INSPECTION		FINAL
																																					1	INSTALLATION		INSTALLATION
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100	25	12.5	12.5	25	12 5	2	7						9	3										12.	25	37.5	12.5									12.		PERCENT		
		•																						ATION	~	MBLY										RE				
																								CONTAMINATION	LOW POWER	POOR ASSEMBLY	DAMAGED									O FAILURE	-			
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																																						Figure 2-2. Therm	nist	or Bead w it ics Type Te



Electronics Type Tem-perature Sensor Failure Matrix 72



AIRESEARCH MANUFACTURING COMPANY

Los Angeles, California

REPORT ON FAILURE AND DESIGN EVALUATION OF APOLLO ECS TEMPERATURE SENSORS,

COIL WITH ELECTRONICS TYPE

CONTRACT NO. NAS 9-12452

72-8537-15, Rev. I

February 10, 1973

Prepared by A. Saginian

APPROVED:

R. E. Vesque

Program Manager

APPROVED.

ي**ل. B**rudnicki

Principal Investigator

NASA MANNED SPACECRAFT CENTER HOUSTON, TEXAS 77058

ABSTRACT

This report presents the results of a failure and design evaluation study conducted on the Apollo ECS temperature sensors, the generic group of coil with electronics type temperature sensors. The study was conducted for NASA-MSC by the AiResearch Manufacturing Company, a division of The Garrett Corporation under Contract NAS9-12452.

The study purpose was to evaluate the integrity of design of this type sensors. Failure information is presented and summarized pertaining to four sensor designs. A failure matrix is presented which describes the failure mode, type, mechanism, cause, and problem areas for 38 rejections out of a lot total of 167 units.

The integrity of the design was confirmed. Recommendations are made to reduce the failure rate from the current level of 15 percent.



CONTENTS

Section		Page
1	INTRODUCTION	1-1
2	DESCRIPTION, FAILURE SUMMARY, AND RECOMMENDATIONS FOR COIL AND ELECTRONICS TYPE TEMPERATURE TRANSDUCER	2-1
3	RADIATOR WATER-GLYCOL OUTLET TEMPERATURE TRANSDUCER	3-1
4	STEAM DUCT TEMPERATURE TRANSDUCER	4-1
5	SUIT SUPPLY TEMPERATURE TRANSDUCER	5-1
6	CABIN TEMPERATURE TRANSDUCER	6-1

INTRODUCTION

This report presents a summary of failure data of the generic group of coil with electronics type temperature transducer, one of several temperature sensor types that are described and categorized in AiResearch Report No. 72-8537-1. Four coil with electronics type temperature transducers were evaluated in one configuration group: (1) cabin temperature transducer, (2) suit supply temperature transducer, (3) steam duct temperature transducer, and (4) radiator water-glycol outlet temperature transducer.

One of the temperature transducers evaluated in this report was used in the Apollo environmental control system (ECS) Block I only was replaced by a bead with electronics type temperature transducer in the Block II ECS. A second transducer used to have a preceding part number which was changed during a design revision. These three temperature transducers have been used in the Apollo ECS Block I and Block II. All four of these transducers may be used to perform other temperature sensing functions with similar requirements.

The temperature transducers that are evaluated and summarized in this report are, by AiResearch part number:

<u>PN</u>	Nomenclature
836064-1	Cabin Temperature Sensor
836064-2	Cabin Temperature Sensor
836950-1	Suit Supply Temperature Sensor
836950-2	Steam Duct Temperature Sensor
836060-1	Steam Duct Temperature Sensor
836054-1	Suit Supply Temperature Sensor
836058-1	Radiator Water-Glycol Outlet Temperature Sensor
836058-2	Radiator Water-Glycol Outlet Temperature Sensor

Section 2 of this report presents a failure summary on all four transducers combined, descriptive information on a typical coil with electronics temperature transducer and recommendations for actions which will reduce the quantity of rejections. The reason for combination of analysis of four temperature transducers in Section 2 and their treatment as a single design is that in reality the principles of operation in all four transducers are identical and only slight variation of packaging and signal conditioning components constitutes the difference.

Detail design and failure data on each of these temperature transducers are presented in Sections 3 through 6 of this report.



DESCRIPTION, FAILURE SUMMARY AND RECOMMENDATIONS FOR COIL AND ELECTRONICS TYPE TEMPERATURE TRANSDUCER

DESCRIPTION

The isometric drawing of a typical coil with electronics temperature transucer is presented in Figure 2-1. The unit consists of a metal housing containing a coil type sensing element, a resistance-bridge circuit, and a transformer coupled output circuit.

The coil type sensing element which is identical in all four of the subject transducers, is a coil of coated 40-gage platinum wire enclosed within a wall of 14K-gold tubular probe and has a positive coefficient of resistance, forms the measured branch of the resistance-bridge circuit of the transducer. The resultant signal is transmitted through the transformer coupled output circuit of the transducer for further signal treatment and eventual implementation.

FAILURE SUMMARY

Summaries of detail failure analysis of each of the four temperature transducers evaluated are presented in Sections 3 through 6 of this report. However, because all four of the transducers have the same principle of operation the failures of individual designs are combined to present the general value and reliability of this type of transducer in its temperature sensing and signal transmitting application.

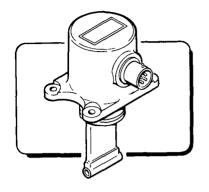
Thirty nine failure reports, written against these transducers and furnished by NASA-MSC, were reviewed. The results of these reports are summarized in the failure matrix shown in Figure 2-2. This matrix is a summary of the individual matrixes presented in turn for each of these four temperature transducers. One of the failure reports was a duplication of another failure report. The remaining 38 rejections (100 percent) were determined to be due to human error. A total of 38 rejections from a population of 176 units represents a rejection rate of 22.8 percent.

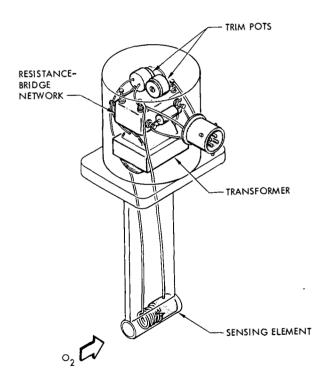
A review of the failure matrix of Figure 2-2 indicates that there is no basic design problem area for this type of temperature transducer. This conclusion is based on the following observations on the failure matrix.

Non-Specific Problem Area

- (a) There was no information concerning the failure cause of the transducers in the two failure reports which were not analyzed.
- (b) Eight failures were not confirmed and the responsibility of the reports belongs to their initiators.







S-32-170

Figure 2-1. Isometric Drawing of a Typical Coii With Electronics Type Temperature Transducer.

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100	7.9	42.1	105	7.9	158	122	7									2.6	100			5.3		2.6					105	2.6	5.3	7.9	263						,		7	21.5	347	PERCENT		
																				SHORT		DAMAGED					SEAL LEAKAGE	LOOSE	POOR A	DAMAG	CAL I BRATION								N	ם מי	NO FAILURE	Figure 2-2. Coil W Type To	emp uce	Electronics erature r Failure



There is no basic problem area to be dealt with; therefore, no corrective action is recommended.

Laboratory Equipment and Handling

- (a) Three units were damaged in handling.
- (b) One unit was rejected because of test equipment failure. Equipment failure has no reflection on the integrity of the transducer.

A problem source exists in handling which must be eliminated.

Manufacturing

- (a) One unit was rejected because of test error while the unit had not failed.
- (b) Nine units failed as a result of faulty calibration.
- (c) Eight units failed because of various assembly problems.

A problem source exists in testing equipment and procedure as well as in manufacturing operations and tooling (MOT) which must be eliminated.

Engineering

- (a) One unit was rejected because of qualification test procedure error while the unit had not failed.
- (b) One unit was rejected because of qualification test error while the unit had not failed.
- (c) four units were rejected because of design errors. One unit exhibited high output because of the sensor orientation in the assembly which the unit had not failed. Three units failed because of wrong choice of components.

All of the engineering problem sources have been eliminated by corrective actions.

Transducer Problem Area Evaluation

Since none of the open problem areas mentioned above are design problems, the conclusion is that the transducer design is trouble-free and is recommended to be considered for future applications.

Failure Distribution

Figure 2-3 illustrates the distribution of failures according to problem area. Figure 2-4 illustrates this distribution after design change which will eliminate the recurrence of engineering-error-related failures and after the discard of unconfirmed failures.



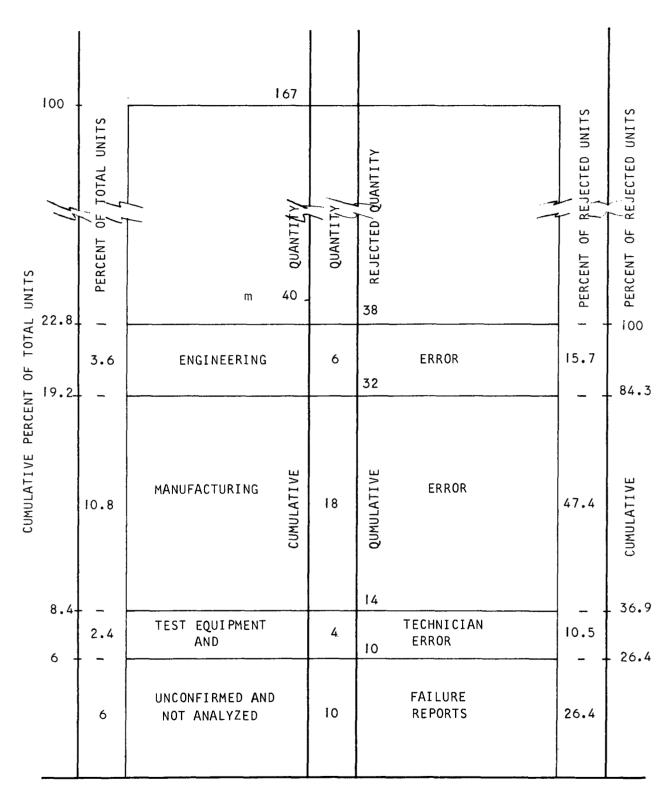


Figure 2-3. Distribution of Failures According to Problem Area.



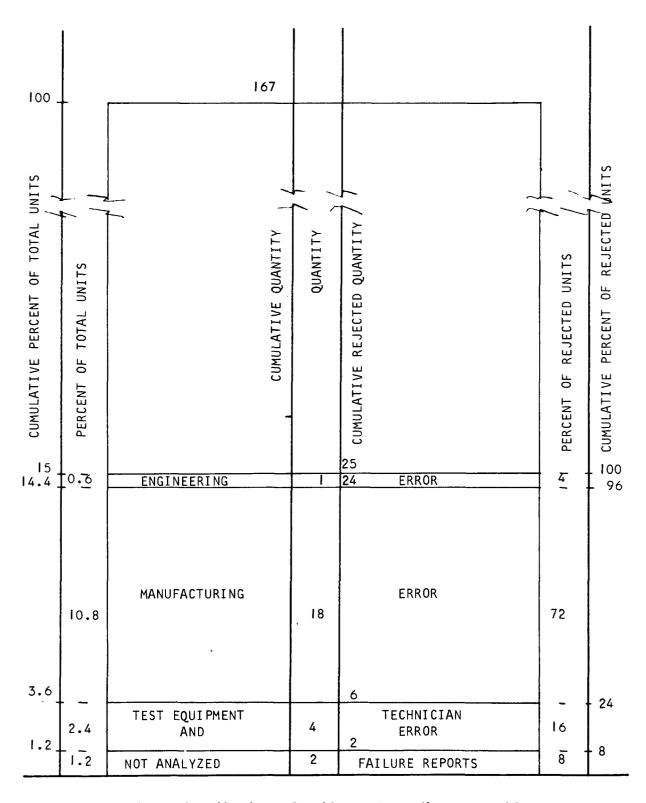


Figure 2-4. Distribution of Failures According to Problem Area After Elimination of Engineering Errors and Unconfirmed Failures

According to the data in Figure 2-4, from the total population of 167 units 15 percent were rejected. Of these, 72 percent were caused by manufacturing errors and none could be classified as random failure and all rejections were potentially avoidable.

RECOMMENDATIONS

Most failure reports on coil with electronics temperature transducers were the result of either manufacturing error or external damage in test and handling. As a result, the following recommendations are made with respect to design, manufacturing, test, and handling criteria:

Design Criteria

(a) Incorporate a protective open shell around the sensing element which will not disturb free flow and in the mean time will protect sensing element from external damage.

Manufacturing Criteria

(a) Necessary inspection requirements should be provided to prevent the passage of the faulty assembled components to the final assembly.

Test and Handling Criteria

- (a) ATP and QTP documents should be reviewed and amended as necessary to minimize the possibility of test technician error in the conduct of the test and to provide adequate calibration tolerance without compromizing specification requirements.
- (b) Protective covers or containers should be provided which will be removed at the assembly time to minimize the possibility of accidental damage to the part during various manufacturing processes.

RADIATOR WATER-GLYCOL OUTLET TEMPERATURE TRANSDUCER (AIRESEARCH PN 836058)

PURPOSE AND DESCRIPTION

This transducer senses the water-glycol coolant temperature at the space radiator outlet and in conjunction with the associated in-flight signal amplifier it provides a signal proportional to the sensed temperature.

The unit consists of a metal housing containing a coil type sensing element, a resistance-bridge circuit, and a transformer coupled output circuit. The coil type sensing element, which has a positive coefficient of resistance, forms the measured branch of the resistance-bridge circuit of this unit. The resultant signal is transmitted to the associated in-flight temperature sensor amplifier through the transformer coupled output circuit of the radiator outlet temperature sensor. This signal is amplified and the amplifier output signal is used for telemetry purposes.

PERFORMANCE AND DESIGN DATA

Table 3-1 lists performance and design data and Figure 3-1 presents the outline for this transducer.

FAILURE REVIEW

Table 3-2 is a summary of 12 failure reports written against 14 units of this transducer. Two of the failure reports were not reported and information is not available. One failure report on unit leakage was not verified. One unit was shorted by faulty soldering. One unit was rejected because of improper location for certain vehicle orientations. Two units were rejected because of moisture entry into the electronic package. One unit was rejected because of moisture in the test equipment. Finally, six units were rejected because of calibration problems.

All of the above mentioned rejection causes were human induced. Calibration of the unit has been a problem source. However, revision of TI and ATP eliminated this problem source and provided for the screening of the leaking units.

TABLE 3-1

PERFORMANCE AND DESIGN DATA FOR PN 836058

Performance Requirements:

- a. Operating temperature range: -50° F to $+100^{\circ}$ F
- b. Accuracy: $\pm 1.0^{\circ} F$ ($\pm 0.67\%$ of total operating range) between $25^{\circ} F$ and $60^{\circ} F$ and $\pm 3.0^{\circ} F$ ($\pm 2.0\%$ of total operating range) at $-50^{\circ} F$ and $+100^{\circ} F$
- c. Output Signal: Proportional to sensed temperature: Zero at -50° F and 59 mv peak-to-peak, sq wave (with 260 ±2.6 ohm load) at 100° F
- d. Output impedance: 1300 ohms max.
- e. Time constant: 6.0 sec max.
- f. Power dissipation of sensing element: 46 mw max.

Bridge Excitation Voltage: 5.4 v peak-to-peak, 300 cps, sq wave at 140 ma max.

Operating Pressures:

- a. Max: 60 psig (relative to cabin)
- b. Pressure drop across sensor: 0.25 in. water max. at flow rate of 200 lb/hr

Structural Requirements:

a. Proof pressure: 90 psig

b. Burst pressure: 150 psig

External Leakage: Zero with 60 psig internal pressure

Environmental Conditions: As per AiResearch Report SS-1060-R; Type I equipment

Installation Envelope: Per AiResearch Drawing 836058

Weight: 0.3 lb

Electrical Connector: In accordance with MIL-C-26482C

Radio Noise: In accordance with NAA Specification MC 999-0002A.



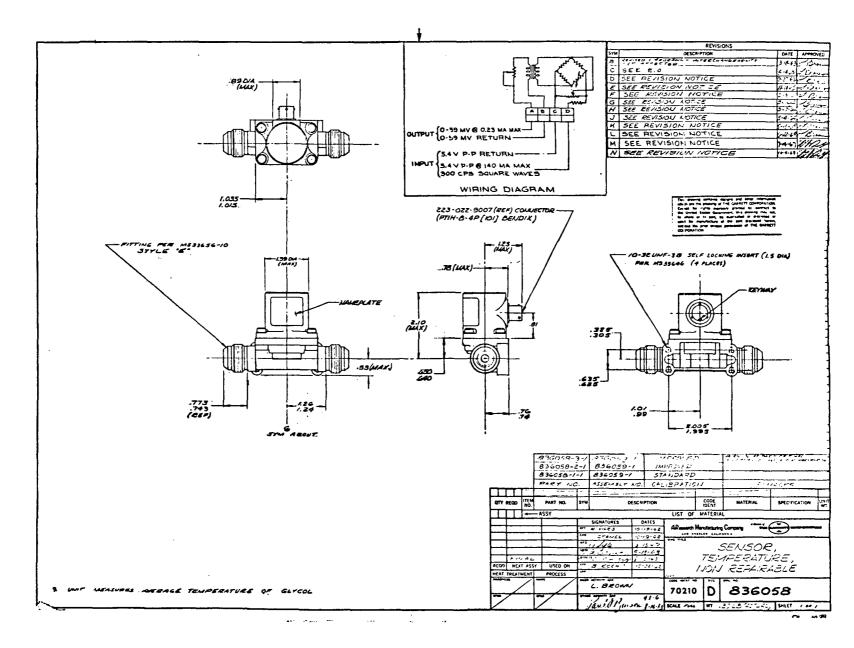


Figure 3-1. Altered Outline of Water-Glycol Outlet Temperature Transducer

FOLDOUT FRAME



RADIATOR WATER-GLYCOL OUTLET TEMPERATURE TRANSDUCER FAILURE EVALUATION

TRANSDUCER	APPLICATI	ON <u>RADIAT</u>	OR WATER-GLY	COL OUTLE	T TEMP SENSOR	TRA	NSDUCER TYPETEMP	PERATURE				
			431-0047 (NA				RATING PRINCIPLE RE	ESISTANCE BRIDGE	1			
TRANSDUCER I	MANUF					MEA	SUREMENT RANGE	F TO +100°F				
TROUBLE REP	ORT SOURC	E AIRES	EARCH			MEA	MEASUREMENT MEDIA WATER-GLYCOL COOLANT					
PART NUMBER	SERIAL NUMBER	FAILURE DATE	T/R NUMBER	FAILURE TYPE	FAILURE MODE	FAILURE MECHANISM	FAILURE CAUSE	PROBLEM AREA	CORRECTIVE ACTION	COMMENTS		
ME431-0047- 0001	00400 0126138	11-22-69 FLIGHT	SD69-429-04	HUMAN	HIGH OUTPUT	SENSOR, IMPROPERLY LOCATED FOR SOME VEHICLE ORIENTATIONS	THERMAL STRATIFI- CATION OF MEDIA	DESIGN, PRIME RESPONSIBILITY	NONE	THIS IS NOT A FAILURE AREA PRIME RESPONSI- BILITY		
836058-2-1	88-145	4-10-69	19173	HUMAN	HIGH OUTPUT	ELECTRONICS PACKAGE	IMPROPER CALIBRATION AND TEST	MANUFACTURING	SURVEILLANCE FOR RECURRENCE OF PROB- L'EM	THIS IS NOT A FAILURE IMPROPER CALIBRATION OCCURRED AT MFG LEVEL		
ME431-0047- 0001	00400 46133	12-27-68 FLIGHT	PF103512	HUMAN	HIGH OUTPUT	ELECTRONICS PACKAGE	MOISTURE	IMPROPER INSTALLA- TION IN VEHICLE	INSTRUCT PERSONNEL IN PROPER HANDLING AND INSTALLATION PROCEDURES	PRIME RESPONSIBILITY		
836058-2-1	46-123	11-20-68	19127	HUMAN	LOW IR	ELECTRONICS PACKAGE	SHORTED SOLDER JOINTS	MANUFACTURING		UNIT RETURNED FROM PRIME-WAS SHIPPED PRIOR TO TI & ATP REVISIONS		
836058-2-1	46-133	11-17-67	16514	HUMAN	HIGH OUTPUT	NONE - HIGH OUTPUT DI	E TO MOISTURE IN TEST	EQUIPMENT, THIS IS	NOT A FAILURE			
836058-1-1	46-121	7-25-67	8884	HUMAN	LOW IR	•	MOISTURE ENTRY THROUGH POROUS POR- TIONS OF SOLDER JOINT	MANUFACTURING	TI AND ATP REVISIONS TO SCREEN OUT DEFECTIVE UNITS			
836058-1-1		10-16-66 8-12-67		HUMAN	OUT OF CALIBRATION	,	WRONG CALIBRATION LIMITS USED	MANUFACTURING	CALIBRATION PROCE- DURES CHANGED			
836058-1-1			11089	HUMAN	LOW OUTPUT	,	IMPROPER INITIAL CALIBRATION	MANUFACTURING	NONE-UNIT RECALI- BRATED	THESE ARE NOT FAILURES. IMPROPER CALIBRATION OCCURRED DURING MFG PRIOR TO ATP.		
							·					

TABLE 3-2 (Continued)

					ET TEMP SENSOR	TR#	NSDUCER TYPETE	MPERATURE				
BASIC PART N	NUMBER <u>83</u>	6058, ME ¹	+31-0047 (NA	R PN)		OPE	RATING PRINCIPLE R					
TRANSDUCER	MANUF					MEA	MEASUREMENT RANGE +50°F TO +100°F					
TROUBLE REP	ORT SOURC	E _ AIRESE	ARCH			MEA	SUREMENT MEDIAWATE	R-GLYCOL COOLANT	 			
PART NUMBER	SERIAL NUMBER	FAILURE DATE	T/R NUMBER	FAILURE TYPE	FAILURE MODE	FAILURE MECHANISM	FAILURE CAUSE	PROBLEM AREA	CORRECTIVE ACTION	COMMENTS		
836058-1-1	46-122	6-12-66	9260	HUMAN	OUT OF CALIBRATION		E - CALIBRATION AND VINGENT FOR EQUIPMENT		ATP REVISED TO EXPAND ACCEPTABLE CALIBRATION & INPUT VOLTAGE PARAMETERS			
836058-1-1	14-102	6-7-66	7661	HUMAN	LEAKAGE	FAILURE COULD NOT BE	VERIFIED					
836058-1-1	104-111	5-20-66	MA 17741	HUMAN	HIGH OUTPUT	NOT REPORTED	NOT REPORTED	NOT REPORTED	NOT REPORTED			
836058-1-1	104-109	4-9-65	5782	HUMAN	HIGH OUTPUT	NOT REPORTED	NOT REPORTED	NOT REPORTED	NOT REPORTED			
					,							
	,, <u> </u>											



STEAM DUCT TEMPERATURE TRANSDUCER (AIRESEARCH PN 836060-1 SUPERCEDED BY PN 836950-2)

PURPOSE AND DESCRIPTION

This transducer senses the steam temperature in the glycol evaporator steam discharge line, and in conjunction with the associated in-flight signal amplifier it provides a signal proportional to the sensed temperature.

The unit consists of a metal housing containing a coil type sensing element, a resistance-bridge circuit, and a transformer coupled output circuit. The coil type sensing element, which has a positive coefficient of resistance, forms the measured branch of the resistance-bridge circuit of this unit. The resultant signal is transmitted to the associated in-flight temperature sensor amplifier through the transformer coupled output circuit of the steam duct temperature sensor. This signal is amplified and the amplifier output signal is used for telemetry purposes.

PERFORMANCE AND DESIGN DATA

Table 4-1 lists performance and design data for this transducer, and Figures 4-1 and 4-2 present the outlines of these two designs.

FAILURE REVIEW

Table 4-2 is a summary of two failure reports on part number 836950-2. Table 4-3 is a summary of four failure reports on part number 836060-1. These NASA-MSC furnished failure reports were reviewed for this transducer evaluation.

The initial design of this transducer, PN 836060-1 had a heat generating electronics package. A design change effort was initiated as a result the new design PN 836950-2 supersedes the initial design. This design change eliminated the self heat generating problem of the electronics package of the superseded unit.

The two failure reports on the new design are results of technician errors. Recommendations to minimize the possibility of the recurrence of such failures are given in Section 2 of this report.

TABLE 4-1

PERFORMANCE AND DESIGN DATA FOR PN'S 836060-1 AND 836950-2

Performance Requirements:

- a. Operating temperature range: $20^{\circ}F$ to $95^{\circ}F$
- b. Accuracy: ±1.5° (±2.0% of total operating range).
- c. Output signal: Proportional to sensed temperature. Zero at 20°F and 59 mv peak-to-peak sq wave (with 260 ±2.6 ohm load) at 95°F
- d. Output impedance: 500 ohms max.
- e. Time constant: 6.0 sec max.
- f. Power dissipation of sensing element: 46 mw max.

Bridge Excitation Voltage: 5.4 v peak-to-peak, 300 cps, sq wave at 140 ma max.

Operating Pressures:

a. Normal: 0 to 1 psia

b. Max: 20 psia

Environmental Conditions: As specified in AiResearch Specification SS-1060-R; Type I equipment

Installation Envelope: Per AiResearch Drawing 836060

Weight: 0.20 lb

Electrical Connector: In accordance with MIL-C-26482C

Radio Noise: In accordance with NAA Specification MC 999-0002A

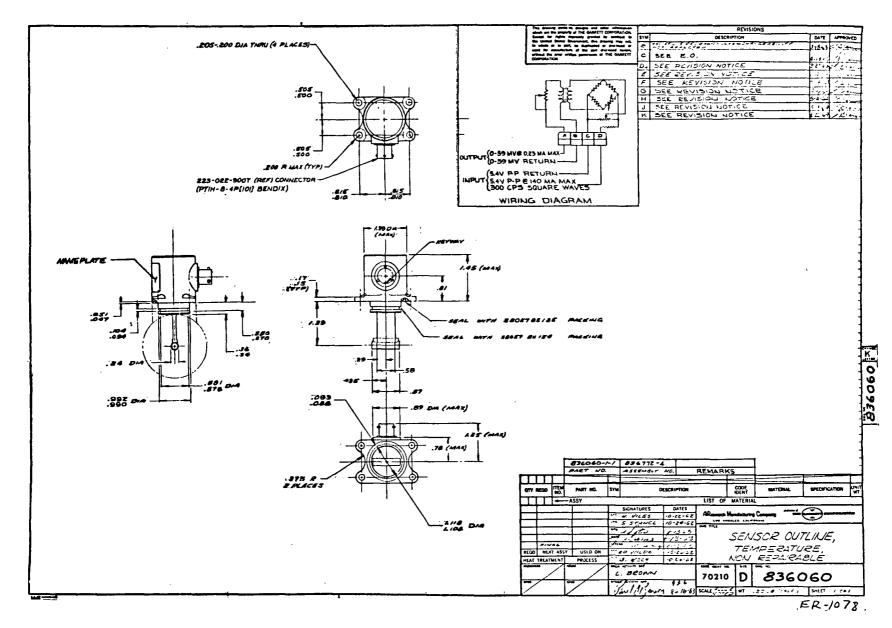


Figure 4-1. Altered Outline Of Steam Duct Temperature Transducer.

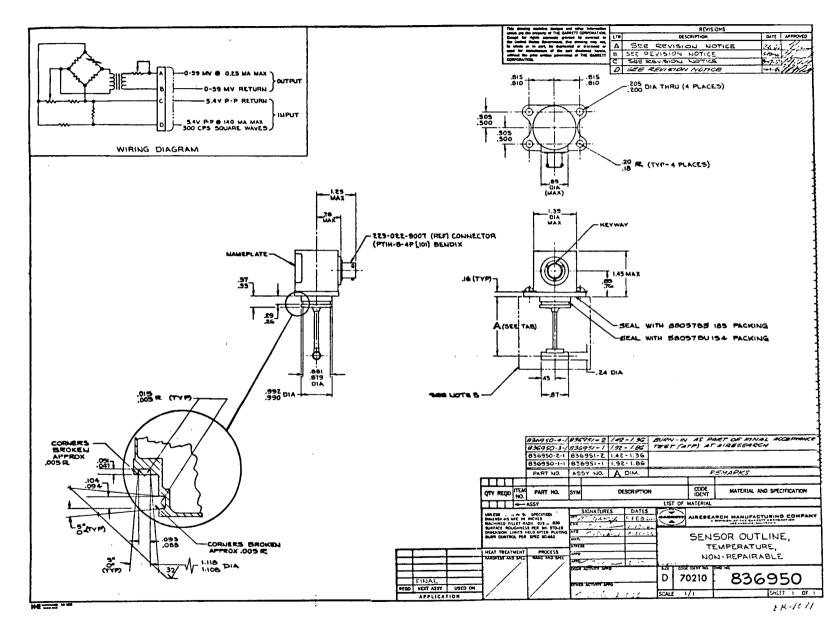


Figure 4-2. Altered Outline of Steam Duct Temperature Transducer.

TABLE 4-2

FOLDOUT FRAME



STEAM DUCT TEMPERATURE TRANSDUCER FAILURE EVALUATION

TRANSDUCER	APPLICATI	ON <u>STE</u>	AM DUCT TEM	PERATURE T	RANSDUCER	TR	ANSDUCER TYPE	TEMPERATURE		
BASIC PART	NUMBER	836950-2		 		OP	ERATING PRINCIPLE _	WHEATSTONE BRIDGE WIT	TH SENSING ELEMENT AS	ONE ARM
TRANSDUCER						ME.	ASUREMENT RANGE			
TROUBLE REP	ORT SOURC	E AIRESE	ARCH			ME.	ASUREMENT MEDIA	STEAM AND FREE H20 EXI	HAUSTED TO SPACE	
PART NUMBER	SERIAL NUMBER	FAILURE DATE	T/R NUMBER	FAILURE TYPE	FAILURE MODE	FAILURE MECHANISM	FAILURE CAUSE	PROBLEM AREA	CORRECTIVE ACTION	COMMENTS
836950-2-1	88-134	5-21-69	19183	HUMAN	LOW OUTPUT	USE OF INCORRECT TEST EQUIPMENT	WRONG LOAD RESISTANCE	TEST	NONE	
836950-2-1	46-101	4-27-67	8896	HUMAN	OUT OF CALIBRATION	ELECTRONIC PACKAGE	R5 DAMAGED	PLANNING	NONE	R5 DAMAGED BY DRILL BIT DURING MODIFICA- TION
				·						
										·



TABLE 4-3

FOLDOUT FRAME

STEAM DUCT TEMPERATURE TRANSDUCER FAILURE EVALUATION

TRANSDUCER	APPLICATI	ON STEAM	DUCT TEMPERA	ATURE TRAI	NSDUCER	TR/	ANSDUCER TYPE <u>TEMPE</u>	RATURE					
BASIC PART	NUMBER	836950, 8	336060 (BLOCE	(1)					NSING ELEMENT AS ONE F	ARM			
TRANSDUCER	MANUF						MEASUREMENT RANGE						
TROUBLE REP	ORT SOURC	E AIRESE	ARCH			MEA	MEASUREMENT MEDIA STEAM AND FREE H20 EXHAUSTED TO SPACE						
PART NUMBER	SERIAL NUMBER	FAILURE DATE	T/R NUMBER	FAILURE TYPE	FAILURE MODE	FAILURE MECHANISM	FAILURE CAUSE	PROBLEM AREA	CORRECTIVE ACTION	COMMENTS			
836060-1-1 (BLK I)	14-103	10-13-66	11364	HUMAN	LOW INSULATION RESISTANCE	ELECTRONIC PACKAGE SHORT CIRCUIT	SENSE ELEMENT CORRODED	DESIGN	REDESIGN TO USE SENSOR ELEMENT WITH BETTER CORROSION RESISTANCE				
836060-1-1	14-104 (BLK 1)	10-21-65	6602	HUMAN	OUT OF CALIBRATION	ELECTRONIC PACKAGE RESISTANCE CHANGE	THERMAL CONDUCTION	DESIGN	REDESIGN				
836060-1-1 (BLK I)	14-104	5-14-65	N.R. TR 313 A/R TR 6056		OUT OF CALIBRATION AT LOW TEMP.	TEST EQUIPMENT	TEST EQUIPMENT	TESTING	REVISE TEST HOOK-UP AND CRITERIA				
836060-1-1 (BLK I)	14-104	5-1-65	6057	NOT REPOR	RTED, DUPLICATION OF	R #6056				TR VOID			
					,								
		·				·							
							·						

SUIT SUPPLY TEMPERATURE TRANSDUCER (AIRESEARCH PN'S 836950-1 AND 836054-1)

PURPOSE AND DESCRIPTION

These transducers sense the oxygen temperature at the suit inlet and in conjunction with the associated in-flight signal amplifier they provide signals proportional to the sensed temperature.

The unit consists of a metal housing containing a coil type sensing element, a resistance-bridge circuit, and a transformer-coupled output circuit. The coil type sensing element, which has a positive coefficient of resistance, forms the measured branch of the resistance-bridge circuit of this unit. The resultant signal is transmitted to the associated in-flight amplifier through the transformer coupled output circuit of the suit supply temperature sensor. This signal is amplified and the amplifier output signal is used for telemetry purposes and visual readout.

PERFORMANCE AND DESIGN DATA

Table 5-1 lists performance and design data for this transducer, and Figures 5-1 and 5-2 present the outlines of these two designs.

FAILURE REVIEW

Table 5-2 is a summary of six failure reports on PN 836950-1. Table 5-3 is a summary of five failure reports on PN 836054-1. These NASA-MSC furnished reports were reviewed for this transducer evaluation.

The initial design of this transducer, PN 836054-1, had a heat generating electronics package. A design change effort was initiated and as a result the new design PN 836950-1 supersedes the initial design. This design change eliminated self heat generating problem of the electronics package of the superseded unit.

The five failure reports on the new design are results of technician errors. Recommendation to minimize the possibility of the recurrence of such failures are given in Section 2 of this report.

TABLE 5-1

PERFORMANCE AND DESIGN DATA FOR PN'S 836054-1 AND 836950-1

Performance Requirements:

a. Operating temp range, ^O F 20 to 99	a.	Operating	temp	range,	°F	20 to 95
--	----	-----------	------	--------	----	----------

c. Output signal, cps 300 sq-type wave with wave magnitude proportional to sensed temp 0 at
$$20^{\circ}$$
F and 29.5 rms, sq wave (with 270 ±2.7 ohms load) at 95° F

Bridge Excitation Voltage: 2.70 ±0.05 vrms, 300 cps, sq-type waves

Operating Pressures:

а.	Normal,	nsia	5.22)
a.	110111111111,	para	7.22	-

Structural Requirements:

a.	Proof	pressure,	psia	6
~ .		p. 033410,	P - 1 - 9	•

External Leakage:
$$6 \times 10^{-6}$$
 lb/hr 0_2 , installed in duct,

at 4 psig and 70⁵F

Environmental Conditions: Per AiResearch Report Ss-1060-R; Type I

equipment

<u>Installation Envelope</u>: Per AiResearch Drawing 836054

TABLE 5-1 (Continued)

Electrical Connector:

In accordance with MIL-C-26482C

Radio Noise:

In accordance with NAA Specification

MC 999-002A

Weight:

0.2 lb

Qualification Testing:

This unit is a qualified Block II

Apollo component

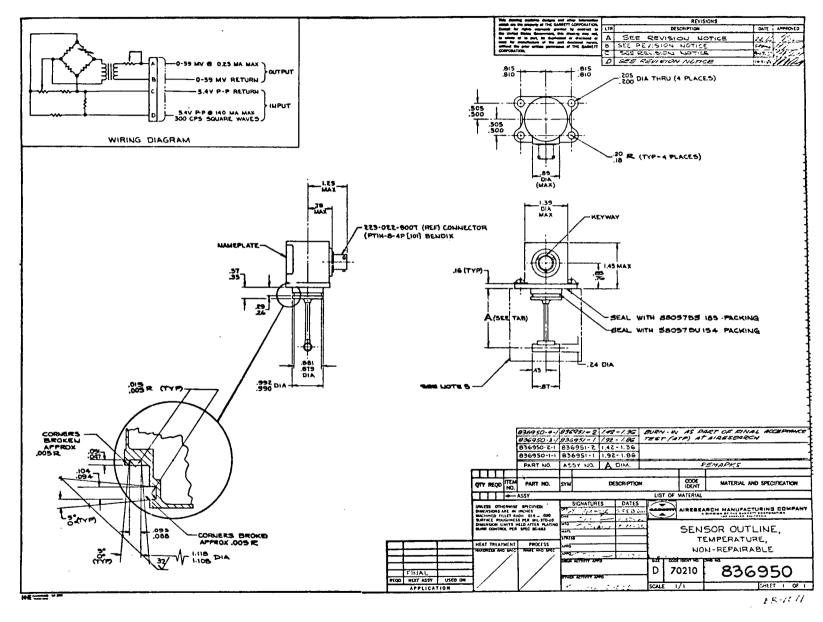


Figure 5-1. Altered Outline of Suit Supply Temperature Transducer

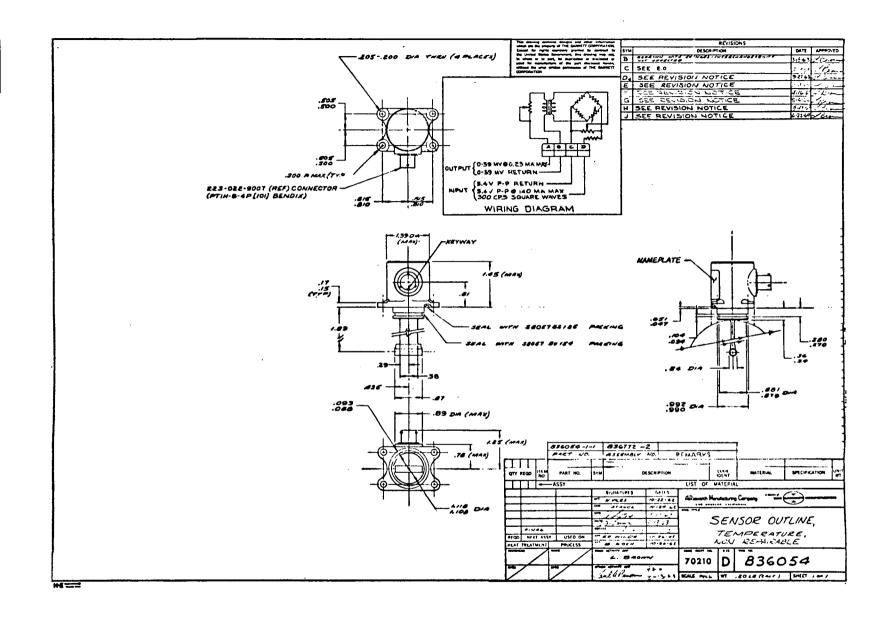


Figure 5-2. Altered Outline of Suit Supply Temperature Transducer

TABLE 5-2 SUIT SUPPLY TEMPERATURE TRANSDUCER FAILURE EVALUATION

TRANSDUCER	APPLICATIO	ON SUIT	SUPPLY TEMP S	SENSOR			TRANSDUCER TYPE					
BASIC PART N	NUMBER NE	R:ME431-00	074 A/R 8369	950			OPERATING PRINCIPLE					
TRANSDUCER I	MANUF. AI	RESEARCH					MEASUREMENT RANGE					
TROUBLE REPO	ORT SOURCE	E					MEASUREMENT MEDIA					
PART NUMBER	SERIAL NUMBER	FAILURE DATE	T/R NUMBER	FAILURE TYPE	FAILURE MODE	FAILURE MECHANISM	FAILURE CAUSE	PROBLEM AREA	CORRECTIVE ACTION	COMMENTS		
836950-1-1	46-111	8-15-66	A/R 10904-9	HUMAN	LOW OUTPUT	CALIBRATION	CALIBRATION ERROR	TEST	UNIT RECALIBRATED			
836950-1-1	46-101	10-14-66	11369	NOT REPOR	TED, TECHNICIAN ERROR	IN READING	•					
836950-1-1	46-118	10-14-69	A/R 20306	HUMAN	HIGH OUTPUT	LOOSE TRIM POT RESISTANCE CARD	RESISTANCE CARD IN TRIM POT WAS NOT CEMENTED	RANDOM HUMAN ERROR	SPECTRAL TRIM POT MODIFIED TO ELIMI- NATE HUMAN ERROR			
836950-1-1	46-101	7-25-67	A/R 15456-9		HIGH EXTERNAL LEAKAGE	CASE LEAKAGE	SPECIAL INSTRUMENTA- TION HOLE FOR QUAL TEST NOT PLUGGED	TEST	XDUCER REMOVED AND IDENTIFIED AS SPECIAL FOR QUAL TEST			
836950-1-1	46-101	10-14-66	A/R 11369-9	HUMAN	HIGH OUTPUT			TECHNICIAN ERROR		NOT A FAILURE		
836950-1-1	46-110	8-19-66	A/R 10925-9	HUMAN	LOW OUTPUT	CALIBRATION	CALIBRATION ERROR	TEST	UNIT RECALIBRATED			



72-8537-15 Page 5-6

FOLDOUT FRAM

TABLE 5-3

SUIT SUPPLY TEMPERATURE TRANSDUCER FAILURE EVALUATION

													
TRANSDUCER	APPLICATION	ON <u>SUIT S</u>	JPPLY TEMP S	SENSOR		TR/	ANSDUCER TYPE		 				
BASIC PART N	NUMBER NI	R ME431-0	074 AIRE	SEARCH 83	6950		ERATING PRINCIPLE						
TRANSDUCER I	MANUF. AIR	RESEARCH					SUREMENT RANGE			•			
TROUBLE REP	ORT SOURC	Ε					MEASUREMENT MEDIA						
PART NUMBER	SERIAL NUMBER	FAILURE DATE	T/R NUMBER	FAILURE TYPE	FAILURE MODE	FAILURE MECHANISM	FAILURE CAUSE	PROBLEM AREA	CORRECTIVE ACTION	COMMENTS			
836054-1	104-108	4-26-65	NR 305		OUTPUT HIGH (SPIKE OF 17.82 MV SHOULD NOT BE OVER 16.32 MV)			TEST EQUIPMENT	REVISE QTP SS-1232R TO ACCOMMODATE SCALE ERROR				
836054-1	14-103	7-16-64	A/R 3524	HUMAN		ELEC SHORT (WIRE TO CASE)	METAL JOINING TEMP OF HOUSING & MANDREL MELTED THE INSULATION	DESIGN	USE HI SILVER 14K GOLD FOR JOINING AT TEMP	-			
ME431-0074- 0001	46-117	10-29-69	NR A146407A	HUMAN		O-RING (BETWEEN SENSOR AND DUCT)	DAMAGED O-RING	INSTALLATION	REPLACE O-RING AND LEAKAGE TEST				
836054-1-1	84-120	9-20-66	TR 8849	HUMAN	DAMAGED	ELEC CONNECTOR PARTIALLY SEPARATED FROM FLANGE BASE	UNKNOWN						
836054-1-1	104-109	9-2-66	NR 22287	HUMAN	I	PROTECTIVE TUBE PULLED LOOSE	CORROSION AND MIS- HANDLING DURING DISASSEMBLY	HANDL I NG	PERSONNEL CAUTIONED				



CABIN TEMPERATURE TRANSDUCER (AIRESEARCH PN 836064-1)

PURPOSE AND DESCRIPTION

This transducer, before it was superseded in Apollo Block II, sensed the cabin temperature and in conjunction with in-flight signal amplifier it provided a signal proportional to the sensed temperature.

The unit consists of a metal housing containing a coil type sensing element, a resistance-bridge circuit, and a transformer coupled output circuit. The coil type sensing element, which has a positive coefficient of resistance, forms the measured branch of the resistance-bridge circuit of this unit. The resultant signal is transmitted to the associated in-flight temperature sensor amplifier through the transformer coupled output circuit of the cabin temperature sensor. This signal is amplified and the amplifier output signal is used for telemetry purposes.

PERFORMANCE AND DESIGN DATA

Table 6-1 lists performance and design data and Figure 6-1 presents the outline for this transducer.

FAILURE REVIEW

Table 6-2 is a summary of five failure reports against eight units of this transducer. One of the units was damaged in handling. The remaining units had not failed and because this design was superseded no further action was taken. Design change was initiated because of end assembly design change which created new physical and functional requirements for this transducer.

TABLE 6-1

PERFORMANCE AND DESIGN DATA FOR PN 836064-1

Performance Requirements:

- a. Operating temperature range: 20°F to 95°F
- b. Accuracy: $\pm 1.0^{\circ}$ F ($\pm 1.33\%$ of total operating range) between 60° F and 90° F and $\pm 1.5^{\circ}$ F ($\pm 2.0\%$ of total operating range) at 20° F and 95° F
- c. Output signal: Proportional to sensed temperature. Zero at 20° F and 59 mv peak-to-peak, sq wave (with 260 ±2.6 ohm load) at 95° F
- d. Output impedance: 500 ohm max.
- e. Time constant: 6.0 sec max.
- f. Power dissipation of sensing element: 46 mw max.

Bridge Excitation Voltage: 5.4 v peak-to-peak, 300 cps, sq wave at 140 ma max.

Operating Pressure:

a. Max: 16 psia

b. Normal: 5 psia

Environmental Conditions: Per AiResearch Report SS-1060-R; Type I equipment

Installation Envelope: Per AiResearch Drawing 836064

Weight: 0.2 lb

Electrical Connector: In accordance with MIL-C-26482C

Radio Noise: In accordance with NAA Specification MC 999-0002A

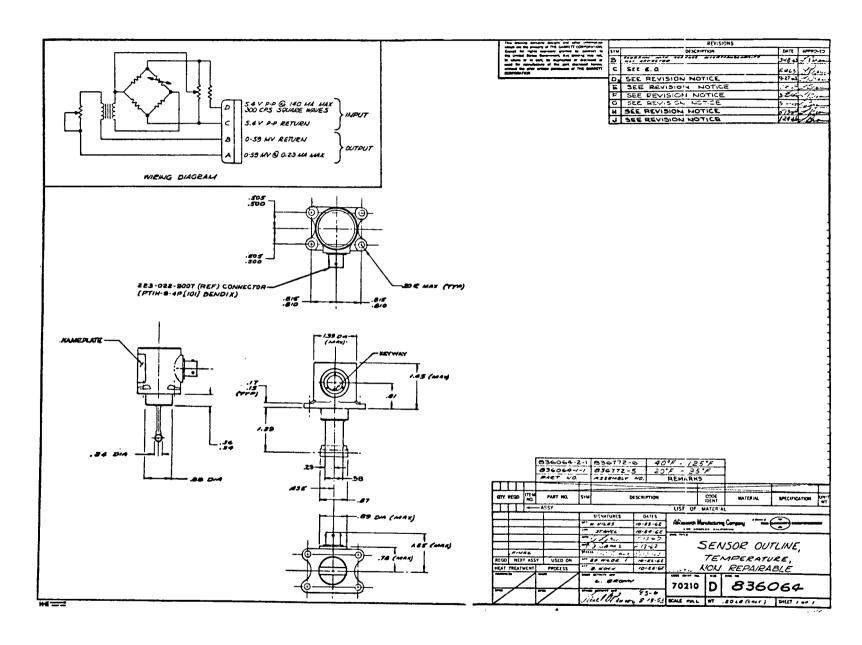


Figure 6-1. Altered Outline of Cabin Temperature Transducer.

TABLE 6-2

FOLDOUT FRAME

TRANSDUCER A	\PPLICATIO	ON <u>CABI</u>	N TEMPERATUR	E TRANSDU	CER (BLOCK I)		TRANSDUCER TYPE TEM	PERATURE		
BASIC PART N	IUMBER	836064					OPERATING PRINCIPLE	RESISTANCE BRIDGE		
TRANSDUCER N	MANUF. AI	RESEARCH					MEASUREMENT RANGE2	i		·
TROUBLE REPO	ORT SOURCE	E AIRES	EARCH				MEASUREMENT MEDIAGA	\$		
PART NUMBER	SERIAL NUMBER	FAILURE DATE	T/R NUMBER	FAILURE TYPE	FAILURE MODE	FAILURE MECHANISM	FAILURE CAUSE	PROBLEM AREA	CORRECTIVE ACTION	COMMENTS
836064-1	104-107 ε 104-108	10-29-65	6601	NONE	HIGH OUTPUT VOLTAGE	NOT A FAILURE				
	104-107 E 104-108	6-4-65	7201	NONE	HIGH OUTPUT VOLTAGE	NOT A FAILURE				
836064-1	104-107	6-4-65	5897	NONE	HIGH OUTPUT VOLTAGE	NOT A FAILURE				
836064-1	104-107	1-4-65	5044	NONE	HIGH OUTPUT VOLTAGE	NOT A FAILURE				
836064-2	16-128	2-24-66	8427	HUMAN	DAMAGED	MISHANDLING	ACCIDENT	HANDLING	NONE	
										·
							·			



AIRESEARCH MANUFACTURING COMPANY

Los Angeles, California

REPORT ON FAILURE AND DESIGN EVALUATION OF APOLLO ECS OXYGEN FLOW TRANSDUCER TEMPERATURE SENSOR WITH ELECTRONICS TYPE

CONTRACT NO. NAS 9-12452

72-8537-22, Rev. 1

February 10, 1973

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Prepared for

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ABSTRACT

This report presents the results of a failure and design evaluation study conducted on the Apollo ECS oxygen flow transducer, the generic group of temperature sensor with electronics type flow transducer. The study was conducted for NASA-MSC by the AiResearch Manufacturing Company, a division of The Garrett Corporation under Contract NAS9-12452.

The study purpose was to evaluate the integrity of design of this type transducers. Failure information is presented and summarized pertaining to one transducer design. A failure matrix is presented which describes the failure mode, type, mechanism, cause, and problem areas for 37 rejections out of a lot total of 63 units.

This unit has had and continues to have much problems with its flow sensing and signal conditioning package designs. A critical design review and redesign effort for this transducer is warranted.

CONTENTS

Section		Page
1.	INTRODUCTION	1-1
2.	DESCRIPTION, FAILURE SUMMARY, AND RECOMMENDATIONS FOR TEMPERATURE SENSOR AND ELECTRONICS TYPE OXYGEN FLOW TRANSDUCER	2-1
	Introduction	2-1
	Purpose and Description	2-1
	Performance and Design Data	2-1
	Qualification Status	2-1
	Failure and Design Review	2-1
	Recommendations	2-9
Addendum	A DESIGN INFORMATION ON SUPERSEDED VENTURI TUBE WITH ELECTRONICS TYPE FLOW-RATE TRANSDUCER	A-1

INTRODUCTION

This report presents a summary of failure data of the generic group of temperature sensor with electronics type flow transducers, one of several flow transducer types that are described and categorized in AiResearch Report No. 72-8537-21.

The flow transducers evaluated in this report were used in the Apollo environmental control system (ECS). This flow transducer may be used to perform any other flow sensing function with similar requirements.

The flow transducer which is evaluated and summarized in this report is the Apollo oxygen flow transducer, PNs 836112 and 836136. These two part numbers are identical in design with the only difference that PN 836136 has an epoxy and bonding material used in its seal installation while PN 836112 does not use this bonding agent. Detail failure data, a summary, and description information on this flow transducer are presented in Section 2 of this report.

DESCRIPTION, FAILURE SUMMARY, AND RECOMMENDATIONS FOR TEMPERATURE SENSOR WITH ELECTRONICS TYPE FLOW TRANSDUCER

INTRODUCTION

The initial design of oxygen flow transducer PN 836028 was implemented at early stages of Apollo Block I ECS. Only five units of this part number were delivered. This transducer, which had a venturi tube sensing element, was replaced by a new design, PN 836112, which was implemented on Apollo Block I ECS. This design was later modified to PN 836136 by incorporation of epoxy bonding agent in its seal installation. This modified transducer was implemented on Apollo Block II ECS. The new design is analyzed in this section. The previous design which utilizes a venturi tube and sensor will not be analyzed because of its limited population and lack of data. Engineering data on this transducer is presented in Addendum A of this report.

PURPOSE AND DESCRIPTION

A typical isometric drawing of the current oxygen flow transducer is presented in Figure 2-1. The subject flow rate transducer, in Apollo ECS application, measures the rate-of-flow from the main oxygen supply. The flow sensing element is located at the outlet of the oxygen pressure regulator assembly. This transducer is powered by the 28 vdc supply of the spacecraft and operates over a flow range of 0.2 to 1.0 pounds per hour. An electrical signal (0 to 5 vdc) proportional to the oxygen flow-rate is provided by the transducer. This signal is used for ground checkout, for the crews visual information, via an indicator for telemetry data to be transmitted to a ground station. A static switch is actuated in the event of an overflow condition (at 2 pound per hour), which turns on an indicator light.

PERFORMANCE AND DESIGN DATA

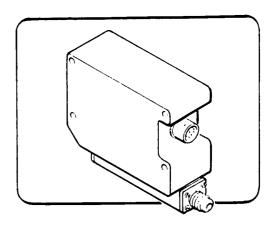
Table 2-1 presents the performance and design data and Figure 2-2 presents the altered outline drawing of this flow-rate transducer.

QUALIFICATION STATUS

The oxygen supply flow rate transducer is a qualified Block II Apollo component.

FAILURE AND DESIGN REVIEW

Table 2-2 is a summary of 38 failure reports written against 37 units of 836112 and 836136 configurations of this transducer. As it was mentioned above, the 836136 design is identical to 836112. The only difference between the two part numbers is that 836136 includes on epoxy adhesive in its seal installation



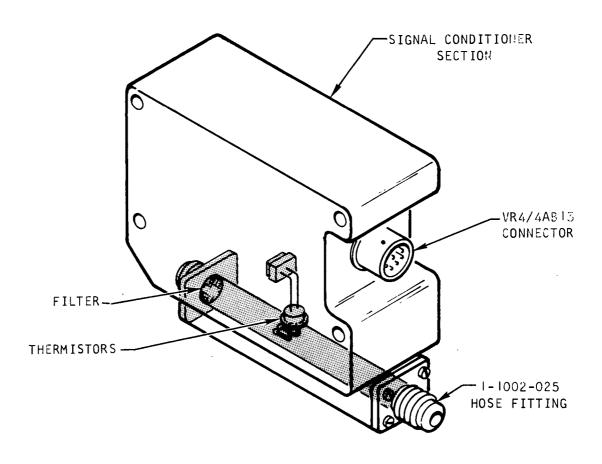


Figure 2-1. Isometric Drawing of a Current Oxygen Flow Transducer

A-11835



TABLE 2-1

Operating flow range, 1b/hr 0.2 to 1.0 Max. overflow, 1b/min 0.7 (42 lb/hr) ± 0.048 (± 0.30 v) 0 to 150° F Accuracy, 1b/hr Differential pressure 1.0 psi max. at 2.0 lb/hr and 100 psig inlet 8.0 psi max. at 0.7 lb/min and 100 psig inlet Operating temperature range, OF -40 to +165 (ambient 0 to 150) 15 max. (to 63.2% with applied step Time constant, sec flow rate) 0 v at 0.2 lb/hr at 5.0 vdc at 1.0 Output signal 1b/hr 6.5 vdc max. at greater flow Ripple component of output signal shall Output ripple, mv rms not exceed 20 Output load, ohm 30,000 500 (max.) Output impedance, ohm MS 33656-4 (1/4 in. OD tube) Fitting ends 85 to '140 (100 nominal) Line pressure, psig 210 Proof pressure, psig Burst pressure, psig 350 6×10^{-6} lb/hr 0_2 max. with 140 psig External leakage internal pressure at 70°F Electrical power requirements Input voltage, vdc 28 per S-1070 80 (max.) Excitation current, ma Weight, 1b 1.0

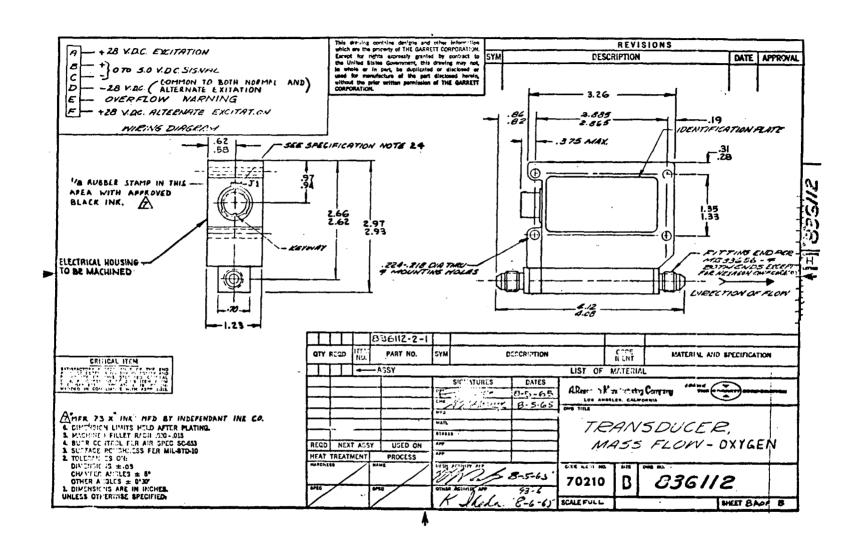


Figure 2-2. Outline Drawing of Oxyger Flow Transducer

FOLDOUT FRAME

TABLE 2-2

OXYGEN FLOW-RATE TRANSDUCER FAILURE EVALUATION

TRANSDUCER	APPLICATI	0 _N 0 ₂ F	LOW TRANSD	UCER		TRA	NSDUCER TYPE 02 F			
BASIC PART I							RATING PRINCIPLE TE			
TRANSDUCER	MANUF	TYLAN F	N 311-2				SUREMENT RANGE 0 to			
TROUBLE REP	ORT SOURC	E AIRE	SEARCH/NOR	TH AMERICA	N ROCKWELL	MEA	SUREMENT MEDIAOXYO	GEN		4100-
PART NUMBER	SERIAL NUMBER	FAILURE DATE	T/R NUMBER	FAILURE TYPE	FAILURE MODE	FAILURE MECHANISM	FAILURE CAUSE	PROBLEM AREA	CORRECTIVE ACTION	COMMENTS
836112-2-1	0040	6-7-67	14181	Human	High output	Sensing probe	Out of position	Manufacturing	improve Manufacturing Quality Control and all parts photographo before delivery.	
836112-2-1	0045	4-12-67	14158	Elect.	Out of tolerance	Electronics package	Faulty thermistor	Unknown	None.	
836112-2-1	0038	2-13-57	13098	Human	Out of tolerance	Wrong part sensing probe	Block part should be Block	Manufacturing	Replace Block II part and assembly passed test	
836112-2-1	0039	12-22-66	12556	Human	Low output	Sensing probe	Out of position	LOX cleaning	Tylan (sub) improve QC of part during cleaning	
836112-2-1	0030	12-22-66	12555	Human	Low output	Sensing probe	Out of position	LOX cleaning	Tylan (sub) improve QC of part during cleaning	- Harris de la constante de la constante de la constante de la constante de la constante de la constante de la
836112-2-1	0041	12-17-66	12547	Human	Low output	Sensing probe	Out of position	LOX cleaning	Tylan (sub) improve QC of part during cleaning	
836112-2-1	0046	12-8-66	11990	Human	Intermittant output	Short	Moisture leakage from excessive ex- ternal pressure.	Design	Unit redesign to withstand higher spacecraft external pressure	
836112-2-1	0041	11-18-66	11935	Human	Out of tolerance	None !	Excessively tight tolerance	Design	SCD revised to open up tolerance	PART DID NOT FAIL
836112-2-1	0024	9-20-66	11301	Human .	Low output	Altered flow path	Inlet screen damage change flow path cause pressure drop	Design	Inlet screen rede- sign to minimize in- stallation damage	



TABLE 1-2 (CONTINUED)



TRANSPICER A	APPLICATIO	ONO ₂	FLOW TRANS	DUCE.			TRADSDUCER TYPE	U2 FLOWMETE		
BASIC PART N	IUMBER	836112-2	-1				OPERATING PRINCIPLE	TEMPERATURE CHANGE		
TRANSDUCER 1	MANUF	TYLAN P	N 311-2				MEASUREMENT RANGE O to			I
TROUBLE REPO	ORT SOURC	E AIRE	SEARCH/NOR	TH AMERICA!	ROCKWELL		MEASUREMENT MEDIA 0			
PART NUMBER	SERIAL NUMBER	FAILURE DATE	T/R NUMBER	FAILURE TYPE	FAILURE MODE	F/ILURE MECHANISM	FAILURE CAUSE		CORRECTIVE ACTION	COMMENTS
836112-2-1	0030	9-8-66	11122	Human	No flow	Electronics package	Subjected to out of specification voltage	Testing	None	
836112-2-1	0020	8-31-66	11110	Mechanic	al Fixed output	Electronic package	Stuck relay	Random	None	
836112-2-1	0039	8-12-66	10902	Human	Low output	None	Impediment in flow path by test equipment	Test	Seal extruded in flow path. Replace seal with one that does not extrude	No failure
836112-2-1	0017	1-10-66	8219	Human	High output	Unknown	Unknown	Unknown	None	Unconfirmed failure
736112-2-1	0018	1-4-66	6620	Human	Output out of tolerance	Un known	Unknown	Specification (design)	Waiver grant to accept part	
836112-2-1	0017	10-27-65	7464	Human	High output	Unknown	Unknown	Unknown	None	Unconfirmed failure
836112-2-1	0019	10-27-65	7463	Human	No output	Electronics package	Shorted diodes	Testing	None. Random test procedure renewed	Input power inad- vertently applied to output.
836112-2-1	0019	12-11-65	6613	Human	Out of calibration	None	Test equipment	Testing	Test equipment corrected	
836112-2-1	0016	10-24-65	7204	Human .	Excessive EMI generated	EMI filters	Inadequate filter	Des i gr.	None	Waiver qualified to continue testing



TRANSDUCER A	APPLICATI	ON 02 FI	LOW TRANSDU	CER		TRAN	NSDUCER TYPE 02	FLOWMETER		
BASIC PART N	NUMBER	836112-2	-1				RATING PRINCIPLE			
TRANSDUCER I	MANUF	TYLAN PN	311-2				UREMENT RANGE 0			
TROUBLE REP	ORT SOURC	E All	RESEARCH/NO	RTH AMERIC	AN ROCKWELL		SUREMENT MEDIAOXY			
PART NUMBER	SERIAL NUMBER	i i	T/R NUMBER	FAILURE TYPE	FAILURE MODE	FAILURE MECHANISM	FAILURE CAUSE	PROBLEM AREA	CORRECTIVE ACTION	COMMENTS
836112-1	0013	7-20-65	5761	Human	Fixed output	Electronics package	Overvoltage spikes	Des i gn	Design change to in- corporated high volt age spike	
836112-1	0011	6-26-65	6758	Human	Insulation resis- tance too low	Solder joint case	Imperfect case seal	Design	Design improved PN 836112-2 replace	
836112-1	0007	6-7-65	6284	Human	Low output	Altered flow path	Inlet screen damage cause pressure drop		Revised test pro- cedure - increasing Ap	
836112-1	009	6-7-65	6283	Human	Insulation resistance	Leaky case	Imperfect case joint	Des i gn	Redesign in progress	836112-2 replaces 836112-1
836112-1	0006	4-7-65	6779	Unknown	Low insulation resistant to ground connector pins	Unknown	Unknown	Unknown	None	Uncomfirmed failure
836136-1-1	0054	9-30-67	15177	Human	Low output	Distortion	Overtorques	Manufacturing	Torque stripe used with revised test procedure	
836136-1-1	0039	9-6-67	15163	Human	Low output	Distortion	Overtorques	Manufacturing	Torque stripe used with revised test procedure	
836136-1-1	0029	8-25-67	14619	Human	Fixed output	Signal condition	Input power applied to output	Testing	Test adaptor changed so that they are dis to misapplication of power source	similar
				·						



TRANSDUCER	APPLICATI	ON 02	FLOW SENSO)R		TRA	NSDUCER TYPE 0	₂ FLOWMETER			
BASIC PART I								TEMPERATURE CHANGE			
TRANSDUCER	MANUF	TYLAN (F)	1S 339-2 fo	or 836136-2)*			0 to 1 lb/hr			
TROUBLE REP	ORT SOURC	E AIRES	EARCH AND N	IORTH AMERI	CAN ROCKWELL			DXYGEN			
PART NUMBER	SERIAL NUMBER	FAILURE DATE	T/R NUMBER	FAILURE TYPE	FAILURE MODE	FAILURE MECHANISM	FAILURE CAUSE	PROBLEM AREA		CORRECTIVE ACTION	COMMENTS
836136-2	0071	2-9-70	20336	Elect.	Low output	Signal conditioners amplifier temperature shift	Resistor failed	None		Failure rred during in	
836136-2	56	11-4-69	18772	Elect.	0pen	Signal conditioners amplifier converter		Testing	None		Support transistor burst, opens incorrect circuit
(836136-2) ME449-0129 -0001 MEM9.2	54 or 4000	7-17-69	PF 107500	Elect.	0pen	Signal conditioners amplifier signal shifted	Open capacitor	Apollo Flight #12	None		
836136-2	68	4-28-69	19171	Human	Low output	North American has s on this			None		Occurred during burnin.
836136-2-1	57	4-8-69	61243 (NR)	Human	No output	Signal conditioner	Transitor burnt open	Manufacturing or Testing		Design change rogress	Suspect was applied voltage
836136-2-1	70	2-5-69	19152	Human	No output	Signal conditioner	Weld from chip to emitters failed open	Manufacturing		Occurred during in test	·
836136-2-	70	12-17-68	19137	Human	Improper signal (erratic)	None	None	Incorrect test setup	None		
836136-2	64	10-13-68	19196	Human	No output	Signal conditioner	Output zenier diode failed open	Testing		Purpose of in test	Overvoltage applied.
836136-2	56	5-1-68	16622	Human	Output High	Signal conditioner	Stabilization	Des ign			Part burnin stabilizes output however, failed in this case. Design i susceptible to shift

^{* 836136-1} Tylan FMS 311-37 836136-2 Ident. T0836136-1 except for testing.



which is not included in 836112 design. Random failures were responsible for five (5) rejections (13.5%), unconfirmed failures were responsible for three rejections (8.1%), and one rejected unit (2.7%) was not analyzed. Design problems, manufacturing errors, and testing errors were responsible for the remaining 28 rejections (75.7%). Figure 2-3 presents the failure matrix of this transducer. The major problem of this transducer is with its sensing elements and signal conditioning package design which has been responsible for 12 failures (32.5%). Figure 2-4 presents the distribution of all rejections according to problem area. Figure 2-5 presents the distribution of relevant failure reports according to problem area.

RECOMMENDATIONS

Most of the design problems of this flow transducer are not resolved. Therefore a meticulous design review and careful redesign effort is recommended. The manufacturer of this transducer, the Tylan Corp., has developed a commercial type flow transducer which utilizes three coils as the sensing element and a newly designed and improved signal conditioning package. The principle of operation of the sensing element is the analogy of the increase in the sensed temperature level by the downstream coil as compared to the indication of the temperature level by the upstream coil as a result of premeasured amount of heat input to the media by the heating coil which is located between the two sensing coils. Of this new design, during the past 4 year period, over 2000 units have been in commercial applications with very satisfactory results. It is recommended to have this commercial design studied for possible aerospace packaging, correction of "g" sensitivity, and demonstration of compliance with SSV vibration requirements.

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							`													LOCATION	WIRING PART	DISTORTION		FAULTY COMP	SHORT	TIGHT TOLL	- 1	HIGH INPUT VOLT	UNKNOWN	MISCONNECTED	INADEQUATE PART	VOLTAGE SPIKES	SEAL	FAULTY WELD	STABILIZATION		NIMONIA NI		Figure 2-3. Fl Fa	ow T ilur	ransducer e Matrix.

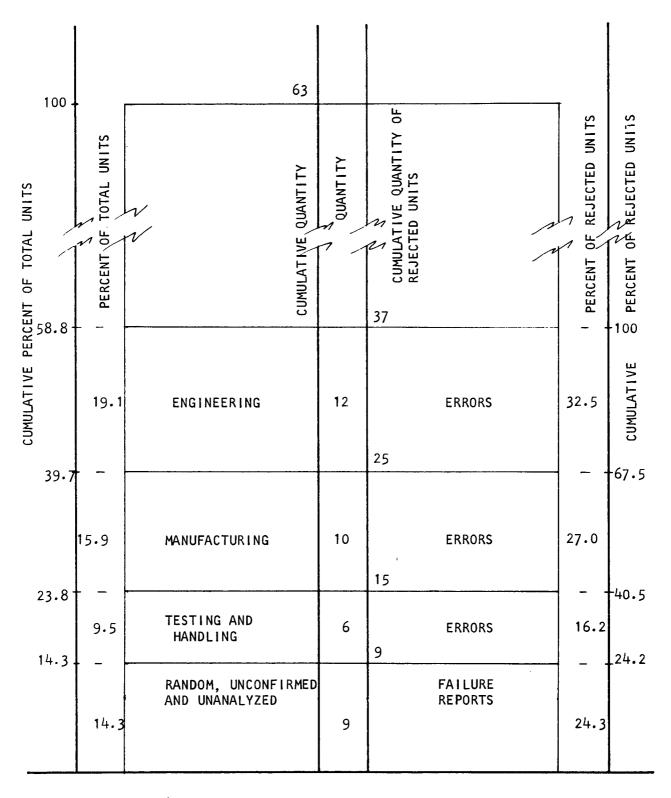


Figure 2-4. Distribution of all Failure Reports According to Problem Area for Oxygen Flow-Rate Transducer.



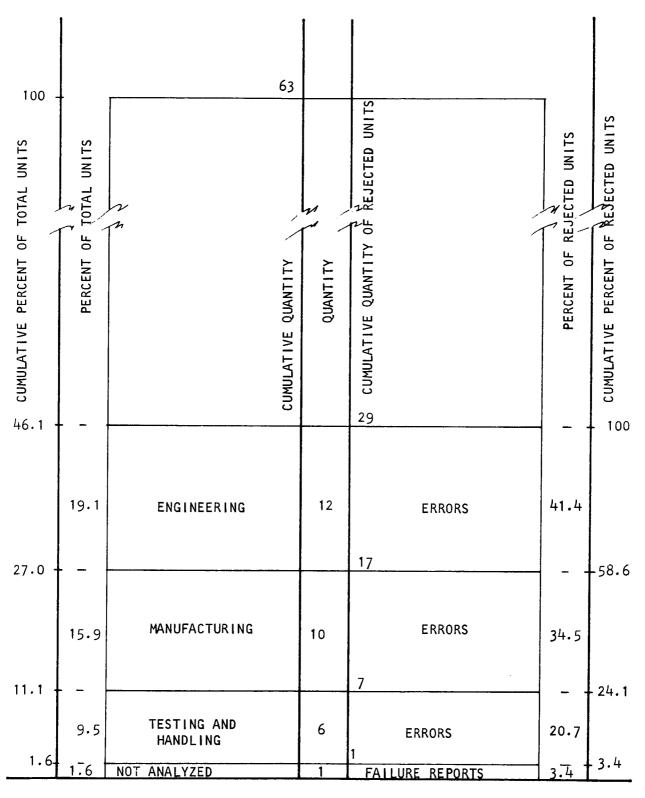


Figure 2-5. Distribution of Relevant Failures According to Problem Area for Oxygen Flow-Rate Transducer.



ADDENDUM A

OXYGEN SUPPLY FLOW-RATE TRANSDUCER PN 837028-1

FUNCTION AND DESCRIPTION

The flow-rate transducer measures the rate-of-flow from the main oxygen supply. The flow-sensing element is located at the outlet of the oxygen pressure regulator assembly.

In its early Apollo ECS application, the transducer was powered by the 28 vdc supply of the spacecraft and operated over a flow range of 0.2 to 0.5 lb/hr. An electrical signal (0 to 5 vdc) proportional to the oxygen flow-rate was provided by the transducer. This signal was used for ground checkout, for the crew's visual information, via an indicator, and for telemetry data to be transmitted to a ground station.

PERFORMANCE AND DESIGN DATA

Table A-1 presents the performance and design data and Figure A-1 presents a typical isometric drawing of this flow rate transducer.

TABLE A-1

Performance Requirement:

- a. Operating flow range: 0.2 to 0.5 lb/hr
- b. Max. overflow: 0.7 lb/min (42 lb/hr)
- c. Accuracy: ±0.018 lb/hr. Also refer to k
- d. Differential pressure: 1.0 psi max. at 0.5 lb/hr. 2.0 psi max. at 0.7 lb/min
- e. Operating temperature range: -110°F to +25°F (ambient 0 to 200°F)
- f. Time constant: Within 30 ms
- g. Output signal: 0 v at 0.2 lb/hr to 5.0 vdc at 0.5 lb/hr
- h. Output ripple: Ripple component of output signal shall not exceed 10 mv, rms.
- i. Output load: 30,000 ohm
- j. Output impedance: 500 ohm max.
- k. Environmental error band: Output signal error resulting from the combined effects of non-linearity, repeatability, and input voltage fluctuation during any rational combination of environmental conditions specified in AiResearch Specification SS-1060-R shall not exceed $\pm 6.0\%$ (± 0.3 v) of full scale from 0 to 100% of flow range.

Structural Requirements:

- a. Line pressure: 85 to 140 psig (100 psig nominal)
- b. Proof pressure: 210 psig
- c. Burst pressure: 350 psig

External Leakage: Zero with 140 psig internal pressure

Electrical Power Requirements:

- a. Input voltage: 28 ±4 vdc
- b. Excitation current: 60 ma max.



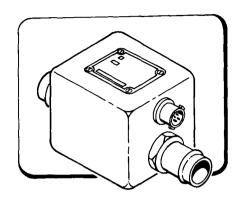
TABLE A-1 (Continued)

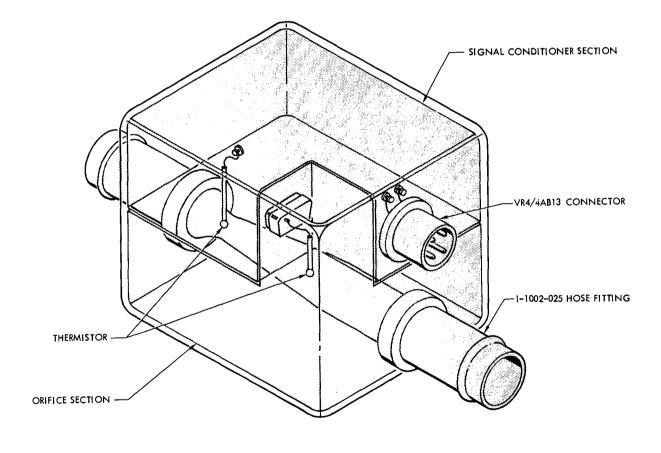
Environmental Conditions: Per AiResearch Report SS-1060-R; Type I equipment

Installation Envelope: Per AiResearch Drawing 837028

Weight: 1.0 lb max.

Electrical Connector: In accordance with MIL-C-26482C





S-32-136

Figure A-1. Typical Isometric of Oxygen Flow Transducer Venturi Tube With Electronics Type.



AIRESEARCH MANUFACTURING COMPANY

Los Angeles, California

REPORT ON FAILURE AND DESIGN EVALUATION
OF APOLLO ECS VALVE POSITION
INDICATOR SWITCHES
CONTRACT NO. NAS 9-12452

72-8537-51, Rev. 1

February 10, 1973

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Program Manager

Prepared for

NASA MANNED SPACECRAFT CENTER HOUSTON, TEXAS 77058

ABSTRACT

This report presents the results of a failure and design evaluation study conducted on precision switches that were used in the Apollo Lunar Module ECS. The switches were assembled to valves, regulators and other components in the ECS for the purpose of providing a telemetry signal that was indicative of valve position. The Valve Position Indication (VPI) switches were also used as control switches to open or close electrical circuits for remote actuation of other components in the system.

The failure and design evaluation study of VPI switches is part of the Apollo ECS Transducer Study Program being conducted for NASA-MSC by the AiResearch Manufacturing Company, a division of The Garrett Corporation under Contract NAS 9-12452.

The purpose of this study was to evaluate the history of VPI switch failures and associated design documents and to make recommendations to reduce the failures of these switches for possible use in future Aerospace Programs. The failure reports, diagrams and technical information contained in this report were taken from NASA furnished documents that were supplied as an input to this study.

CONTENTS

Section		<u>Page</u>
1	INTRODUCTION	1 - 1
2	DESCRIPTION AND APPLICATION OF PRECISION SWITCHES	2-1
3	FAILURE EVALUATION	3-1
4	RECOMMENDATIONS AND CONCLUSIONS	4- 1

SECTION 1

INTRODUCTION

This report presents a summary of the failures experienced with the use of precision switches for monitoring value position and for switching other system valves and controls in the Lunar Module ECS. Fourteen (14) Valve Position Indicator (VPI) switches and nine (9) control switches were used in eight (8) different component items in each Environmental Control System (ECS) for the Lunar Module.

The VPI switches provide an open or closed signal to stimulate a telemetry signal and also cause panel lights to illuminate on the crew monitoring panels. The application of the VPI switches were found to be troublesome because the mechanical displacement required for switch actuation was transmitted through several component parts in their next assembly valves. The tolerance and gaps associated with the component parts required each VPI switch to be shimmed to its next assembly valve. In spite of this, switch operation was reported to be intermittent and frequently the VPI would stay actuated even after the valve handle was restored to the original (switch open) position.

The addition of the VPI switches required the component parts of the next assembly valves to be made to closer tolerances and also required acurate cam surfaces to be made for actuating the switches. These costs plus the cost of the VPI switches could have been better spent on flow, pressure or temperature transducers that could be used to provide continuous performance monitoring of the ECS. The VPI switches were redundant to visual inspection by the crew and also to the voice link for verification of proper subsystem configuration.

SECTION 2

DESCRIPTION AND APPLICATION OF PRECISION SWITCHES

The precision switches are position indicating and control switch assemblies used to indicate the position of ECS component controls and to control component electrical power. The valve position indicating (VPI) switch assemblies develop a switch closure (or opening) as an input to the telemetry system.

The switch assemblies were made by Texas Instruments, Inc., Control Products Division, and are identified by Klixon part numbers. These switches were procured in accordance with Hamilton Standard (HS) specifications and are identified by the following HS part numbers:

Hamilton Standard PN	Klixon PN
SV 700952	AT 225-1
SV 707744	AT200
SV 715076	AT250
SV 715077	AT249
SV 712948	10AT52-1 and 10AT53-1
SV 730077	AT298-1

Figure 2-1 is a photograph of position switch SV 715077-2 (AT249-2) and Figure 2-2 contains the outline dimensions for position switch SV 730077 (AT298-1). The size and shape of the other VPI switches used in the LM ECS are similar. The operational characteristics of the VPI switches and their next assembly requirements are summarized in Table 2-1.

A review of the VPI and control switch requirements show them to be unique to the Lunar Module ECS. A total of fourteen VPI switches and nine control switches are used in the valves described below in each LM ECS. Failure reports recorded against the next assembly valves were reviewed to isolate the failure reports that pertained to the precision VPI switches. Table 2-2 describes the LM ECS hardware items that include VPI and control switches.

The following describes the application of the VPI and control switches in the ECS hardware for the Grumman Aircraft Engineering Corp. (GAEC) LM Vehicle:

Item 112 Suit Gas Diverter Valve (GAEC PN 330-112)

The SUIT GAS DIVERTER valve is a manually operated, two-way valve (one inlet and two outlets) with a solenoid override in one direction. When the valve handle is pushed into CABIN position, oxygen is directed into the cabin.

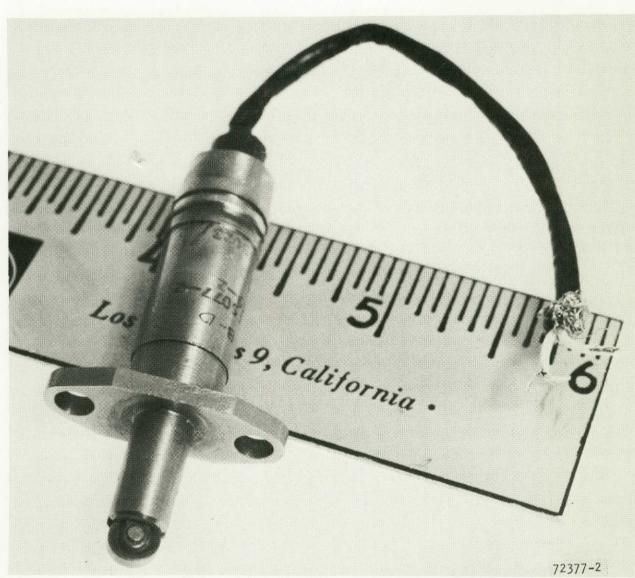
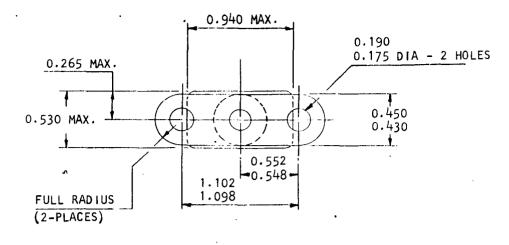


Figure 2-1. Valve Position Switch SV 715077-2(AT249-2)



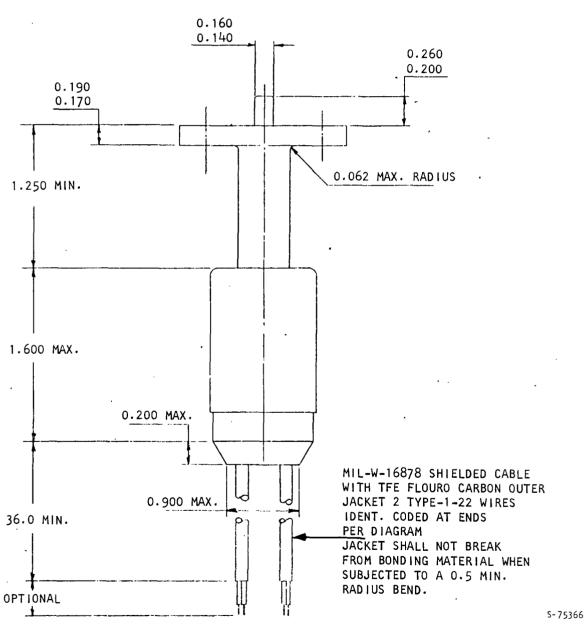


Figure 2-2. Value Position Switch (AT 298-1)

TABLE 2-1 OPERATIONAL CHARACTERISTICS OF VPI AND CONTROL SWITCHES

Application	Lo Level Indicator	VPI	Control Switch	VPI	VPI	VPI	Control Switch	Control Switch (two per unit)
Туре	SPST NC	SPST NC	SPST NO	SPST NC	SPST NO	SPST NC	SPST NC	NC NO
Used in GAEC P/N's 330-	210	113	112	112 309 114	128 117 114	306 138	306 138	306
Amps at rated load	0.002	0.002	3.00	0.002	0.002	0.002	3.00	3.00/switch
Contact resistant at rated load - ohms	0.1	0.1	1.0	1.0	0.1	0.1	0.1	0.2/switch
Voltage rating-vdc	20-32	20-32	20-32	20-32	20-32	20-32	20-32	20-32/switch
Actuation force-max oz	24	24	24	24	24	24	24	8 1b
Release force-min oz	1	ı	1	1	1	1	1	2 lb
Overtravel force-min lb	20	20	20	20	20	20	20	20
Pretravel-max inches	0.010	0.010	0.010	0.010	0.010	0.010	0.010	0.025
Movement differential-max in.	0.005	0.005	0.005	0.005	0.005	0.005	0.005	0.020
Overtravel-min inches	0.125	0.125	0.125	0.125	0.125	0.125	0.125	0.125
Weight-ounces	3.2	2.0	3.1	3.1	3.1	3.3	3.3	4.0 per unit

TABLE 2-2

LUNAR MODULE ECS EQUIPMENT CONTAINING POSITION SWITCHES

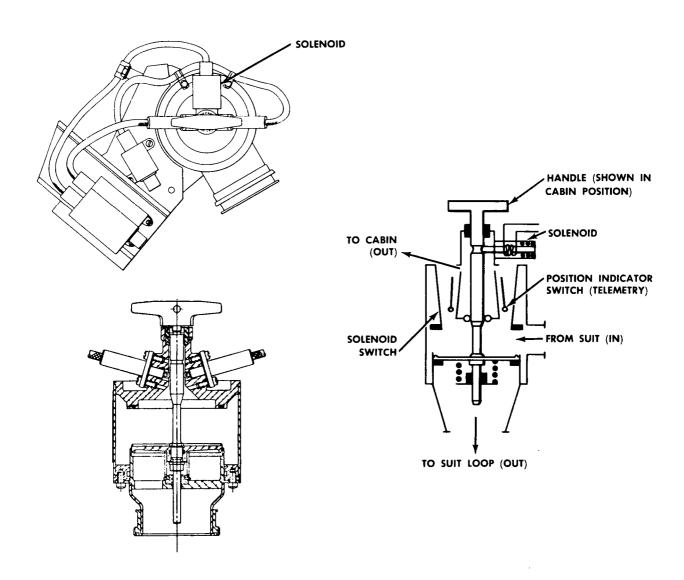
GAEC No. LSC	Component Description	VPI Switch Ham-Std.No.	Measurement, Descrip- tion and Range
330-112	Suit gas diverter valve	SV 715077-2	Suit diverter VPI closed
		SV 707744-2	Open - closed
330-113	Cabin gas return check valve	SV 715077-2	Cabin gas return VPI closed
		SV 707743-2	Open - closed
330-114	LiOH canister selector valve	SV 715077-2	CO ₂ cartridge in sec
		SV 707744-2	No - yes
330-117	Suit circuit relief valve	SV 715077-3	Suit pressure relief VPI open
		SV 707744-3	Open - closed
330-138	Solenoid valve	SV 715077-3	Suit flow control disconnect Open - closed
330-210	Glycol accumulator	SV 707741	Coolant accum. low level ABS - PRS
330-306	Oxygen inflow regulator	SV 715077-4	Oxygen regulator valve locked closed
		SV 707744-4	No - yes
330-309	Cabin repressurization	SV 715077-2	Emergency 0 ₂ valve elec. open
	Solenoid Valve	SV 707744-2	No - yes

The valve is maintained in this position, against main valve spring pressure, by a deenergized solenoid. Pulling the valve handle to EGRESS position overrides the solenoid and permits the valve to reposition to its upper seat, blocking flow to the cabin.

This valve incorporates a normally closed (NC) VPI switch and a normally open (NO) control switch. These switches are shown mounted on each side of the valve shown in the Figure below.

Handle positions - Normal - suit circuit flow open to cabin

Closed - suit circuit flow closed to cabin



Suit Circuit Diverter Valve-Item 112



Item 113 Cabin Gas Return Check Valve (GAEC PN 330-113)

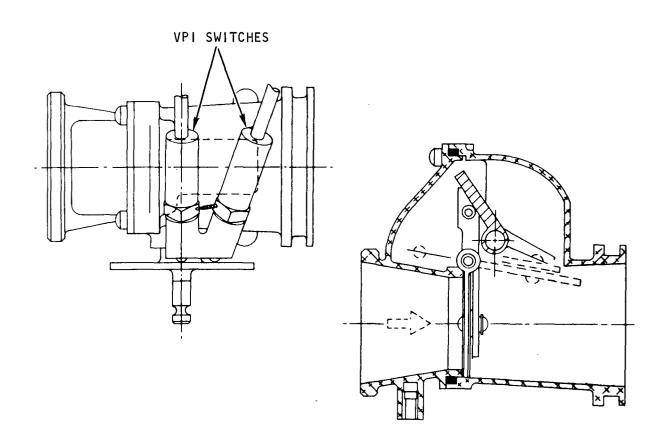
The CABIN GAS RETURN check valve is a spring-loaded, flapper-type valve. The valve has AUTO, OPEN, and EGRESS (closed) positions. In the AUTO position, the valve automatically permits cabin gas to return to the suit circuit. When the cabin is depressurized, the suit circuit pressure closes the valve, preventing backflow into the cabin. The OPEN and EGRESS positions provide manual override of the AUTO position. Valve-position-indicating switches provide telemetry signals when the valve is set to OPEN or EGRESS.

Handle positions - full counterclockwise - valve locked "OPEN"

mid-position - normal operation "AUTO"

full clockwise - valve locked closed "EGRESS"

The figure below shows a sketch of the cabin gas return check valve including the two VPI switches.



Cabin Gas Return Check Valve Item 113



Item 114 LiOH Canister Selector Valve (GAEC PN 330-114)

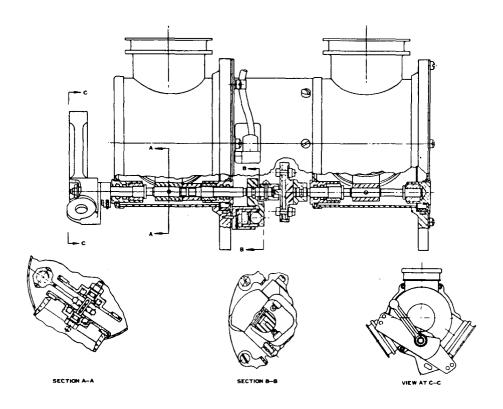
The CO₂ canister selector valve is a dual-flapper-type valve that routes flow through the CO₂ and odor removal canisters. The valve has PRIM and SEC positions. One flapper is at the inlet to the canisters: the other, at the outlet.

Two VPI switches are incorporated on the valve to indicate the position of the selector. One switch is normally opened and the other is normally closed.

Handle positions: Full clockwise - 0_2 flow is through the primary LiOH canister

Full counterclockwise - 0_2 flow is through the secondary (small) LiOH canister

The roller ends of the VPI switches are shown in Section B-B of the figure below.



Sectional View of Lithium Hydroxide Selector Valve Item 114

Item 117 Suit Circuit Relief Valve (GAEC PN 330-117)

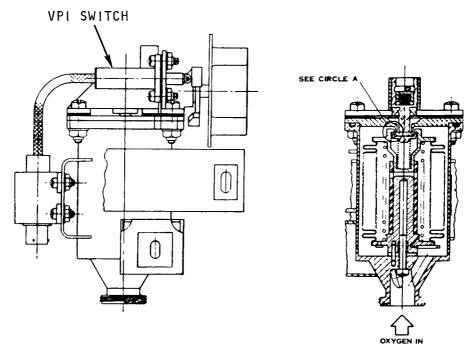
The SUIT CIRCUIT RELIEF valve is an aneroid-operated, poppet-type valve that protects the suit circuit against overpressurization. The valve has AUTO, OPEN, and CLOSE positions. Two externally mounted microswitches provide telemetry signals when the OPEN or CLOSE position is selected.

Handle positions: 180 deg handle rotation

Normal position - relief valve actuated by pressure of an aneroid bellows. Discharge is vented into the cabin.

Closed position - Manual override closes valve to cabin.

The figure below shows one of the two VPI switches mounted on the valve.



HANDLE IN THE NORMAL POSITION - POPPET CLOSED

HANDLE IN THE NORMAL POSITION-POPPET OPEN HANDLE IN THE OPEN POSITION

HANDLE IN THE CLOSED POSITION









Sectional View of Suit Circuit Relief Valve Item 117



Item 138 Solenoid Valve (Suit Isolation Valve) (GAEC PN 330-138)

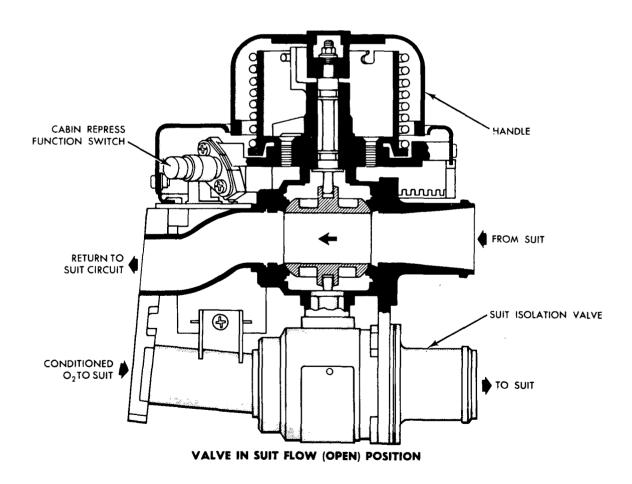
Two of these valves are utilized in the LM ECS. Each valve incorporates a normally closed VPI switch and a normally closed control switch.

The suit isolation valves are manually operated, two-position dual-ball valves. In the SUIT FLOW position, suit-circuit gas is directed through the valve into the Pressure Garment Assembly (PGA), and from the PGA back into the suit circuit. In the SUIT DISC position, the valves keep the gas in the suit circuit bypassing the PGA's and preventing flow in either direction between the suit circuit and PGA's.

Handle positions: Normal - Full counterclockwise and locked. Flow is through the suit.

Bypass - 90 deg clockwise from normal. Flow bypasses the suit.

One of the two switches is shown in the figure below.

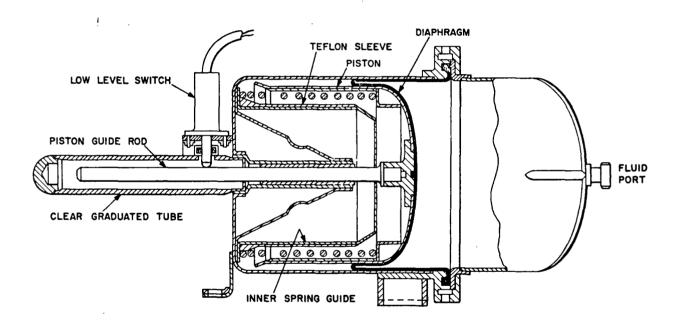


Solenoid Valve (Suit Isolation Valve), Item 138



Item 210 Glycol Accumulator (GAEC PN 330-210)

Each of the two glycol accumulators incorporate a position switch that is actuated by the piston at a point when 10 ± 5 percent of the usable capacity of coolant remains within the accumulator. The figure below shows the position switch and actuator.



Glycol Accumulator, Item 210



Item 306 Oxygen Inflow Regulator (GAEC PN 330-306)

Two oxygen inflow regulators are used in the LM ECS. Each regulator incorporates two NC control switches, a NO control switch and an NC VPI switch. The regulator handle actuates each of the four switches, which control the arming of the electrical switching logic associated with the cabin repressurization solenoid valve (Item 309), the suit circuit diverter solenoid valve (Item 112) and the two cabin air recirculation fans.

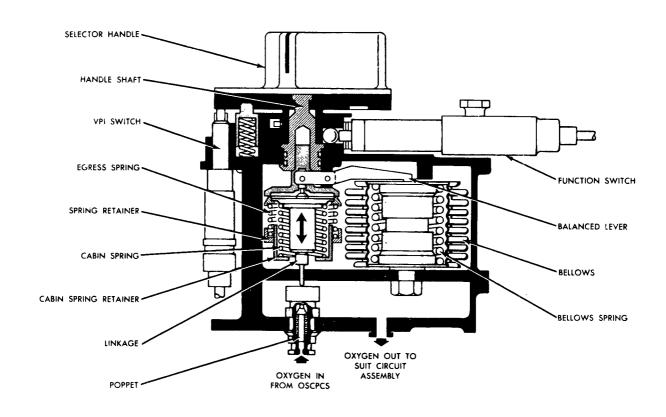
Handle positions: Egress - Valve fully counterclockwise - suit pressure maintained at 3.8 psia.

Normal - 90 deg from egress position - suit pressure maintained at 4.8 psig, cabin maintained at nominal 4.8 psia.

Open - 180 deg from egress position.

Closed - 270 deg from egress position.

Two of the four switches are shown installed on the oxygen inflow regulator in the figure below.



Oxygen Inflow Regulator, Item 306



Item 309 Cabin Repressurization Solenoid Valve (GAEC PN 330-309)

The cabin repressurization and emergency oxygen (CABIN REPRESS) valve is a solenoid-operated valve with manual override (MANUAL and CLOSE positions). It is used to repressurize the cabin after a deliberate decompression and provides an emergency flow of oxygen if the cabin is punctured.

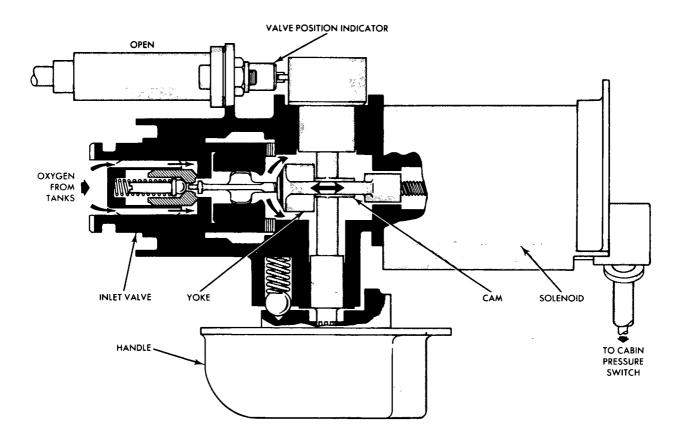
This valve incorporates a single normally closed VPI switch.

Handle positions: Manual open - Full counterclockwise

Automatic - 90 deg clockwise from open

Manual closed - 180 deg clockwise from open

The position switch is shown attached to the cabin repressurization solenoid valve in the figure below.



Cabin Repressurization Solenoid Valve, Item 309



SECTION 3

FAILURE EVALUATION

The NASA furnished failure reports on the precision switches used in the Lunar Module ECS were reviewed to determine if the failure modes and/or causes were repetitive. The most common failure mode was "intermittant switching" resulting from improper shimming of the switch to the next assembly valve. Only 28 failure reports were received from NASA that are summarized on Table 3-1. Several of these reports refer to numerous similar failures giving cause to suspect that the 28 reports do not represent the total failures experienced. Some of the failure reports state that the switching malfunction is a nuisance failure and that inadvertent actuation or de-actuation of the switch is not catastrophic because the valve position can be visually inspected and manually positioned by the crew. In this sense the VPI switches are redundant to the voice link for verification of proper subsystem configuration.

The corrective action stipulated on the failure reports generally specified a re-shimming of the switch to the next assembly valve. Factory shimming procedures were sent out to cover rework to systems delivered. Changes were made to these procedures with little apparent success, since intermittent switching was reported soon after re-shimming was completed and verified.

Very small plunger travel is required to cause the VPI switches to be actuated. Table 2-1 shows that the switch pretravel is 0.010 inches and that a movement differential of only 0.005 inches is required for actuation of the switch. In one application (suit isolation valve item 138 shown in Section 2), more than a half dozen indirect measurements (with cumulative tolerances) are required for the switch installation. In another application (oxygen inflow regulator item 306), a review of the cross sectional drawing in Section 2 of this report shows the housing of the switch to be attached to the lower surface of the upper housing of the valve. The roller/plunger of the switch rides along the lower surface of the selector knob. Any looseness between the knob and the shaft and the shaft and the housing will allow the knob to wobble causing the roller/plunger to change position. This condition is further complicated by the addition of allowable tolerances for imperfections of the cam surface, the lack of normality between the cam surface and the centerline of the shaft, eccentricity of the rotary parts and variations in the pretravel and switch actuation travel of the VPI switches. It is highly conceivable that a dimensional analyses of the component parts of the next assembly valve would show that variations caused by the above described tolerances could result in intermittent switch operation.

The failure reports reviewed indicate that at least three of the switches suspect of failure were returned to Texas Instruments for a teardown analysis. The performance tests, x-ray analysis and detail dimensional check revealed that the switches were not at fault.

One failure was reported where the switch contacts remained closed, regardless of plunger position. A tear-down analysis revealed that the

positive stop was not properly staked in place resulting in movement of the internal parts such that the switch contacts remained closed. X-rays taken of all delivered parts proved this to be an isolated failure.

A breakage of the insulation and fraying of wires was found at the point where the pigtail wires emerge from the hard stycast potting. An ECP E31486 was processed in March 1968 for incorporating a soft EC1663 potting. No failures of this type were reported following the change except for the case of improper handling.

NASA technical report 'Apollo Experience Report - Lunar Module Environmental Control Subsystem' NASA TN D-6724 dated March 1972 indicated that the VPI switches were found to be susceptible to a change in performance (actuation force) with a change in ambient pressure. The control specification SV HS 3023 requires that certain of the VPI switches are to contain a sealed roller/plunger. An actuation force change of approximately 0.25 lb (4 oz) can result when dumping cabin pressure from 14.7 psia ambient to a high vacuum during a chamber test. Less severe; however similar differential pressures can be experienced across the sealed plunger during various mission modes of the LM vehicle. Table 2-1 herein shows that the switches were required to meet a 24 oz max force to actuate the switch with a 1 oz min force for release of the switch point. If the differential pressure acting across the sealed plunger is acting in the direction of keeping the switch depressed, it is possible the return spring force may not be able to deactuate the switch. This condition may explain why certain switches displayed intermittent operation during some of the chamber test runs and later performed satisfactorily when cycled by the failure evaluation committee.

TABLE 3-1

OLDOUT FRAME

VPI SWITCH FAILURE EVALUATION

TRANSDUCER	APPLICATIO	ON <u>VPI</u>	SWITCH SV 71	5077-3		TR	ANSDUCER TYPE PRECIS	SION VALVE POSITION	SWITCH	
BASIC PART	NUMBER	LŞC	330-114 CANI	STER SELE	CTOR VALVE		ERATING PRINCIPLE ME			
TRANSDUCER	MANUF	TEXA	S INSTRUMENT	S (AT 24	9-3)		ASUREMENT RANGE ON			
TROUBLE REP	ORT SOURC	E NASA				ME	ASUREMENT MEDIAME	CHANICAL FORCE		
PART NUMBER	SERIAL NUMBER	FAILURE DATE	T/R NUMBER	FAILURE TYPE	FAILURE MODE	FAILURE MECHANISM	FAILURE CAUSE	PROBLEM AREA	CORRECTIVE ACTION	COMMENTS
LSC 330- 114	ур I S/N 063	8-18-69	FGAH 5688	нимаи	INTERMITTENT SWITCHING	LMPROPER SHIMMING	SHORT SPRING IN SWITCH CAUSES 0.008 OF SHIMMING	INSTALLATION	NONE CONSIDERED NUISANCE FAILURE	NOT CRITICAL SINCE CREW CAN VERIFY POSITION OF CO SELECTOR VALVE
				}						
								·		
								•		



OLDOUT FRAME

TABLE 3-1 (Continued)

	APPLICATIO	,			****	TRA	ANSDUCER TYPE			1	
ASIC PART	NUMBER	LSC	330-117 ŞL	JIT CIRCUIT	RELIEF VALVE	OPI	ERATING PRINCIPLE	MECHANICAL ROLLER	/PLUNC	ER	
RANSDUCER	MANUF	TEX	AS INSTRUME	NTS		ME/	ASUREMENT RANGE	ON-OFF			
ROUBLE REF	PORT SOURCE	NAS	Α			ME/	SUREMENT MEDIA	MECHANICAL FORCE	=		
PART NUMBER	SERIAL NUMBER	FAILURE DATE	T/R NUMBER	FAILURE TYPE	FAILURE MODE	FAILURE MECHANISM	FAILURE CAUSE	PROBLEM AREA		CORRECTIVE ACTION	COMMENTS
-SC 330- 117	NOT SPECI- FIED	3-11-71	FHAA 72608	MECH	EXCESS HANDLE TORQUE	VPI SWITCH PLUNGER CONTAINS SEVERAL AXIAL SCRATCHES	HIGH SURFACE ROUGHNESS ON SWITCH PLUNGER	MANUFACTURING	FOI HIC	NE SINCE SWITCH CE WAS ON THE CH SIDE OF THE OWABLE	ACTUATING FORCE OF 21.6 OZ VS REQUIRED MAX. OF 24 OZ
330- 117	129	9-22-70	FGAJ 5156	HUMAN	VPI DEACTUATION IS 7° BEFORE TRUE DETENT SHOULD BE 5°	IMPROPER SHIMMING	INCORRECT ASSEMBLY	INSTALLATION		VE RESHIMMED REQUIRED	
330- 117	SV715077 -3 S/N 066	9-24-68	FHAA 44895	ME CH	SWITCH FAILED IN CLOSED POSITION	SWITCH OVERTRAVEL STOP MOVED	POSITIVE STOP WAS NOT STAKED	MANUFACTURING	NO	SWITCHES X-RAYED OTHER DISCREP- IES FOUND	
-SC 330- 117	127	3-31-71	FGAJ 6012	HUMAN	INTERMITTENT SWITCHING	IMPROPER SHIMMING	INCORRECT SHIMMING PROCEDURE	INSTALLATION		VISED SHIMMING DCEDURE	
LSC 330-	122	12-27-68	FGAG 6293	HUMAN	SWITCH FAILED IN OPEN POSITION	IMPROPER SHIMMING	INCORRECT ASSEMBLY	INSTALLATION		ITCH SHIMMED	
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72-8537-51, Rev. 1 Page 3-4

TABLE 3-1 (Continued)

ASIC PART N	IIIMRED	ON	•	CH SV 7150	SOLATION VALVE			PRECISION VALVE POSITI		
				STRUMENTS	SOLATION VALVE			MECHANICAL ROLLER/PLUN	GER	
RANSDUCER N			NASA	3 I VOLIENI 2				ON-OFF MECHANICAL FORCE		
ROUBLE REPO	I	T	T ====================================				T TEDIA	TECHANICAL FUNCE		
PART NUMBER	SERIAL NUMBER	FAILURE DATE	T/R NUMBER	FAILURE TYPE	FAILURE MODE	FAILURE MECHANISM	FAILURE CAUSE	PROBLEM AREA	CORRECTIVE ACTION	COMMENTS
LSC 330- 138-1-5	UNKNOWN	11-6-69	FGAH 7929	ME CH	INTERMITTENT SWITCHING	WAS NOT ESTABLISHED	RANDOM MECHANICAL SWITCH FAILURE	NOT DETERMINED	NONE	
LSC 330- 190-3-21	0004	4-1-70	FGAK 1068	HUMAN	INTERMITTENT SWITCHING	VALVE HANDLE	INTERFERENCE BETWEEN VALVE HANDLE AND VPI PLUNGER	DUE TO BUILD-UP OF TOLERANCES	HANDLE REPLACED	
SWITCH SV715077-4 LSC 330- 138	UNKNOWN	5-3-69	FGAH 8408	HUMAN	INTERMITTENT SWITCHING	SUSPECT HANDLE BAD	TOLERANCE BUILD-UP	LOOSENESS OF COMPONENT PARTS GREATER THAN SWITCH THROW	HANDLE REPLACED AND SWITCH RESHIMMED. HANDLE LATER FOUND TO BE OK	CONSIDERED A NUISANCE FAILURE
LSC 330- 138	UNKNOWN	4-29-69	FGAH 6440	HUMAN	INTERMITTENT SWITCHING	IMPROPER SHIMMING OF SWITCH	SHIMMING PROCEDURE INCORRECT	INSTALLATION	SHIM SWITCH PER PER NEW PROCEDURE LCD 3894	
LSC 330- 138	12	5-7-68	FHAA 43417	HUMAN	HANDLE TORQUE HIGH	VPI SWITCH ROLLER WORE GROOVE IN VALVE HANDLE	EXCESS CYCLING DURING QUAL TEST	2850 VALVE CYCLES SHOULD BE 1000 MAX	NONE	
LSC 330- 138	00015	3-5-69	FHAA 56204	HUMAN	INTERMITTENT SWITCHING	IMPROPER SHIMMING OF VPI SWITCH	HANDLE WAS CHANGED AT KSC	INSTALLATION	NONE	
LSC 330- 138	12	5-9-68	FHAA 43418	ELEC	SWITCH REMAINED OPEN SHOULD BE CLOSED	BREAK IN LEAD WIRES	STYCAST (HARD) POTTING CAUSED BREAK IN LEAD WIRES	HANDLING	CHANGED TO SOFT POTTING EC 1663	
LSC 330- 138	10	1-23-68	FHAA 38849	HUMAN	INTERMITTENT SWITCHING	IMPROPER SHIMMING OF VPI SWITCH	SWITCH IMPROPERLY SHIMMED TO VALVE	INSTALLATION	NONE	

FOLDOUT FRAME

TABLE 3-1 (Continued)

TRANSDUCER	APPLICATI	0N <u>VP</u>	I SWITCH			TRA	NSDUCER TYPEPF	RECISION VALVE POSI	TION SWITCH	
BASIC PART	NUMBER	LS	C 330-210 GL	YCOL ACCU	JMULATOR	OPE	RATING PRINCIPLE <u>M</u> E	CHANICAL ROLLER PL	UNGER	
TRANSDUCER	MANUF	TE	XAS INSTRUME	ENTS	ALL DESCRIPTION	MEAS	SUREMENT RANGE <u>O</u> N	N-OFF		·
TROUBLE RE	PORT SOURC	E NA	SA			MEA:	SUREMENT MEDIAME	CHANICAL FORCE		
PART NUMBER	SERIAL NUMBER	FAILURE DATE	T/R NUMBER	FAILURE TYPE	FAILURE MODE	FAILURE MECHANISM	FAILURE CAUSE	PROBLEM AREA	CORRECTIVE ACTION	COMMENTS
LSC 330- 210	108	8-23-68	FGAF- 6525	HUMAN	DEFECTIVE ELECTRICAL WIRING	BROKEN WIRE INSULATION AND WIRE KINKED	MISHANDLING	ASSEMBLY	LOW LEVEL SWITCH IS NOT REQUIRED TO FUNCTION ON LM4, 5, AND 8	
LSC 330- 210	39	7-25-66	A52900	HUMAN	LOW LEVEL SWITCH FAILED TO OPERATE	MISALIGNED SWITCH MOUNTING BRACKET	BRKT WAS NOT DESIGNED TO HOLD SWITCH PARALLEL TO ACCUMULATOR TUBE	DESIGN	BRKT REDESTIGNED	
LSC 330-210	42	10-1-66	A33928	HUMAN	LOW LEVEL SWITCH FAILED TO OPERATE	MISALIGNED SWITCH MOUNTING BRACKET	BRKT WAS NOT DESIGNED TO HOLD SWITCH PARALLEL TO ACCUMULATOR TUBE	DESIGN	BRKT REWORKED	
LSC 330-210	3	1-4-67	A35094	HUMAN	LOW LEVEL SWITCH FAILED TO OPERATE	MISALIGNED SWITCH MOUNTING BRACKET	BRKT WAS NOT DESIGNED TO HOLD SWITCH PARALLEL TO ACCUMULATOR TUBE	DESIGN	BRKT REWORKED	
LSC 330-210	041	12-21-67	UNABLE TO READ	HUMAN	LOW LEVEL SWITCH FAILED TO ACTUATE AT 5-15%	ACCUMULATOR TUBE WAS NOT MARKED CORRECTLY	PREVIOUS REWORK OF ACCUMULATOR LEFT TUBE IN- CORRECTLY MARKED	ASSEMBLY	UNIT CORRECTLY MARKED	
LSC 330-210	121	8-16-68	FHAA 44869	HUMAN	LOW LEVEL SWITCH FAILED TO ACTUATE	SWITCH IMPROPERLY SHIMMED TO ACCUMULATOR	EXCESSIVE AMOUNT OF SHIMS USED	ASSEMBLY	UNIT CORRECTLY SHIMMED	
LSC 330-210	039	8-30-67	A45978	ELEC	FAILED CONTINUITY TEST	NO ANALYSIS	NO ANALYSIS	NO ANALYSIS	NO ANALYSIS	
							·			



FOLDOUT FRAME

TABLE 3-1 (Continued)

TRANSDUCER	APPLICATI	ON	I SWITCH S	SV 715077		TRA	ANSDUCER TYPE	PRECISION VALVE POS	ITION SWITCH	
BASIC PART	NUMBER	LSC 330-	306, OXYGE	N INFLOW RE	GULATOR	OPE	RATING PRINCIPLE	MECHANICAL ROLLER/F	LUNGER	
TRANSDUCER	MANUF	TEXAS IN	STRUMENTS			MEA	SUREMENT RANGE	ON-OFF		
TROUBLE RE	PORT SOURC	E NASA				MEA	SUREMENT MEDIA	MECHANICAL FORCE		
PART NUMBER	SERIAL NUMBER	FAILURE DATE	T/R NUMBER	FAILURE TYPE	FAILURE MODE	FAILURE MECHANISM	FAILURE CAUSE	PROBLEM AREA	CORRECTIVE ACTION	COMMENTS
LSC 330- 306-1-8	0015	6-8-70	FGAK 9928	HUMAN	INTERMITTENT SWITCHING	IMPROPER SHIMMING	SWITCH TRANSFERRED TO NEW NEXT ASSY WITH RESHIMMING	INSTALLATION	NONE SWITCH USED ONLY FOR TELEMETRY INDICATION	O DEMAND REGULATOR EVENT LIGHT IS NOT ON WITH REG IN LOCKED/ CLOSE POSITION
306-1-6	330- 390- 1-11	9-26-68	FGAD 4823	HUMAN	INTERMITTENT SWITCHING	IMPROPER SHIMMING	SWITCH NOT SHIMMED PER FACTORY INSTRUCTIONS	INSTALLATION	RESHIM IN PLACE	
330-306 SV730077	011	11-29-68	FGAD 4861	HUMAN	FAILED TO TURN OFF O SUPPLY WITH REGULATOR IN EGRESS POSITION	LOOSE INTERNAL NUT CRACKED EXTERNAL SOLDER JOINT	MISHANDLING	INSTALLATION	INSPECT ALL INSTALLATIONS FOR CRACKED SOLDER JOINT	
330-306 SV730077	006	12-8-68	FGAD 4872	HUMAN	FAILED TO TURN OFF O SUPPLY WITH REGULATOR IN "CLOSE" POSITION	NONE FOUND	NOT FOUND	NOT FOUND	REPLACE POSITION SWITCH	SWITCH DISASSEMBLED BY VENDOR - NO DISCREPANCY FOUND
330-306	106	6-15-67	FGAA 2755	HUMAN	INTERMITTENT SWITCHING	HANDLE DEFLECTION CAUSED SWITCH TO ACTUATE OR DEACTUATE	NOT REPORTED	NOT REPORTED	NOT REPORTED	
330-306	106	7-12-67	FGAA 5377	HUMAN	POS'N SWITCH NOT SYNCHRONIZED WITH VALVE HANDLE POS'N	HANDLE NOT INDEXED CORRECTLY	INCORRECT ASSEMBLY	INSTALLATION	HANDLE RE-INDEXED	
LSC 330- 306		8-31-67	FGAA 45980	ELEC	FAILED ELEC CONTINUITY TEST	'	WIRING LOGIC DIAGRAM CHANGED	HDWE NOT PER LATEST CHANGE		



SECTION 4

RECOMMENDATIONS AND CONCLUSIONS

Most of the failures associated with the precision switches that were used to indicate valve position in the Lunar Module ECS were attributed to improper shimming of the switch to the next assembly valve. Several of the switches were returned to the manufacturer (Texas Instruments) for a tear down analysis. In only one case where the internal positive stop came loose due to improper staking was the switch found to be at fault. All other failures except for improper handling of the pigtail wires can be attributed to the method by which the switches are actuated in the next assembly valves. This method involves transferring the switch actuating displacement/force through several component parts in the next assembly valve. Section 2 of this report describes these conditions in greater detail.

The following design criteria is suggested for future use of the precision switches described in this report:

Design Criteria

- (a) Design the precision switch next assembly so that there are a minimum number of component parts between the part that supports the body of the switch and the part that actuates the roller/plunger of the switch.
- (b) Incorporate springs or similar means to bias all of the next assembly component parts against known surface(s) so that the looseness of parts do not inadvertently actuate the precision switch(es).
- (c) Provide high rise cams (within good design practices) to ensure overstroke of the switch at the desired valve position.
- (d) Cam surfaces for actuating the roller/plunger on the switch should contain a 32 finish or better and should be hardened to a Rockwell C of 40 to 60 to minimize side loading of the switch plunger and minimize wear of the cam surface.

The following design criteria is suggested for possible re-design of the precision position indicating switches:

- (a) Control maximum and minimum forces for switch actuation, release and overtravel. Control maximum and minimum switch stroke for pre-travel, switch actuation and overtravel. These values as shown in Table 2-1 are only held to one side of the tolerance allowed.
- (b) Design pressure balanced switch seals so that the switch actuation force is not affected by changes in ambient pressure.

(c) Design the switch with dual rollers such that the switch is actuated by differential movement of the two rollers. Both rollers should be spring loaded by a single spring acting against two adjacent cams that are machined relative to each other on a common part. Any movement of the cam surfaces due to tolerances and clearances of the component parts of the next assembly valve would act on both cams simultaneously. The movement would be taken up by the common spring however the differential movement of the two rollers would not be disturbed. This type of design would allow the component parts to be manufactured to standard tolerances at a lower resultant cost.